具有 12GSPS DAC 和 3GSPS ADC 的 AFE7900 4T6R 射频采样 AFE

1 特性

- 申请完整数据表
- 四通道射频采样 12 GSPS 发送 DAC
- 四通道射频采样 3 GSPS 接收 ADC
- 双通道射频采样 3 GSPS 反馈（辅助 RX）ADC
- 最大射频信号带宽：
  - 4TX 或 2FB：1200 MHz 或 2TX：2400 MHz
  - RX）：1200 MHz（无 FB）、600 MHz（带 FB）
- 射频频率范围：
  - TX：5MHz - 7.4GHz
  - RX/FB：5MHz -7.4GHz
- 数字步进衰减器 (DSA)：
  - TX：40 dB 范围，0.125 dB 步进
  - RX 或 FB：25 dB 范围，0.5 dB 步进
- 用于 TX 和 RX 的单频带或双频带 DUC/DDC
- 每个 TX/RX 和 FB 为 16 个 NCO
- 可选内部 PLL/VCO，提供 DAC 或 ADC 采样率下的 DAC/ADC 时钟或外部时钟
- Sysref 对齐检测器
- 串行器/解串器数据接口：
  - 可兼容 JESD204B 和 JESD204C
  - 8 个高达 29.5 Gbps 的串行器/解串器收发器
  - 子类 1 多器件同步
- 封装：17mm × 17mm FCBGA，间距 0.8 mm

2 应用

- 雷达
- 导引头前端
- 国防无线电
- 战术通信基础设施
- 无线通信测试

3 说明

AFE7900 是一款高性能、高带宽、多通道收发器，集成了四个射频采样发送链、四个射频采样接收链和两个射频采样反馈链（总计六个射频采样 ADC）。此器件具有高达 7.4GHz 的工作频率，支持直接在 L、S 和 C 频带频率范围内进行射频采样，无需额外的频率转换级。密度和灵活性提高后可支持高通道数、多任务系统。

TX 信号路径支持插值和数字上变频选项，从而为四个 TX 提供高达 1200MHz 的信号带宽，或者为两个 TX 提供高达 2400MHz 的信号带宽。DUC 的输出驱动一个 12GSPS DAC（数模转换器），通过混合模式输出选项增强在第二奈奎斯特区的运行。DAC 输出包括一个具有 40dB 范围以及 1dB 模拟和 0.125dB 数字步进的可变增益放大器 (TX DSA)。

每个接收器链均包含一个 25dB 范围的数字步进衰减器 (DSA)，后跟一个 3GSPS 模数转换器 (ADC)。每个接收器通道都有多个模拟峰值功耗检测器和各种数字功耗检测器，可辅助进行外部或内部自主自动增益控制器，另外还具有一个射频过载检测器，用于提供器件可靠性保护。灵活的抽取选项可为数据带宽提供高达 1200MHz 的优化（对于四条不带 FB 路径的 RX），或为带两条 FB 路径（每条 1200MHz 带宽）提供 600MHz 的优化。

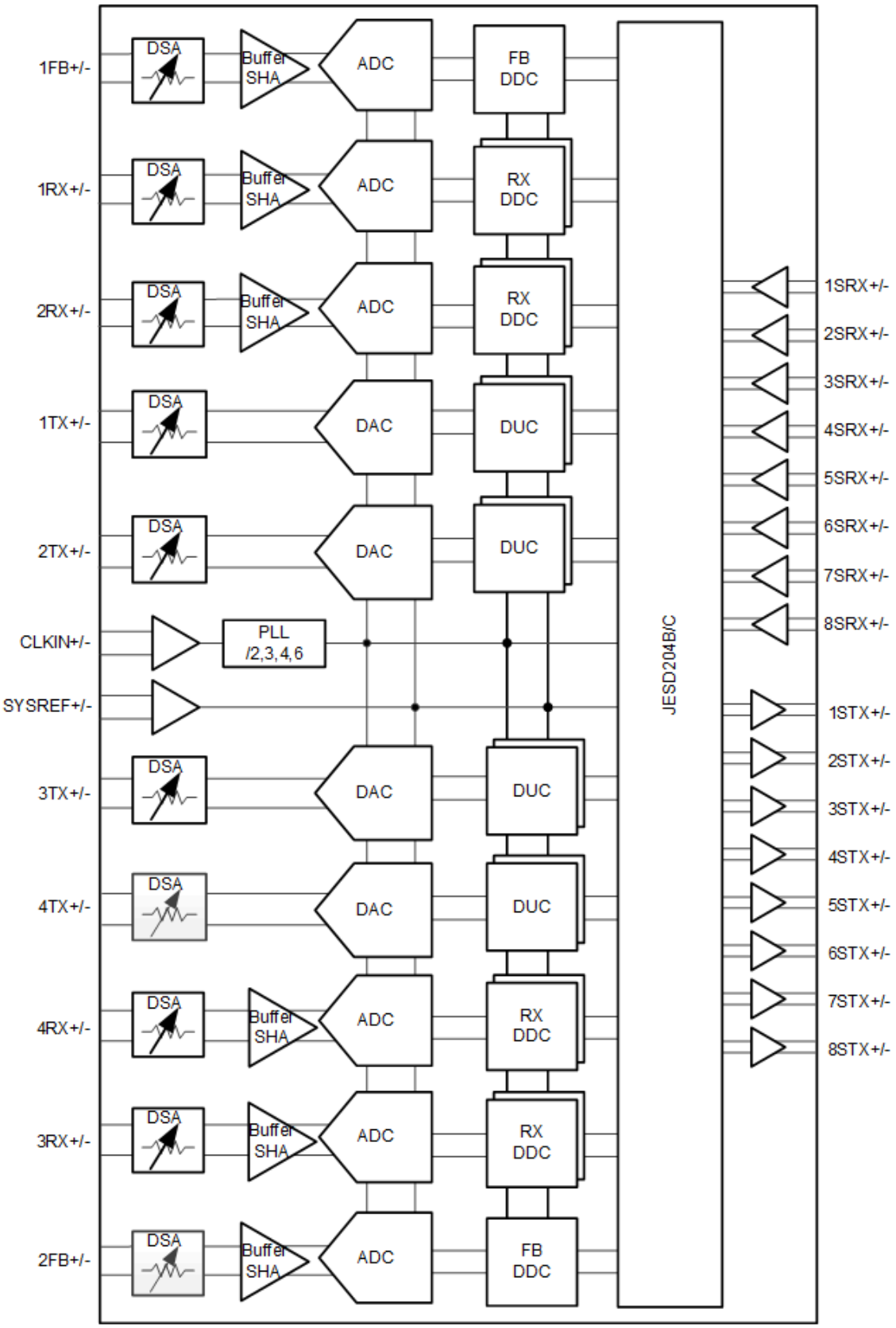
该器件包含一个 SYSREF 时序检测器，用于优化相对于器件时钟的 SYSREF 输入时序。

封装信息

器件型号	封装(1)	封装尺寸(2)
AFE7900	FC-BGA	17 mm × 17 mm

(1) 如需了解更多信息，请参阅*机械、封装和可订购信息*。
(2) 封装尺寸（长 × 宽）为标称值，并包括引脚（如适用）。

本文档旨在为方便起见，提供有关 TI 产品中文版本的信息，以确认产品的概要。有关适用的官方英文版本的最新信息，请访问 www.ti.com，其内容始终优先。TI 不保证翻译的准确性和有效性。在实际设计之前，请务必参考最新版本的英文版本。



功能方框图

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4 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from August 6, 2021 to June 14, 2023 (from Revision A (August 2021) to Revision B (June 2023)) **Page**

- 更改了“封装信息”表以加入注释 2 1
- Changed I_{IH} and I_{IL} units to µA 23
- Changed 0RX - 3RX to 1RX - 4RX in several plots 55
- Changed 0RX - 3RX to 1RX - 4RX in several plots 60
- Changed 0TX - 3TX to 1TX - 4TX 73
- Removed dither plot. This is set automatically in the configuration software 73
- Deleted TX Clock Dither Enabled from all TX Typical Characteristics Sections 73
- Change 0TX - 3TX to 1TX to 4TX in several plots 103
- Removed figure vs dither. This is set automatically in the configuration software 103
- Changed 0TX - 3TX to 1TX - 4TX 116
- Removed dither plot. This is set automatically in the configuration software 116
- Change 0TX - 3TX to 1TX - 4TX 137
- Changed 1st Nyquist zone output to 2nd Nyquist zone output 137

Changes from Revision * (February 2021) to Revision A (August 2021) **Page**

- 向“申请完整数据表”添加了*特性* 1
- Added the Specification tables to the data sheet 4

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5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Supply Voltage Range	DVDD0P9, VDDT0P9	–0.3	1.2	V
	VDD1P2RX, VDD1P2TXCLK, VDD1P2TXENC, VDD1P2PLL, VDD1P2PLLCLKREF, VDD1P2FB, VDD1P2FBCML, VDD1P2RXCML	–0.3	1.4	V
	VDD1P8RX, VDD1P8RXCLK, VDD1P8TX, VDD1P8TXDAC, VDD1P8TXENC, VDD1P8PLL, VDD1P8PLLVCO, VDD1P8FB, VDD1P8FBCLK, VDD1P8GPIO, VDDA1P8	–0.5	2.1	V
Pin Volatge Range	{1/2/3/4}RXIN+/-	–0.5	VDDRX1P8+0.3	V
	1FBIN+/-, 2FB+/-	–0.5	VDDFB1P8+0.3	V
	{1/2/3/4}TXOUT+/-	–0.5	VDDTX1P8+0.3	V
	REFCLK+/-, SYSREF+/-	–0.3	1.4	V
	{1:8}SRX+/-	–0.3	1.4	V
	{1:8}STX+/-	–0.3	1.4	V
	GPIO{B/C/D/E}x, SPICLK, SPISDIO, SPISDO, SPISEN, RESETZ, BISTB0, BISTB1	–0.5	VDD1P8GPIO + 0.3	V
	IFORCE, VSENSE	–0.3	VDDCLK1P8 + 0.3	V
	SRDAMUX1, SRDAMUX2	–0.3	VDDA1P8+0.3	V
Peak Input Current	any input		20	mA
T_J	Junction temperature		150	°C
T_{stg}	Storage temperature	–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	1000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins	150	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

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5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
DVDD0P9, VDDT0P9	Supply voltage 0.9V	0.9	0.925	0.95	V
VDD1P2{RX/TXCLK/TXENC/FB/PLL/PLLCLKREF/FBCML/RXCML}	Supply voltage 1.2V	1.15	1.2	1.25	V
VDD1P8{RX/RXCLK/TX/TXDAC/TXENC/PLL/PLLVCO/FB/FBCLK/GPIO}, VDDA1P8	Supply voltage 1.8V	1.75	1.8	1.85	V
T_A	Ambient temperature	–40		85	°C
T_J	Operating Junction Temperature			110(1)	°C
	Maximum Operating Junction Temperature	125			°C

(1) Prolonged use at or above this junction temperature can increase the device failure-in-time (FIT) rate. Refer to SBAA403 application note for additional details

5.4 Thermal Information

THERMAL METRIC(1)		AFE7900 FC-BGA 400 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	16.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	0.42	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	4.85	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	0.12	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	4.6	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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5.5 Transmitter Electrical Characteristics

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DAC_{RES}	DAC resolution			14		bits
f_{RFout}	RF output frequency range	f_{DAC} = 12 GSPS, 1st Nyquist	5		6000	MHz
		f_{DAC} = 9 GSPS, 1st Nyquist	5		4500	
		f_{DAC} = 9 GSPS, 2nd Nyquist	4500		7400	
		f_{DAC} = 6 GSPS, 1st Nyquist	5		3000	
		f_{DAC} = 6 GSPS, 2nd Nyquist	3000		6000	
P_{max_FS}	Max Full Scale Output Power, max gain 1 tone, at device pins	f_{out} = 10 MHz, f_{DAC} = 6GSPS, -0.1dBFS		6.5		dBm
		f_{out} = 30 MHz, f_{DAC} = 6GSPS, -0.1dBFS		6.5		dBm
		f_{out} = 400 MHz, f_{DAC} = 6GSPS, -0.1dBFS		5.6		dBm
		f_{out} = 850 MHz, f_{DAC} = 5898.24 MSPS, -0.5dBFS		4.3		dBm
		f_{out} = 1800 MHz, f_{DAC} = 5898.24 MSPS, -0.5dBFS		3.2		dBm
		f_{out} = 2600 MHz, f_{DAC} = 8847.36 MSPS, -0.5dBFS		2.3		dBm
		f_{out} = 3500 MHz, -0.5dBFS		2.9		dBm
		f_{out} = 4900 MHz, -0.5dBFS		-0.6		dBm
		f_{out} = 3500 MHz, f_{DAC} = 5898.24 MSPS, -0.5dBFS, straight mode		-2.3		dBm
		f_{out} = 4900 MHz, f_{DAC} = 5898.24 MSPS, -0.5dBFS, straight mode		-3.4		dBm
		f_{out} = 4900 MHz, f_{DAC} = 8847.36 MSPS, -0.5dBFS, straight mode		-3.9		dBm
R_{TERM}	Output termination resistor	Default setting		100		Ω
ATT_{range}	DSA Attenuation range			40		dB
ATT_{step}	DSA Analog Attenuation step			1.0		dB
	DSA Attenuation step accuracy (DNL) (2)	0 < Atten < 40dB, after calibration		±0.1		dB
		0 < Atten < 40dB, before calibration		±0.2		
ATT_{step}	DSA Gain Steps Phase accuracy, any 8dB range(2)	f_{out} = 30MHz		±1		deg
		f_{out} = 400MHz		±1		deg
		f_{out} = 850MHz		±1		deg
		f_{out} = 1800MHz		±1		deg
		f_{out} =2600MHz		±1		deg
		f_{out} = 3500MHz		±1		
		f_{out} = 4900MHz		±1		deg
G_{flat}	Gain flatness	any 20MHz		0.1		dB
		600MHz BW, F_{out} < 4.9G		1.2		

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
IMD3	3rd Order Intermodulation distortion	f_{DAC} =6 GSPS, f_{out} = 5MHz ±1MHz, -7dBFS each tone		-48		dBc
		f_{DAC} =6 GSPS, f_{out} = 30MHz ±1MHz, -7dBFS each tone		-47		dBc
		f_{DAC} =6 GSPS, f_{out} = 400MHz ±2MHz, -7dBFS each tone		-51		dBc
		f_{out} = 850MHz ±10MHz, -7dBFS each tone		-61		dBc
		f_{out} = 1800MHz ±10MHz, -7dBFS each tone		-62		dBc
		f_{out} = 2600MHz ±10MHz, -7dBFS each tone		-64		dBc
		f_{out} = 3500MHz ±10MHz, -7dBFS each tone		-63		dBc
		f_{out} = 4900MHz ±10MHz, -7dBFS each tone		-64		dBc
		f_{out} = 5MHz ±1MHz, -13dBFS each tone		-72		dBc
		f_{DAC} =6 GSPS, f_{out} = 30MHz ±1MHz, -13dBFS each tone		-71		dBc
		f_{DAC} =6 GSPS, f_{out} = 400MHz ±2MHz, -13dBFS each tone		-72		dBc
		f_{out} = 850MHz ±10MHz, -13dBFS each tone		-73		dBc
		f_{out} = 1800MHz ±10MHz, -13dBFS each tone		-75		dBc
		f_{out} = 2600MHz ±10MHz, -13dBFS each tone		-79		dBc
		f_{out} = 3500MHz ±10MHz, -13dBFS each tone		-77		dBc
		f_{out} = 4900MHz ±10MHz, -13dBFS each tone		-77		dBc
SFDR	Spurious Free Dynamic Range (within Nyquist zone)	f_{out} = 30 MHz, f_{DAC} = 6000 MSPS, interleave mode, 20Gbps SerDes rate		45		dBc
		f_{out} = 400 MHz, f_{DAC} = 6000 MSPS, interleave mode, 20Gbps SerDes rate		48		dBc
		f_{out} = 850 MHz, f_{DAC} = 11796.48 MSPS		62		dBc
		f_{out} = 1800 MHz, f_{DAC} = 11796.48 MSPS		56		dBc
		f_{out} = 2600 MHz, f_{DAC} = 11796.48 MSPS		39		dBc
		f_{out} = 3500 MHz, f_{DAC} = 11796.48 MSPS		42		dBc
		f_{out}= 4900 MHz, f_{DAC} = 11796.48 MSPS		60		dBc

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_S/2 - f_{OUT}$	Interleaving Image	f_{DAC} = 5898.24MSPS, interleave mode		-47		dBc
		f_{DAC} = 8847.36 MSPS, interleave mode		-43		dBc
		f_{DAC} = 11796.48MSPS, interleave mode		-43		dBc
HD2	2nd Harmonic Distortion (within Nyquist zone)	f_{DAC} =6 GSPS, f_{out} = 5 MHz		-72		dBc
		f_{DAC} =6 GSPS, f_{out} = 30 MHz		-75		dBc
		f_{DAC} =6 GSPS, f_{out} = 100 MHz		-73		dBc
		f_{out} = 400 MHz		-46		dBc
		f_{out} = 850 MHz		-65		dBc
		f_{out} = 1800 MHz		-68		dBc
		f_{out} = 2600 MHz		-47		dBc
		f_{out} = 3500 MHz		-59		dBc
		f_{out}= 4900 MHz		-48		dBc
		f_{out} = 850 MHz, A_{OUT}=-12dBFS		-74		dBc
		f_{out} = 1800 MHz, A_{OUT}=-12dBFS		-67		dBc
		f_{out} = 2600 MHz, A_{OUT}=-12dBFS		-58		dBc
		f_{out} = 3500 MHz, A_{OUT}=-12dBFS		-69		dBc
		f_{out}= 4900 MHz, A_{OUT}=-12dBFS		-59		dBc
HD3	3rd Harmonic Distortion (within Nyquist zone)	f_{DAC} =6 GSPS, f_{out} = 5 MHz		-46		dBc
		f_{DAC} =6 GSPS, f_{out} = 30 MHz		-48		dBc
		f_{DAC} =6 GSPS, f_{out} = 100 MHz		-49		dBc
		f_{DAC} =6 GSPS, f_{out} = 400 MHz		-49		dBc
		f_{out} = 850 MHz		-56		dBc
		f_{out} = 1800 MHz		-58		dBc
		f_{out} = 2600 MHz		-60		dBc
		f_{out} = 3500 MHz		-63		dBc
		f_{out}= 4900 MHz		-66		dBc
		f_{DAC} =6 GSPS, f_{out} = 5 MHz, A_{OUT}=-12dBFS		-83		dBc
		f_{DAC} =6 GSPS, f_{out} = 30 MHz, A_{OUT}=-12dBFS		-83		dBc
		f_{DAC} =6 GSPS, f_{out} = 100 MHz, A_{OUT}=-12dBFS		-82		dBc
		f_{DAC} =6 GSPS, f_{out} = 400 MHz, A_{OUT}=-12dBFS		-79		dBc
		f_{out} = 850 MHz, A_{OUT}=-12dBFS		-87		dBc
		f_{out} = 1800 MHz, A_{OUT}=-12dBFS		-84		dBc
		f_{out} = 2600 MHz, A_{OUT}=-12dBFS		-79		dBc
		f_{out} = 3500 MHz, A_{OUT}=-12dBFS		-84		dBc
		f_{out}= 4900 MHz, A_{OUT}=-12dBFS		-88		dBc

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
HDn, n >= 4	Harmonic Distortion n >= 4 (within Nyquist zone)	f_{DAC} =6 GSPS, f_{out} = 5 MHz		-58		dBc
		f_{DAC} =6 GSPS, f_{out} = 30 MHz		-60		dBc
		f_{DAC} =6 GSPS, f_{out} = 100 MHz		-61		dBc
		f_{DAC} =6 GSPS, f_{out} = 400 MHz		-50		dBc
		f_{out} = 850 MHz		-85		dBc
		f_{out} = 1800 MHz		-90		dBc
		f_{out} = 2600 MHz		-84		dBc
		f_{out} = 3500 MHz		-86		dBc
		f_{out}= 4900 MHz		-87		dBc
		f_{DAC} =6 GSPS, f_{out} = 5 MHz, A_{OUT}=-12dBFS		-92		dBc
		f_{DAC} =6 GSPS, f_{out} = 30 MHz, A_{OUT}=-12dBFS		-94		dBc
		f_{DAC} =6 GSPS, f_{out} = 100 MHz, A_{OUT}=-12dBFS		-93		dBc
		f_{DAC} =6 GSPS, f_{out} = 400 MHz, A_{OUT}=-12dBFS		-85		dBc
		f_{out} = 850 MHz, A_{OUT}=-12dBFS		-89		dBc
		f_{out} = 1800 MHz, A_{OUT}=-12dBFS		-92		dBc
		f_{out} = 2600 MHz, A_{OUT}=-12dBFS		-87		dBc
		f_{out} = 3500 MHz, A_{OUT}=-12dBFS		-88		dBc
		f_{out}= 4900 MHz, A_{OUT}=-12dBFS		-89		dBc
SFDR +/- 250 MHz	Spurious Free Dynamic Range within +/- 250 MHz	f_{DAC} =6 GSPS, f_{out} = 400 MHz		87		dBc
		f_{out} = 850 MHz, f_{DAC} = 11796.48 MSPS		84		dBc
		f_{out} = 1800 MHz, f_{DAC} = 11796.48 MSPS		78		dBc
		f_{out} = 2600 MHz, f_{DAC} = 11796.48 MSPS		80		dBc
		f_{out} = 3500 MHz, f_{DAC} = 11796.48 MSPS		81		dBc
		f_{out}= 4900 MHz, f_{DAC} = 11796.48 MSPS		74		dBc
$f_S/4$	Fixed Spur	f_{DAC} = 5898.24MSPS, f_{OUT}=f_{DAC}/4-50MHz		-95		dBFS
		f_{DAC} = 8847.36MSPS, f_{OUT}=f_{DAC}/4-50MHz		-88		dBFS
		f_{DAC} = 11796.48MSPS, f_{OUT}=f_{DAC}/4-50MHz		-76		dBFS
$f_S/2$	Fixed Spur	f_{DAC} = 5898.24MSPS, f_{OUT}=f_{DAC}/2-50MHz		-52		dBFS
		f_{DAC} = 8847.36MSPS, f_{OUT}=f_{DAC}/2-50MHz		-45		dBFS
		f_{DAC} = 11796.48 MSPS, f_{OUT}=f_{DAC}/2-50MHz		-49		dBFS

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$3*f_S/4$	Fixed Spur	2nd Nyquist, f_{DAC} = 5898.24MSPS, $f_{OUT}=3*f_{DAC}/4$-50MHz		-82		dBFS
		2nd Nyquist, f_{DAC} = 8847.36MSPS, $f_{OUT}=3*f_{DAC}/4$-50MHz		-75		dBFS
		2nd Nyquist, f_{DAC} = 11796.48MSPS, $f_{OUT}=3*f_{DAC}/4$-50MHz		-49		dBFS
$ACPR_{1xcarr}$	ACPR - 1 carrier, LTE 20MHz E-TM1.1 carrier f_{out} = 0.85 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-70		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-66		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-62		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-51		dBc
$ACPR_{1xcarr}$	ACPR - 1 carrier, LTE 20MHz E-TM1.1 carrier f_{out} = 1.8425 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-71		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-66		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-61		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-50		dBc
$ACPR_{1xcarr}$	ACPR - 1 carrier, LTE 20MHz E-TM1.1 carrier f_{out} = 2.6 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-72		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-66		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-60		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-49		dBc
$ACPR_{1xcarr}$	ACPR - 1 carrier, LTE 20MHz E-TM1.1 carrier f_{out} = 3.5 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-71		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-65		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-58		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-47		dBc
$ACPR_{1xcarr}$	ACPR - 1 carrier, LTE 20MHz E-TM1.1 carrier f_{out} = 4.9 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-69		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-64		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-58		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-47		dBc

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$ACPR_{1xcarr}$	ACPR - 1 carrier, NR 100MHz E-TM1.1 carrier f_{out} = 2.6 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-65		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-59		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-53		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-41		dBc
$ACPR_{1xcarr}$	ACPR - 1 carrier, NR 100MHz E-TM1.1 carrier f_{out} = 3.5 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-63		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-56		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-49		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-38		dBc
$ACPR_{1xcarr}$	ACPR - 1 carrier, NR 100MHz E-TM1.1 carrier f_{out} = 4.9 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-63		dBc
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-56		dBc
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-51		dBc
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFS		-41		dBc
EVM	Error Vector Magnitude, 1x 20MHz E-TM3.1/3.1a, no ref. clock noise	F_{out} =0.85 GHz, f_{DAC} = 11796.48MSPS, P_{OUT}=-13dBFs		0.16		%
		F_{out} =1.8425 GHz, f_{DAC} = 11796.48MSPS, P_{OUT}=-13dBFs		0.21		%
		F_{out} =2.6 GHz, f_{DAC} = 11796.48MSPS, P_{OUT}=-13dBFs		0.24		%
		F_{out} =3.5 GHz, P_{OUT}=-13dBFs		0.27		%
		F_{out} =4.9 GHz, P_{OUT}=-13dBFs		0.38		%
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 5 MHz	Atten=0dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-148		dBFS/Hz
		Atten=20dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-143		dBFS/Hz
		Atten=28dB, f_{DAC} =6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-139		dBFS/Hz
		Atten=39dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-129		dBFS/Hz
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 30 MHz	Atten=0dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-154		dBFS/Hz
		Atten=20dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-146		dBFS/Hz
		Atten=28dB, f_{DAC} =6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-142		dBFS/Hz
		Atten=39dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-132		dBFS/Hz

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 100 MHz	Atten=0dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-158		dBFS/Hz
		Atten=20dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-150		dBFS/Hz
		Atten=28dB, f_{DAC} =6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-146		dBFS/Hz
		Atten=39dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-136		dBFS/Hz
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 400 MHz	Atten=0dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-160		dBFS/Hz
		Atten=20dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-153		dBFS/Hz
		Atten=28dB, f_{DAC} =6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-150		dBFS/Hz
		Atten=39dB, f_{DAC} = 6000MSPS, 20Gbps SerDes rate, Pout=-12dBFs		-139		dBFS/Hz
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 0.85 GHz	Atten=0dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-158.8		dBFS/Hz
		Atten=20dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-152.7		dBFS/Hz
		Atten=28dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-148.7		dBFS/Hz
		Atten=39dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-137.9		dBFS/Hz
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 1.8 GHz	Atten=0dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-157.9		dBFS/Hz
		Atten=20dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-151.3		dBFS/Hz
		Atten=28dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-145.6		dBFS/Hz
		Atten=39dB, f_{DAC} = 5898.24MSPS, Pout=-13dBFs		-134.8		dBFS/Hz
NSD_{dBFS}	Noise Spectral Density 20MHz offset f_{OUT} = 2.6 GHz	Atten=0dB, f_{DAC} = 8847.36MSPS, Pout=-13dBFs		-158.3		dBFS/Hz
		Atten=20dB, f_{DAC} = 8847.36MSPS, Pout=-13dBFs		-151.6		dBFS/Hz
		Atten=28dB, f_{DAC} = 8847.36MSPS, Pout=-13dBFs		-144.9		dBFS/Hz
		Atten=39dB, f_{DAC} = 8847.36MSPS, Pout=-13dBFs		-134.0		dBFS/Hz
NSD_{dBFS}	Noise Spectral Density 20MHz offset F_{out} =3.5 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-158.2		dBFS/Hz
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-150.9		dBFS/Hz
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-144.4		dBFS/Hz
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-133.4		dBFS/Hz

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
NSD_{dBFS}	Noise Spectral Density 20MHz offset F_{out} =4.9 GHz	Atten=0dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-154.6		dBFS/Hz
		Atten=20dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-147.0		dBFS/Hz
		Atten=28dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-140.7		dBFS/Hz
		Atten=39dB, f_{DAC} = 11796.48MSPS, Pout=-13dBFs		-129.9		dBFS/Hz
S22	Output Return Loss, +/- fc * 10%	with matching		-12		dB
Isolation	Near Channel: 1TXOUT to 2TXOUT or 3TXOUT to 4TXOUT(1)	f_{out} = 10 MHz, f_{DAC} =6000MSPS, straight mode(3)		-96		dB
		f_{out} = 30 MHz, f_{DAC} = 6000MSPS, straight mode(3)		-97		dB
		f_{out} = 100 MHz, f_{DAC} = 6000MSPS, straight mode(3)		-102		dB
		f_{out} = 400 MHz, f_{DAC} = 6000MSPS, straight mode(4)		-85		dB
		f_{out} = 900 MHz, f_{DAC} = 8847.36MSPS, straight mode		-80		dB
		f_{out} = 1850 MHz, f_{DAC} = 8847.36MSPS, straight mode		-77		dB
		f_{out} = 2600 MHz, f_{DAC} = 8847.36MSPS, straight mode		-64		dB
		f_{out} = 3500 MHz, f_{DAC} = 8847.36MSPS, straight mode		-61		dB
		f_{out}= 4900 MHz, f_{DAC} = 8847.36MSPS, straight mode		-60		dB
Isolation	Far Channel: 1/2TXOUT to 3/4TXOUT	f_{out} = 10 MHz, f_{DAC} =6000MSPS, straight mode(3)		-104		dB
		f_{out} = 30 MHz, f_{DAC} = 6000MSPS, straight mode(3)		-100		dB
		f_{out} = 100 MHz, f_{DAC} = 6000MSPS, straight mode(3)		-105		dB
		f_{out} = 400 MH, f_{DAC} = 6000MSPS, straight mode(4)		-97		dB
		f_{out} = 900 MHz, f_{DAC} = 8847.36MSPS, straight mode		-90		dB
		f_{out} = 1850 MHz, f_{DAC} = 8847.36MSPS, straight mode		-91		dB
		f_{out} = 2600 MHz, f_{DAC} = 8847.36MSPS, straight mode		-93		dB
		f_{out} = 3500 MHz, f_{DAC} = 8847.36MSPS, straight mode		-94		dB
		f_{out}= 4900 MHz, f_{DAC} = 8847.36MSPS, straight mode		-83.2		dB

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5.5 Transmitter Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS below 6GHz and 750MSPS above 6GHz, f_{DAC} = 11796.48MSPS below 6GHz and f_{DAC} = 9000MSPS above 6GHz; PLL clock mode below 6GHz output frequency and External clock mode above 6GHz output frequency; interleave mode for 1st Nyquist, non-interleave mix mode for 2nd Nyquist, nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
PN_{TXADD}	Additive Phase Noise External Clock Mode (5)	f_{out} = 3.7GHz, f_{OFFSET} = 100Hz		-97		dBc/Hz
		f_{out} = 3.7GHz, f_{OFFSET} = 1kHz		-106		dBc/Hz
		f_{out} = 3.7GHz, f_{OFFSET} = 10kHz		-117		dBc/Hz
		f_{out} = 3.7GHz, f_{OFFSET} = 100kHz		-128		dBc/Hz
		f_{out} = 3.7GHz, f_{OFFSET} = 1MHz		-138		dBc/Hz
		f_{out} = 3.7GHz, f_{OFFSET} = 10MHz		-144		dBc/Hz

(1) Measured with differential 100 ohm across TxP/M. The DC bias to 1.8V to each TxP/M at each pin remains and is not removed. Other external components on the TX paths are disconnected.
(2) After DSA calibration procedure
(3) measured with 1µH DC feed inductor
(4) measured with 0.39µH DC feed inductor
(5) Input clock phase noise subtracted.

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5.6 RF ADC Electrical Characteristics

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, f_{ADC} = 2949.12MSPS below 6GHz and f_{ADC} = 3000MSPS above 6GHz; PLL clock mode with f_{REF} = 491.52MHz below 6GHz input frequency and External clock mode with f_{CLK} = 11796.48MHz above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ADC_{RES}	ADC resolution			14		bits
F_{RFin}	RF input frequency range		5		7400	MHz
$P_{FS_CW,min}$	Min Full scale input power, at device pins (1)	f_{IN} = 5 MHz, DSA=0dB, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-0.4		dBm
		f_{IN} = 30 MHz, DSA=0dB, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-2.2		dBm
		f_{IN} = 410 MHz, DSA=0dB, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 12		-2.5		dBm
		f_{IN} = 830 MHz, DSA=0dB		-2.9		dBm
		f_{IN} = 1760 MHz, DSA=0dB		-2.8		dBm
		f_{IN} = 2610 MHz, DSA=0dB		-1.8		dBm
		f_{IN} = 3610 MHz, DSA=0dB		-0.4		dBm
		f_{IN} = 4910 MHz, DSA=0dB		0.1		dBm
$P_{FS_CW,MAX}$	MAX Full scale input power - reliability limited, at device pins	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		19.7		dBm
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		17.8		dBm
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		17.6		dBm
		f_{IN} = 830 MHz		16.7		dBm
		f_{IN} = 1760 MHz		17.0		dBm
		f_{IN} = 2610 MHz		18		dBm
		f_{IN} = 3610 MHz		18.5		dBm
		f_{IN} = 4910 MHz		19.3		dBm
R_{TERM}	Input reference impedance			100.0		Ω
ATT_{range}	DSA Attenuation range			25.0		dB
ATT_{step}	DSA Attenuation step			0.5		dB
	DSA Attenuation step accuracy	Delta=Gatt(X)-Gatt(X-1), F_{in}=3610MHz, after calibration		0.1		dB
	DSA Gain Steps Phase accuracy any 8dB range	F_{in}=3610MHz, after calibration		0.9		deg
	DSA Gain Steps Phase accuracy any 8dB range	F_{in}=4910MHz, after calibration		1.8		deg
G_{flat}	Gain flatness	Measured Over 80MHz BW		0.2		dB
		Measured Over 200MHz BW		0.5		dB
		Measured Over 400MHz BW		1.1		dB

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5.6 RF ADC Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, f_{ADC} = 2949.12MSPS below 6GHz and f_{ADC} = 3000MSPS above 6GHz; PLL clock mode with f_{REF} = 491.52MHz below 6GHz input frequency and External clock mode with f_{CLK} = 11796.48MHz above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
NSD	Noise Density (3) (small signal = -30dBFS)	f_{IN} = 5 MHz, DSA = 3dB, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-147.1		dBFS/Hz
		f_{IN} = 30 MHz, DSA = 3dB, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-150.7		dBFS/Hz
		f_{IN} = 410 MHz, DSA = 3dB, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		-155.4		dBFS/Hz
		f_{IN} = 830 MHz, DSA = 3dB		-156.2		dBFS/Hz
		f_{IN} = 1760 MHz, DSA = 3dB		-156.0		dBFS/Hz
		f_{IN} = 2610 MHz, DSA = 3dB		-155.4		dBFS/Hz
		f_{IN} = 3610 MHz, DSA = 3dB		-155.1		dBFS/Hz
		f_{IN} = 4910 MHz, DSA = 3dB		-155.1		dBFS/Hz
		f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48, 3<=Atten<=22		-147.8		dBFS/Hz
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24, 3<=Atten<=22		-151.5		dBFS/Hz
		f_{IN} = 410 MHz, 3<=Atten<=22, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		-156.6		dBFS/Hz
		f_{IN} = 830 MHz, 3<=Atten<=22		-156.0		dBFS/Hz
		f_{IN} = 1760 MHz, 3<=Atten<=25		-155.8		dBFS/Hz
		f_{IN} = 2610 MHz, 3<=Atten<=25		-155.7		dBFS/Hz
		f_{IN} = 3610 MHz, 3<=Atten<=25		-155.4		dBFS/Hz
		f_{IN} = 4910 MHz, 3<=Atten<=25		-155.8		dBFS/Hz
NF_{min}	Noise Figure min DSA Atten=0 - 3dB	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		29.4		dB
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		24.5		dB
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		19.3		dB
		f_{IN} = 830 MHz		19.1		dB
		f_{IN} = 1760 MHz		19.0		dB
		f_{IN} = 2610 MHz		20.9		dB
		f_{IN} = 3610 MHz		22.8		dB
		f_{IN} = 4910 MHz		22.4		dB

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5.6 RF ADC Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, f_{ADC} = 2949.12MSPS below 6GHz and f_{ADC} = 3000MSPS above 6GHz; PLL clock mode with f_{REF} = 491.52MHz below 6GHz input frequency and External clock mode with f_{CLK} = 11796.48MHz above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
NF	Noise Figure[4] DSA Atten=4dB	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		30.6		dB
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		25.1		dB
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		20.1		dB
		f_{IN} = 830 MHz		20.0		dB
		f_{IN} = 1760 MHz		20.6		dB
		f_{IN} = 2610 MHz		21.9		dB
		f_{IN} = 3610 MHz		23.5		dB
		f_{IN} = 4910 MHz		22.3		dB
NF_{max}	Noise Figure DSA Atten=20dB	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		45.9		dB
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		40.2		dB
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		35.0		dB
		f_{IN} = 830 MHz		34.7		dB
		f_{IN} = 1760 MHz		35.2		dB
		f_{IN} = 2610 MHz		36.0		dB
		f_{IN} = 3610 MHz		37.3		dB
		f_{IN} = 4910 MHz		37.6		dB
IMD3	3rd order intermodulation 2 tones at at f_{IN} ± 10MHz -7dBFS each tone	f_{IN} = 30±1 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-82		dBc
		f_{IN} = 400MHz and 405MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		-75		dBc
		f_{IN} = 840 MHz		-82		dBc
		f_{IN} = 1770 MHz		-84		dBc
		f_{IN} = 2610 MHz		-74		dBc
		f_{IN} = 3610 MHz		-77		dBc
		f_{IN} = 4920 MHz		-76		dBc
SFDR	Spurious Free Dynamic Range within output bandwidth, A_{IN} = -3 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		78		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		100		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		94		dBFS
		f_{IN} = 830 MHz		88		dBFS
		f_{IN} = 1760 MHz		81		dBFS
		f_{IN} = 2610 MHz		88		dBFS
		f_{IN} = 3610 MHz		84		dBFS
		f_{IN} = 4910 MHz		79		dBFS

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5.6 RF ADC Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, f_{ADC} = 2949.12MSPS below 6GHz and f_{ADC} = 3000MSPS above 6GHz; PLL clock mode with f_{REF} = 491.52MHz below 6GHz input frequency and External clock mode with f_{CLK} = 11796.48MHz above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
HD2	2nd Harmonic Distortion A_{IN} = -3 dBFS(2)	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-84		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, Bypass Mode (TI only test mode)		-91		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, Bypass Mode (TI only test mode)		-90		dBFS
		f_{IN} = 830 MHz		-86		dBFS
		f_{IN} = 1760 MHz		-90		dBFS
		f_{IN} = 2610 MHz		-88		dBFS
		f_{IN} = 3610 MHz		-87		dBFS
		f_{IN} = 4910 MHz		-84		dBFS
HD3	3rd Harmonic Distortion A_{IN} = -3 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-78		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, Bypass Mode (TI only test mode)		-96		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, Bypass Mode (TI only test mode)		-94		dBFS
		f_{IN} = 830 MHz		-80		dBFS
		f_{IN} = 1760 MHz		-85		dBFS
		f_{IN} = 2610 MHz		-86		dBFS
		f_{IN} = 3610 MHz		-78		dBFS
		f_{IN} = 4910 MHz		-75		dBFS
HDn, n>3	SFDR excl. HD2 and HD3 A_{IN} = -3 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-94		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-94		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		-94		dBFS
		f_{IN} = 830 MHz		-88		dBFS
		f_{IN} = 1760 MHz		-81		dBFS
		f_{IN} = 2610 MHz		-88		dBFS
		f_{IN} = 3610 MHz		-84		dBFS
		f_{IN} = 4910 MHz		-82		dBFS
SFDR	Spurious Free Dynamic Range A_{IN} = -13 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		101		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		105		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		95		dBFS
		f_{IN} = 830 MHz		89		dBFS
		f_{IN} = 1760 MHz		89		dBFS
		f_{IN} = 2610 MHz		95		dBFS
		f_{IN} = 3610 MHz		87		dBFS
		f_{IN} = 4910 MHz		90		dBFS

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5.6 RF ADC Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, f_{ADC} = 2949.12MSPS below 6GHz and f_{ADC} = 3000MSPS above 6GHz; PLL clock mode with f_{REF} = 491.52MHz below 6GHz input frequency and External clock mode with f_{CLK} = 11796.48MHz above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
HD2	2nd Harmonic Distortion[2] A_{IN} = -13 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-104		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, Bypass Mode (TI only test mode)		-91		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, Bypass Mode (TI only test mode)		-104		dBFS
		f_{IN} = 830 MHz, with board trim		-79		dBFS
		f_{IN} = 1760 MHz, with board trim		-102		dBFS
		f_{IN} = 2610 MHz, with board trim		-100		dBFS
		f_{IN} = 3610 MHz, with board trim		-101		dBFS
		f_{IN} = 4910 MHz, with board trim		-99		dBFS
HD3	3rd Harmonic Distortion A_{IN} = -13 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-103		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, Bypass Mode (TI only test mode)		-84		dBFS
		f_{IN} = 381 MHz, f_{ADC} = 3000MSPS, Bypass Mode (TI only test mode)		-91		dBFS
		f_{IN} = 830 MHz		-95		dBFS
		f_{IN} = 1760 MHz		-95		dBFS
		f_{IN} = 2610 MHz		-98		dBFS
		f_{IN} = 3610 MHz		-97		dBFS
		f_{IN} = 4910 MHz		-94		dBFS
HDn, n>3	SFDR excl. HD2 and HD3 A_{IN} = -13 dBFS	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-104		dBFS
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-105		dBFS
		f_{IN} = 410 MHz, f_{ADC} = 3000MSPS, f_{NCO} = 400MHz, Decimate by 24		-95		dBFS
		f_{IN} = 830 MHz		-89		dBFS
		f_{IN} = 1760 MHz		-89		dBFS
		f_{IN} = 2610 MHz		-95		dBFS
		f_{IN} = 3610 MHz		-90		dBFS
		f_{IN} = 4910 MHz		-90		dBFS
RX-RX/FB Isolation	Near Channel: 1RXIN to 2RXIN 3RXIN to 4RXIN 1FBIN to 1RXIN 2FBIN to 3RXIN	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-98		dB
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-98		dB
		f_{IN} = 400 MHz		-88		dB
		f_{IN} = 830 MHz		-77		dB
		f_{IN} = 1760 MHz		-71		dB
		f_{IN} = 2610 MHz		-74		dB
		f_{IN} = 3610 MHz		-77		dB
		f_{IN} = 4910 MHz		-65		dB

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5.6 RF ADC Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; RX Output Rate = 491.52MSPS below 6GHz input frequency and 1500MSPS above 6GHz input frequency, f_{ADC} = 2949.12MSPS below 6GHz and f_{ADC} = 3000MSPS above 6GHz; PLL clock mode with f_{REF} = 491.52MHz below 6GHz input frequency and External clock mode with f_{CLK} = 11796.48MHz above 6GHz input frequency; nominal power supplies; DSA Setting =3dB; SerDes rate =24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TX-FB Isolation	Near Channel: 1TXOUT to 1FBIN 3TXOUT to 2FBIN	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-92		dB
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-93		dB
		f_{IN} = 400 MHz		-92		dB
		f_{IN} = 830 MHz		-84		dB
		f_{IN} = 1760 MHz		-88		dB
		f_{IN} = 2610 MHz		-86		dB
		f_{IN} = 3610 MHz		-82		dB
		f_{IN} = 4910 MHz		-81		dB
TX-RX Isolation	Far Channel: 1TXOUT to 1RXIN 3TXOUT to 2RXIN	f_{IN} = 5 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 17MHz, Decimate by 48		-105		dB
		f_{IN} = 30 MHz, f_{ADC} = 1500MSPS, f_{NCO} = 30MHz, Decimate by 24		-101		dB
		f_{IN} = 400 MHz		-99		dB
		f_{IN} = 830 MHz		-86		dB
		f_{IN} = 1760 MHz		-87		dB
		f_{IN} = 2610 MHz		-84		dB
		f_{IN} = 3610 MHz		-82		dB
		f_{IN} = 4910 MHz		-82		dB

(1) The input fullscale at minimum attenuation can be reduce by adding a digital gain range to the DSA, extending the useful range of the DSA. The noise figure remains constant over the digital gain range.
(2) After HD2 trim on specific printed circuit board.
(3) From DSA = 3dB down to 0dB, NSD increases 1dB per DSA dB
(4) NF increase 1dB per DSA 1dB above DSA = 3dB

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5.7 PLL/VCO/Clock Electrical Characteristics

Typical values at TA = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; Reference clock input frequency 491.52MHz (unless otherwise noted), $f_{DAC} = f_{VCO}$, $f_{OUT} = f_{DAC}/4$, normalized to f_{VCO}.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{VCO1}	VCO1 min frequency				7.2	GHz
	VCO1 max frequency		7.68			GHz
f_{VCO2}	VCO2 min frequency				8.848	GHz
	VCO2 max frequency		9.216			GHz
f_{VCO3}	VCO3 min frequency				9.8304	GHz
	VCO3 max frequency		10.24			GHz
f_{VCO4}	VCO4 min frequency				11.7965	GHz
	VCO4 max frequency		12.288			GHz
DIV_{DAC}	DAC sample rate divider			1, 2 or 3		
DIV_{FBADC}	ADC sample rate divider from DAC sample rate			1, 2, 3, 4, 6 or 8		
DIV_{RXADC}	ADC sample rate divider			1, 2, 3, 4, 6 or 8		
PN_{VCO}	Closed Loop Phase Noise F_{PLL} = 11.79848 GHz F_{REF}=491.52MHz	600kHz		-113		dBc/Hz
		800kHz		-116		dBc/Hz
		1MHz		-119		dBc/Hz
		1.8MHz		-125		dBc/Hz
		5MHz		-133		dBc/Hz
		50MHz		-141		dBc/Hz
	Closed Loop Phase Noise F_{PLL}=8.84736 GHz F_{REF}=491.52MHz	600kHz		-114		dBc/Hz
		800kHz		-118		dBc/Hz
		1MHz		-120		dBc/Hz
		1.8MHz		-127		dBc/Hz
		5MHz		-135		dBc/Hz
		50MHz		-142		dBc/Hz
	Closed Loop Phase Noise F_{PLL}= 9.8403 GHz F_{REF}=491.52MHz	600kHz		-113		dBc/Hz
		800kHz		-116		dBc/Hz
		1MHz		-119		dBc/Hz
		1.8MHz		-125		dBc/Hz
		5MHz		-134		dBc/Hz
		50MHz		-140		dBc/Hz
	Closed Loop Phase Noise F_{PLL}= 7.86432GHz F_{REF}=491.52MHz	600kHz		-116		dBc/Hz
		800kHz		-119		dBc/Hz
		1MHz		-122		dBc/Hz
		1.8MHz		-127		dBc/Hz
		5MHz		-136		dBc/Hz
		50MHz		-143		dBc/Hz
F_{rms}	Clock PLL integrated phase error(1)	f_{PLL}=11.79848 GHz, [1KHz, 100MHz]		-43.4		dBc/Hz
		f_{PLL}=8.8536 GHz, [1KHz, 100MHz]		-47.6		dBc/Hz
		f_{PLL}=9.8304 GHz, [1KHz, 100MHz]		-46.2		dBc/Hz
f_{PFD}	PFD frequency		100		500	MHz
PN_{pll_flat}	Normalized PLL flat Noise	f_{VCO} = 11796.48MHz		-226.5		dBc/Hz

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5.7 PLL/VCO/Clock Electrical Characteristics (continued)

Typical values at TA = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; Reference clock input frequency 491.52MHz (unless otherwise noted), $f_{DAC} = f_{VCO}$, $f_{OUT} = f_{DAC}/4$, normalized to f_{VCO}.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
F_{REF}	Input Clock frequency		0.1		12	GHz
V_{SS}	Input Clock level		0.6		1.8	Vppdiff
Coupling				AC Coupling Only		
	REFCLK input impedance(2)	Parallel resistance		100		Ω
		Parallel capacitance		0.5		pF

(1) Single Sideband, not including the reference clock contribution
(2) Refer to S11 data available from TI for impedance vs frequency

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5.8 Digital Electrical Characteristics

Typical values at TA = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
CML SerDes Inputs [8:1]SRX+/-						
V_{SRDIFF}	SerDes Receiver Input Amplitude	differential	100		1200	mVpp
V_{SRCOM}	SerDes Input Common Mode			400		mV
Z_{SRdiff}	SerDes Internal Differential Termination(1)			100		Ω
F_{SerDes}	SerDes Bit Rate	Full rate mode	19		29.5	Gbps
		Half rate mode	9.5		16.25	Gbps
		Quarter rate mode	4.75		8.125	Gbps
	Insertion Loss Tolerance(2)	Serdes supply = 1.8V		25		dB
TJ	Total Jitter Tolerance				0.42	UI
CML SerDes Outputs [8:1]STX+/-						
V_{STDIFF}	SerDes Transmitter Output Amplitude	differential	500		1000	mVpp
V_{STCOM}	SerDes Output Common Mode		0.4	0.45	0.55	V
Z_{STdiff}	SerDes Output Impedance			100		Ω
TRF	Output rise and fall time	20-80%	8			ps
TEQS	Equalization range				7	dB
TTJ	Output total jitter				0.21	UI
CMOS I/O: GPIO{B/C/D/E}x, SPICLK, SPISDIO, SPISDO, SPISEN, RESETZ, BISTB0, BISTB1						
V_{IH}	High-Level Input Voltage		0.6×VDD1 P8GPIO			V
V_{IL}	Low-Level Input Voltage				0.4×VDD1 P8GPIO	V
I_{IH}	High-Level Input Current		–250		250	µA
I_{IL}	Low-Level Input Current		–250		250	µA
C_L	CMOS input capacitance			2		pF
V_{OH}	High-Level Input Voltage		VDD1P8G PIO – 0.2			V
V_{OL}	Low-Level Input Voltage				0.2	V
Differential Inputs: SYSREF+/- Mode A						
$F_{SYSREFMAX}$	SYSREF Input Frequency Maximum			40		MHz
$V_{SWINGSRMAX}$	SYSREF Input Swing Maximum			1.8		Vppdiff(3)
$V_{SWINGSRMIN}$	SYSREF Input Swing Minimum	f_{REF} < 500MHz		0.3		Vppdiff(3)
$V_{SWINGSRMIN}$	SYSREF Input Swing Minimum	f_{REF} > 500MHz		0.6		Vppdiff(3)
$V_{COMSRMAX}$	SYSREF Input Common Mode Voltage Maximum			0.8		V
$V_{COMSRMIN}$	SYSREF Input Common Mode Voltage Minimum			0.6		V
Z_T	Input termination	differential		100 (1)		Ω
C_L	Input capacitance	Each pin to GND		0.5		pF
LVDS Inputs: 0SYNCIN+/- and 1SYNCIN+/-						
V_{ICOM}	Input Common Voltage			1.2		V
V_{ID}	Differential Input Voltage swing			450		Vppdiff(3)
Z_T	Input termination	differential		100		Ω
LVDS Outputs: 0SYNCOUT+/- and 1SYNCOUT+/-						
V_{OCOM}	Output Common Voltage			1.2		V

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5.8 Digital Electrical Characteristics (continued)

Typical values at TA = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OD}	Differential Output Voltage swing			500		Vppdiff(3)
Z_T	Internal Termination			100		Ω

(1) SYSREF termination is programmable between 100 Ω, 150 Ω and 300 Ω
(2) Loss tolerance is bump to bump from STX to SRX
(3) Vppdiff is the difference between the maximum differential voltage (positive value) and minimum differential voltage (negative value).

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5.9 Power Supply Electrical Characteristics

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 737.28MSPS, f_{DAC} = 8847.36MSPS interleave mode; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 1: 4T2F - FDD FB 100% on, no RX TX/FB Rate: 491.52 Msps Single Band: 12x Int, FB 6x Dec f_{DAC} = 5898.24 SPS f_{ADC} = 2949.12MSPS f_{TX} = 1.85 GHz 64/66 coding, 16.22Gbps TX: 4-8-4-1, FB: 2-4-4-1		948.2		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			533.7		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			77.3		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			299.4		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			804.5		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			49.1		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2041.3		mA
P_{diss}	Power Dissipation			6027.1		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 2: 4T4R - TDD 1F shared with RX TX 75%, RX 25%, FB 75% Dual Band: 12x Int, FB 6x Dec, RX 24x Dec TX/FB Rate 491.52 Msps RX Rate 122.88 Msps f_{DAC} = 8847.36MSPS f_{ADC} = 2949.12MSPS f_{OUT}=f_{IN}= 1.9, 2.6 GHz 64/66 coding, 16.22Gbps TX: 8-16-4-1, FB: 2-4-4-1, RX: 2-16-16-1		820.4		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			735.2		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			74.4		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			289.0		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			822.0		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			45.6		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2263.8		mA
P_{diss}	Power Dissipation			6359.2		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 3: 4T4R2F - FDD FB 100% on TX Dual Band: 12x Int, FB 6x Dec RX Dual Band: RX 24x TX/FB Rate 491.52 Msps RX Rate 122.88 Msps f_{DAC} = 11796.48 MSPS f_{ADC} = 2949.12 MSPS f_{TX} = 1.85 + 2.15 GHz f_{RX} = 1.75 + 1.88 GHz 64/66 coding, 16.22Gbps TX: 8-16-4-1, FB: 2-4-4-1, RX: 2-16-16-1		1668.6		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			965.1		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			77.6		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			893.4		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			879.5		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			50.7		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			3826.9		mA
P_{diss}	Power Dissipation			10513.0		mW

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5.9 Power Supply Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 737.28MSPS, f_{DAC} = 8847.36MSPS interleave mode; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 4: 4T4R2F - FDD FB 100% on 7.5 GSPS DAC, 2.5 GSPS ADC Single Band: 15x Int, FB 5x Dec Dual Band: RX 20x TX/FB Rate 491.52 Msps RX Rate 122.88 Msps f_{DAC} = 7372.8 MSPS f_{ADC} = 2457.6 MSPS f_{TX} = 1.85 + 2.15 GHz f_{RX} = 1.75 + 1.88 GHz 64/66 coding, 16.22Gbps TX: 4-8-4-1, FB: 2-4-4-1, RX: 2-16-16-1		1611.5		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			694.5		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			72.8		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			768.5		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			940.5		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			45.5		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			3000.5		mA
P_{diss}	Power Dissipation			9087.4		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 5: 4T4R - TDD 1F shared with RX TX 75%, RX 25%, FB 75% Single Band: 12x Int, FB 3x Dec, RX 6x Dec TX/FB Rate = 983.04 Msps RX Rate 491.52 Msps f_{DAC} = 11796.48 MSPS f_{ADC} = 2949.12 MSPS f_{TX} = 3.5 GHz f_{RX} =3.5 GHz 64/66 coding, 16.22Gbps TX: 8-8-2-1, FB: 4-4-4-2, RX: 4-8-4-1		821.8		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			808.5		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			77.4		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			289.5		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			682.0		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			49.0		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2123.3		mA
P_{diss}	Power Dissipation			6209.3		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 8: same configuration as mode 7, Sleep Mode. SLEEP pin is pull high.		20.3		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			292.8		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			12.6		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			4.6		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			54.3		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			15.3		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			313.1		mA
P_{diss}	Power Dissipation			956.8		mW

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5.9 Power Supply Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 737.28MSPS, f_{DAC} = 8847.36MSPS interleave mode; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 9: 4T4R2F - FDD FB 100% on TX Single Band: 24x Int, FB 12x Dec RX Single Band: RX 24x TX/FB Rate 245.76 Msps RX Rate 122.88 Msps f_{DAC} = 5898.24 MSPS f_{ADC} = 2949.12 MSPS f_{TX} = 0.85 GHz f_{RX} = 0.8 GHz 8/10 coding, 9.8304Gbps TX: 4-8-4-1, FB: 2-4-4-1, RX: 2-8-8-1		1593.2		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			840.6		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			77.3		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			905.0		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			817.7		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			52.1		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2405.2		mA
P_{diss}	Power Dissipation			8814.3		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 10: 4T4R2F - FDD FB 100% on TX Single Band: 18x Int, FB 6x Dec RX Single Band: RX 12x TX/FB Rate 491.52 Msps RX Rate 245.76 Msps f_{DAC} = 8847.36 MSPS f_{ADC} = 2949.12 MSPS f_{TX} = 1.85 GHz f_{RX} = 1.75 GHz 8/10 coding, 9.8304Gbps TX: 8-8-2-1, FB: 4-4-2-1, RX: 4-8-4-1		1626.2		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			976.4		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			74.6		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			902.7		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			1111.9		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			48.0		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			3578.9		mA
P_{diss}	Power Dissipation			10515.0		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 11a: TDD 4T1FB (RX in Standby) Single Band: 8x Int, FB 2x Dec, RX uses FB TX/FB/RX Rate = 1474.56 Msps f_{DAC} = 11796.48 MSPS, interleave mode, f_{ADC} = 2949.12 MSPS f_{TX} = f_{RX} = 3.7 GHz 64/66 coding, 24.33 Gbps TX: 8-8-2-1, FB/RX: 8-8-2-1		797		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			817		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			73.2		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			179		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			906		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			70.5		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2483		mA
P_{diss}	Power Dissipation			6754		mW

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5.9 Power Supply Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 737.28MSPS, f_{DAC} = 8847.36MSPS interleave mode; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 11b: TDD 4R (TX in Standby) Single Band: 8x Int, FB 2x Dec, RX uses FB TX/FB/RX Rate = 1474.56 Msps f_{DAC} = 11796.48 MSPS, interleave mode, f_{ADC} = 2949.12 MSPS f_{TX} = f_{RX} = 3.7 GHz 64/66 coding, 24.33 Gbps TX: 8-8-2-1, FB/RX: 8-8-2-1		726		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			876		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			72.8		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			583		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			270		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			71.6		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2130		mA
P_{diss}	Power Dissipation			6124		mW

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5.9 Power Supply Electrical Characteristics (continued)

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 737.28MSPS, f_{DAC} = 8847.36MSPS interleave mode; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 11c: TDD 4T4R1FB average TX/FB: 75%, RX 25% Single Band: 8x Int, FB 2x Dec, RX uses FB TX/FB/RX Rate = 1474.56 Msps f_{DAC} = 11796.48 MSPS, interleave mode, f_{ADC} = 2949.12 MSPS f_{TX} = f_{RX} = 3.7 GHz 64/66 coding, 24.33 Gbps TX: 8-8-2-1, FB/RX: 8-8-2-1		779		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			832		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			73.1		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			280		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			747		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			70.8		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			2395		mA
P_{diss}	Power Dissipation			6596		mW
I_{VDD1P8}	Group 3A: VDD1P8FB + VDD1P8RX + VDD1P8TX	Mode 11d: FDD 4T4R Single Band: 8x Int, RX uses FB TX/FB/RX Rate = 1474.56 Msps f_{DAC} = 11796.48 MSPS, interleave mode, f_{ADC} = 2949.12 MSPS f_{TX} = f_{RX} = 3.7 GHz 64/66 coding, 24.33 Gbps TX: 8-8-2-1, FB/RX: 8-8-2-1		1236		mA
	Group 3B: VDD1P8FBCLK + VDD1P8RXCLK + VDD1P8TXDAC+ VDD1P8GPIO + VDDA1P8			915		mA
	Group 3C: VDD1P8PLL + VDD1P8PLLVCO			73.2		mA
I_{VDD1P2}	Group 2A: VDD1P2FB + VDD1P2RX			583		mA
	Group 2B: VDD1P2TXCLK + VDD1P2TXENC			923		mA
	Group 2C: VDD1P2FBCML + VDD1P2RXCML + VDD1P2PLLCLKREF			72		mA
I_{VDD0P9}	Group 1A: DVDD0P9 + VDDT0P9			3097		mA
P_{diss}	Power Dissipation			8798		mW

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5.10 Timing Requirements

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS, f_{DAC} = 8847.36MSPS; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

		MIN	NOM	MAX	UNIT
Timing: SYSREF+/-					
$t_{s(SYSREF)}$	Setup Time, SYSREF+/- Valid to Rising Edge of CLK+/-		50		ps
$t_{h(SYSREF)}$	Hold Time, SYSREF+/- Valid after Rising Edge of CLK+/-		50		ps
Timing: Serial ports					
$t_{s(SENB)}$	Setup Time, SENB to Rising Edge of SCLK		15		ns
$t_{h(SENB)}$	Hold Time, SENB after last Rising Edge of SCLK (1)		5 + t_{SCLK}		ns
$t_{s(SDIO)}$	Setup Time, SDIO valid to Rising Edge of SCLK		15		ns
$t_{h(SDIO)}$	Hold Time, SDIO valid after Rising Edge of SCLK		5		ns
$t_{(SCLK)_W}$	Minimum SCLK period: registers write		25		ns
$t_{(SCLK)_R}$	Minimum SCLK period: registers read		50		ns
$t_{d(data_out)}$	Minimum Data Output delay after Falling Edge of SCLK		0		ns
	Maximum Data Output delay after Falling Edge of SCLK		15		ns
t_{RESET}	Minimum RESETZ Pulse Width		1		ms

(1) SDEN\\ need to be held one more extra clock cycle with the last SCLK edge

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5.11 Switching Characteristics

Typical values at T_A = +25°C, full temperature range is $T_{A,MIN}$ = -40°C to $T_{J,MAX}$ = +110°C; TX Input Rate = 491.52MSPS, f_{DAC} = 8847.36MSPS; f_{ADC} = 2949.12MSPS; nominal power supplies; 1 tone at -1 dBFS; DSA Attenuation =0dB; SerDes rate = 24.33Gbps; unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TX Channel Latency						
	SerDes Receiver Analog Delay	Full rate		2.8		ns
t_{JESDTX}	JESD to TX output Latency	LMFSHd=2-8-8-1, 368.64 MSPS input rate, 24x Interpolation, Serdes rate = 16.22Gbps (JESD204C)		152		interface clock cycles(1)
		LMFSHd=8-16-4-1, 491.52 MSPS 24x Interpolation, Serdes rate = 16.22Gbps (JESD204C)		176		
		LMFSHd=4-16-8-1, 245.76 MSPS 48x Interpolation, Serdes rate = 16.22Gbps (JESD204C)		124		
		LMFSHd=2-16-16-1, 122.88 MSPS 96x Interpolation, Serdes rate = 16.22Gbps (JESD204C)		97		
RX Channel Latency						
	SerDes Transmitter Analog Delay			3.6		ns
t_{JESDRX}	RX input to JESD output Latency	LMFS=2-16-16-1, 122.88 MSPS, 24x Decimation, Serdes rate = 16.22Gbps (JESD204C)		92		interface clock cycles(1)
		LMFS=4-16-8-1, 245.76 MSPS, 12x Decimation, Serdes rate = 16.22Gbps (JESD204C)		108		
		LMFS=2-8-8-1, 368.64 MSPS, 8x Decimation, Serdes rate = 16.22Gbps (JESD204C)		118		
		LMFS=4-8-4-1, 491.52 MSPS, 6x Decimation, Serdes rate = 16.22Gbps (JESD204C)		153		
FB Channel Latency						
	SerDes Transmitter Analog Delay			3.6		ns
t_{JESDFB}	FB input to JESD output Latency	LMFS=1-2-8-1, 368.64 MSPS, 8x Decimation		151		interface clock cycles(1)
		LMFS=2-4-4-1, 491.52 MSPS, 6x Decimation		177		

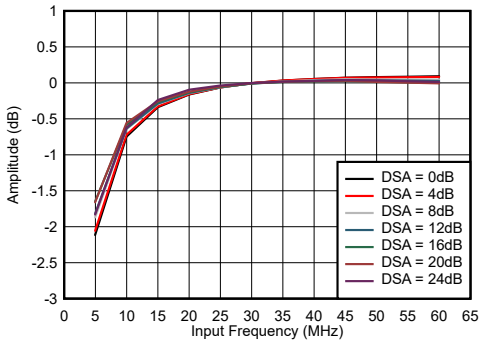
(1) Interface clock cycles is the period of the digital interface clock rate, e.g. 1GSPS = 1ns.

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5.12 Typical Characteristics

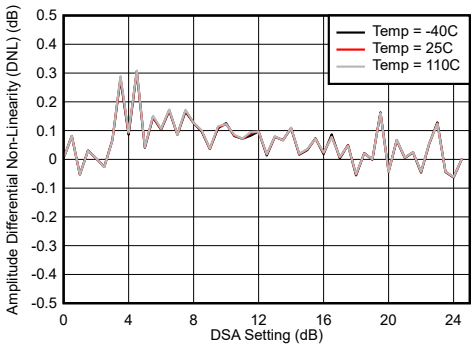
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



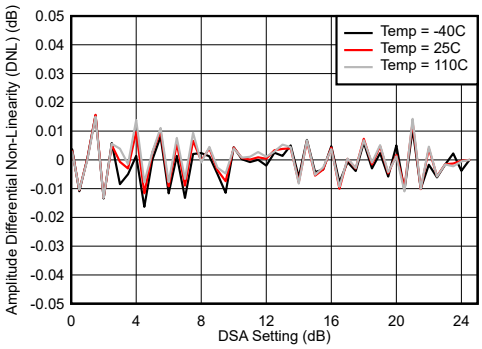
Normalized to 30 MHz

图 5-1. RX In-Band Gain Flatness, f_{IN} = 30 MHz



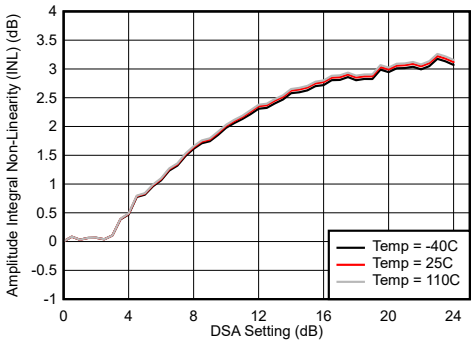
Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-2. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 30 MHz



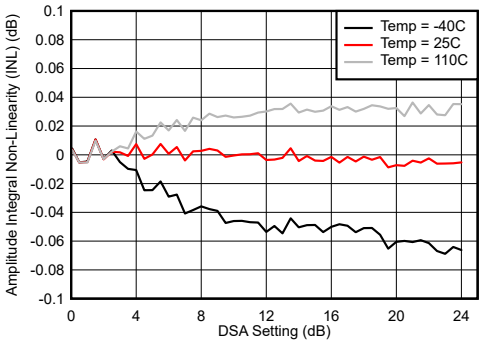
Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-3. RX Calibrated Differential Amplitude Error vs DSA Setting at 30 MHz



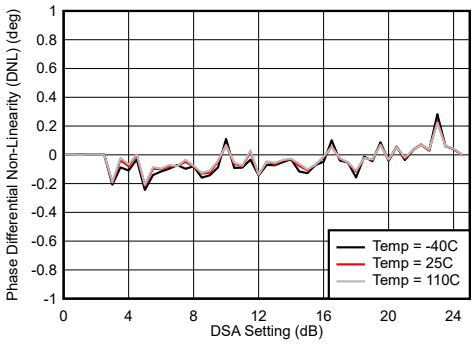
Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-4. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 30 MHz



Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-5. RX Calibrated Integrated Amplitude Error vs DSA Setting at 30 MHz



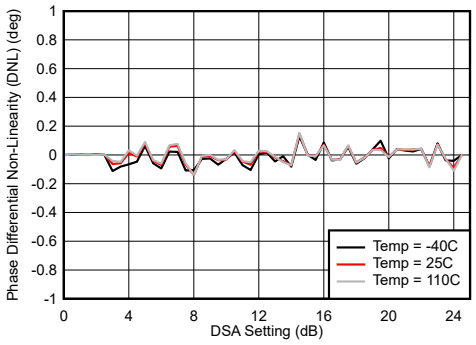
Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-6. RX Uncalibrated Differential Phase Error vs DSA Setting at 30 MHz

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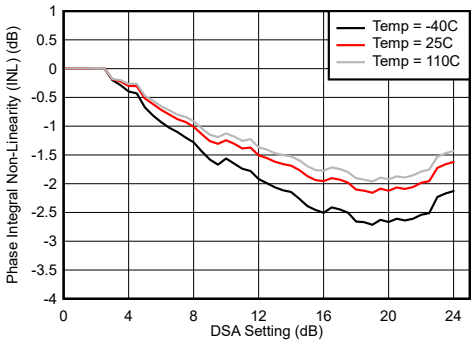
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



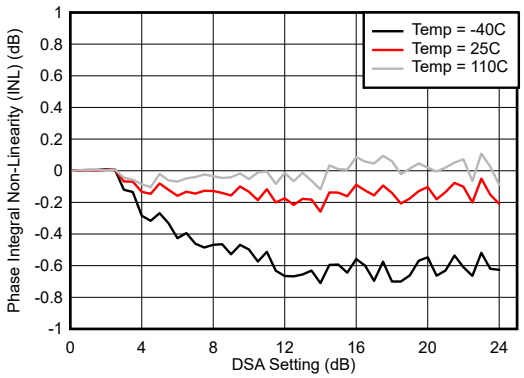
Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-7. RX Calibrated Differential Phase Error vs DSA Setting at 30 MHz



Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

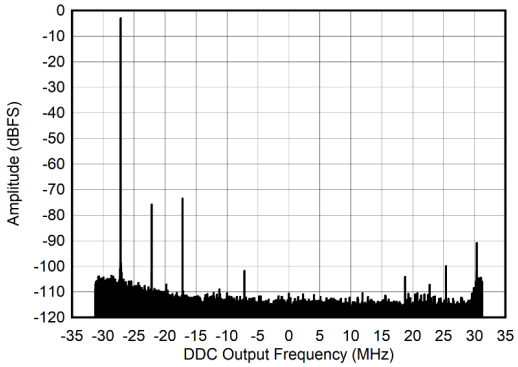
图 5-8. RX Uncalibrated Integrated Phase Error vs DSA Setting at 30 MHz



With 0.8 GHz matching

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-9. RX Calibrated Integrated Phase Error vs DSA Setting at 30 MHz

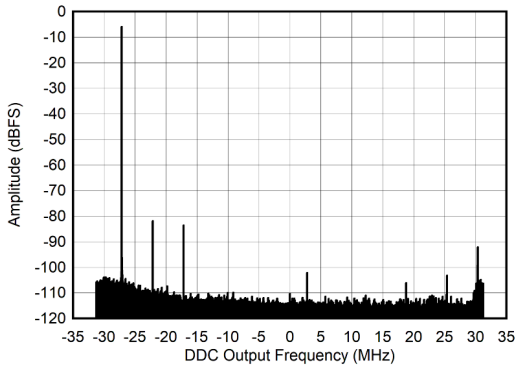


A_{IN} = -3 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-10. RX Output FFT at 5 MHz

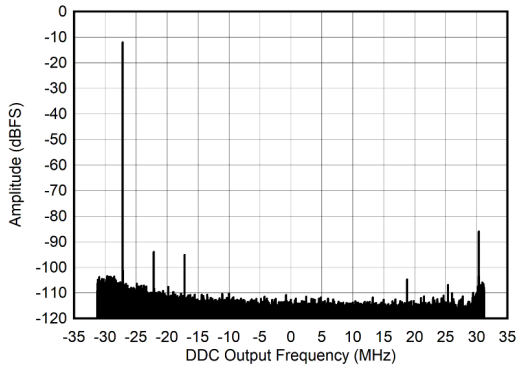
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



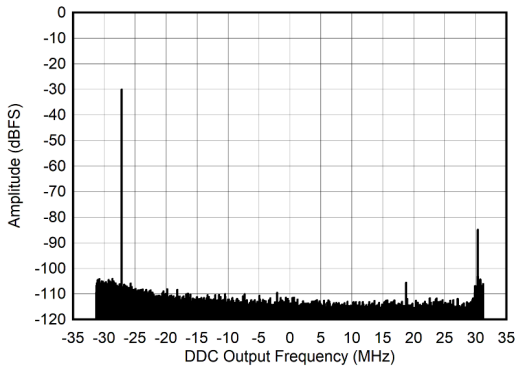
A_{IN} = -6 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32. , Decimate by 24x

图 5-11. RX Output FFT at 5 MHz



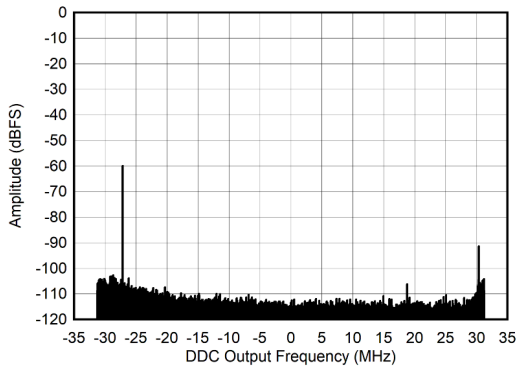
A_{IN} = -12 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-12. RX Output FFT at 5 MHz



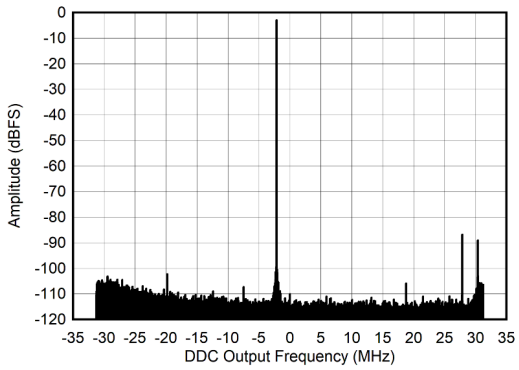
A_{IN} = -30 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-13. RX Output FFT at 5 MHz



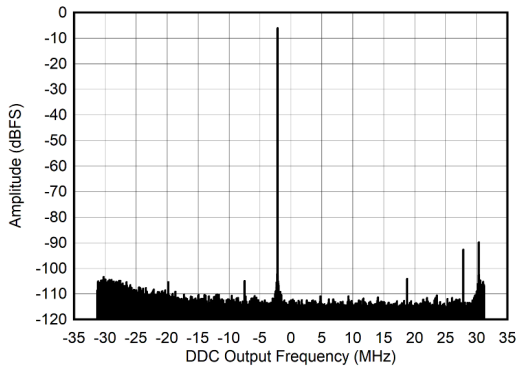
A_{IN} = -60 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-14. RX Output FFT at 5 MHz



A_{IN} = -3 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-15. RX Output FFT at 30 MHz



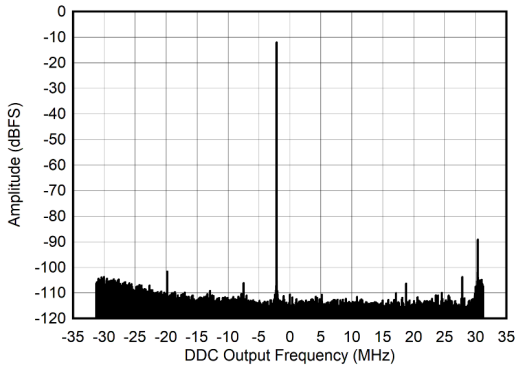
A_{IN} = -6 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-16. RX Output FFT at 30 MHz

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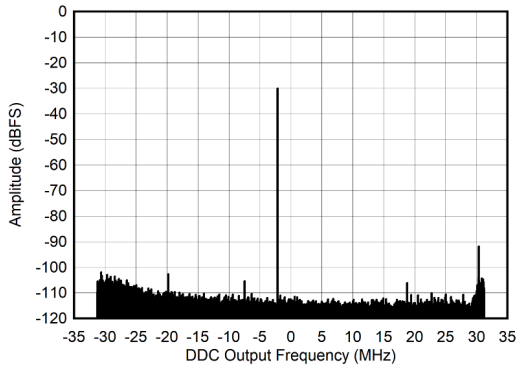
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



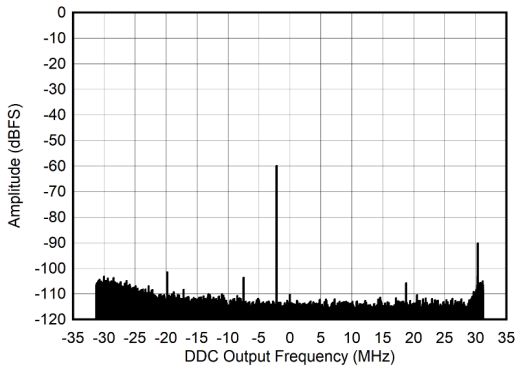
A_{IN} = -12 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-17. RX Output FFT at 30 MHz



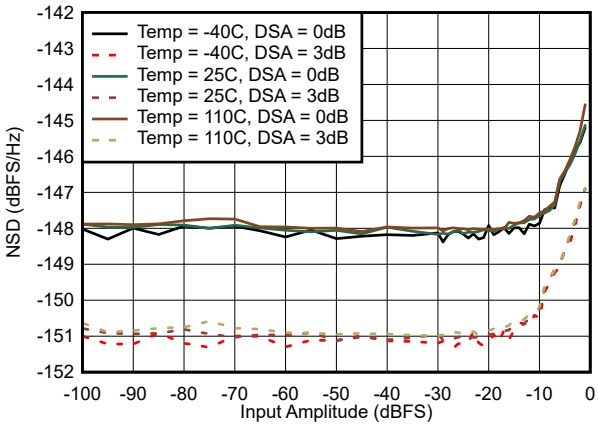
A_{IN} = -30 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-18. RX Output FFT at 30 MHz



A_{IN} = -60 dBFS, f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-19. RX Output FFT at 30 MHz

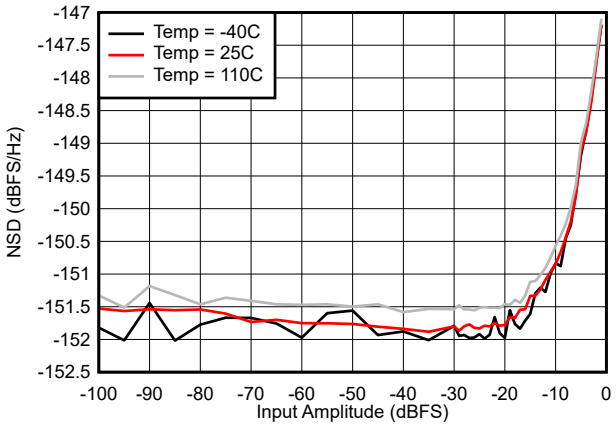


f_{ADC} = 1500MSPS, f_{NCO} = 32.13MHz, Decimate by 24x

图 5-20. NSD vs Input Amplitude at 30 MHz with DSA = 0 and 3dB

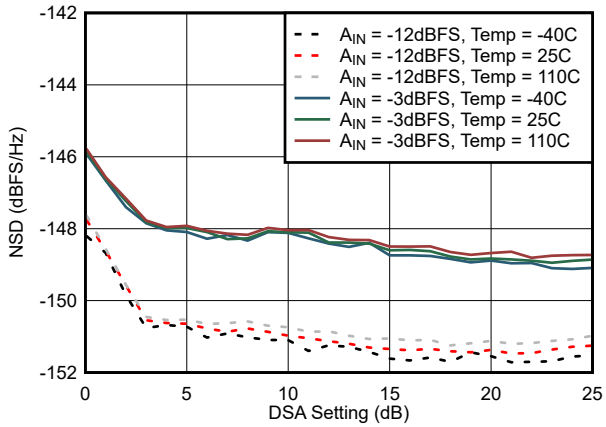
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



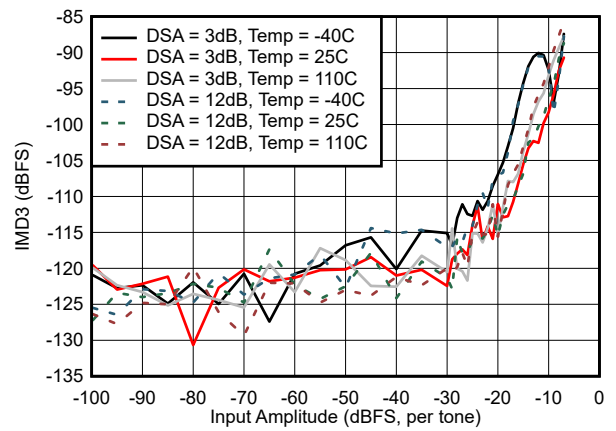
f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-21. NSD vs Input Amplitude at 30 MHz with DSA = 12



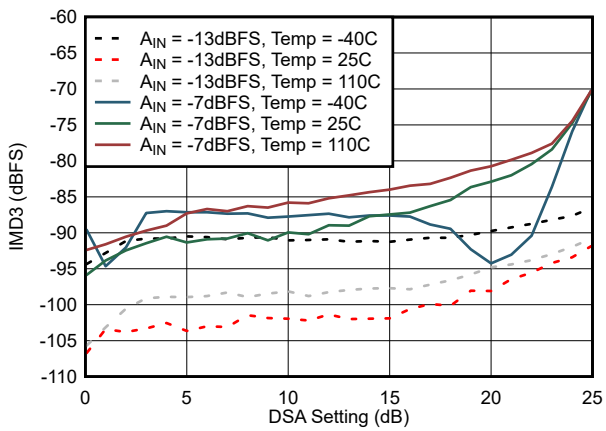
f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-22. NSD vs DSA Attenuation at 30 MHz



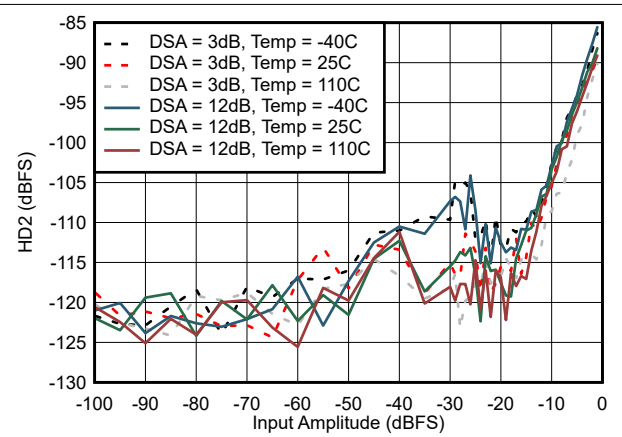
f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-23. IMD3 vs Input Amplitude at 30 MHz



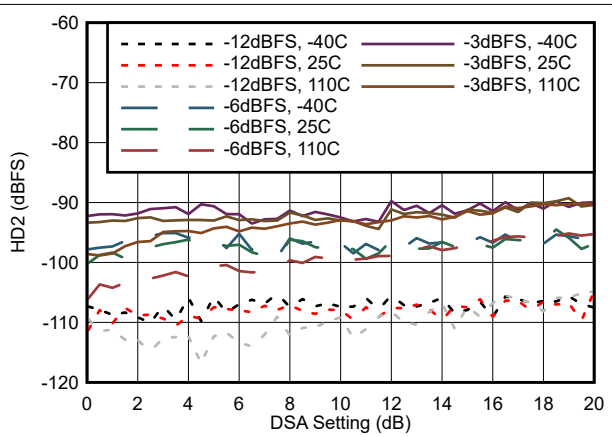
f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-24. IMD3 vs DSA Setting at 30 MHz



f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-25. HD2 vs Input Amplitude at 30 MHz



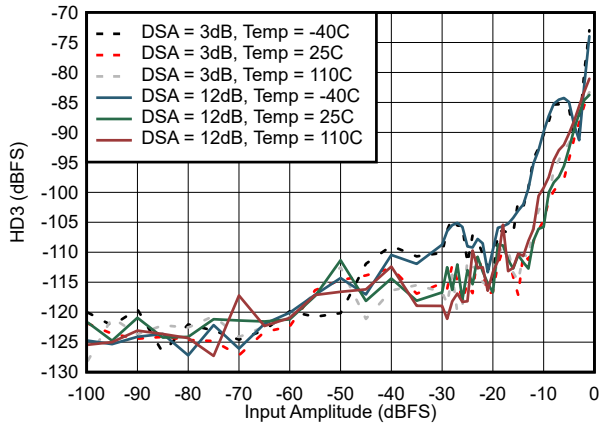
f_{ADC} = 1500 MSPS, f_{NCO} = 32. , Decimate by 24x

图 5-26. HD2 vs DSA Setting at 30 MHz

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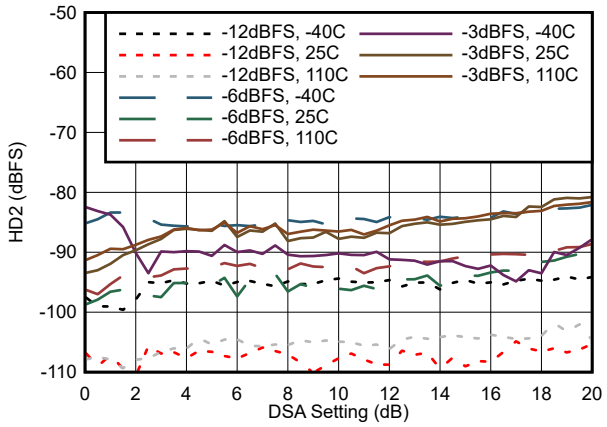
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



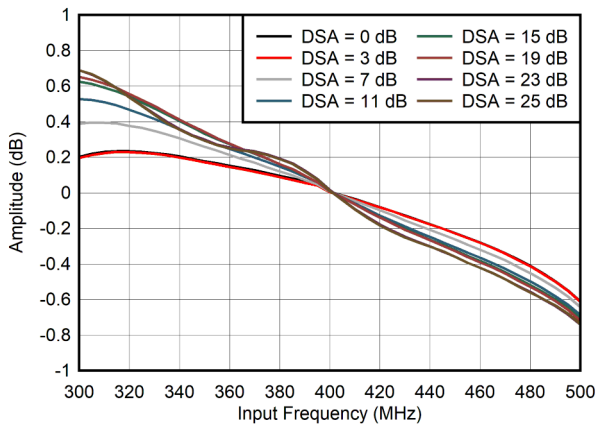
f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-27. HD3 vs Input Amplitude at 30 MHz



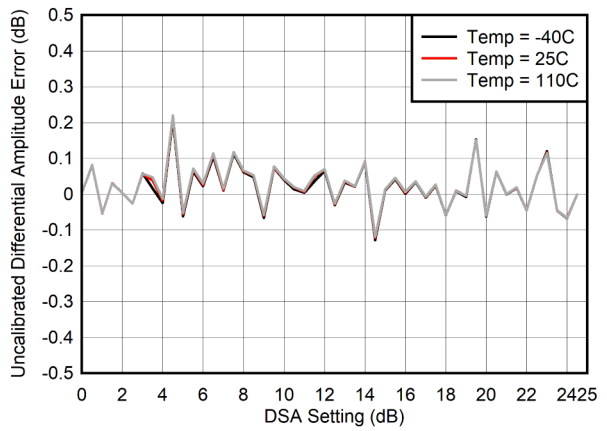
f_{ADC} = 1500 MSPS, f_{NCO} = 32.13 MHz, Decimate by 24x

图 5-28. HD3 vs DSA Setting at 30 MHz



Normalized to 4000 MHz

图 5-29. RX In-Band Gain Flatness, f_{IN} = 400 MHz



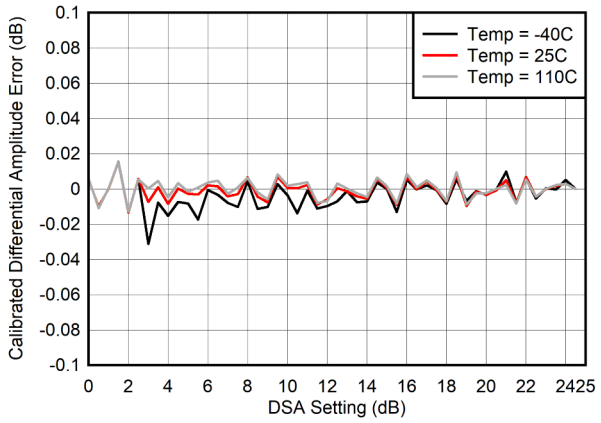
Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-30. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 30 MHz

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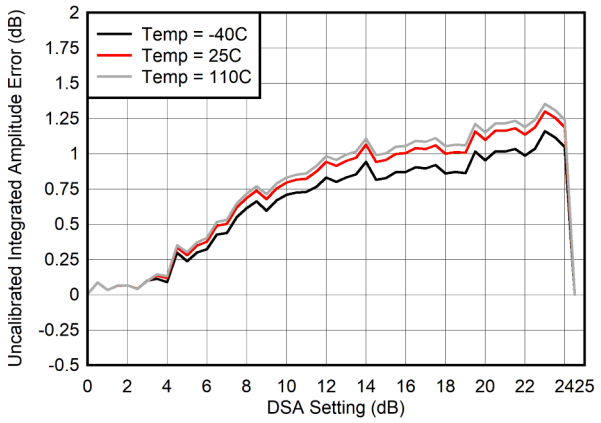
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



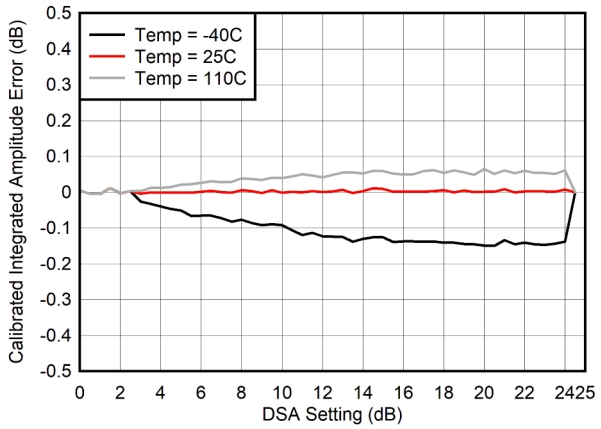
Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-31. RX Calibrated Differential Amplitude Error vs DSA Setting at 400 MHz



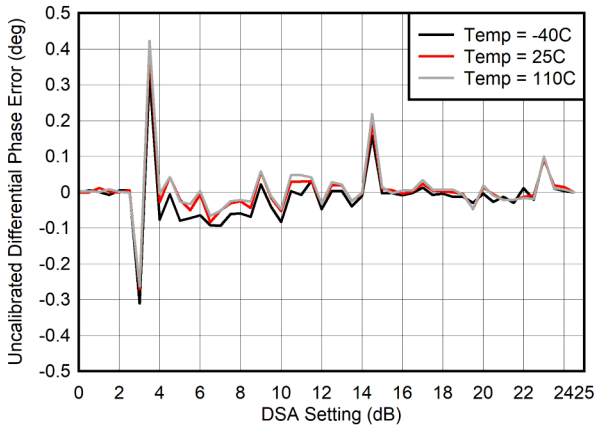
Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-32. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 400 MHz



Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-33. RX Calibrated Integrated Amplitude Error vs DSA Setting at 400 MHz



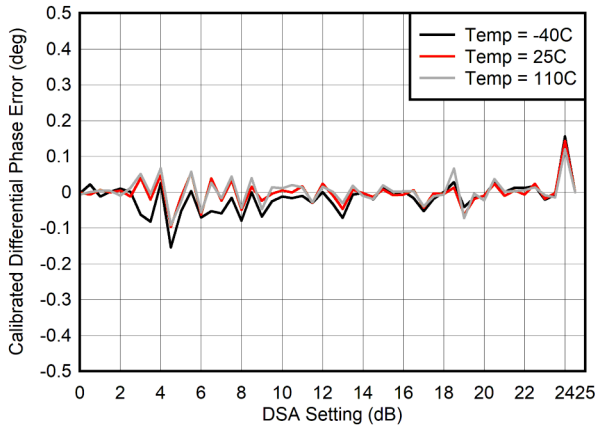
Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-34. RX Uncalibrated Differential Phase Error vs DSA Setting at 400 MHz

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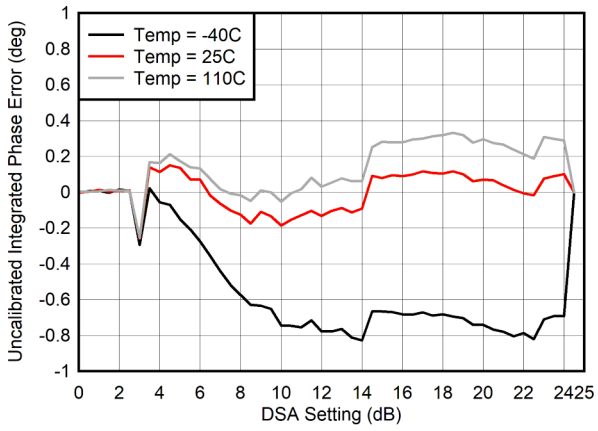
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



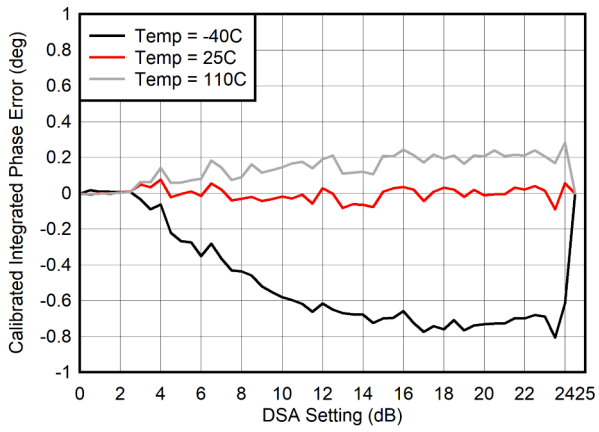
Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-35. RX Calibrated Differential Phase Error vs DSA Setting at 400 MHz



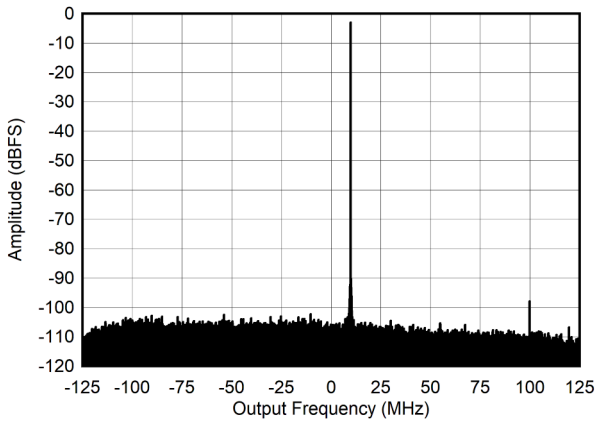
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-36. RX Uncalibrated Integrated Phase Error vs DSA Setting at 400 MHz



Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-37. RX Calibrated Integrated Phase Error vs DSA Setting at 400 MHz

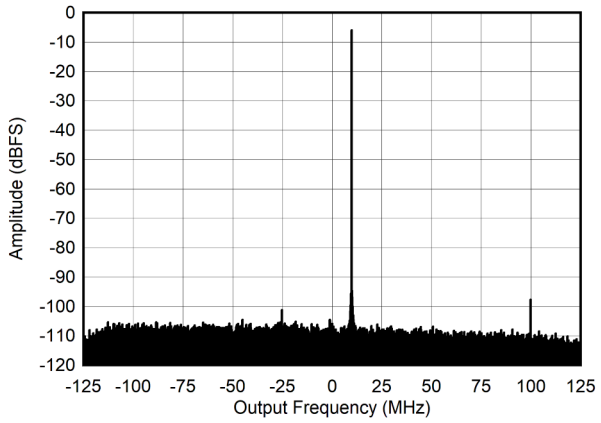


f_{NCO} = 400MHz

图 5-38. RX Output FFT at 405 MHz and -3dBFS

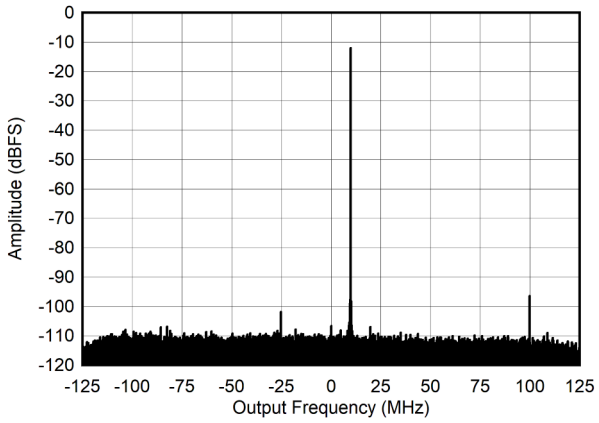
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



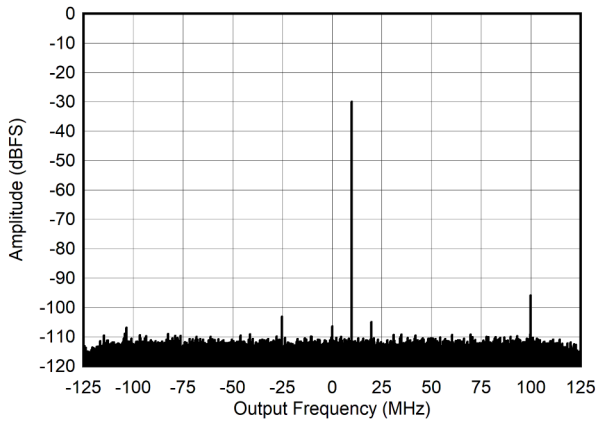
f_{NCO} = 400MHz

图 5-39. RX Output FFT at 405 MHz and -6dBFS



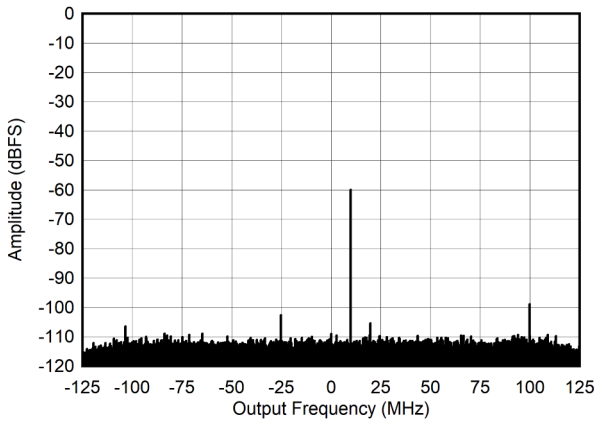
f_{NCO} = 400MHz

图 5-40. RX Output FFT at 405 MHz and -12dBFS



f_{NCO} = 400MHz

图 5-41. RX Output FFT at 405 MHz and -30dBFS



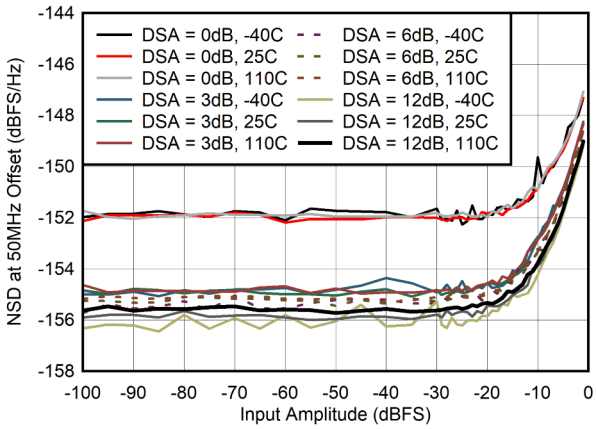
f_{NCO} = 400MHz

图 5-42. RX Output FFT at 405 MHz and -60dBFS

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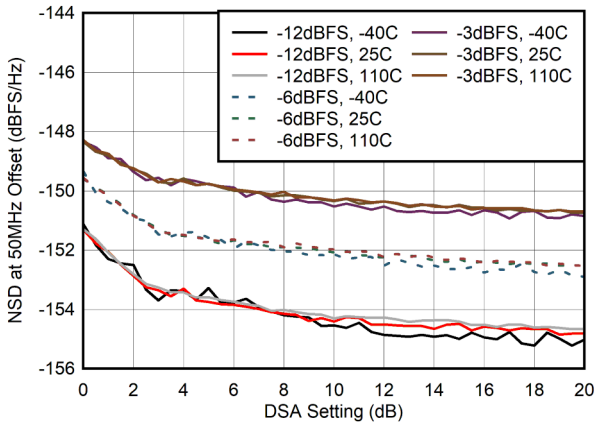
5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.



f_{OFFSET} = 50MHz

图 5-43. NSD vs Input Amplitude at 400MHz



f_{OFFSET} = 50MHz

图 5-44. NSD vs DSA Setting at 400MHz

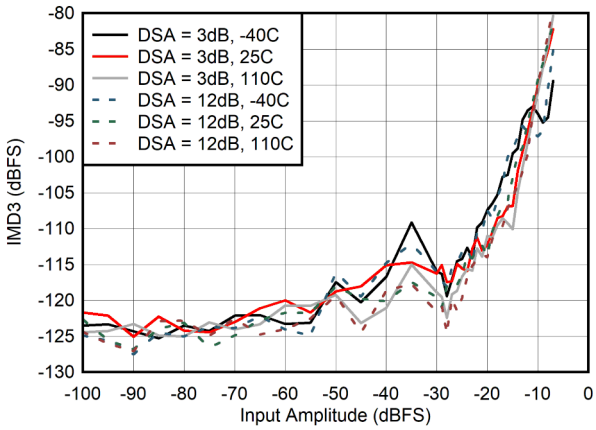


图 5-45. IMD3 vs Input Amplitude at 400MHz

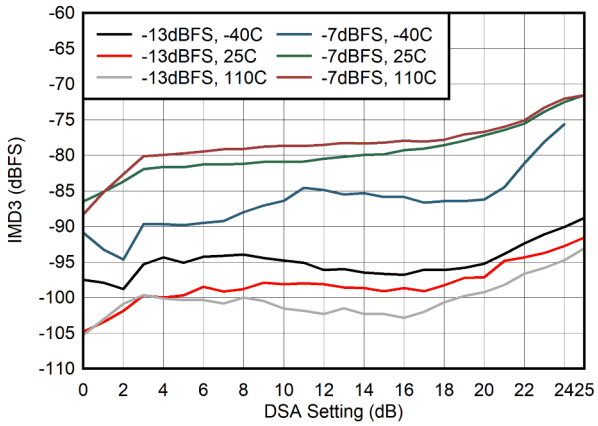


图 5-46. IMD3 vs DSA Setting at 400MHz

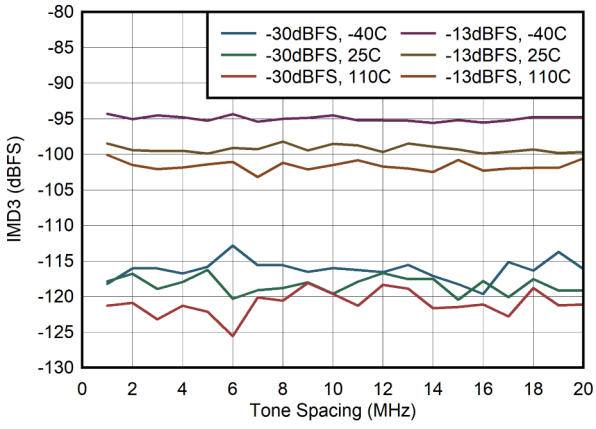


图 5-47. IMD3 vs Tone Spacing at 400MHz

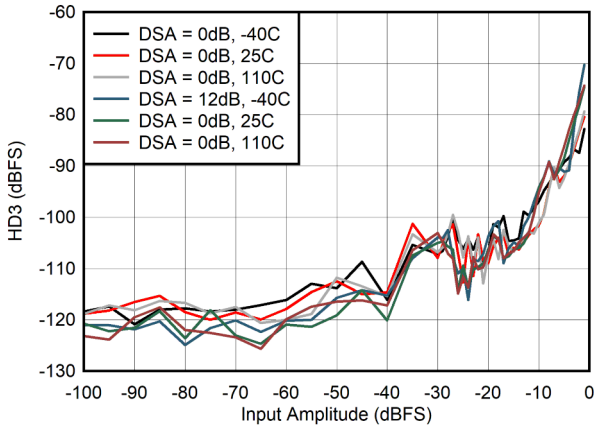


图 5-48. HD3 vs Input Amplitude at 400MHz

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5.12.1 RX Typical Characteristics 30 MHz and 400 MHz (continued)

Typical values at T_A = +25°C. Default conditions at 30MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 62.5 MSPS (decimate by 24x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB. Default conditions at 400 MHz: ADC Sampling Rate = 1500 MSPS, output sample rate = 125 MSPS (decimate by 12x), PLL clock mode with f_{REF} = 500 MHz, A_{IN} = – 3 dBFS, DSA setting = 3 dB.

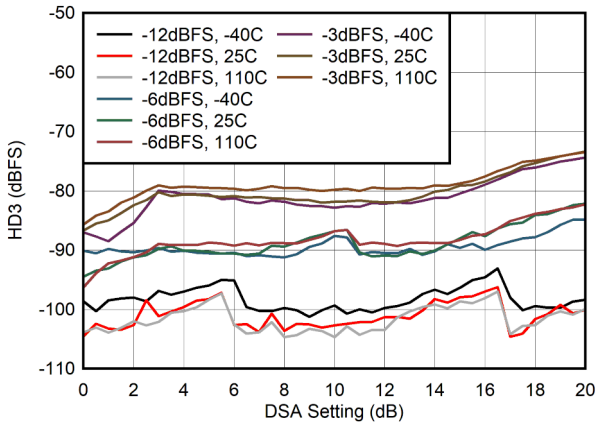
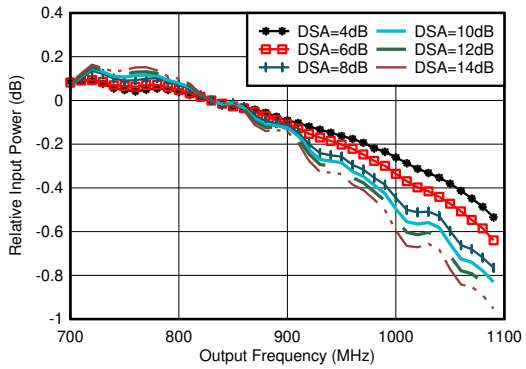


图 5-49. HD3 vs DSA Setting at 400MHz

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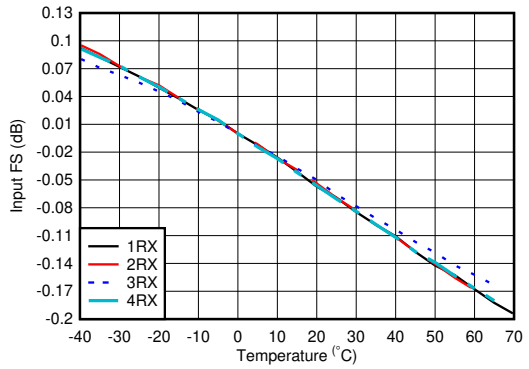
5.12.2 RX Typical Characteristics at 800MHz

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



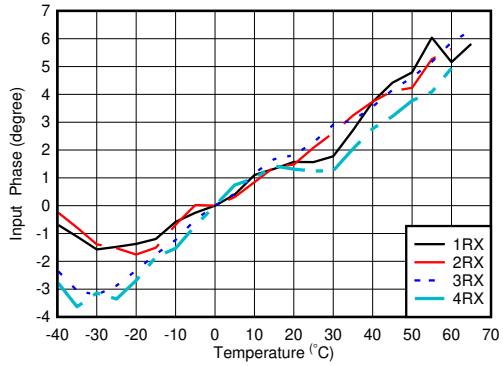
With 0.8 GHz matching, normalized to 830 MHz

图 5-50. RX In-Band Gain Flatness for Channel 1RX, f_{IN} = 830 MHz



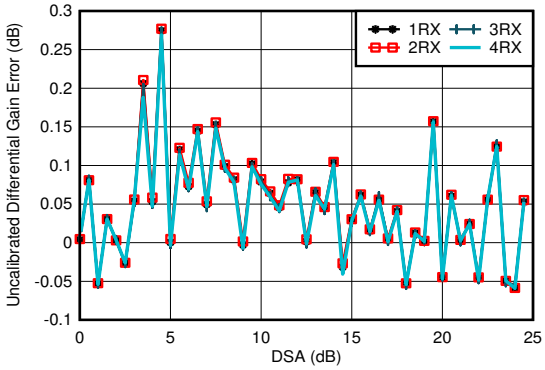
With 0.8 GHz matching, normalized to fullscale at 25°C for each channel

图 5-51. RX Input Fullscale vs Temperature and Channel at 800MHz



With 0.8 GHz matching, normalized to phase at 25°C

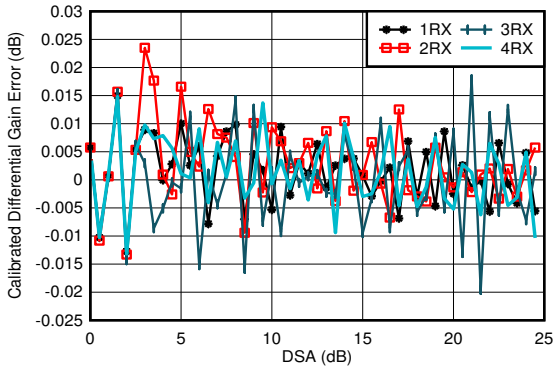
图 5-52. RX Input Phase vs Temperature and DSA at f_{OUT} = 0.8 GHz



With 0.8 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

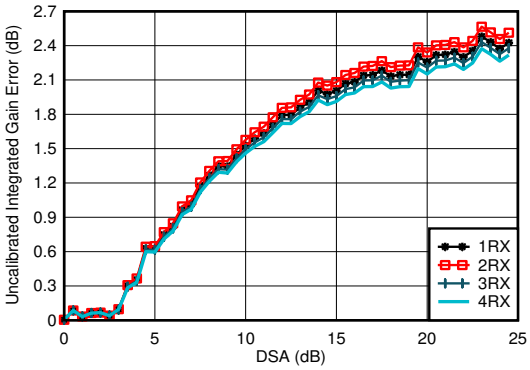
图 5-53. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 0.8 GHz



With 0.8 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-54. RX Calibrated Differential Amplitude Error vs DSA Setting at 0.8 GHz



With 0.8 GHz matching

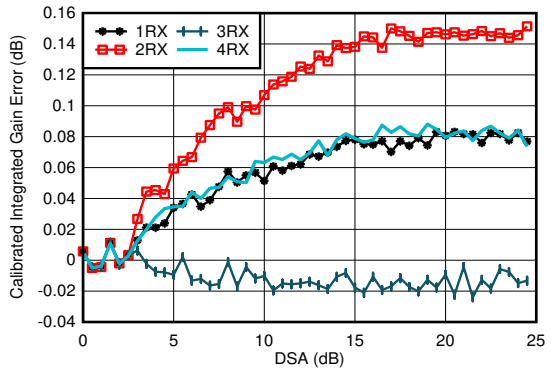
Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-55. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 0.8 GHz

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5.12.2 RX Typical Characteristics at 800MHz (continued)

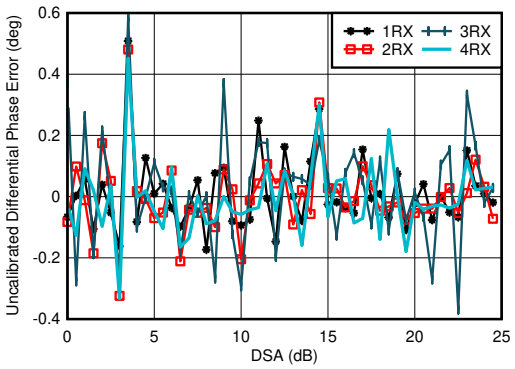
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 0.8 GHz matching

Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

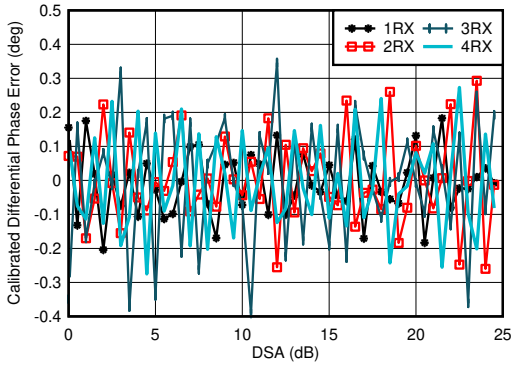
图 5-56. RX Calibrated Integrated Amplitude Error vs DSA Setting at 2.6 GHz



With 0.8 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

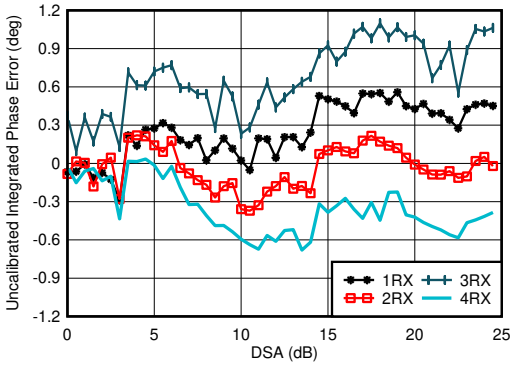
图 5-57. RX Uncalibrated Differential Phase Error vs DSA Setting at 0.8 GHz



With 0.8 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-58. RX Calibrated Differential Phase Error vs DSA Setting at 0.8 GHz



With 0.8 GHz matching

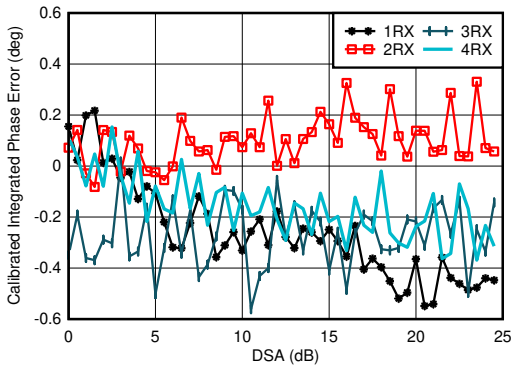
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-59. RX Uncalibrated Integrated Phase Error vs DSA Setting at 0.8 GHz

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5.12.2 RX Typical Characteristics at 800MHz (continued)

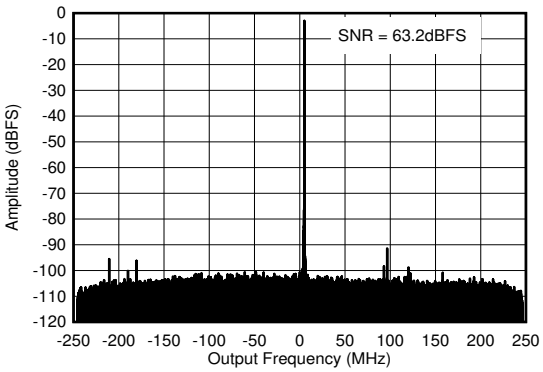
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 0.8 GHz matching

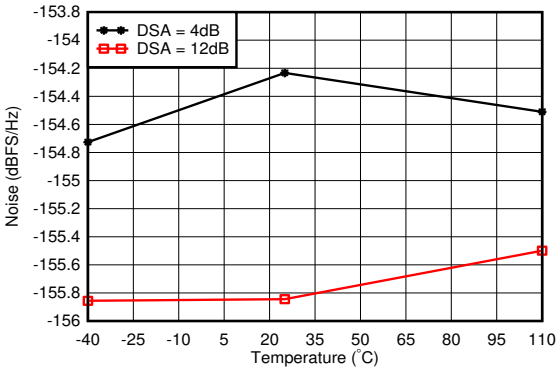
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-60. RX Calibrated Integrated Phase Error vs DSA Setting at 0.8 GHz



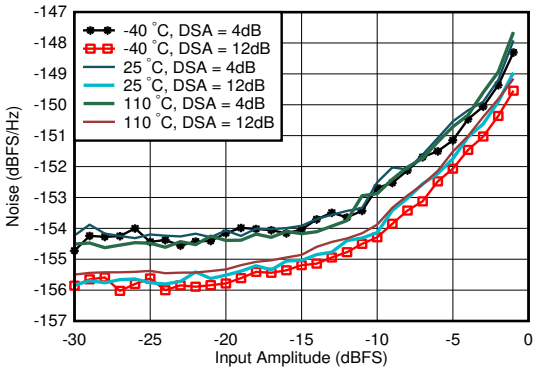
With 0.8 GHz matching, f_{IN} = 840 MHz, A_{IN}= – 3 dBFS

图 5-61. RX Output FFT at 0.8 GHz



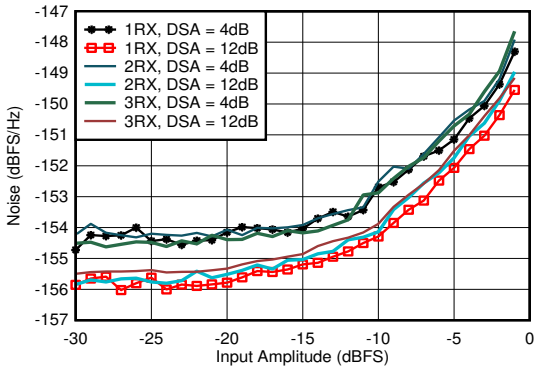
With 0.8 GHz matching, 12.5-MHz offset from tone

图 5-62. RX Noise Spectral Density vs Temperature at 0.8 GHz



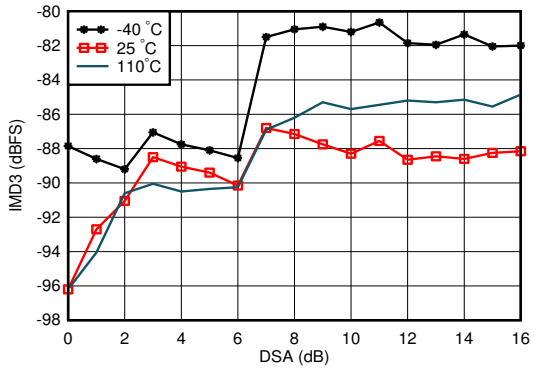
With 0.8 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 5-63. RX Noise Spectral Density vs Input Amplitude and Temperature at 0.8 GHz



With 0.8 GHz matching, 12.5-MHz offset from tone

图 5-64. RX Noise Spectral Density vs Input Amplitude and Channel at 0.8 GHz



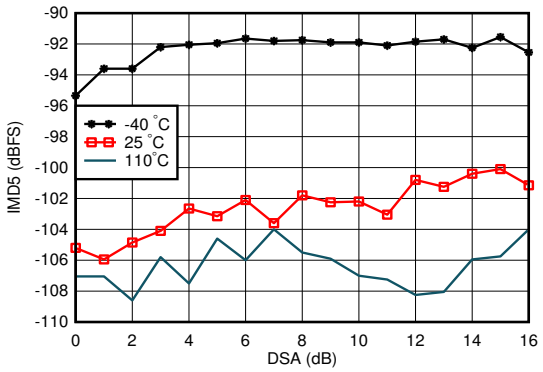
A. With 0.8 GHz matching, each tone – 7 dBFS, tone spacing = 20 MHz

图 5-65. RX IMD3 vs DSA Setting and Temperature at 0.8 GHz

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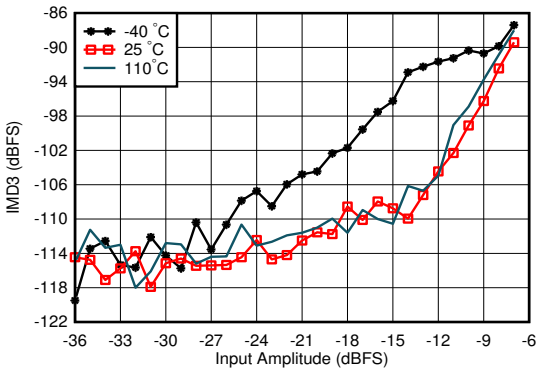
5.12.2 RX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



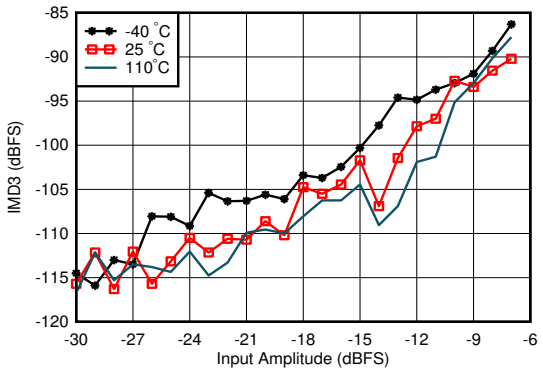
With 0.8 GHz matching, each tone – 7 dBFS, tone spacing = 20 MHz

图 5-66. RX IMD5 vs DSA Setting and Temperature at 0.8 GHz



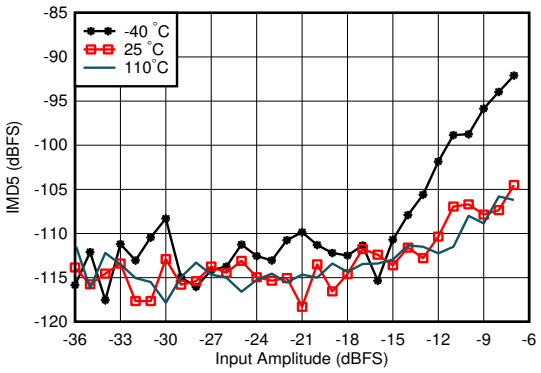
With 0.8 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 5-67. RX IMD3 vs Input Level and Temperature at 0.8 GHz



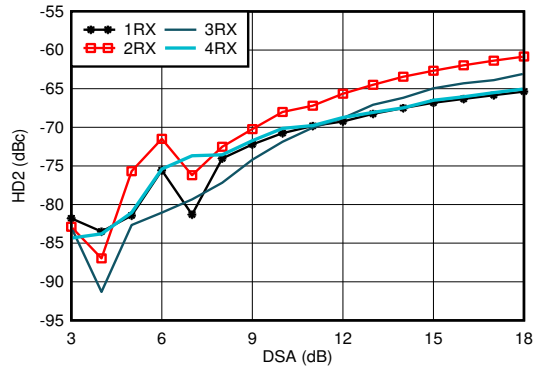
With 0.8 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 5-68. RX IMD3 vs Input Level and Temperature at 0.8 GHz



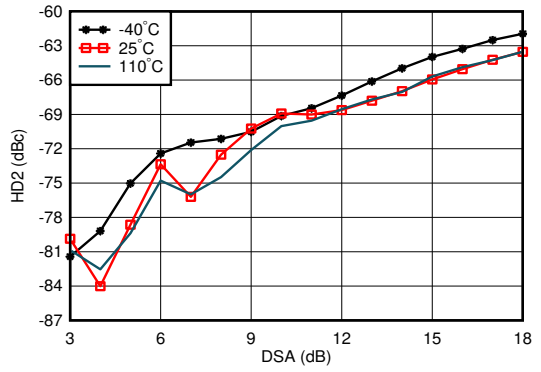
With 0.8 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 5-69. RX IMD5 vs Input Level and Temperature at 0.8 GHz



With 0.8 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-70. RX HD2 vs DSA Setting and Channel at 0.8 GHz



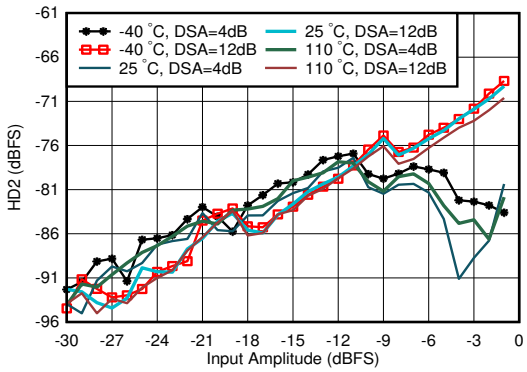
With 0.8 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-71. RX HD2 vs DSA Setting and Temperature at 0.8 GHz

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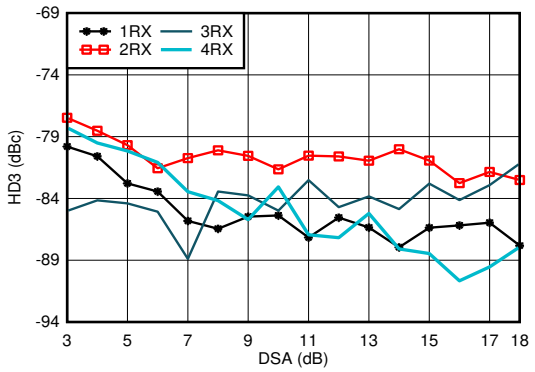
5.12.2 RX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



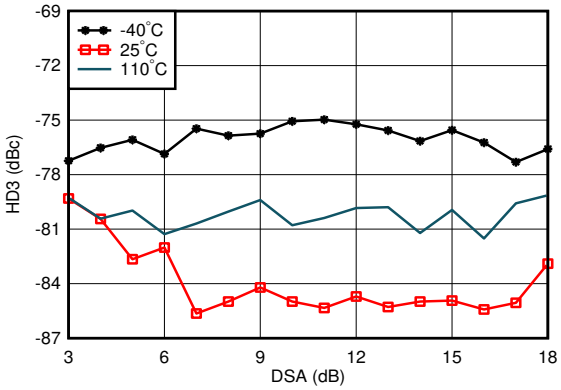
With 0.8 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-72. RX HD2 vs Input Level and Temperature at 0.8 GHz



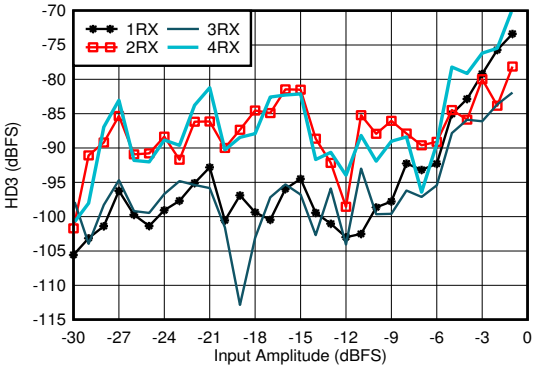
With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-73. RX HD3 vs DSA Setting and Channel at 0.8 GHz



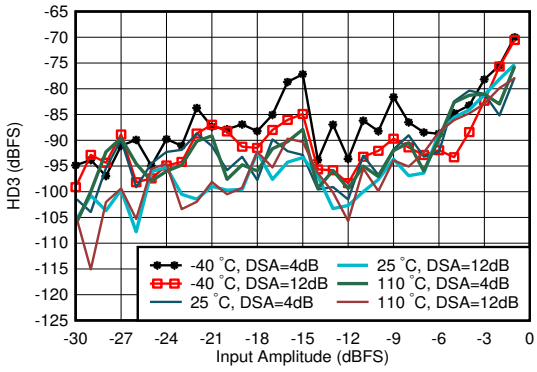
With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-74. RX HD3 vs DSA Setting and Temperature at 0.8 GHz



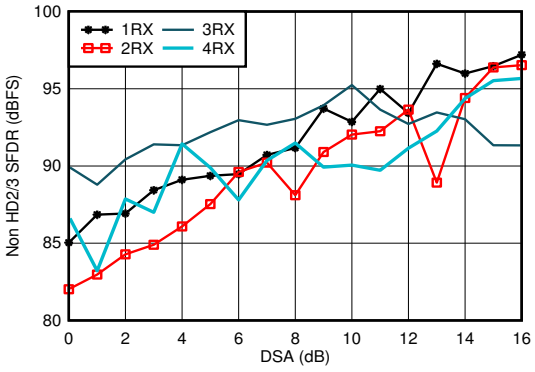
With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-75. RX HD3 vs Input Level and Channel at 0.8 GHz



With 0.8 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-76. RX HD3 vs Input Level and Temperature at 0.8 GHz



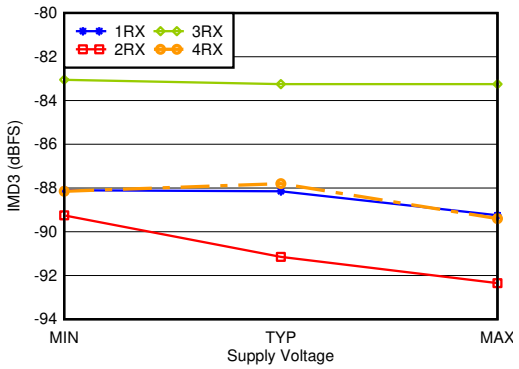
With 0.8 GHz matching

图 5-77. RX Non-HD2/3 vs DSA Setting at 0.8 GHz

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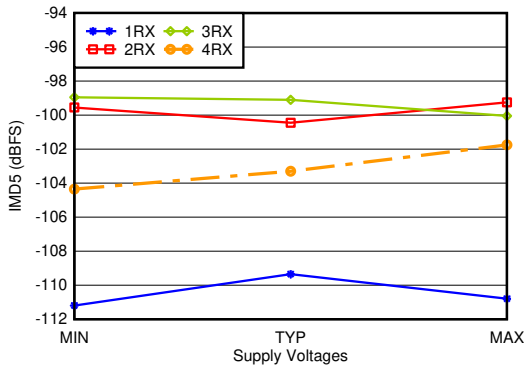
5.12.2 RX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



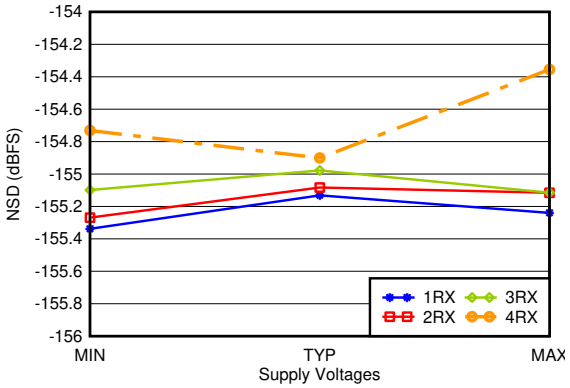
With 0.8 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-78. RX IMD3 vs Supply and Channel at 0.8 GHz



With 0.8 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-79. RX IMD5 vs Supply and Channel at 0.8 GHz



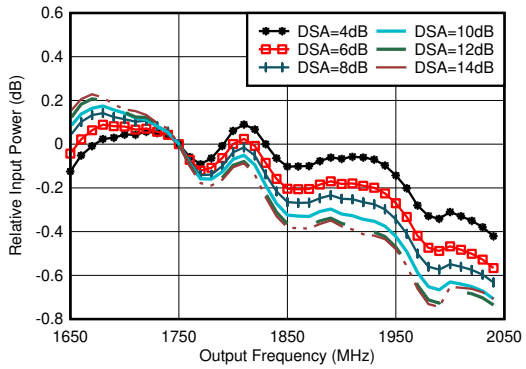
With 0.8 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-80. RX Noise Spectral Density vs Supply and Channel at 0.8 GHz

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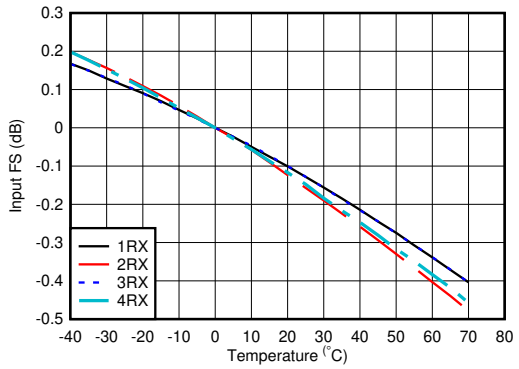
5.12.3 RX Typical Characteristics 1.75GHz to 1.9GHz

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



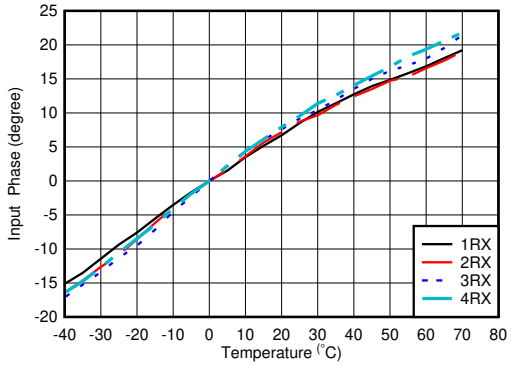
With 1.8 GHz matching, normalized to 1.75 GHz

图 5-81. RX In-Band Gain Flatness, f_{IN} = 1750 MHz



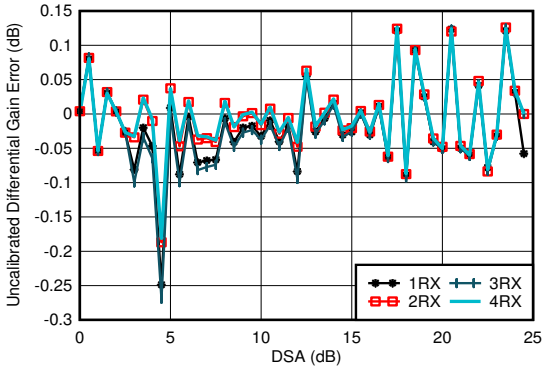
With 1.8 GHz matching, normalized to fullscale at 25°C for each channel

图 5-82. RX Input Fullscale vs Temperature and Channel at 1.75 GHz



With 2.6 GHz matching, normalized to phase at 25°C

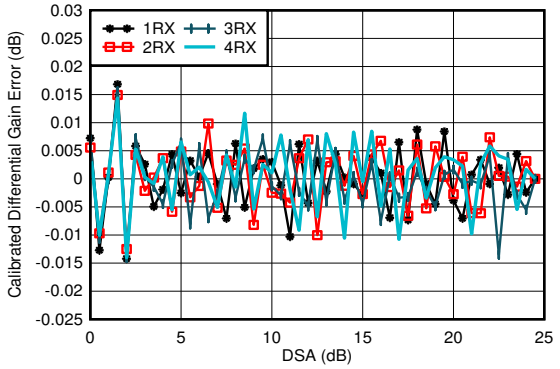
图 5-83. RX Input Phase vs Temperature and DSA at f_{IN} = 1.75 GHz



With 1.8 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

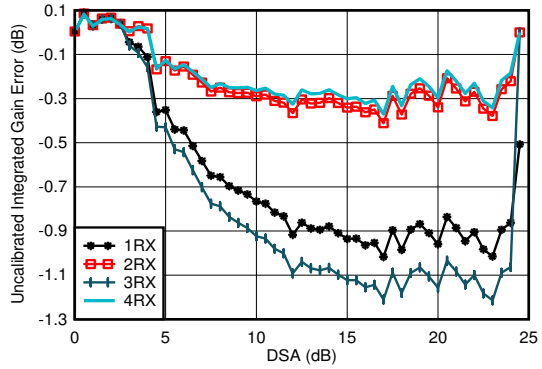
图 5-84. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-85. RX Calibrated Differential Amplitude Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

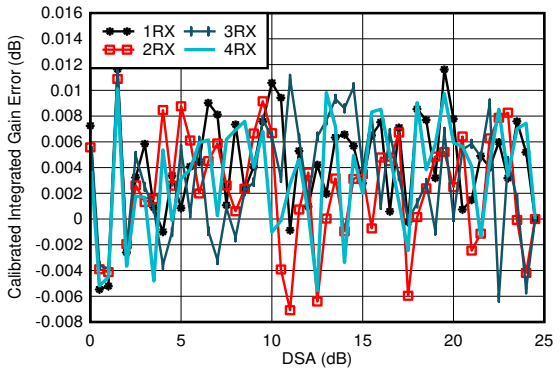
Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-86. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 1.75 GHz

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5.12.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

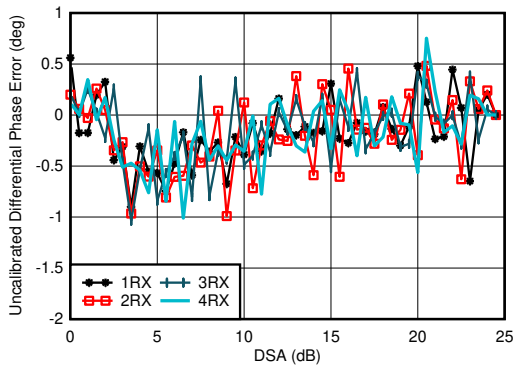
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 1.8 GHz matching

Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

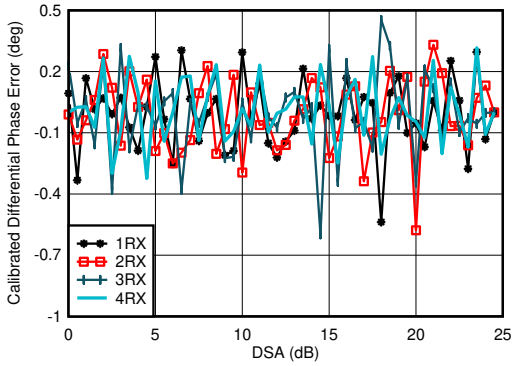
图 5-87. RX Calibrated Integrated Amplitude Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

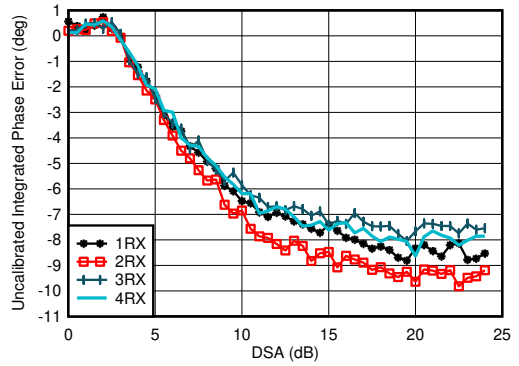
图 5-88. RX Uncalibrated Differential Phase Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-89. RX Calibrated Differential Phase Error vs DSA Setting at 1.75 GHz



With 1.8 GHz matching

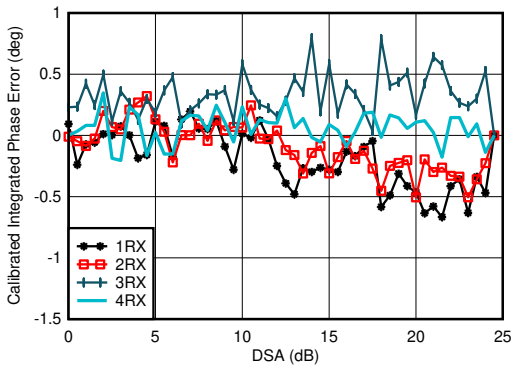
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-90. RX Uncalibrated Integrated Phase Error vs DSA Setting at 1.75 GHz

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5.12.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

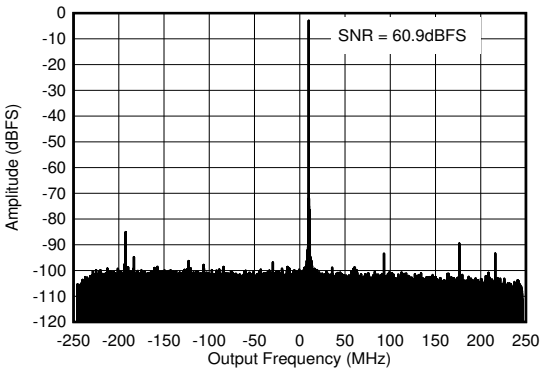
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 1.8 GHz matching

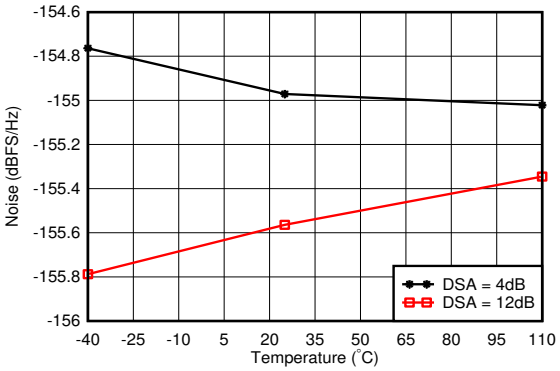
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-91. RX Calibrated Integrated Phase Error vs DSA Setting at 1.75 GHz



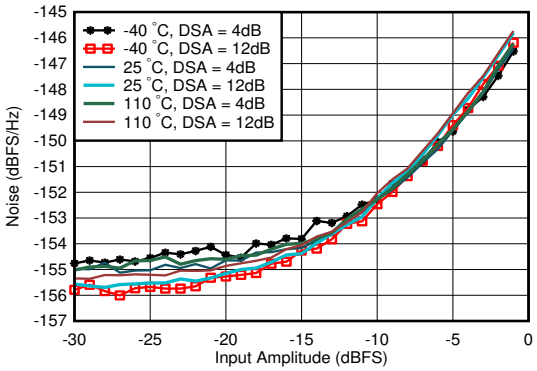
With 1.8 GHz matching, f_{IN} = 2610 MHz, A_{IN}= – 3 dBFS

图 5-92. RX Output FFT at 1.75 GHz



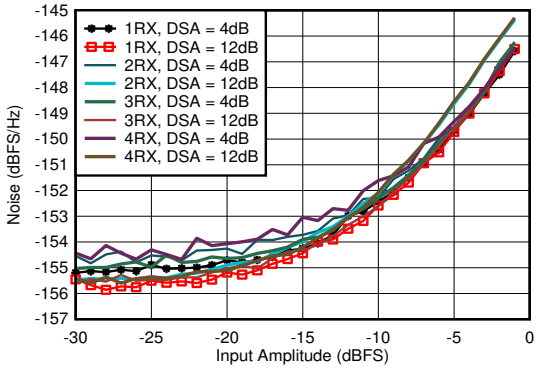
With 1.8 GHz matching, 12.5-MHz offset from tone

图 5-93. RX Noise Spectral Density vs Temperature at 1.75 GHz



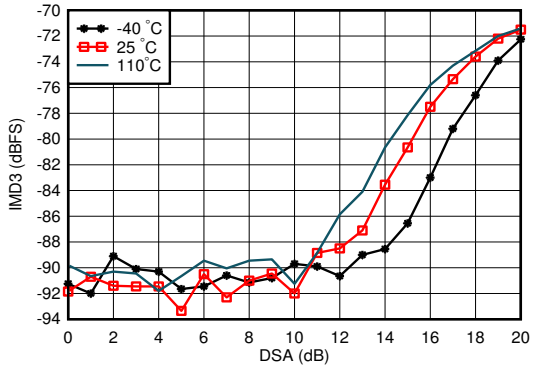
With 1.8 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 5-94. RX Noise Spectral Density vs Input Amplitude and Temperature at 1.75 GHz



With 1.8 GHz matching, 12.5-MHz offset from tone

图 5-95. RX Noise Spectral Density vs Input Amplitude and Channel at 1.75 GHz



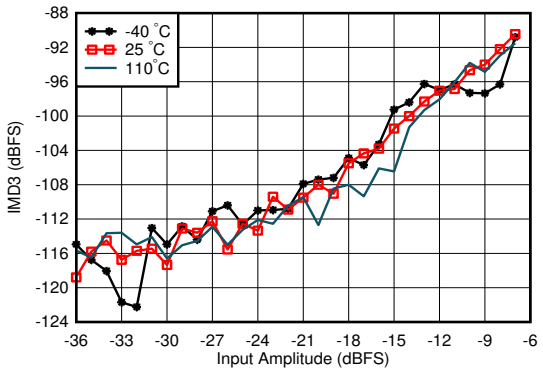
With 1.8 GHz matching, each tone – 7 dBFS, tone spacing = 20 MHz

图 5-96. RX IMD3 vs DSA Setting and Temperature at 1.75 GHz

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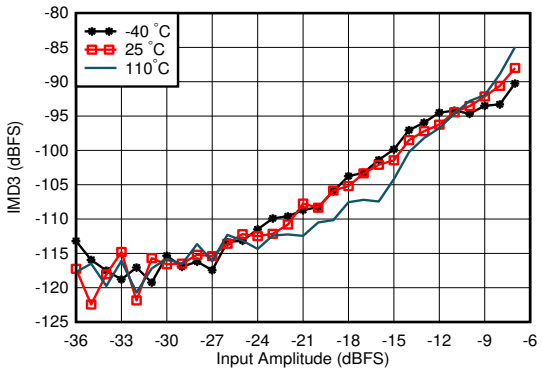
5.12.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



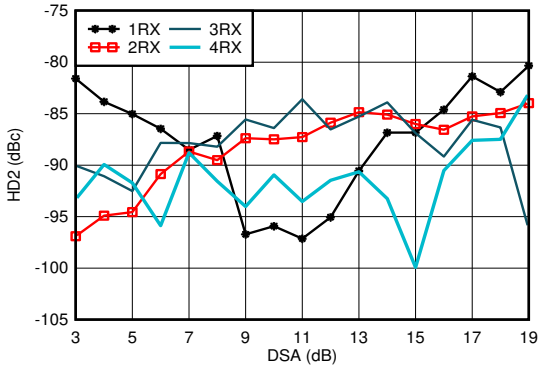
With 1.8 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 5-97. RX IMD3 vs Input Level and Temperature at 1.75 GHz



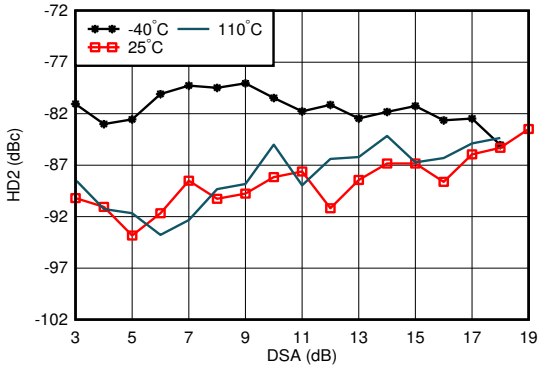
With 1.8 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 5-98. RX IMD3 vs Input Level and Temperature at 1.75 GHz



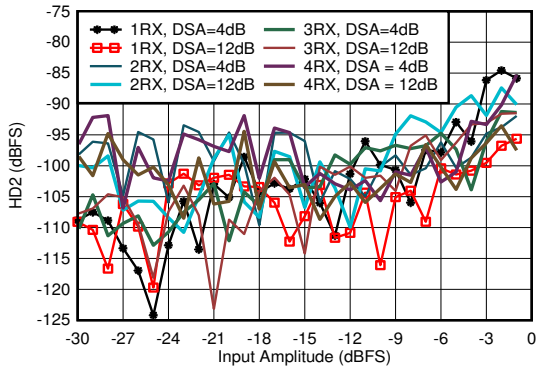
With 1.8 GHz matching, f_{in} = 1900MHz, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-99. RX HD2 vs DSA Setting and Channel at 1.9 GHz



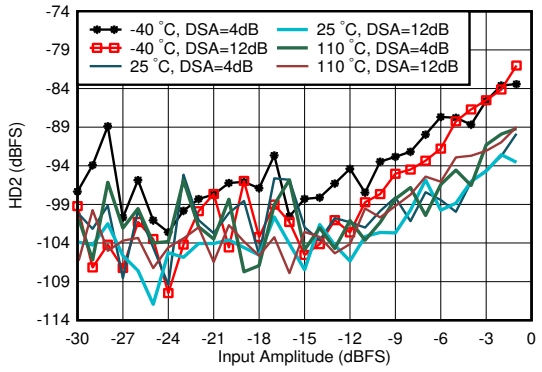
With 1.8 GHz matching, f_{in} = 1900MHz, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-100. RX HD2 vs DSA Setting and Temperature at 1.9 GHz



With 1.8 GHz matching, f_{in} = 1900MHz, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-101. RX HD2 vs Input Amplitude and Channel at 1.9 GHz



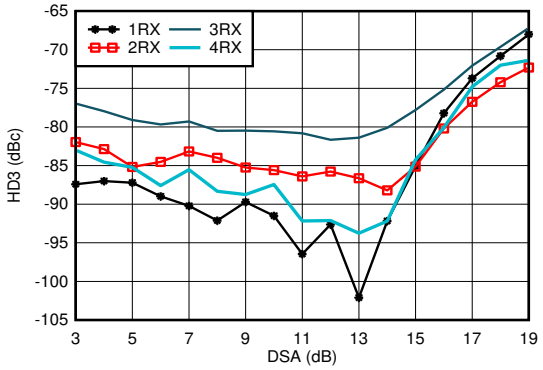
With 1.8 GHz matching, f_{in} = 1900MHz, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-102. RX HD2 vs Input Amplitude and Temperature at 1.9 GHz

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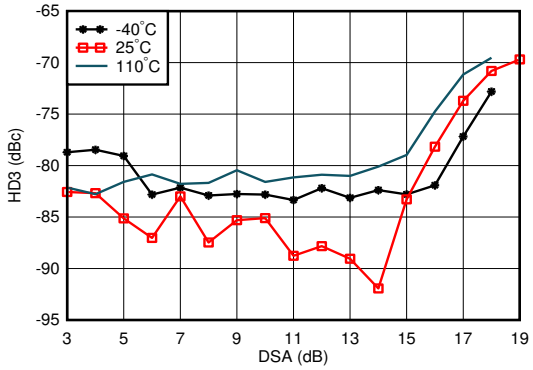
5.12.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



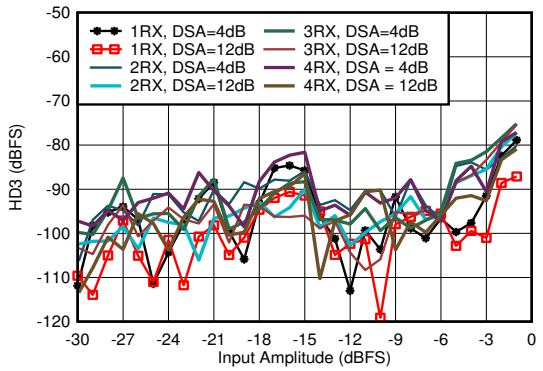
With 1.8 GHz matching, f_{in} = 1900MHz, DDC bypass mode (TI only mode for characterization)

图 5-103. RX HD3 vs DSA Setting and Channel at 1.9 GHz



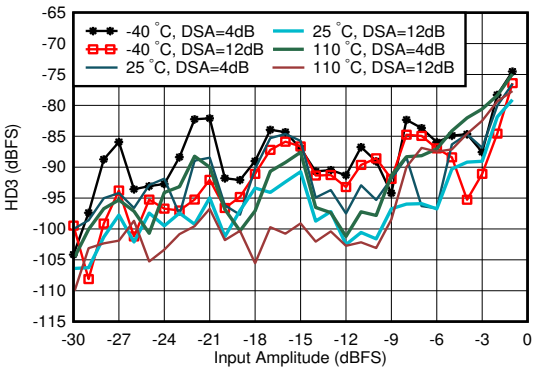
With 1.8 GHz matching, f_{in} = 1900MHz, DDC bypass mode (TI only mode for characterization)

图 5-104. RX HD3 vs DSA Setting and Temperature at 1.9 GHz



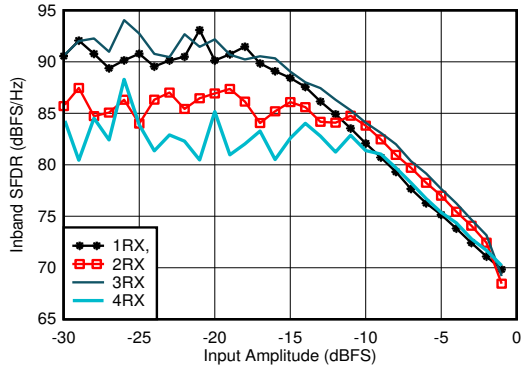
With 1.8 GHz matching, f_{in} = 1900MHz, DDC bypass mode (TI only mode for characterization)

图 5-105. RX HD3 vs Input Level and Channel at 1.9 GHz



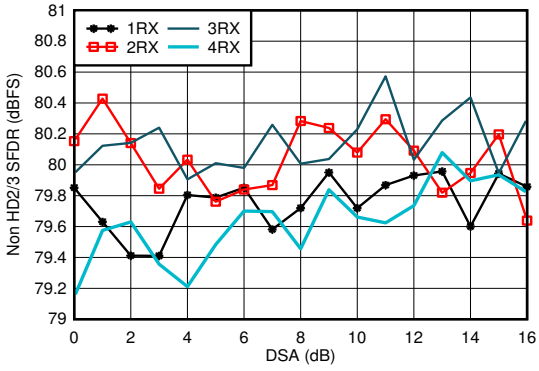
With 1.8 GHz matching, f_{in} = 1900MHz, DDC bypass mode (TI only mode for characterization)

图 5-106. RX HD3 vs Input Level and Temperature at 1.9 GHz



With 1.8 GHz matching, decimated by 3

图 5-107. RX In-Band SFDR (±400 MHz) vs Input Amplitude at 1.75 GHz



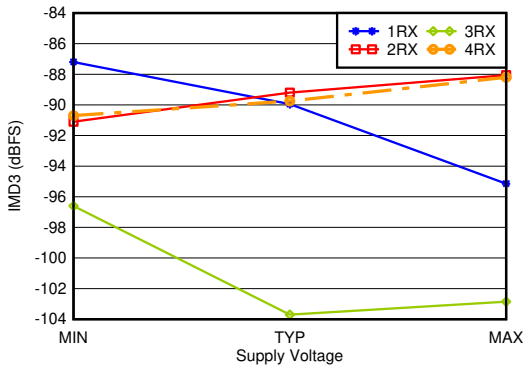
With 1.8 GHz matching

图 5-108. RX Non-HD2/3 vs DSA Setting at 1.75 GHz

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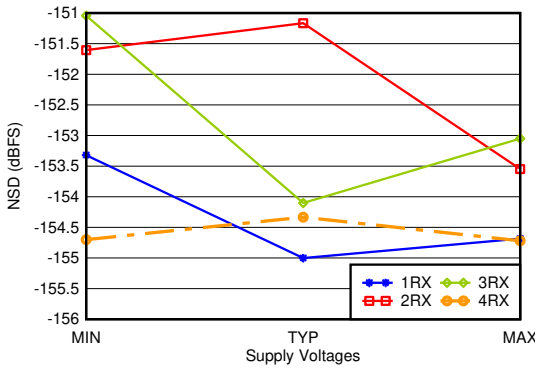
5.12.3 RX Typical Characteristics 1.75GHz to 1.9GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 1.8 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-109. RX IMD3 vs Supply and Channel at 1.75 GHz



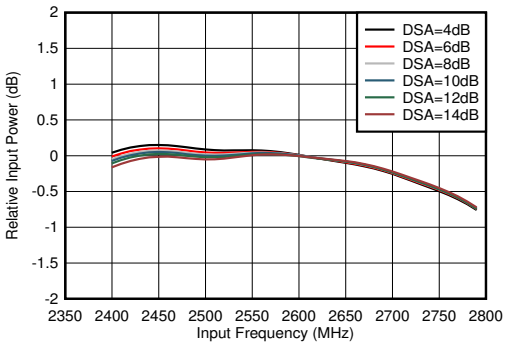
With 1.8 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-110. RX Noise Spectral Density vs Supply and Channel at 1.75 GHz

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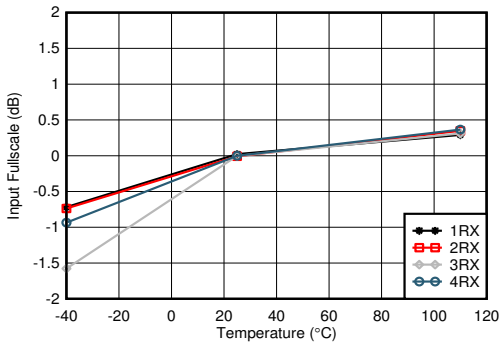
5.12.4 RX Typical Characteristics 2.6GHz

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



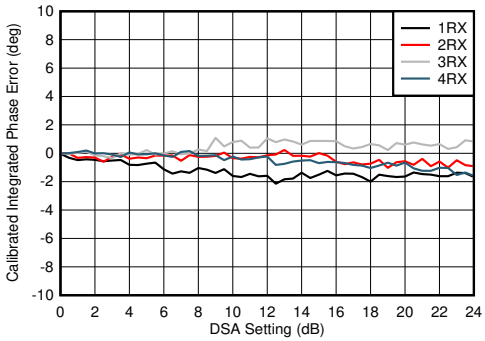
With matching, normalized to power at 2.6 GHz for each DSA setting

图 5-111. RX Inband Gain Flatness, f_{IN} = 2600 MHz



With 2.6 GHz matching, normalized to fullscale at 25°C for each channel

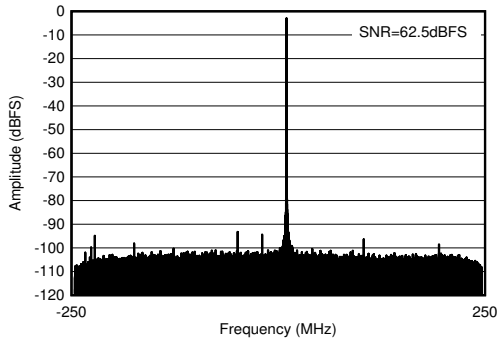
图 5-112. RX Input Fullscale vs Temperature and Channel at 2.6 GHz



With 2.6 GHz matching

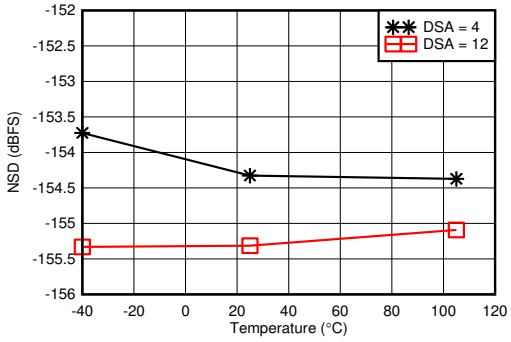
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-113. RX Calibrated Integrated Phase Error vs DSA Setting at 2.6 GHz



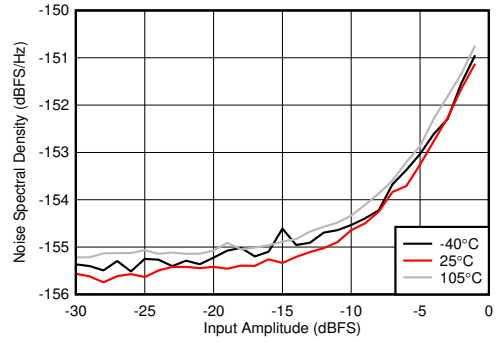
With 2.6 GHz matching, f_{IN} = 2610 MHz, A_{IN}= – 3 dBFS

图 5-114. RX Output FFT at 2.6 GHz



With 2.6 GHz matching, 12.5-MHz offset from tone

图 5-115. RX Noise Spectral Density vs Temperature at 2.6 GHz



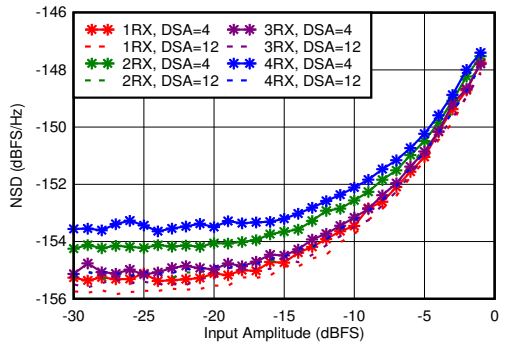
With 2.6 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 5-116. RX Noise Spectral Density vs Input Amplitude and Temperature at 2.6 GHz

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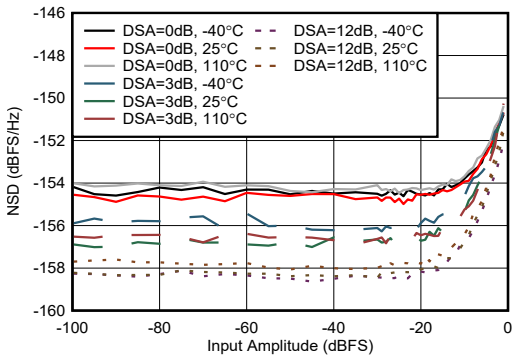
5.12.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



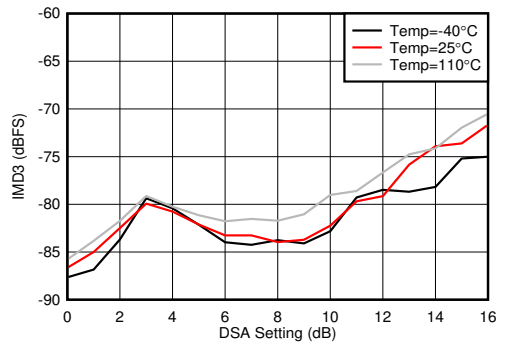
With 2.6 GHz matching, 12.5-MHz offset from tone

图 5-117. RX Noise Spectral Density vs Input Amplitude and Channel at 2.6 GHz



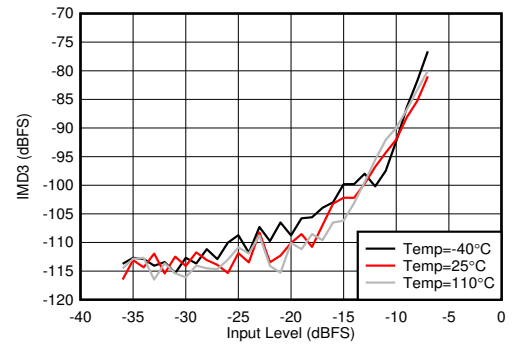
50-MHz offset from tone, external clock mode

图 5-118. RX Noise Spectral Density vs Input Amplitude at 2.61 GHz (Ext. Clock)



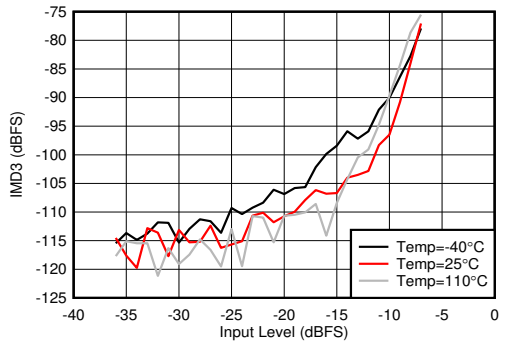
With 2.6 GHz matching, each tone – 7 dBFS, tone spacing = 20 MHz

图 5-119. RX IMD3 vs DSA Setting and Temperature at 2.6 GHz



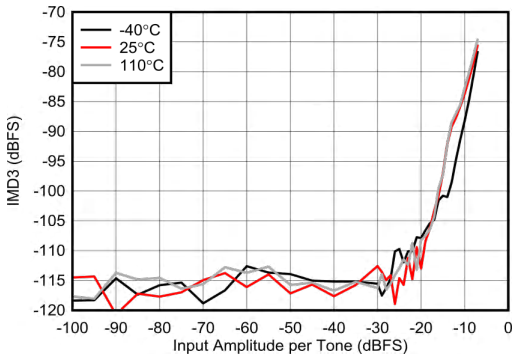
With 2.6 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 5-120. RX IMD3 vs Input Level and Temperature at 2.6 GHz



With 2.6 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 5-121. RX IMD3 vs Input Level and Temperature at 2.6 GHz



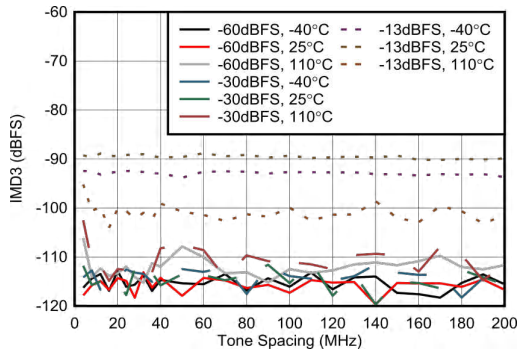
Tone spacing = 50 MHz, External clock mode

图 5-122. RX IMD3 vs Input Level at 2.6 GHz (Ext. Clock)

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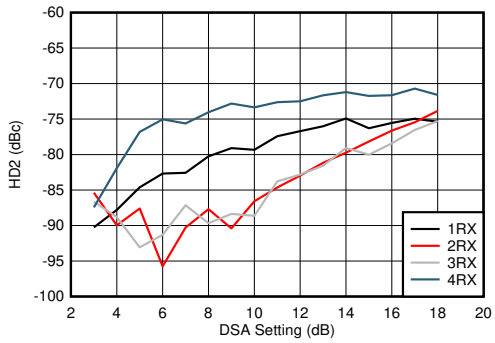
5.12.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



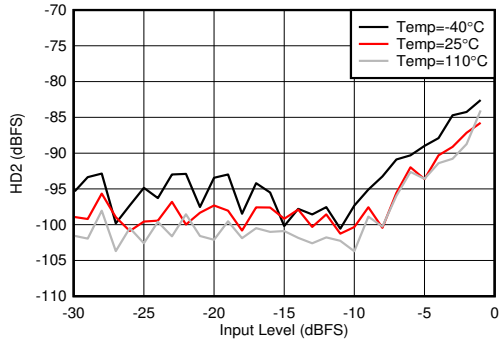
External clock mode

图 5-123. RX IMD3 vs Tone Spacing at 2.6 GHz (Ext. Clock)



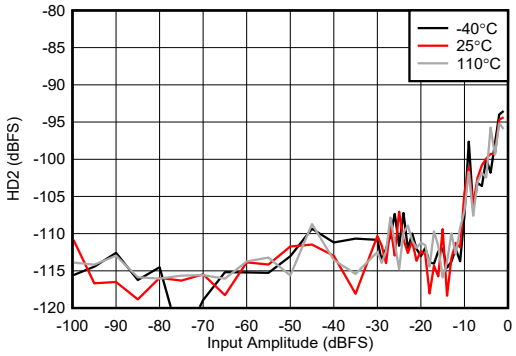
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-124. RX HD2 vs DSA Setting and Channel at 2.6 GHz



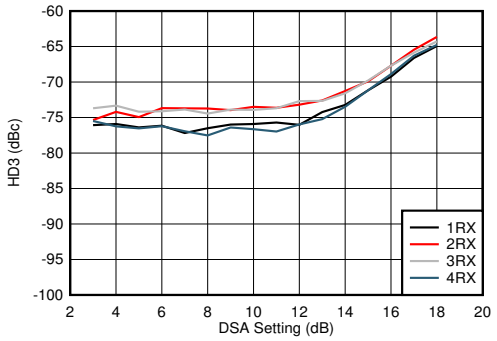
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-125. RX HD2 vs Input Level and Temperature at 2.6 GHz



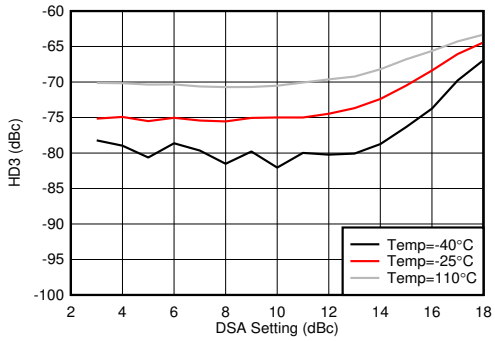
External clock mode

图 5-126. RX HD2 vs Input Level and Temperature at 2.6 GHz



With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-127. RX HD3 vs DSA Setting and Channel at 2.6 GHz



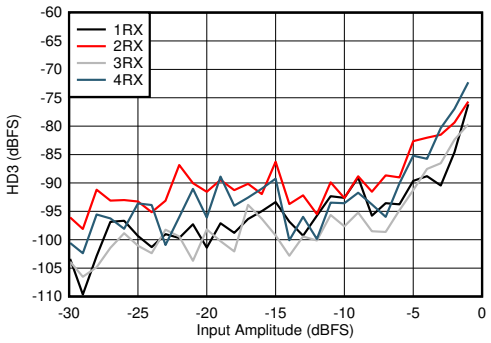
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-128. RX HD3 vs DSA Setting and Temperature at 2.6 GHz

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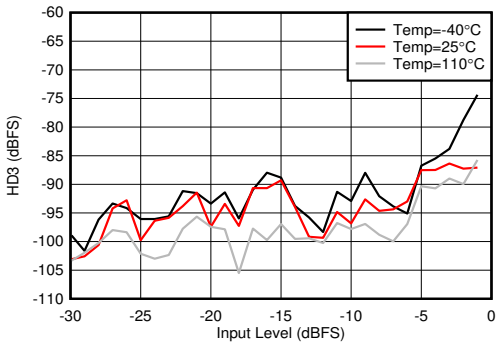
5.12.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



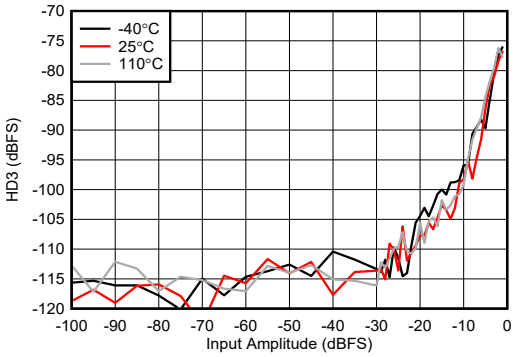
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-129. RX HD3 vs Input Level and Channel at 2.6 GHz



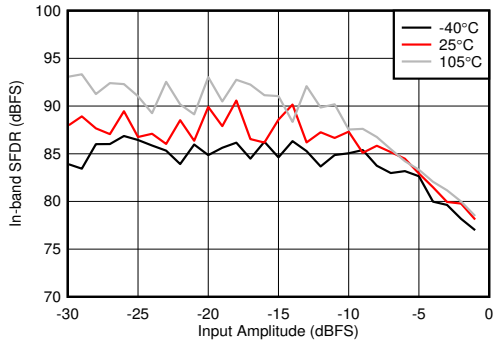
With 2.6 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-130. RX HD3 vs Input Level and Temperature at 2.6 GHz



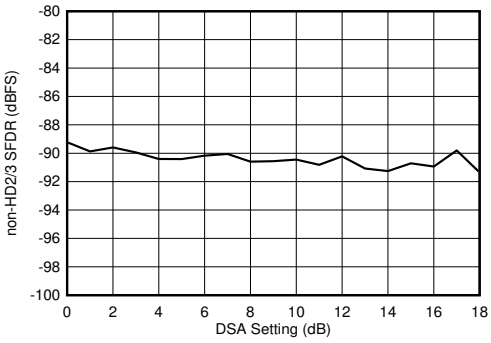
External clock mode

图 5-131. RX HD3 vs Input Level and Temperature at 2.6 GHz



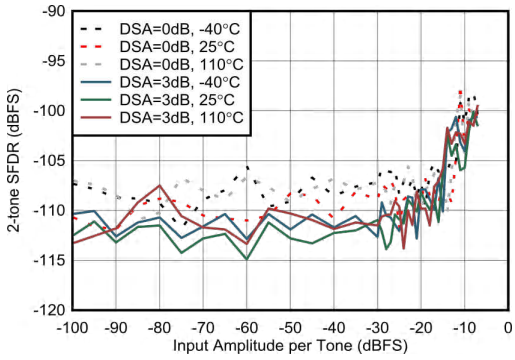
With 2.6 GHz matching, decimate by 4

图 5-132. RX In-Band SFDR (±300 MHz) vs Input Amplitude and Temperature at 2.6 GHz



With 2.6 GHz matching

图 5-133. RX Non-HD2/3 vs DSA Setting at 2.6 GHz



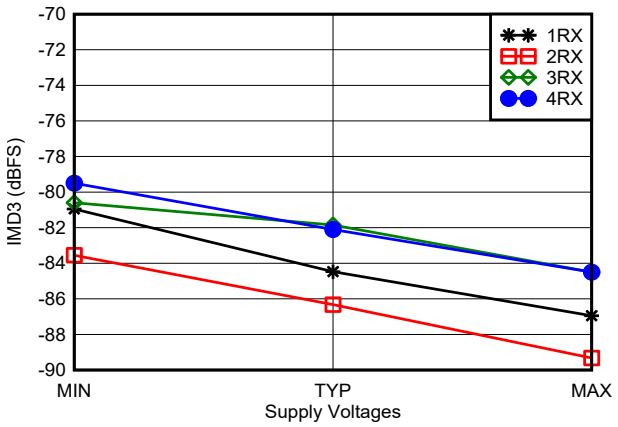
External clock mode, 50MHz tone spacing, excluding 3rd order distortion

图 5-134. RX 2-tone SFDR vs Input Amplitude at 2.6 GHz

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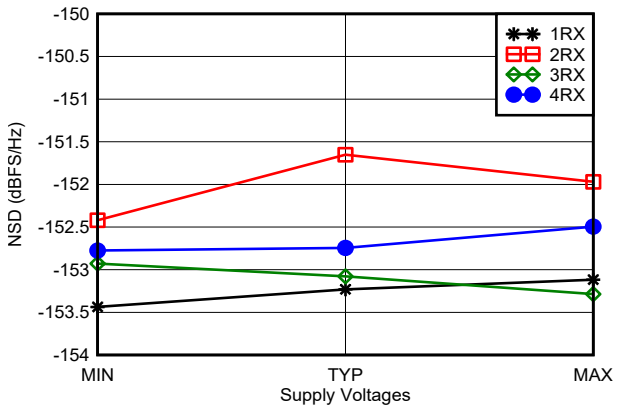
5.12.4 RX Typical Characteristics 2.6GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 2.6 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-135. RX IMD3 vs Supply and Channel at 2.6 GHz

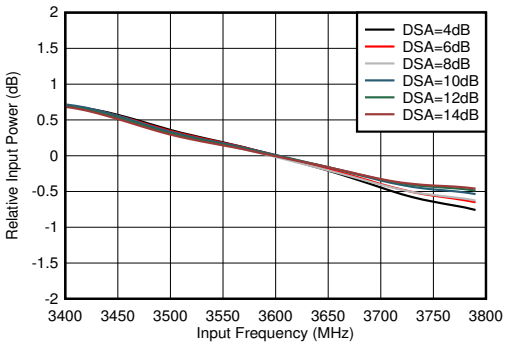


With 2.6 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-136. RX Noise Spectral Density vs Supply and Channel at 2.6 GHz

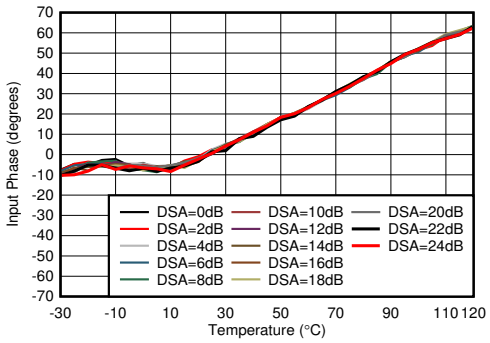
5.12.5 RX Typical Characteristics 3.5GHz

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



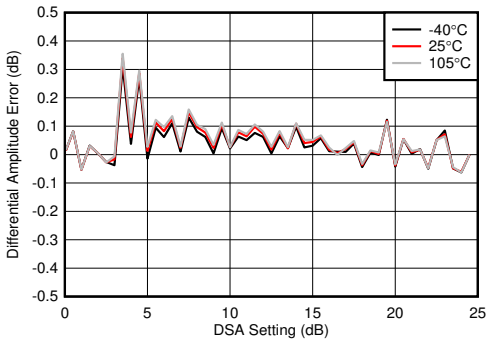
With 3.6 GHz matching, normalized to 3.6 GHz

图 5-137. RX In-Band Gain Flatness, f_{IN} = 3600 MHz



With 3.6 GHz matching, normalized to phase at 25°C

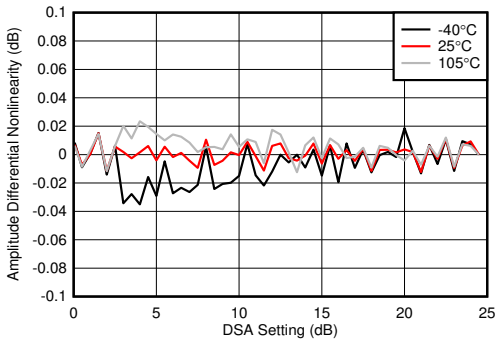
图 5-138. RX Input Phase vs Temperature at 3.6 GHz



With 3.6 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

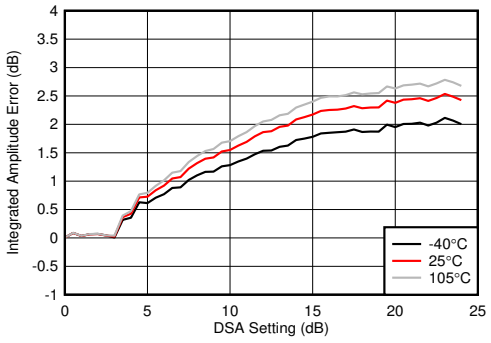
图 5-139. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

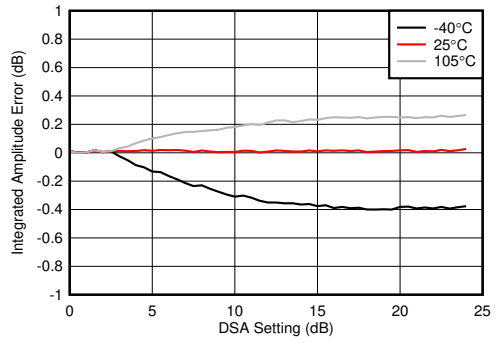
图 5-140. RX Calibrated Differential Amplitude Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-141. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

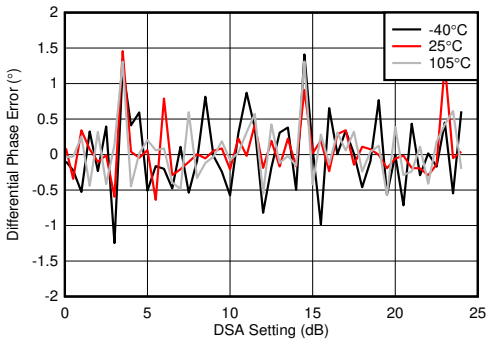
Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-142. RX Calibrated Integrated Amplitude Error vs DSA Setting at 3.6 GHz

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5.12.5 RX Typical Characteristics 3.5GHz (continued)

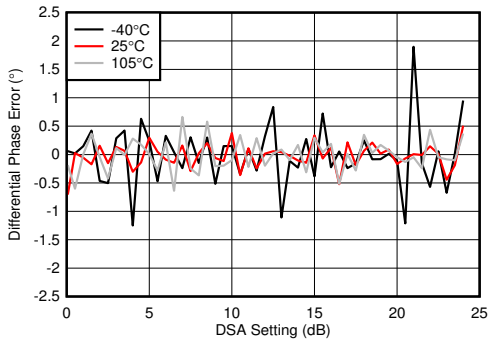
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 3.6 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

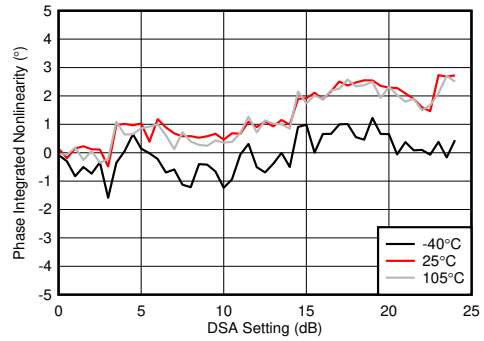
图 5-143. RX Uncalibrated Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

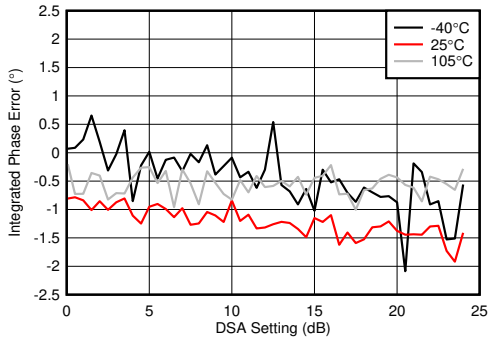
图 5-144. RX Calibrated Differential Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

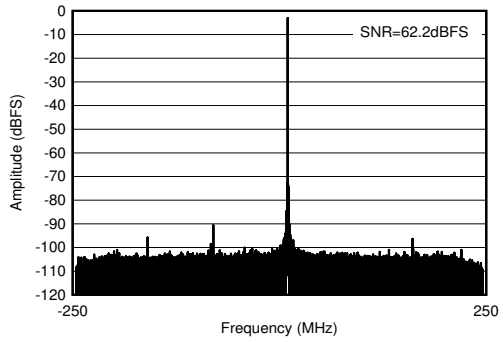
图 5-145. RX Uncalibrated Integrated Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching

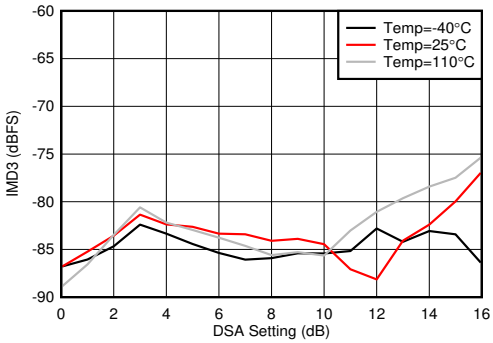
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-146. RX Calibrated Integrated Phase Error vs DSA Setting at 3.6 GHz



With 3.6 GHz matching , f_{IN} = 3610 MHz, A_{IN} = – 3 dBFS

图 5-147. RX Output FFT at 3.6 GHz



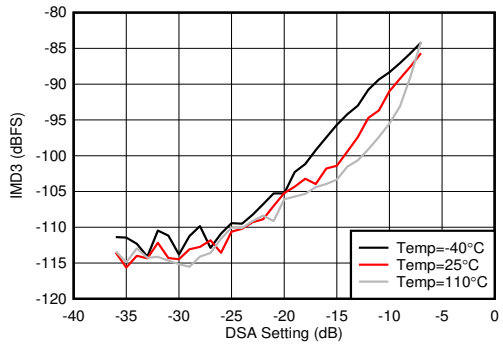
With 3.5 GHz matching, each tone at – 7 dBFS, 20-MHz tone spacing

图 5-148. RX IMD3 vs DSA Setting and Temperature at 3.6 GHz

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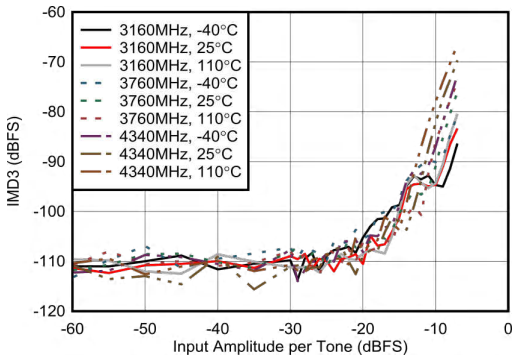
5.12.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



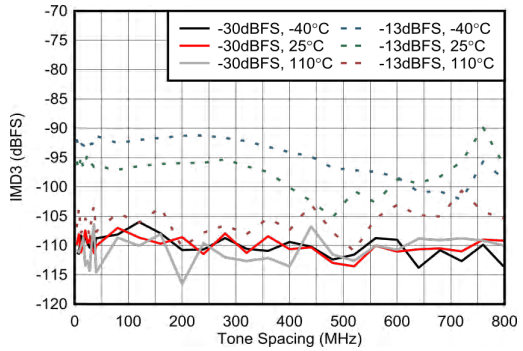
With 3.5 GHz matching, 20-MHz tone spacing

图 5-149. RX IMD3 vs Input Level and Temperature at 3.6 GHz



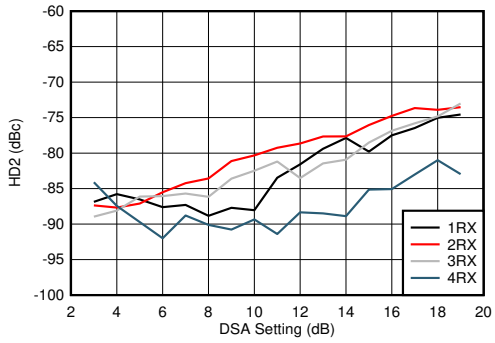
External clock mode, 20-MHz tone spacing, 2x Decimation

图 5-150. RX IMD3 vs Input Level



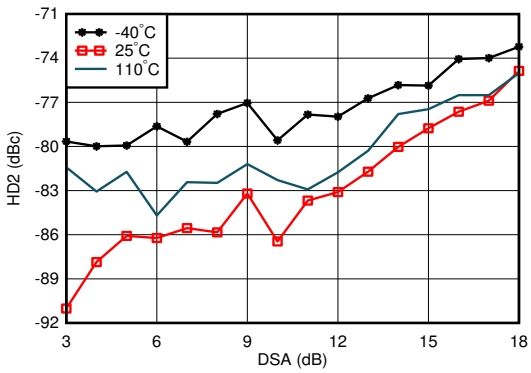
External clock mode, 2x Decimation

图 5-151. RX IMD3 vs Tone Spacing at 3.76GHz



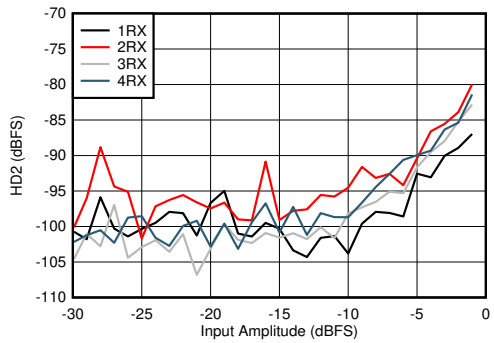
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-152. RX HD2 vs DSA Setting and Channel at 3.6 GHz



With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-153. RX HD2 vs DSA Setting and Temperature at 3.6 GHz



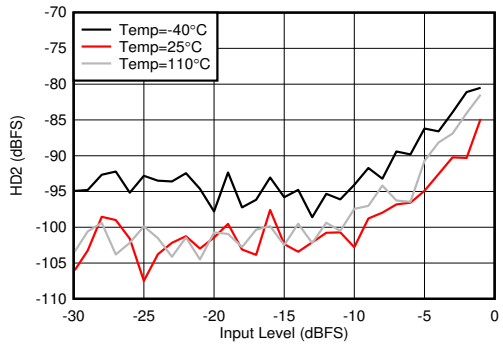
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-154. RX HD2 vs Input Level and Channel at 3.6 GHz

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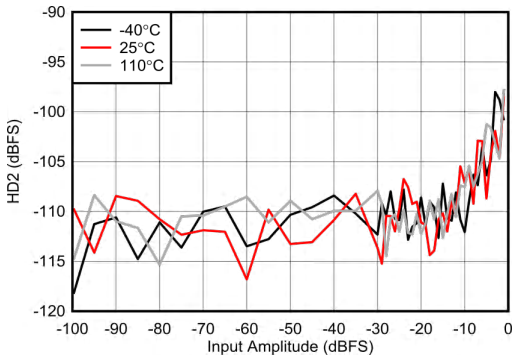
5.12.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



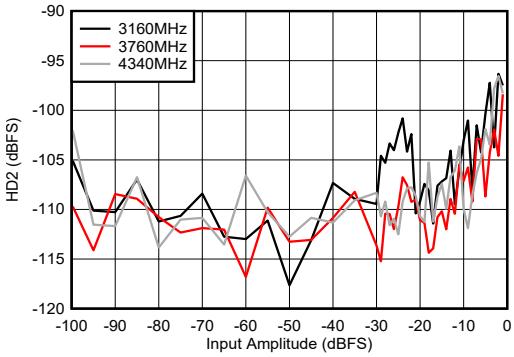
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-155. RX HD2 vs Input Level and Temperature at 3.6 GHz



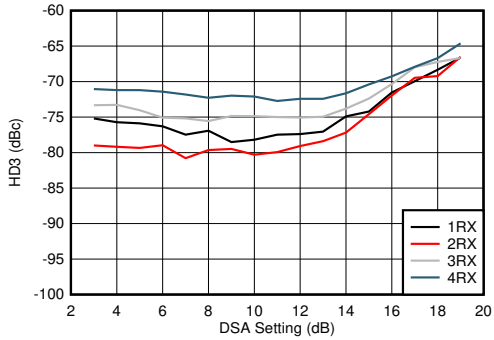
External clock mode, 2x Decimation

图 5-156. RX HD2 vs Input Level at 3.76 GHz



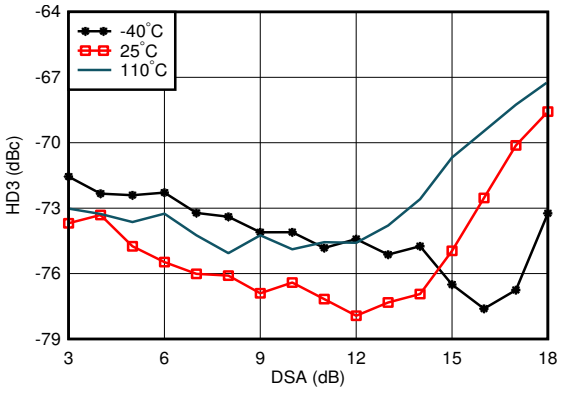
External clock mode, 25°C, 2x Decimation

图 5-157. RX HD2 vs Input Level



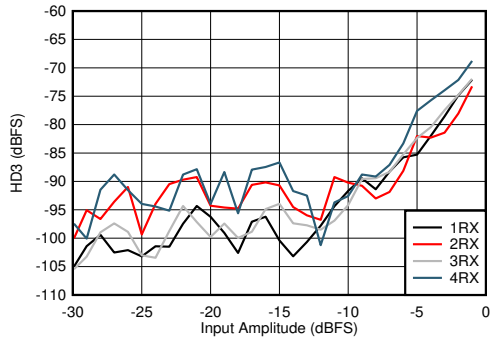
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-158. RX HD3 vs DSA Setting and Channel at 3.6 GHz



With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-159. RX HD3 vs DSA Setting and Temperature at 3.6 GHz



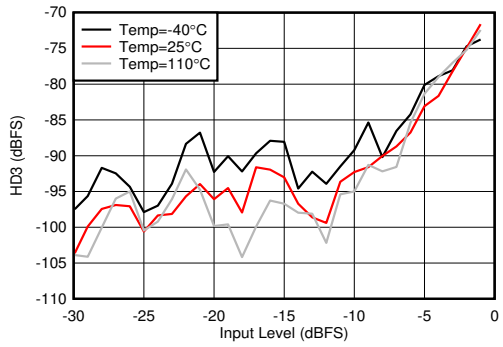
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-160. RX HD3 vs Input Level and Channel at 3.6 GHz

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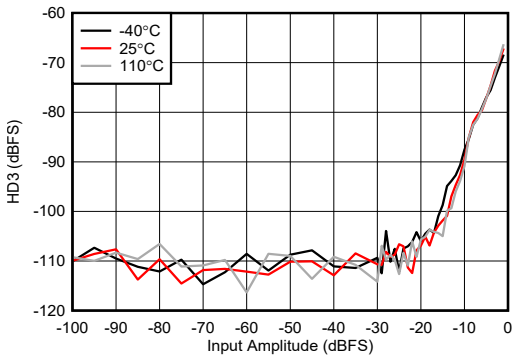
5.12.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



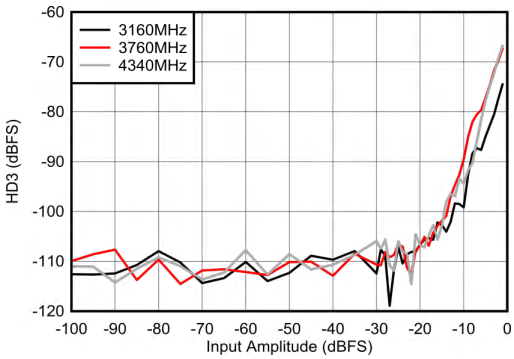
With 3.5 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-161. RX HD3 vs Input Level and Temperature at 3.6 GHz



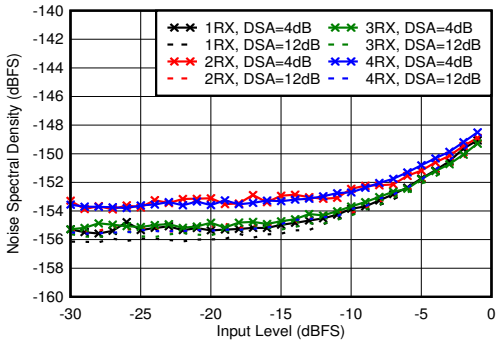
External clock mode, 2x Decimation

图 5-162. RX HD3 vs Input Level at 3.76GHz



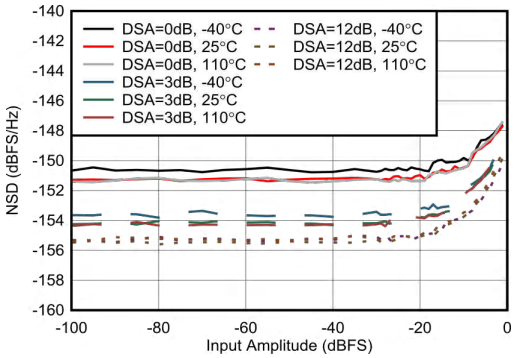
External clock mode, 25°C, 2x Decimation

图 5-163. RX HD3 vs Input Level



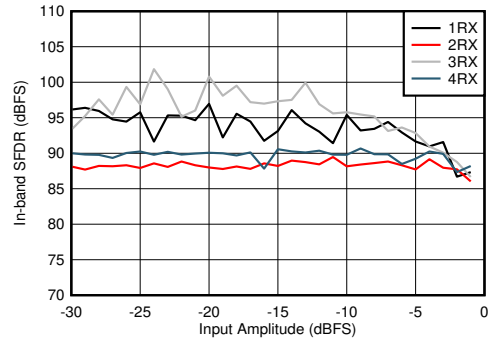
With 3.5 GHz matching, 12.5-MHz offset from tone

图 5-164. RX Noise Spectral Density vs Input Level and DSA Setting at 3.6 GHz



External clock mode, 25°C, 2x Decimation

图 5-165. RX Noise Spectral Density vs Input Level at 3.76GHz



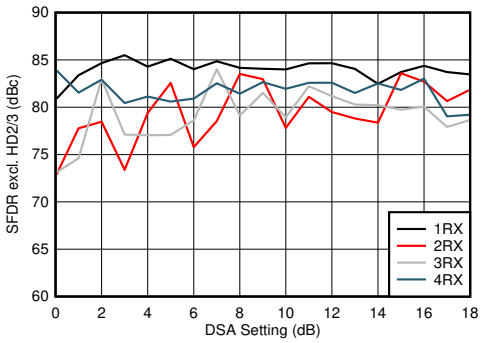
With 3.5 GHz matching

图 5-166. RX In-Band SFDR (±200 MHz) vs Input Level and Channel at 3.6 GHz

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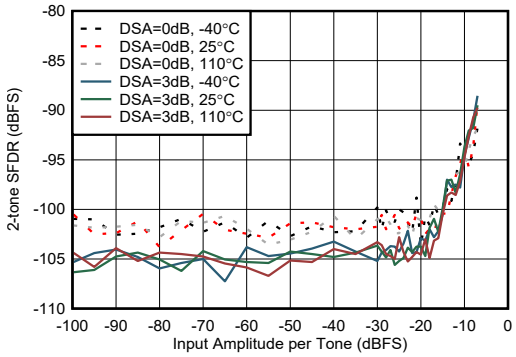
5.12.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



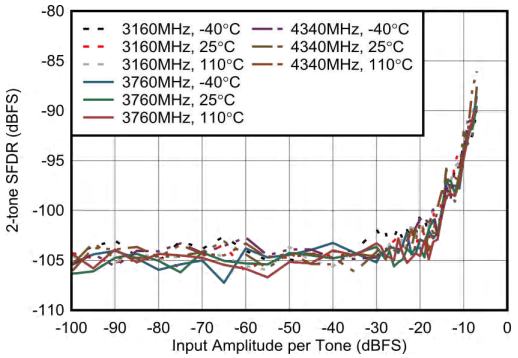
With 3.5 GHz matching

图 5-167. RX SFDR Excluding HD2/3 vs DSA Setting and Channel at 3.6 GHz



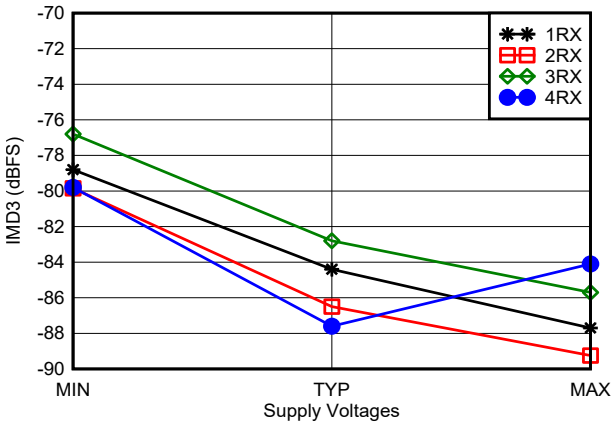
External clock mode, 20MHz tone spacing, excluding 3rd order distortion

图 5-168. RX 2-tone SFDR vs Input Amplitude and DSA Setting at 3.7 GHz



External clock mode, 20MHz tone spacing, excluding 3rd order distortion

图 5-169. RX 2-tone SFDR vs Input Amplitude and Frequency at 3.7 GHz

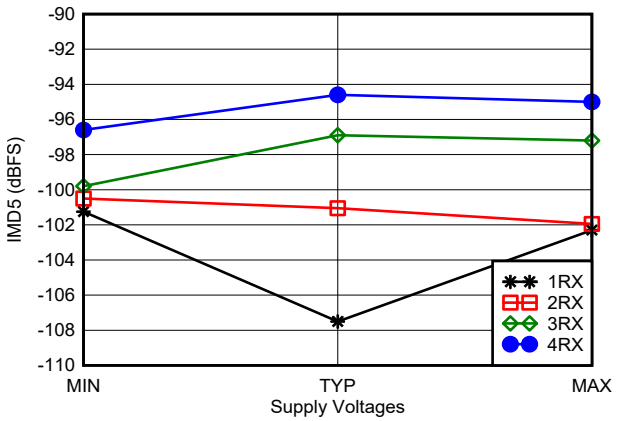


With 3.6 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-170. RX IMD3 vs Supply Voltage and Channel at 3.6 GHz

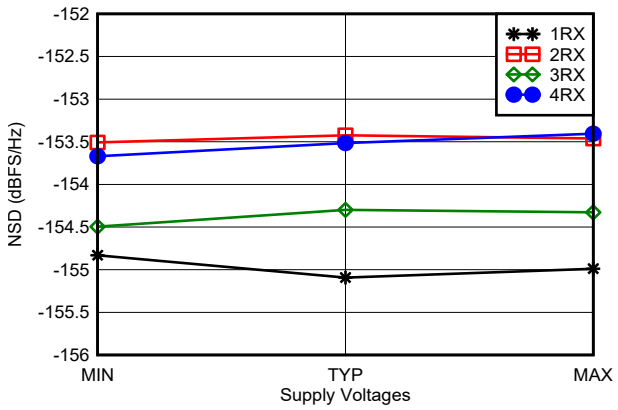
5.12.5 RX Typical Characteristics 3.5GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 3.6 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-171. RX IMD5 vs Supply Voltage and Channel at 3.6 GHz



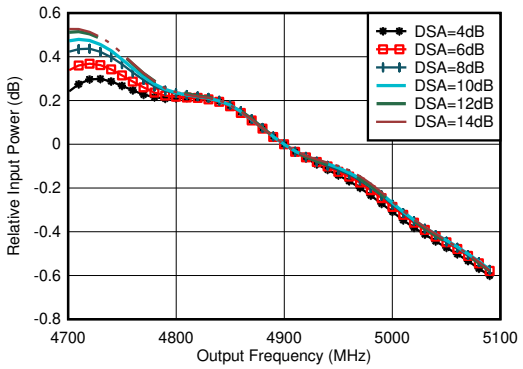
With 3.6 GHz matching, tone at – 20 dBFS, 12.5-MHz offset frequency, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-172. RX Noise Spectral Density vs Supply Voltage and Channel at 3.6 GHz

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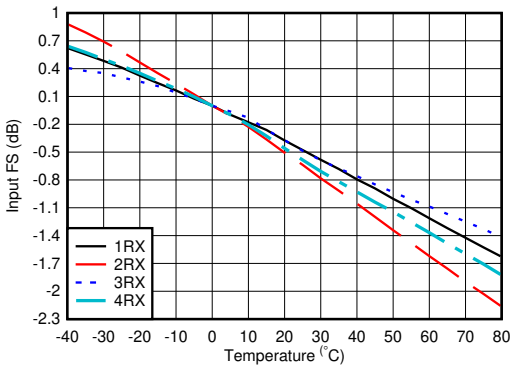
5.12.6 RX Typical Characteristics 4.9GHz

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



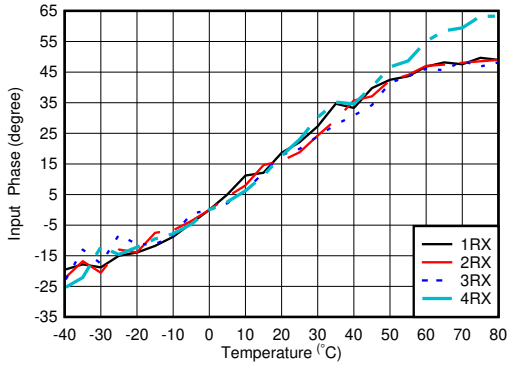
With matching, normalized to power at 4.9GHz for each DSA setting

图 5-173. RX Inband Gain Flatness, f_{IN} = 4900 MHz



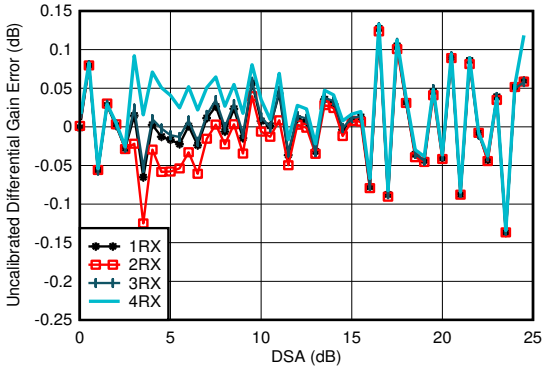
With 4.9 GHz matching, normalized to fullscale at 25°C for each channel

图 5-174. RX Input Fullscale vs Temperature and Channel at 4.9 GHz



With 4.9 GHz matching, normalized to phase at 25°C

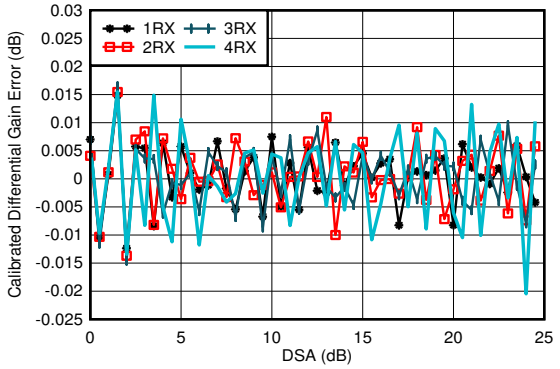
图 5-175. RX Input Phase vs Temperature and DSA at f_{OUT} = 4.9 GHz



With 4.9 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

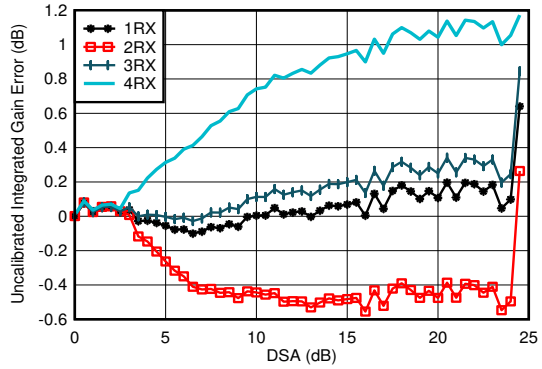
图 5-176. RX Uncalibrated Differential Amplitude Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

Differential Amplitude Error = P_{IN}(DSA Setting – 1) – P_{IN}(DSA Setting) + 1

图 5-177. RX Calibrated Differential Amplitude Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

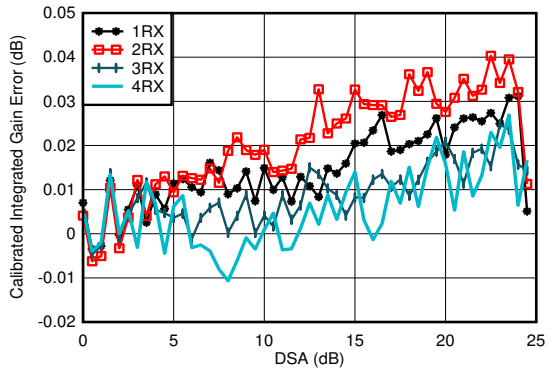
Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

图 5-178. RX Uncalibrated Integrated Amplitude Error vs DSA Setting at 4.9 GHz

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5.12.6 RX Typical Characteristics 4.9GHz (continued)

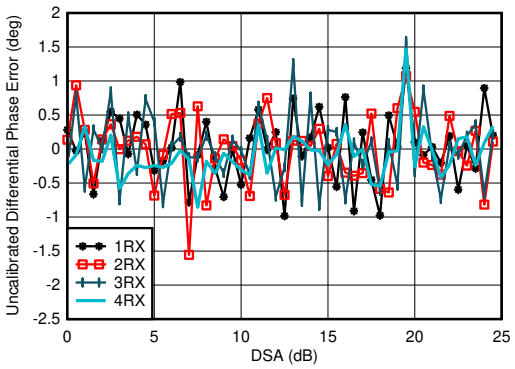
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 4.9 GHz matching

Integrated Amplitude Error = P_{IN}(DSA Setting) – P_{IN}(DSA Setting = 0) + (DSA Setting)

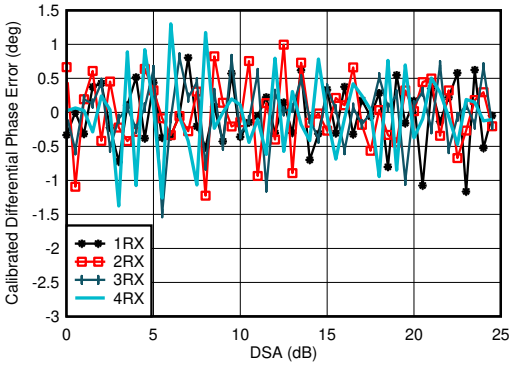
图 5-179. RX Calibrated Integrated Amplitude Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

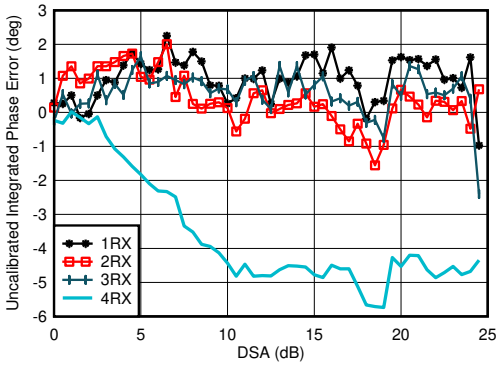
图 5-180. RX Uncalibrated Differential Phase Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

Differential Phase Error = $Phase_{IN}$(DSA Setting – 1) – $Phase_{IN}$(DSA Setting)

图 5-181. RX Calibrated Differential Phase Error vs DSA Setting at 4.9 GHz



With 4.9 GHz matching

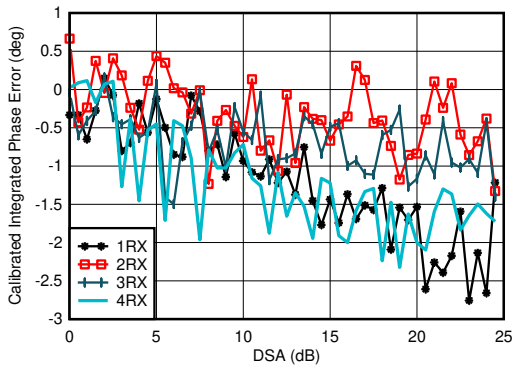
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-182. RX Uncalibrated Integrated Phase Error vs DSA Setting at 4.9 GHz

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5.12.6 RX Typical Characteristics 4.9GHz (continued)

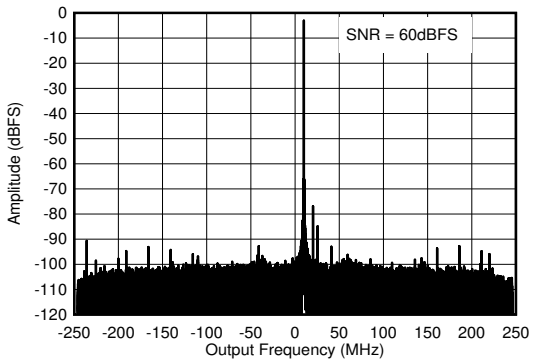
Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



With 4.9 GHz matching

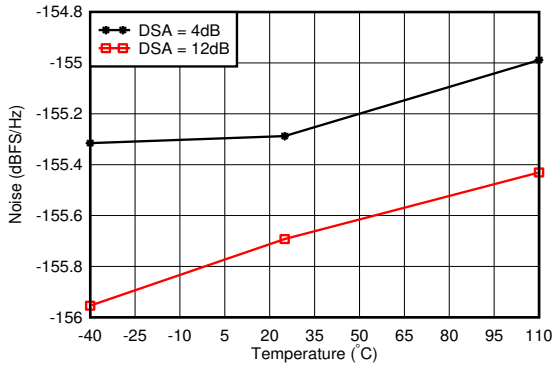
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-183. RX Calibrated Integrated Phase Error vs DSA Setting at 4.9 GHz



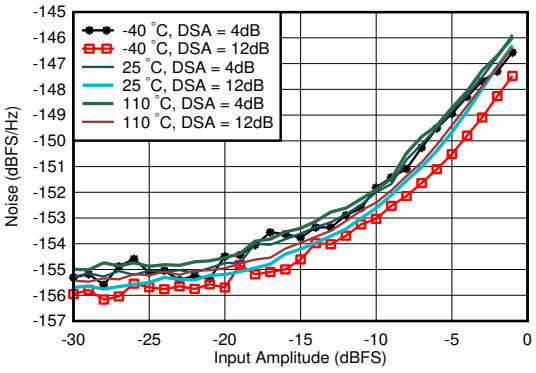
With 4.9 GHz matching, f_{IN} = 4910 MHz, A_{IN}= – 3 dBFS

图 5-184. RX Output FFT at 4.9 GHz



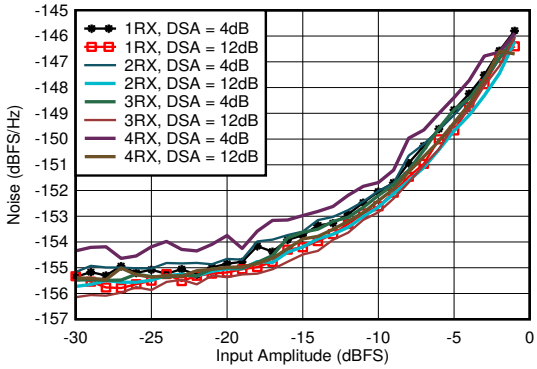
With 4.9 GHz matching, 12.5-MHz offset from tone

图 5-185. RX Noise Spectral Density vs Temperature at 4.9 GHz



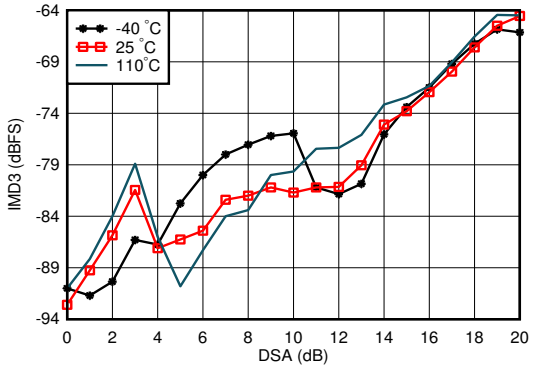
With 4.9 GHz matching, DSA Setting = 12 dB, 12.5-MHz offset from tone

图 5-186. RX Noise Spectral Density vs Input Amplitude and Temperature at 4.9 GHz



With 4.9 GHz matching, 12.5-MHz offset from tone

图 5-187. RX Noise Spectral Density vs Input Amplitude and Channel at 4.9 GHz



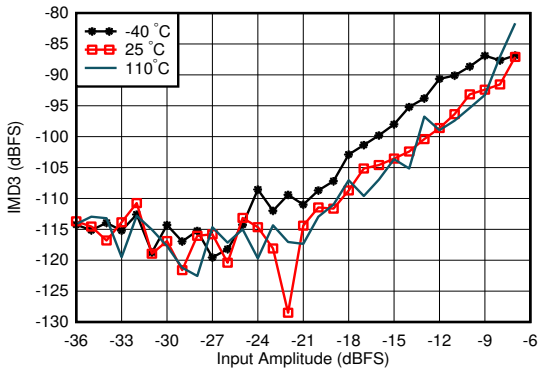
With 4.9 GHz matching, each tone –7 dBFS, tone spacing = 20 MHz

图 5-188. RX IMD3 vs DSA Setting and Temperature at 4.9 GHz

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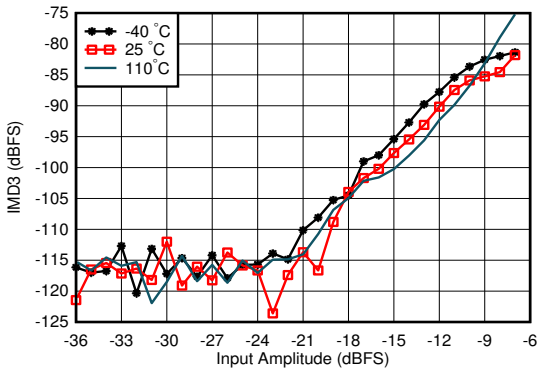
5.12.6 RX Typical Characteristics 4.9GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



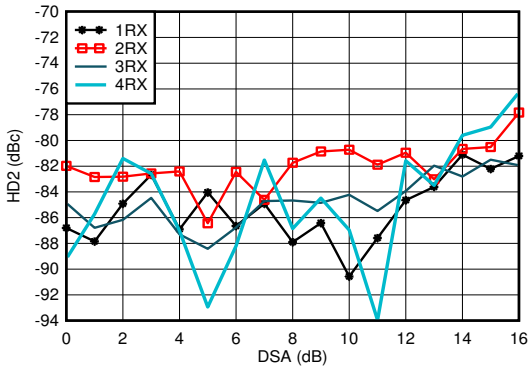
With 4.9 GHz matching, tone spacing = 20 MHz, DSA = 4 dB

图 5-189. RX IMD3 vs Input Level and Temperature at 4.9 GHz



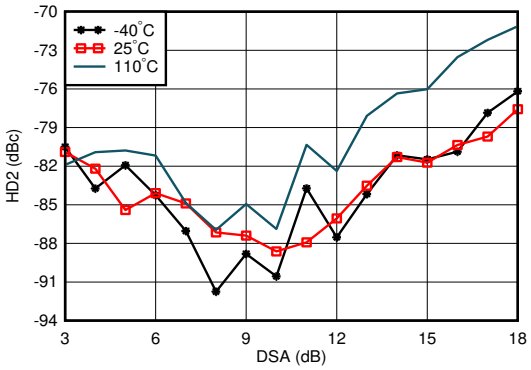
With 4.9 GHz matching, tone spacing = 20 MHz, DSA = 12 dB

图 5-190. RX IMD3 vs Input Level and Temperature at 4.9 GHz



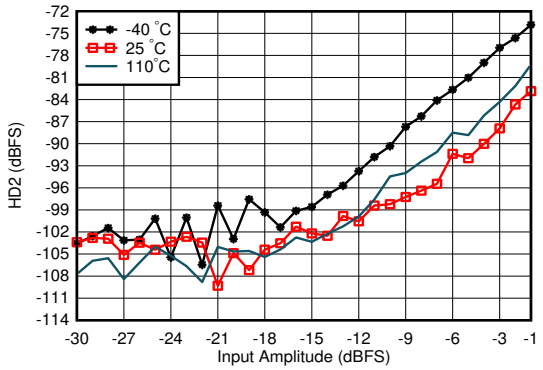
With 4.9 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-191. RX HD2 vs DSA Setting and Channel at 4.9 GHz



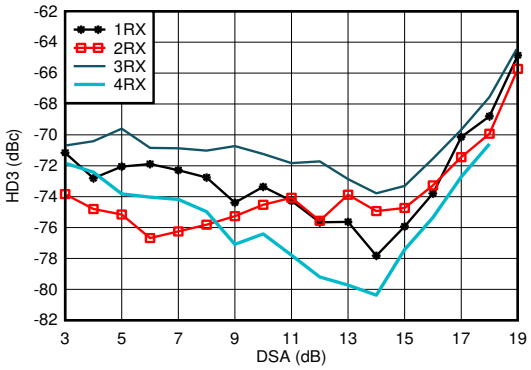
With 4.9 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-192. RX HD2 vs DSA and Temperature at 4.9 GHz



With 4.9 GHz matching, measured after HD2 trim, DDC bypass mode (TI only mode for characterization)

图 5-193. RX HD2 vs Input Level and Temperature at 4.9 GHz



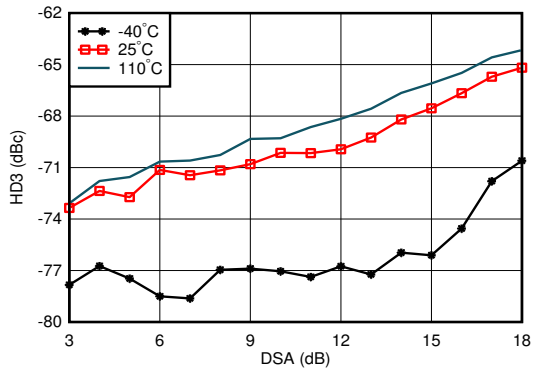
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-194. RX HD3 vs DSA Setting and Channel at 4.9 GHz

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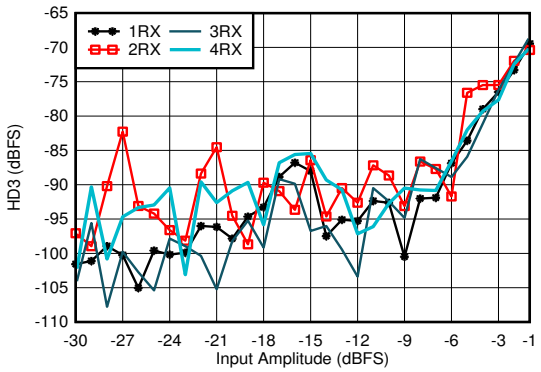
5.12.6 RX Typical Characteristics 4.9GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



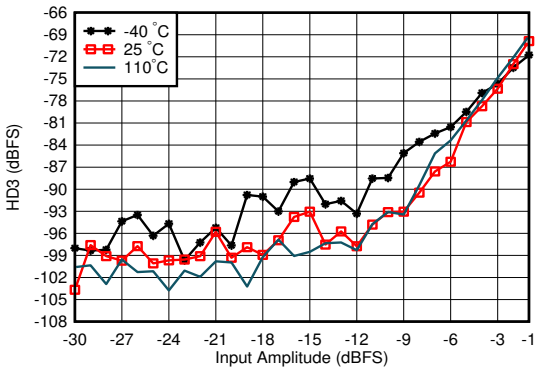
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-195. RX HD3 vs DSA Setting and Temperature at 4.9 GHz



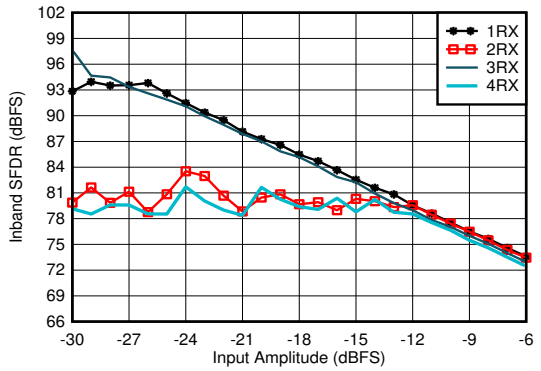
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-196. RX HD3 vs Input Level and Channel at 4.9 GHz



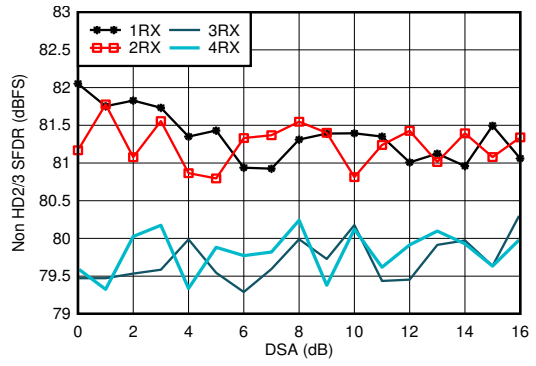
With 4.9 GHz matching, DDC bypass mode (TI only mode for characterization)

图 5-197. RX HD3 vs Input Level and Temperature at 4.9 GHz



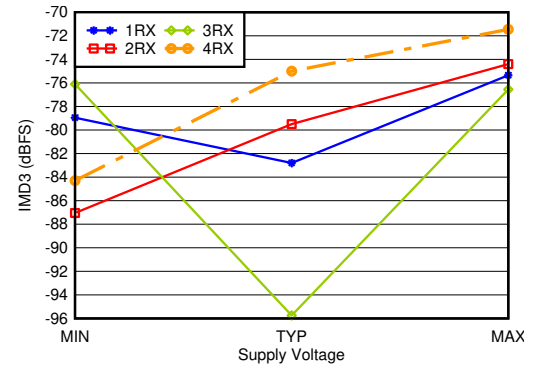
With 4.9 GHz matching, decimate by 3

图 5-198. RX In-Band SFDR (±400 MHz) vs Input Amplitude and Channel at 4.9 GHz



With 4.9 GHz matching

图 5-199. RX Non-HD2/3 vs DSA Setting at 4.9 GHz



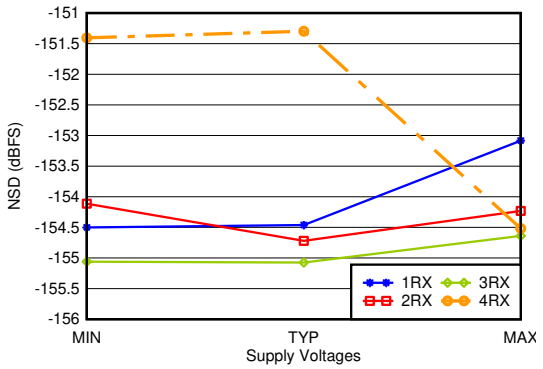
With 4.9 GHz matching, – 7 dBFS each tone, 20-MHz tone spacing, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-200. RX IMD3 vs Supply and Channel at 4.9 GHz

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5.12.6 RX Typical Characteristics 4.9GHz (continued)

Typical values at T_A = +25°C, ADC Sampling Rate = 2949.12 GHz. Default conditions: output sample rate = 491.52MSPS (decimate by 6), PLL clock mode with f_{REF} = 491.52MHz, A_{IN} = – 3 dBFS, DSA setting = 4 dB.



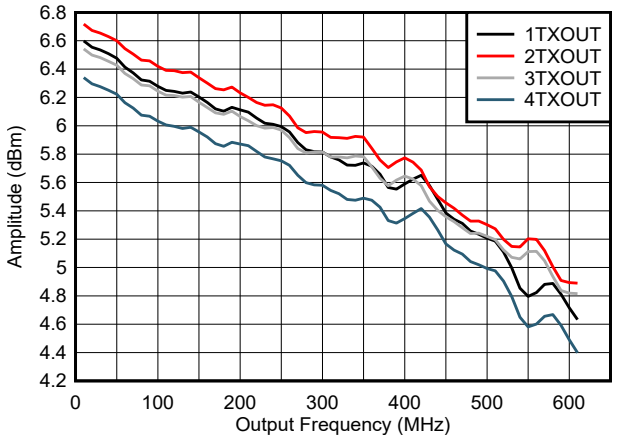
With 4.9 GHz matching, 12.5-MHz offset, all supplies at MIN, TYP, or MAX recommended operating voltages

图 5-201. RX Noise Spectral Density vs Supply and Channel at 4.9 GHz

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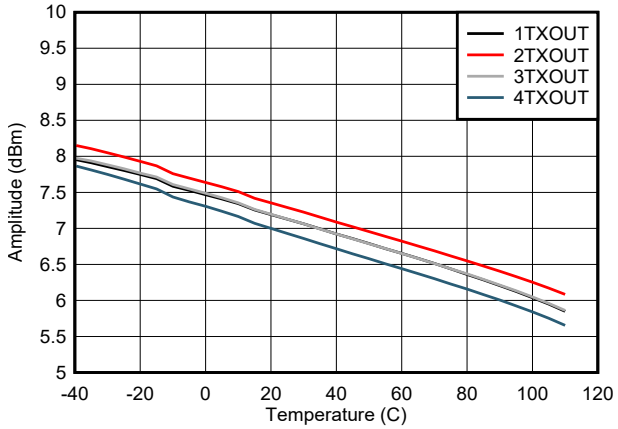
5.12.7 TX Typical Characteristics at 30MHz and 400MHz

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



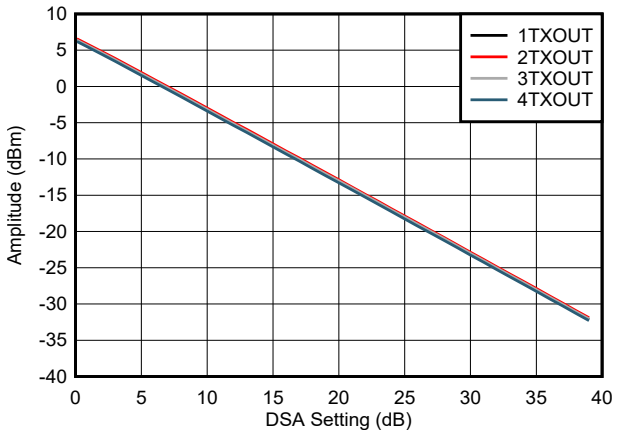
including PCB and cable losses

图 5-202. TX Output Fullscale vs Output Frequency: 5 MHz - 600 MHz



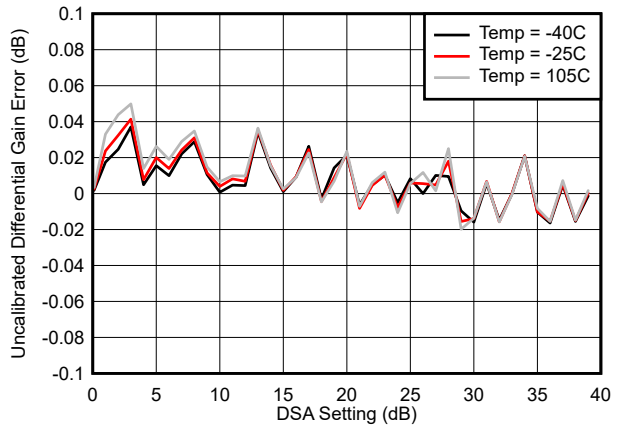
including PCB and cable losses

图 5-203. TX Output Fullscale vs Temperature at 30 MHz



including PCB and cable losses

图 5-204. TX Output Fullscale vs DSA Setting at 30 MHz

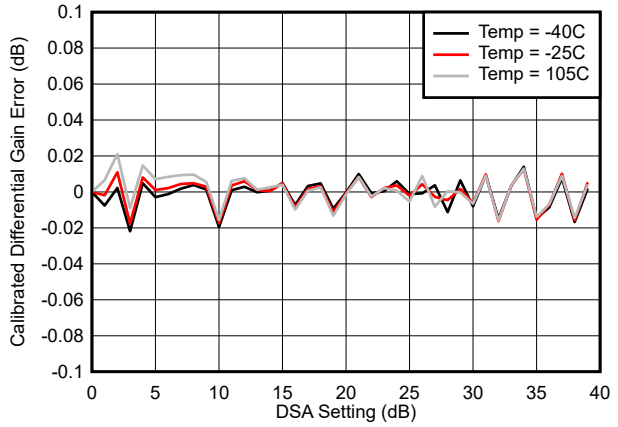


Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-205. Uncalibrated TX Differential Gain Error (DNL) at 30 MHz

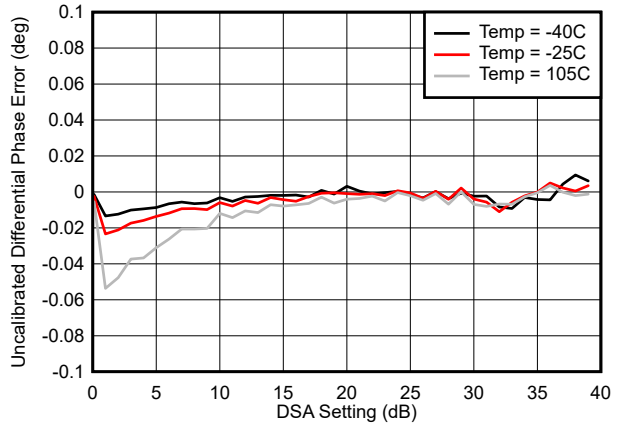
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



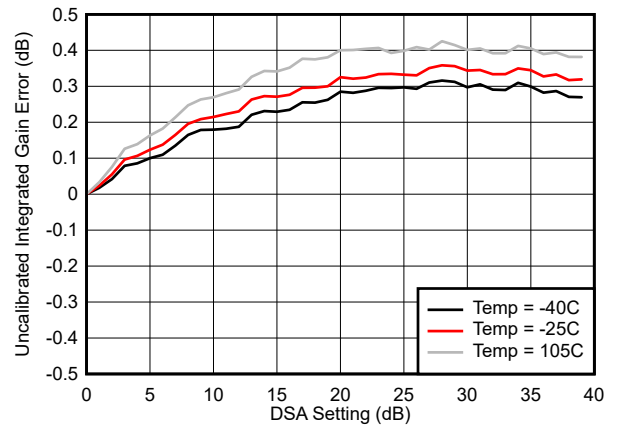
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-206. Calibrated TX Differential Gain Error (DNL) at 30MHz



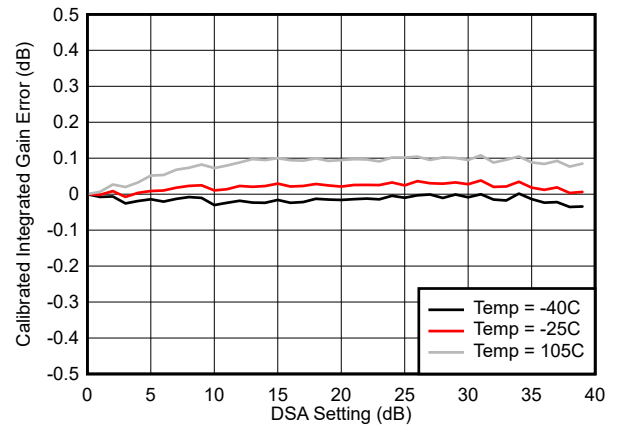
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-207. Calibrated TX Differential Gain Error (DNL) at 30 MHz



Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSASetting = 0) + (DSA Setting)

图 5-208. Uncalibrated TX Integrated Gain Error (INL) at 30 MHz



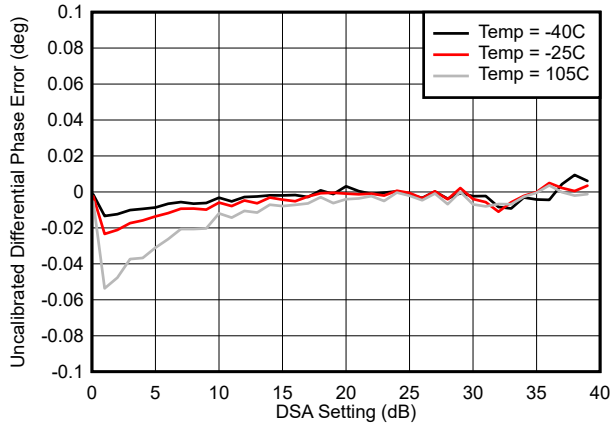
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSASetting = 0) + (DSA Setting)

图 5-209. Calibrated TX Integrated Gain Error (INL) at 30 MHz

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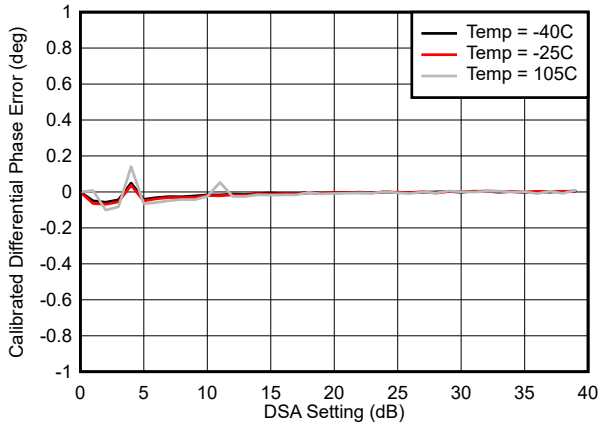
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



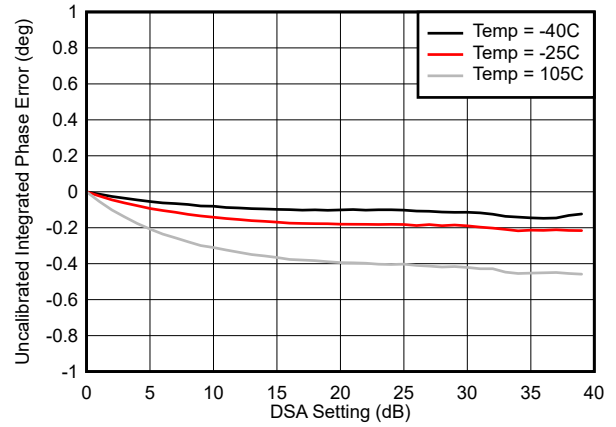
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-210. Uncalibrated TX Differential Phase Error (DNL) at 30 MHz



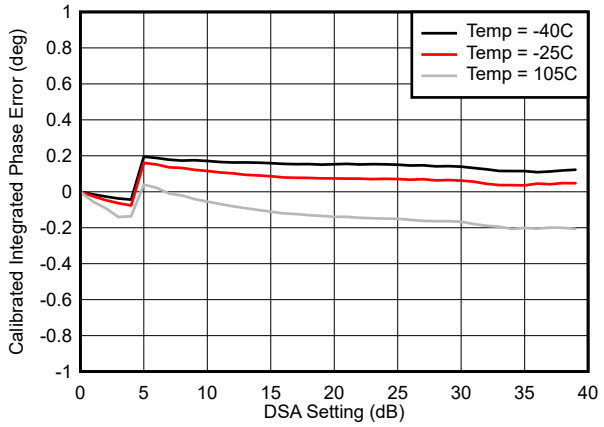
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-211. Calibrated TX Differential Phase Error (DNL) at 30 MHz



Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSASetting = 0)

图 5-212. Uncalibrated TX Integrated Phase Error (INL) at 30 MHz



Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSASetting = 0)

图 5-213. Calibrated TX Integrated Phase Error (INL) at 30 MHz

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5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

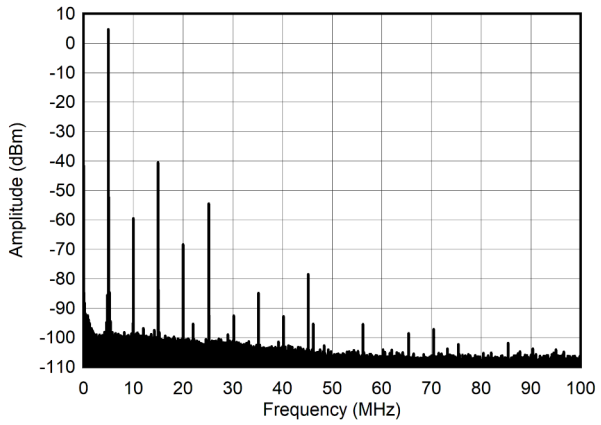


图 5-214. Single Tone Spectrum at 5 MHz and -1 dBFS (0 - 100 MHz)

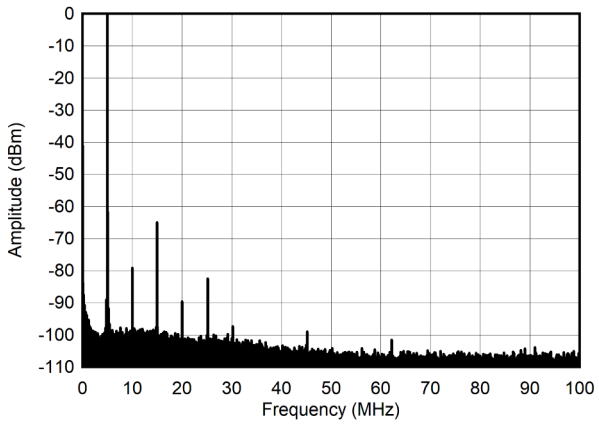


图 5-215. Single Tone Spectrum at 5 MHz and -6d BFS (0 - 100 MHz)

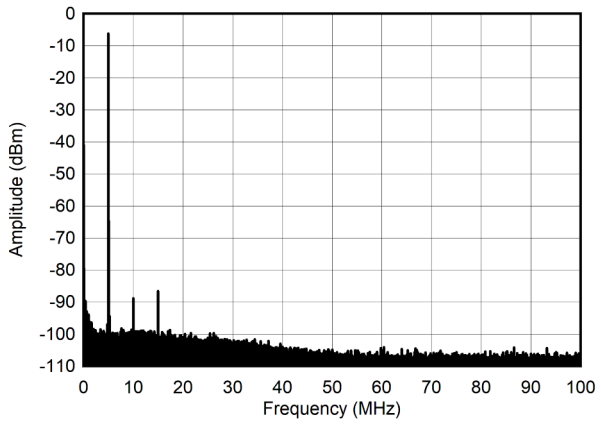


图 5-216. Single Tone Spectrum at 5 MHz and -12 dBFS (0 - 100 MHz)

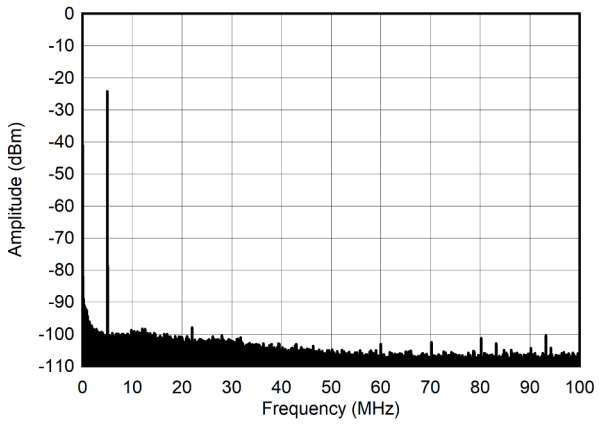


图 5-217. Single Tone Spectrum at 5 MHz and -30 dBFS (0 - 100 MHz)

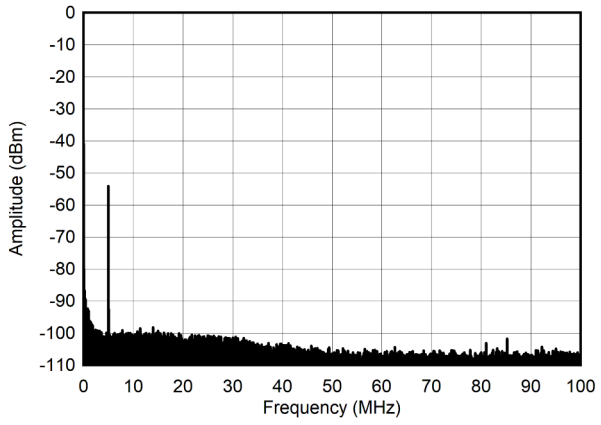


图 5-218. Single Tone Spectrum at 5 MHz and -60 dBFS (0 - 100 MHz)

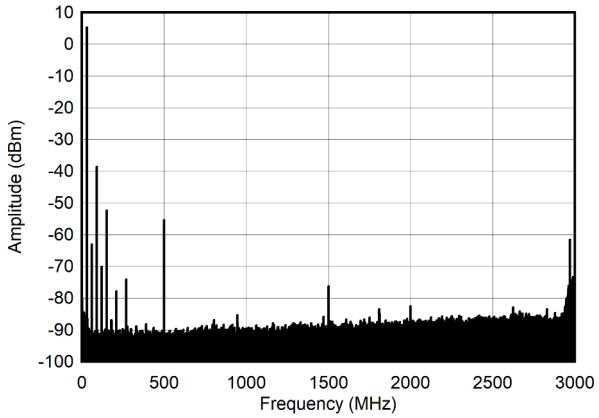


图 5-219. Single Tone Spectrum at 30 MHz and -1 dBFS (Nyquist)

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5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

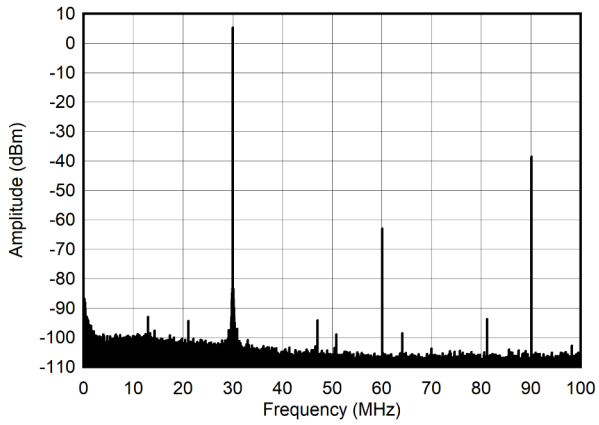


图 5-220. Single Tone Spectrum at 30 MHz and -1 dBFS (0 - 100 MHz)

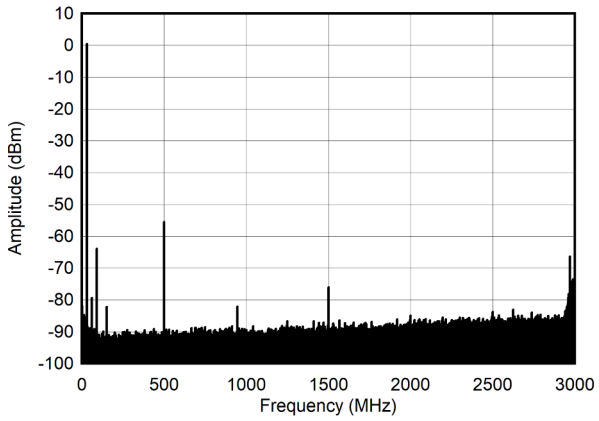


图 5-221. Single Tone Spectrum at 30 MHz and -6 dBFS (Nyquist)

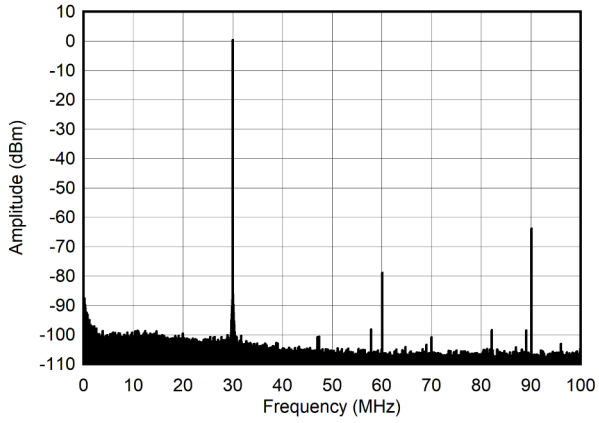


图 5-222. Single Tone Spectrum at 30 MHz and -6 dBFS (0 - 100 MHz)

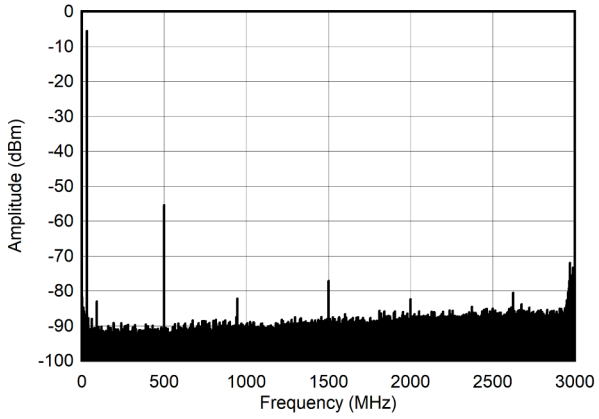


图 5-223. Single Tone Spectrum at 30 MHz and -12 dBFS (Nyquist)

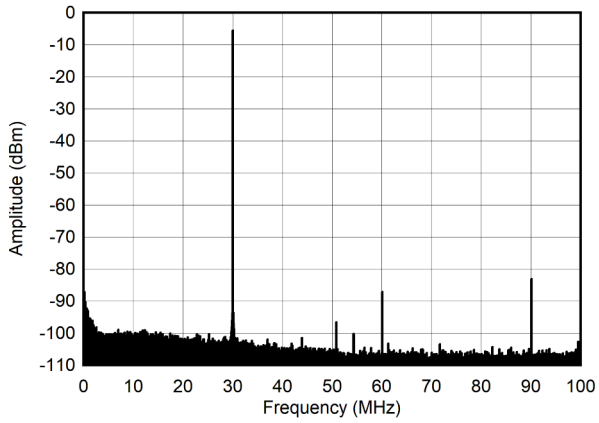


图 5-224. Single Tone Spectrum at 30 MHz and -12 dBFS (0 - 100 MHz)

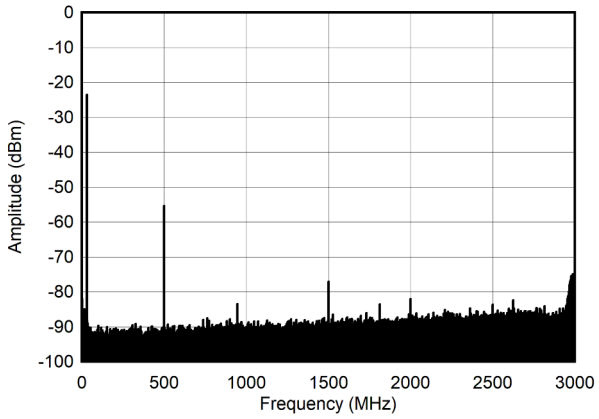


图 5-225. Single Tone Spectrum at 30 MHz and -30 dBFS (Nyquist)

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5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

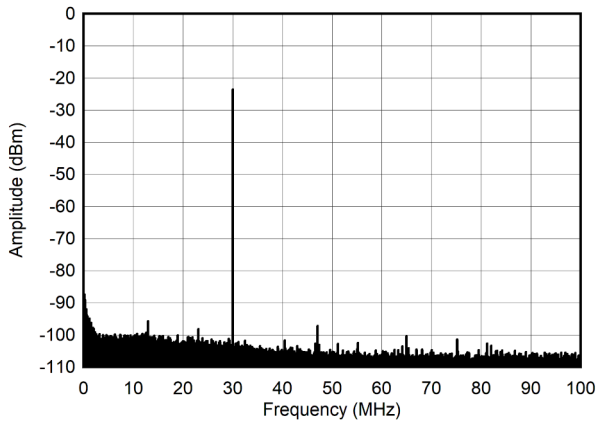


图 5-226. Single Tone Spectrum at 30 MHz and -30 dBFS (0 - 100 MHz)

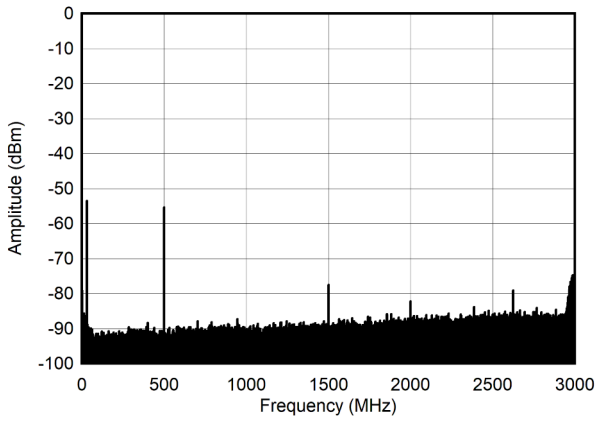


图 5-227. Single Tone Spectrum at 30 MHz and -60 dBFS (Nyquist)

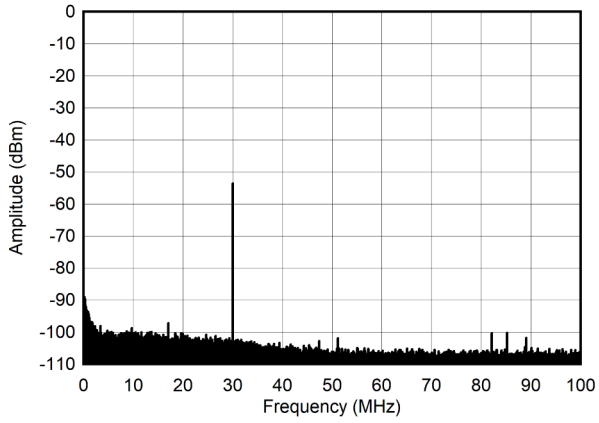


图 5-228. Single Tone Spectrum at 30 MHz and -60 dBFS (0 - 100 MHz)

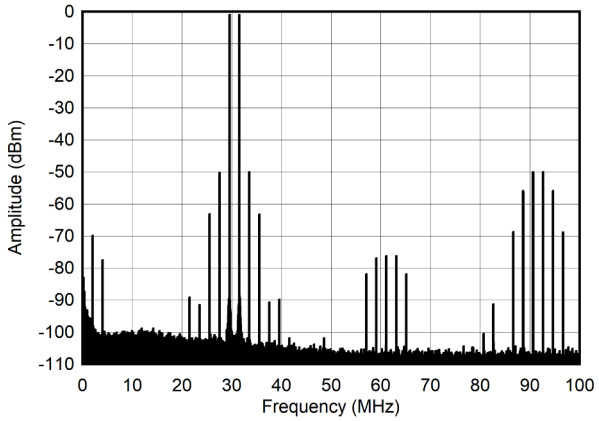


图 5-229. Dual Tone Spectrum at 30 MHz and -7 dBFS (0 - 100 MHz)

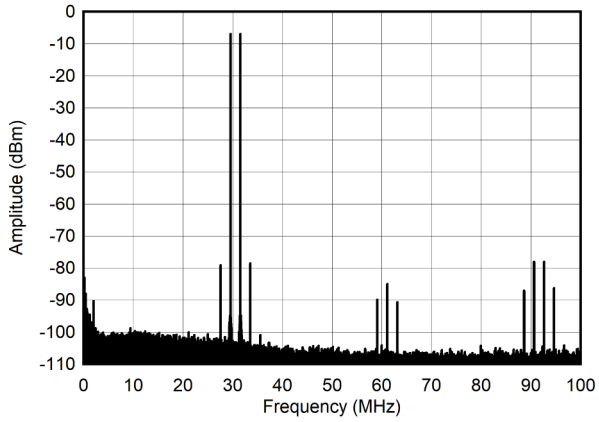


图 5-230. Dual Tone Spectrum at 30 MHz and -13 dBFS (0 - 100 MHz)

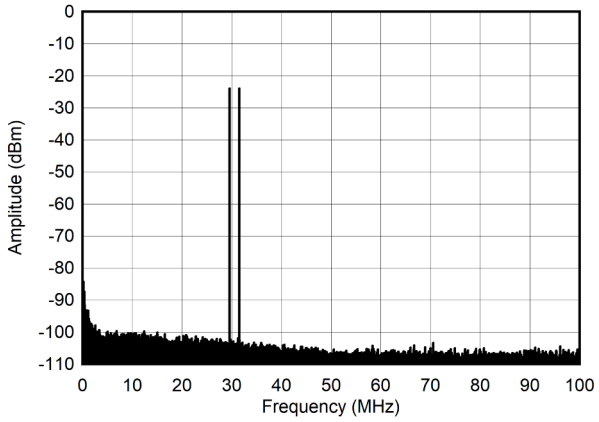


图 5-231. Dual Tone Spectrum at 30 MHz and -30 dBFS (0 - 100 MHz)

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5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

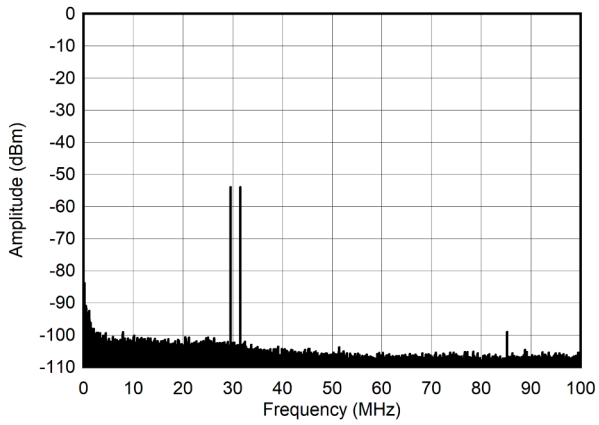
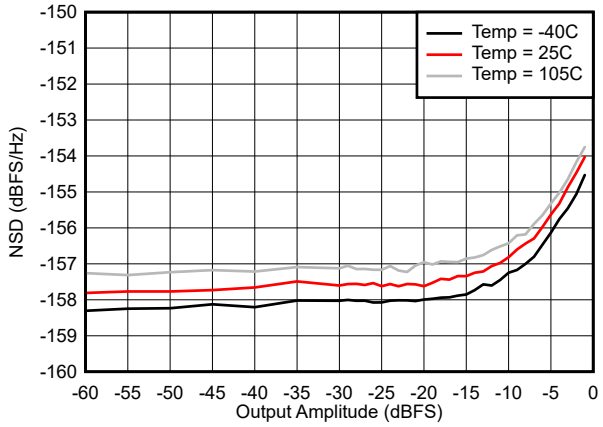
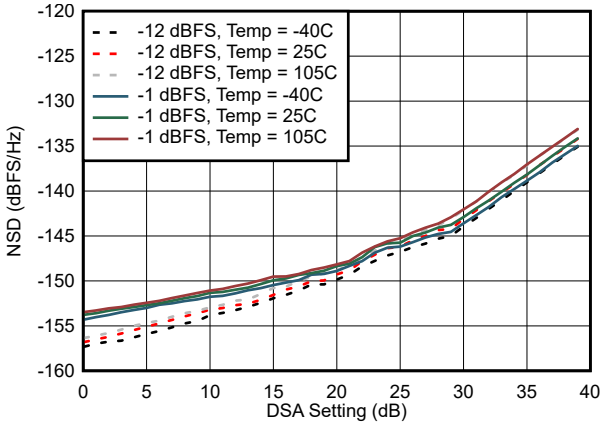


图 5-232. Dual Tone Spectrum at 30 MHz and -60d BFS (0 - 100 MHz)



measured at +50 MHz offset

图 5-233. Noise Spectral Density vs Digital Amplitude at 30 MHz



measured at +50 MHz offset

图 5-234. Noise Spectral Density vs DSA Setting at 30 MHz

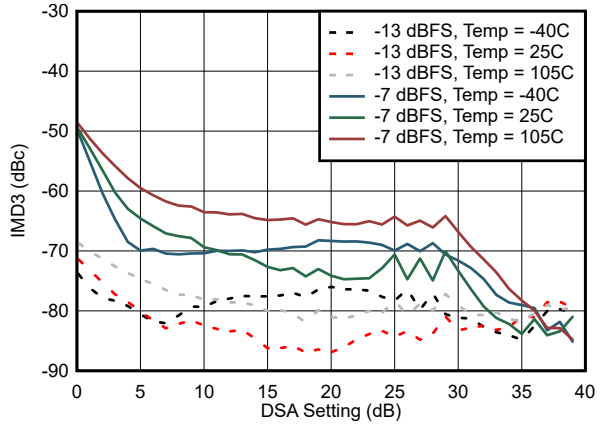


图 5-235. IMD3 vs DSA Setting at 30 MHz

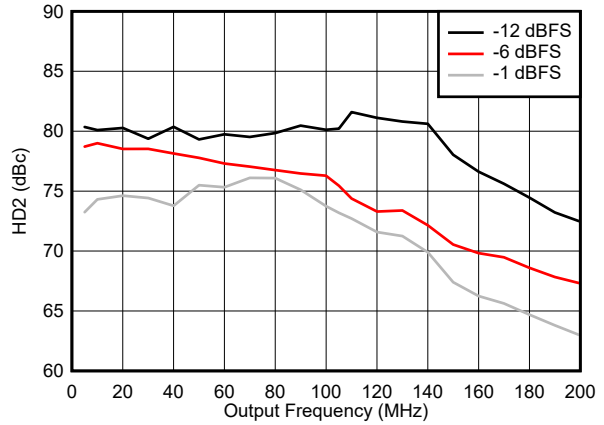


图 5-236. HD2 vs Frequency 0 - 200 MHz

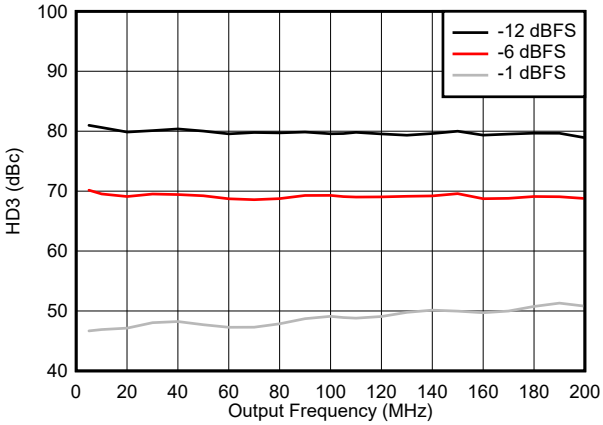
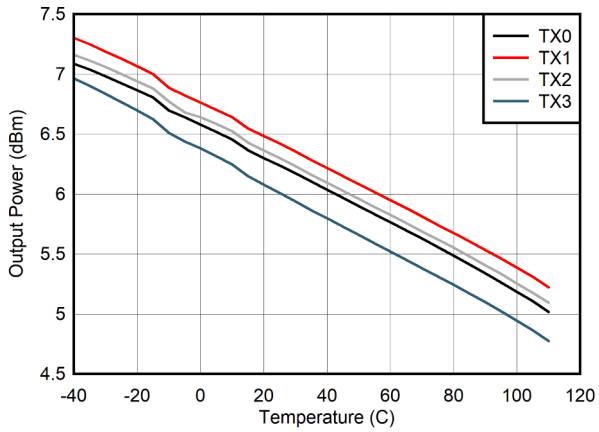


图 5-237. HD3 vs Frequency 0 - 200 MHz

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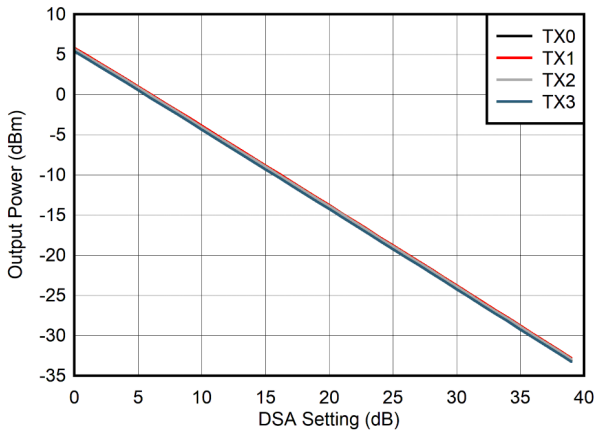
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



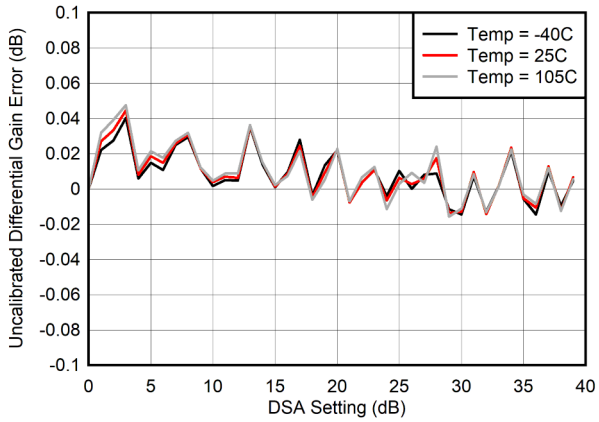
including PCB and cable losses

图 5-238. TX Output Fullscale vs Temperature at 400 MHz



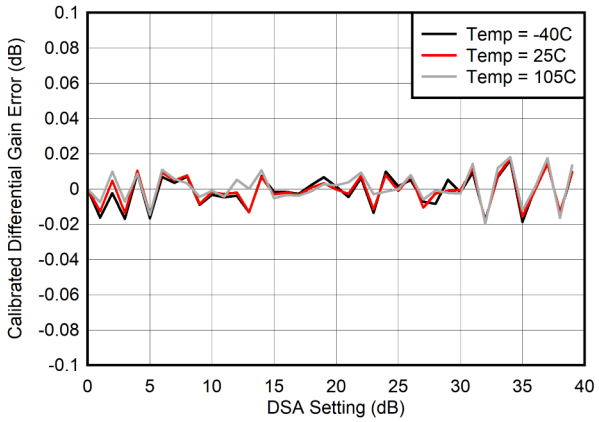
including PCB and cable losses

图 5-239. TX Output Fullscale vs DSA Setting at 400 MHz



Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-240. Uncalibrated TX Differential Gain Error (DNL) at 400 MHz



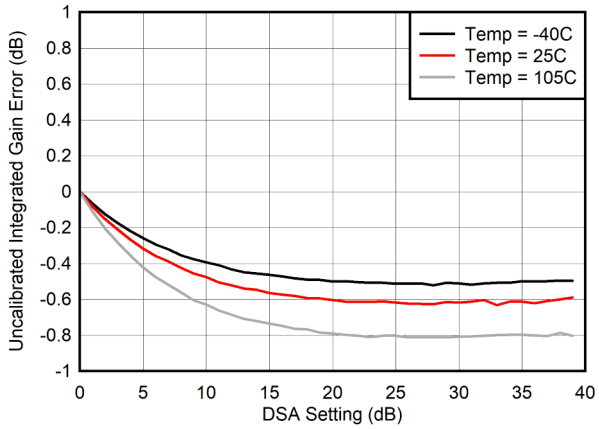
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-241. Calibrated TX Differential Gain Error (DNL) at 400 MHz

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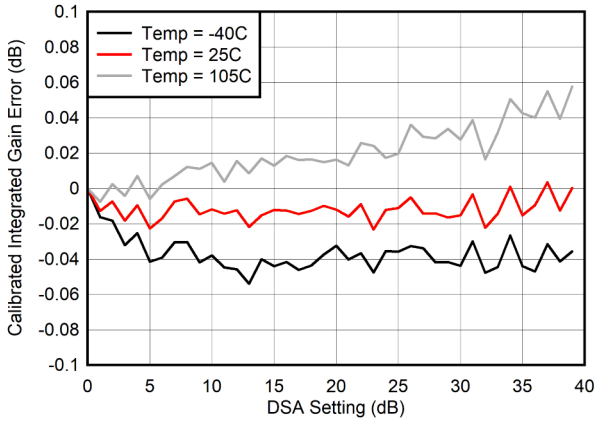
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



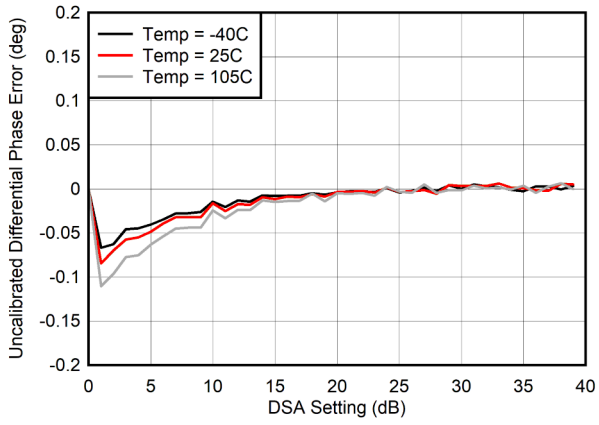
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSASetting = 0) + (DSA Setting)

图 5-242. Uncalibrated TX Integrated Gain Error (INL) at 400 MHz



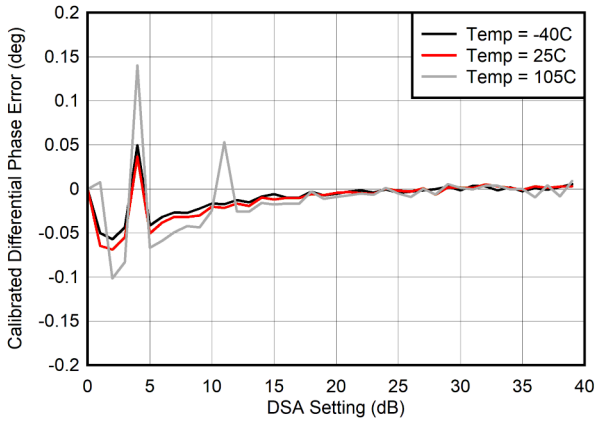
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSASetting = 0) + (DSA Setting)

图 5-243. Calibrated TX Integrated Gain Error (INL) at 400 MHz



Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-244. Uncalibrated TX Differential Phase Error (DNL) at 400 MHz



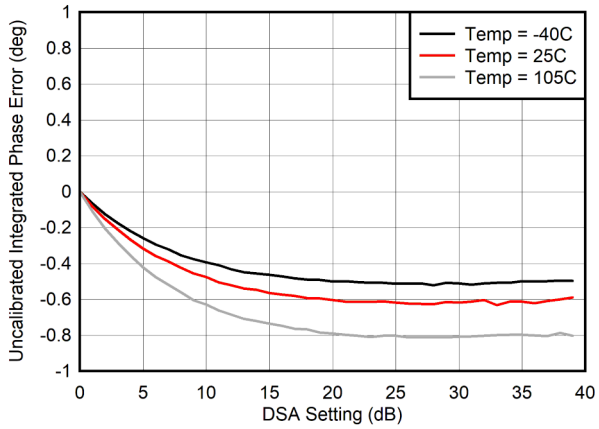
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-245. Calibrated TX Differential Phase Error (DNL) at 400 MHz

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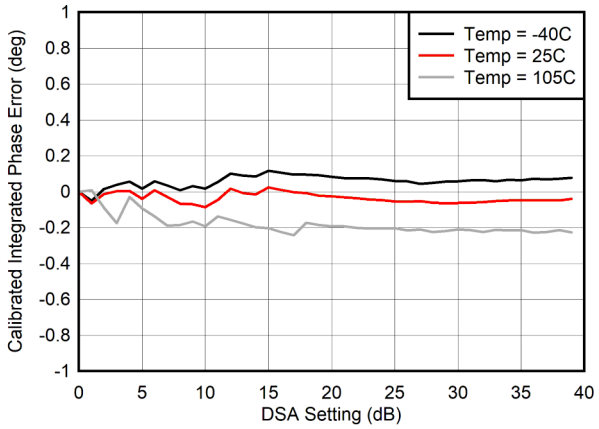
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSASetting = 0)

图 5-246. Uncalibrated TX Integrated Phase Error (INL) at 400 MHz



Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSASetting = 0)

图 5-247. Calibrated TX Integrated Phase Error (INL) at 400 MHz

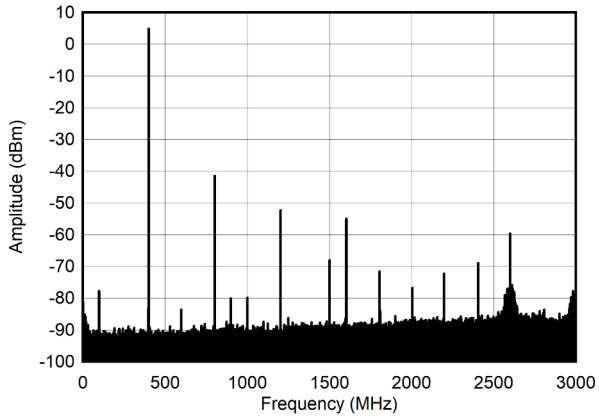


图 5-248. Single Tone Spectrum at 400 MHz and -1 dBFS (Nyquist)

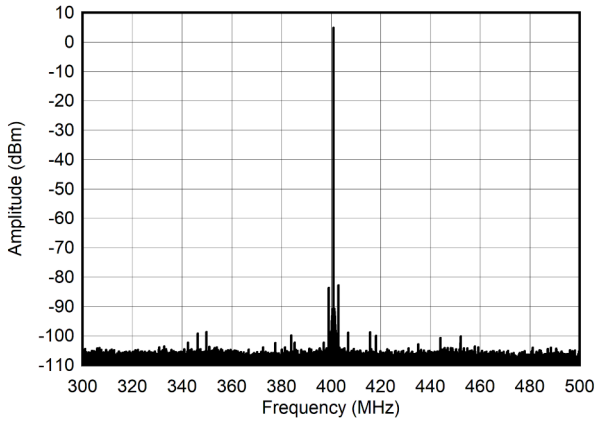


图 5-249. Single Tone Spectrum at 400 MHz and -1 dBFS (±100MHz)

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5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

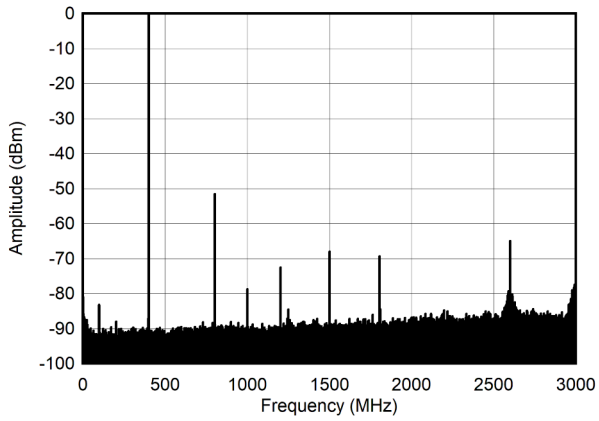


图 5-250. Single Tone Spectrum at 400 MHz and -6 dBFS (Nyquist)

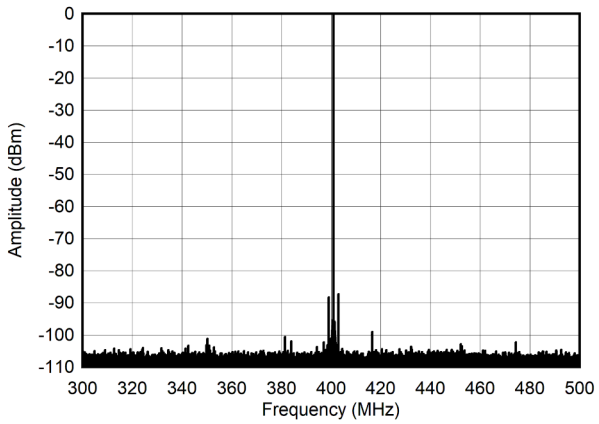


图 5-251. Single Tone Spectrum at 400 MHz and -6 dBFS (±100MHz)

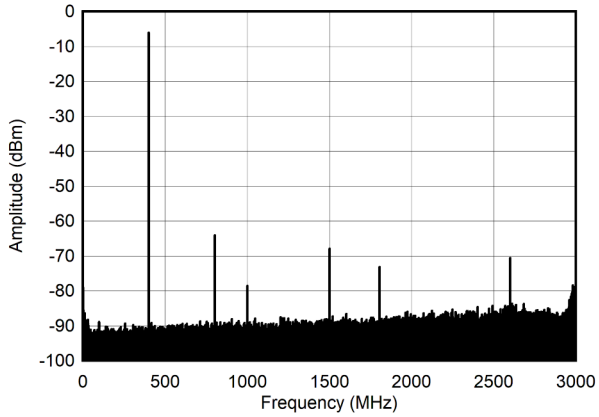


图 5-252. Single Tone Spectrum at 400 MHz and -12 dBFS (Nyquist)

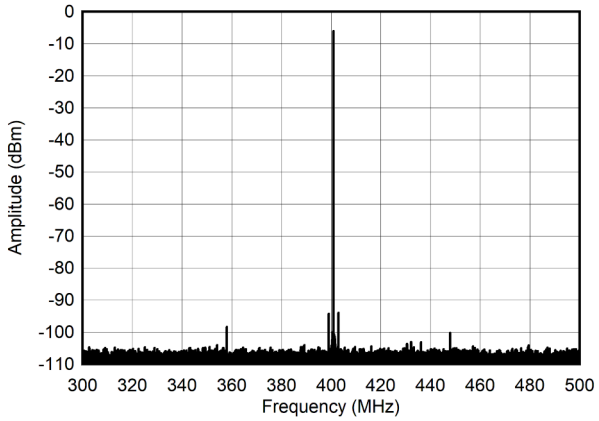


图 5-253. Single Tone Spectrum at 400 MHz and -12 dBFS (±100MHz)

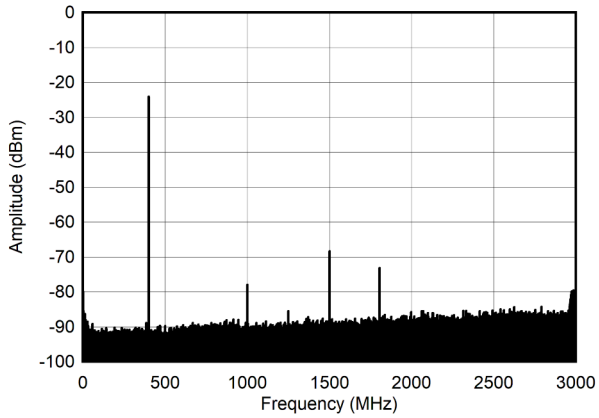


图 5-254. Single Tone Spectrum at 400 MHz and -30 dBFS (Nyquist)

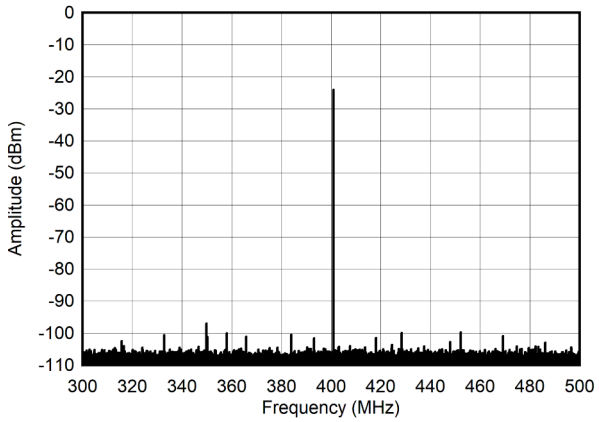


图 5-255. Single Tone Spectrum at 400 MHz and -30 dBFS (±100MHz)

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5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

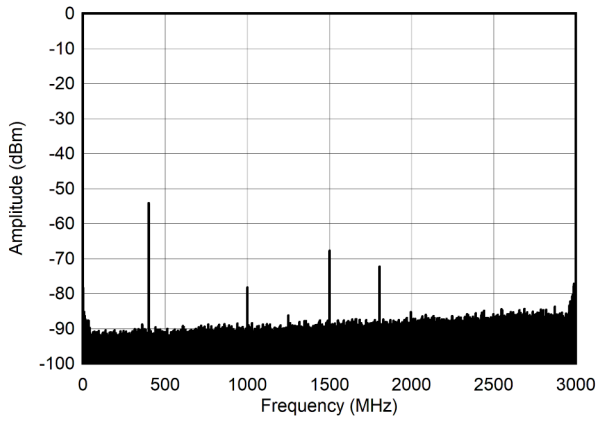


图 5-256. Single Tone Spectrum at 400 MHz and -60 dBFS (Nyquist)

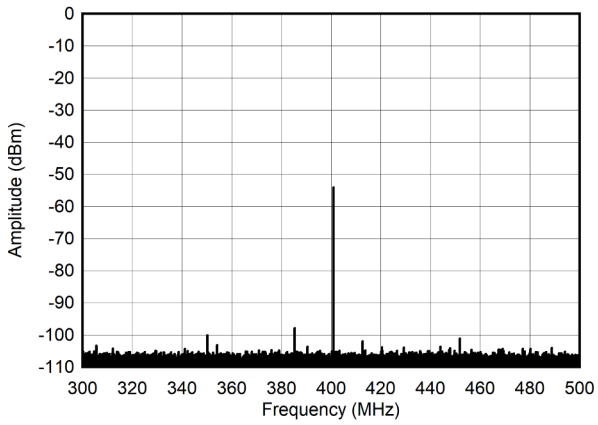
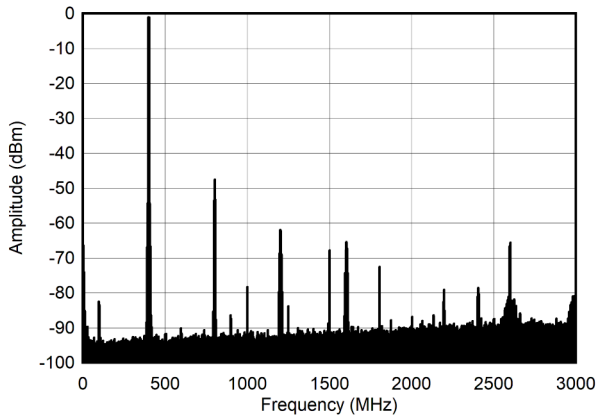
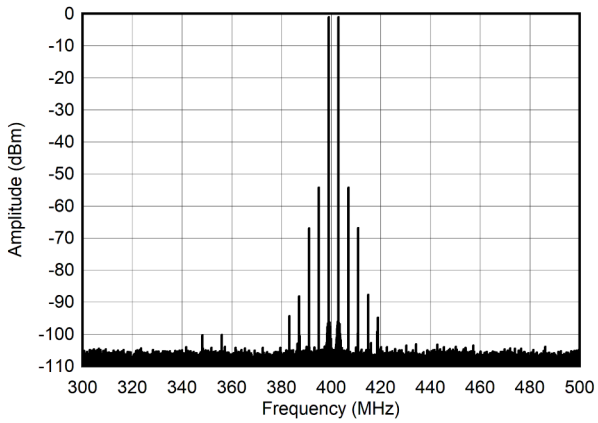


图 5-257. Single Tone Spectrum at 400 MHz and -60 dBFS (±100MHz)



Tone Spacing = 4 MHz

图 5-258. Dual Tone Spectrum at 400 MHz and -7 dBFS (Nyquist)



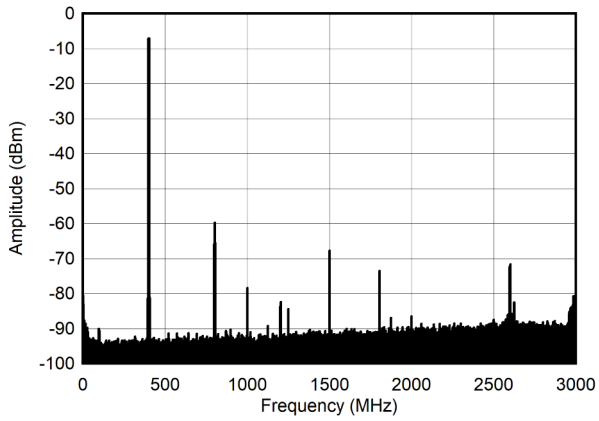
Tone Spacing = 4 MHz

图 5-259. Dual Tone Spectrum at 400 MHz and -7 dBFS (±100MHz)

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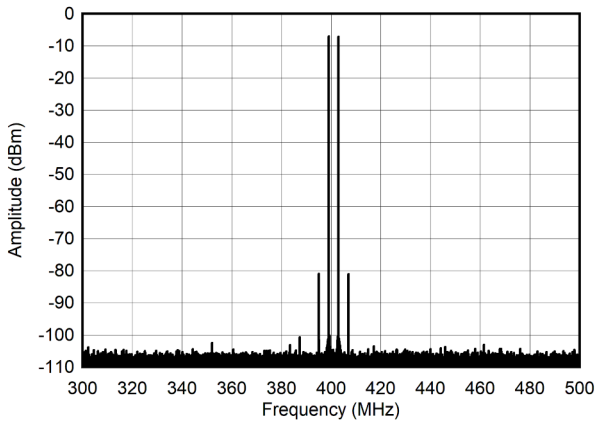
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



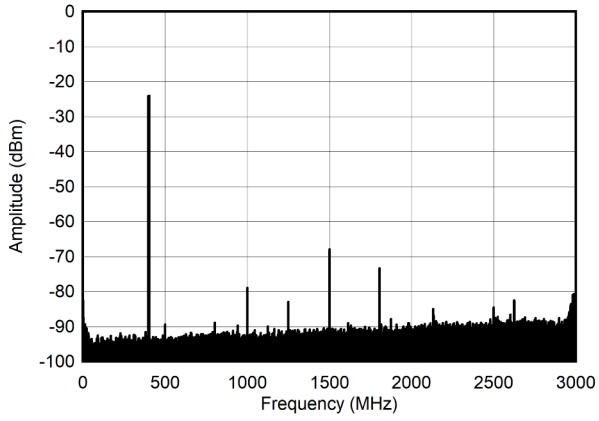
Tone Spacing = 4 MHz

图 5-260. Dual Tone Spectrum at 400 MHz and -13 dBFS (Nyquist)



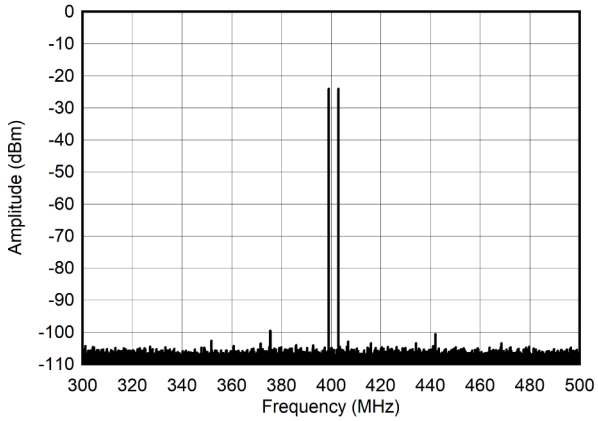
Tone Spacing = 4 MHz

图 5-261. Dual Tone Spectrum at 400 MHz and -13 dBFS (±100MHz)



Tone Spacing = 4 MHz

图 5-262. Dual Tone Spectrum at 400 MHz and -30 dBFS (Nyquist)



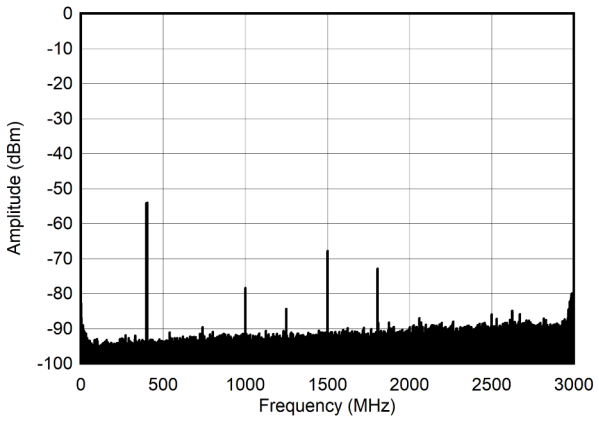
Tone Spacing = 4 MHz

图 5-263. Dual Tone Spectrum at 400 MHz and -30 dBFS (±100MHz)

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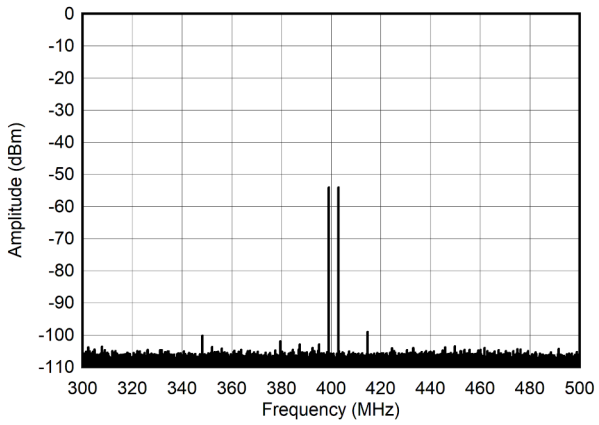
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



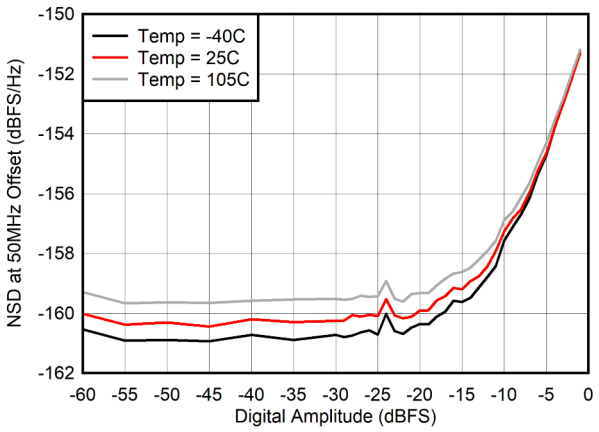
Tone Spacing = 4 MHz

图 5-264. Dual Tone Spectrum at 400 MHz and -60 dBFS (Nyquist)



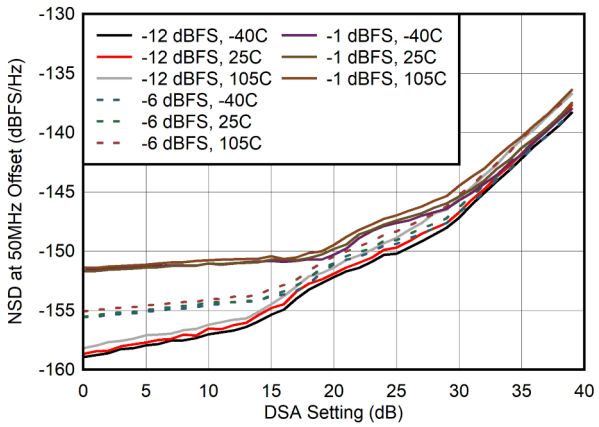
Tone Spacing = 4 MHz

图 5-265. Dual Tone Spectrum at 400 MHz and -60 dBFS (±100MHz)



measured at 50 MHz offset

图 5-266. Noise Spectral Density vs Digital Amplitude at 400 MHz



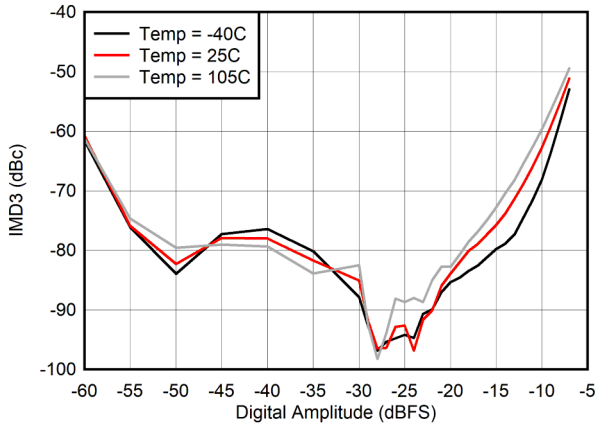
measured at 50 MHz offset

图 5-267. Noise Spectral Density vs DSA Setting at 400 MHz

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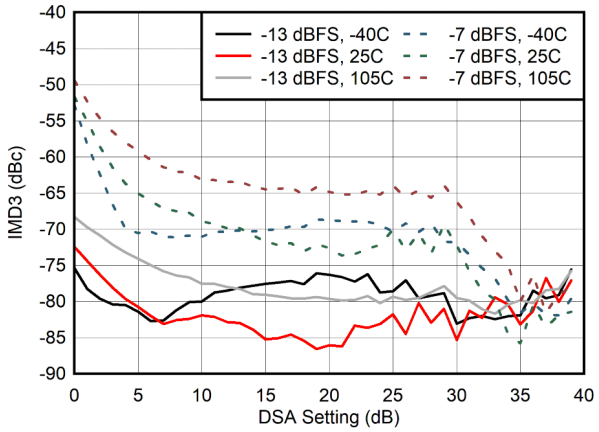
5.12.7 TX Typical Characteristics at 30MHz and 400MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Default conditions: TX input data rate = 125 MSPS, f_{DAC} = 6000 MSPS (48x interpolation), interleave mode, 1st Nyquist zone output, PLL clock mode with f_{REF} = 500 MHz. Additional default conditions for all plots, A_{OUT} = – 1 dBFS, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



Tone Spacing = 4 MHz

图 5-268. IMD3 vs Digital Amplitude at 400 MHz



Tone Spacing = 4 MHz

图 5-269. IMD3 vs DSA Setting at 400 MHz

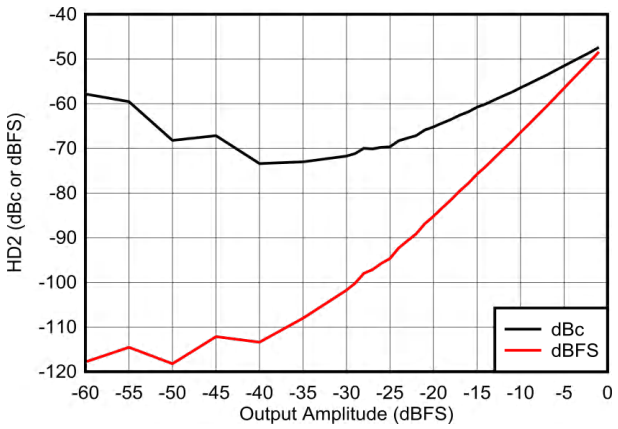


图 5-270. HD2 vs Amplitude at 400 MHz

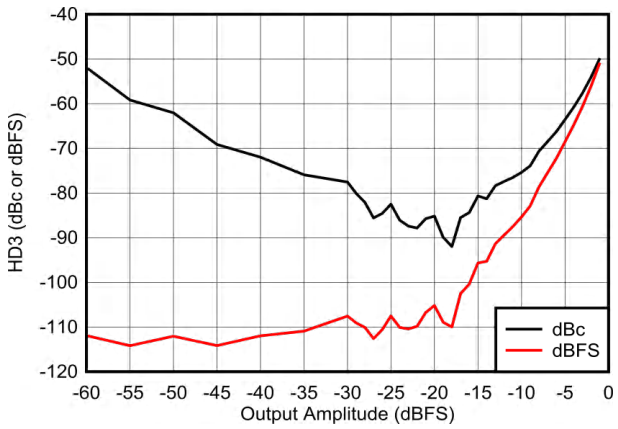
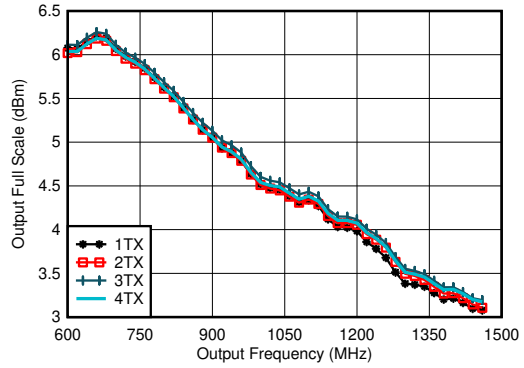


图 5-271. HD3 vs Amplitude at 400 MHz

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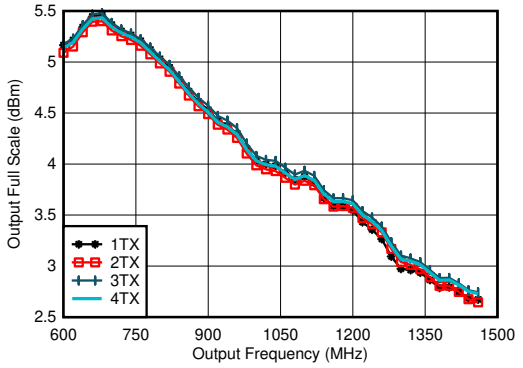
5.12.8 TX Typical Characteristics at 800MHz

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



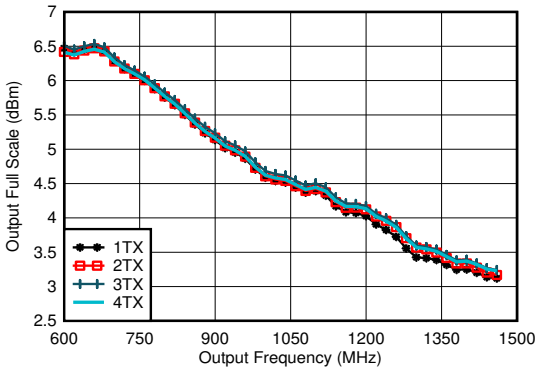
Including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHz matching

图 5-272. TX Full Scale vs RF Frequency and Channel at 5898.24MSPS, Straight Mode



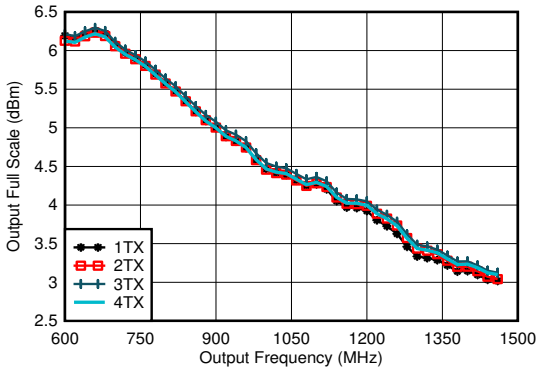
Including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHzmatching

图 5-273. TX Full Scale vs RF Frequency and Channel at 8847.36MSPS, Straight Mode



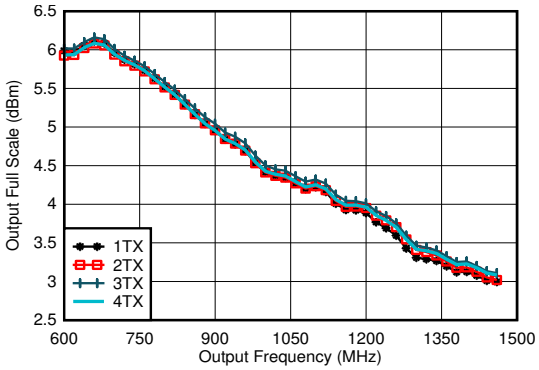
Including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHz matching

图 5-274. TX Full Scale vs RF Frequency and Channel at 5898.24MSPS, Interleave Mode



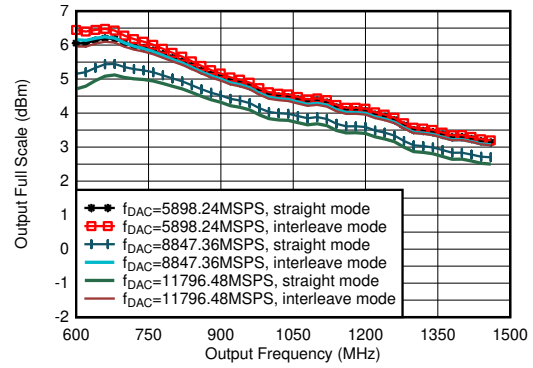
Including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHz matching

图 5-275. TX Full Scale vs RF Frequency and Channel at 8847.36MSPS, Interleave Mode



Including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHz matching

图 5-276. TX Full Scale vs RF Frequency and Channel at 11796.48MSPS, Interleave Mode



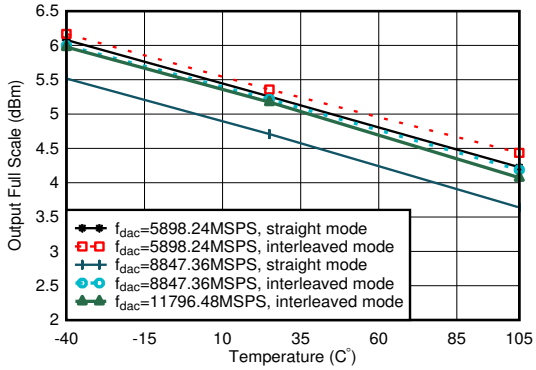
including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHz matching

图 5-277. TX Output Fullscale vs Output Frequency

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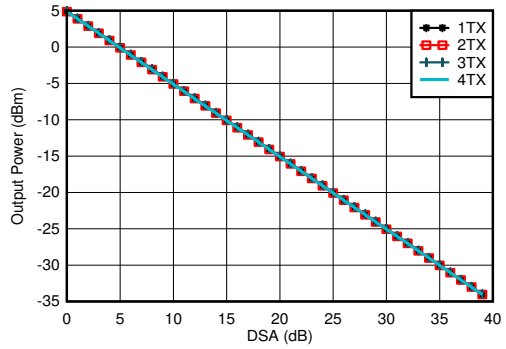
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



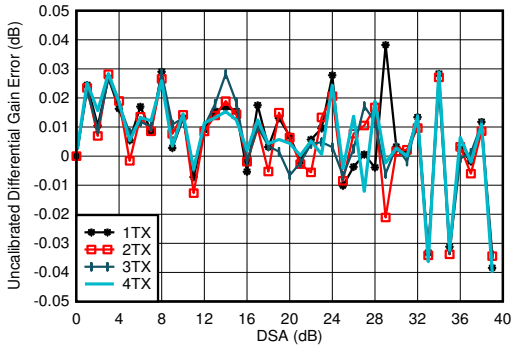
including PCB and cable losses, A_{out} = -0.5dFBS, DSA = 0, 0.8 GHz matching

图 5-278. TX Output Fullscale vs Temperature



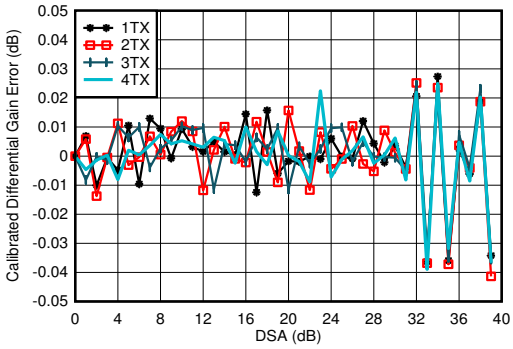
f_{DAC} = 11796.48 MSPS, interleave mode, A_{out} = -0.5dFBS, matching 0.8 GHz

图 5-279. TX Output Power vs DSA Setting and Channel at 0.85 GHz



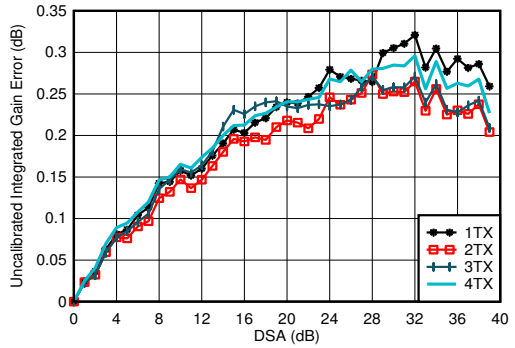
f_{DAC}=5898.24MSPS, interleave mode, matching at 0.8 GHz Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-280. TX Uncalibrated Differential Gain Error vs DSA Setting and Channel at 0.85 GHz



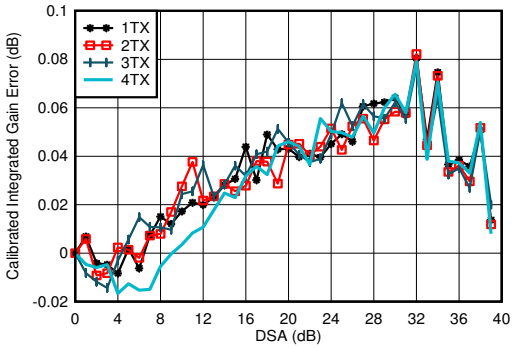
f_{DAC}=5898.24MSPS, interleave mode, matching at 0.8 GHz Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-281. TX Calibrated Differential Gain Error vs DSA Setting and Channel at 0.85 GHz



f_{DAC}=5898.24MSPS, interleave mode, matching at 0.8 GHz Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + DSA Settings

图 5-282. TX Uncalibrated Integrated Gain Error vs DSA Setting and Channel at 0.85 GHz



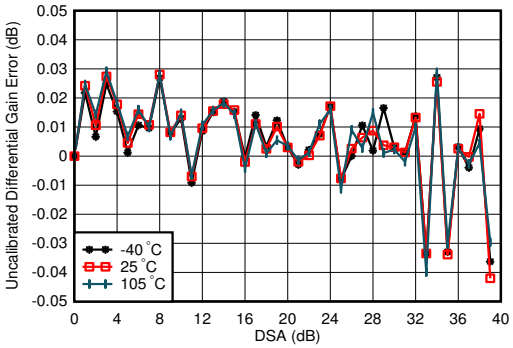
f_{DAC}=5898.24MSPS, interleave mode, matching at 0.8 GHz Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + DSA Setting

图 5-283. TX Calibrated Integrated Gain Error vs DSA Setting and Channel at 0.85 GHz

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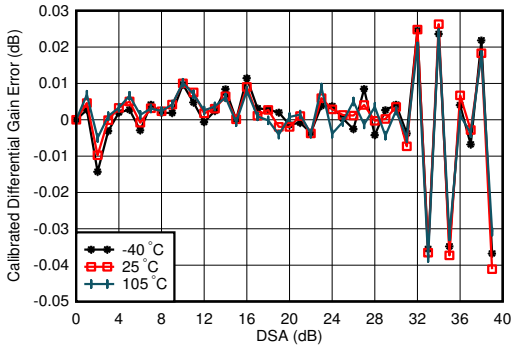
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



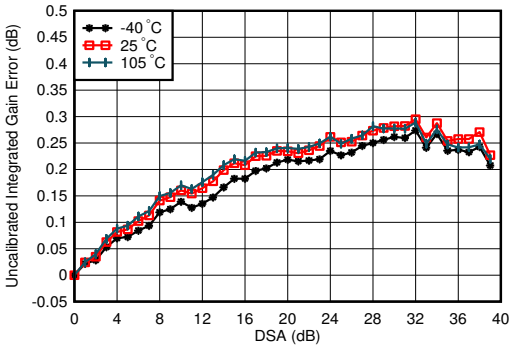
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-284. TX Uncalibrated Differential Gain Error vs DSA Setting and Temperature at 0.85 GHz



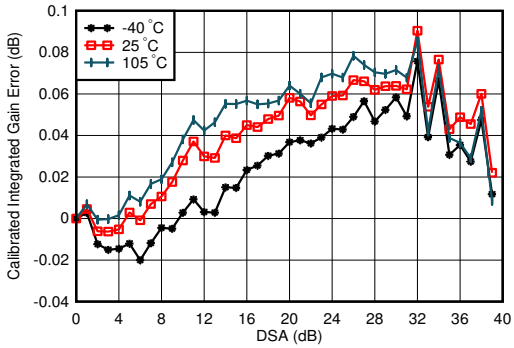
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-285. TX Calibrated Differential Gain Error vs DSA Setting and Temperature at 0.85 GHz



f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + DSA Setting

图 5-286. TX Uncalibrated Integrated Gain Error vs DSA Setting and Temperature at 0.85 GHz



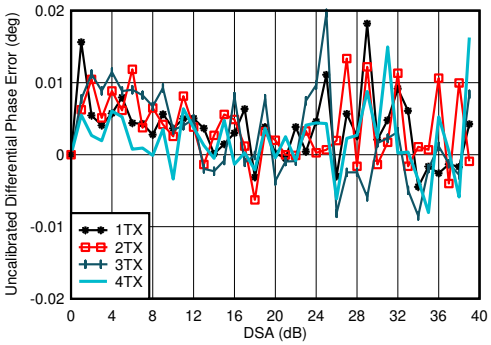
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + DSA Setting

图 5-287. TX Calibrated Integrated Gain Error vs DSA Setting and Temperature at 0.85 GHz

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5.12.8 TX Typical Characteristics at 800MHz (continued)

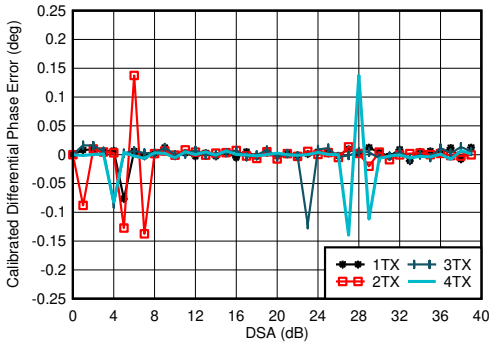
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-288. TX Uncalibrated Differential Phase Error vs DSA Setting and Channel at 0.85 GHz

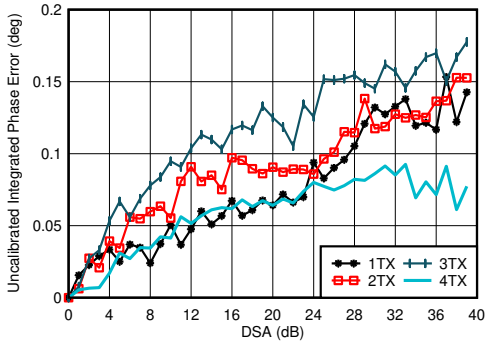


f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

Phase DNL spike may occur at any DSA setting.

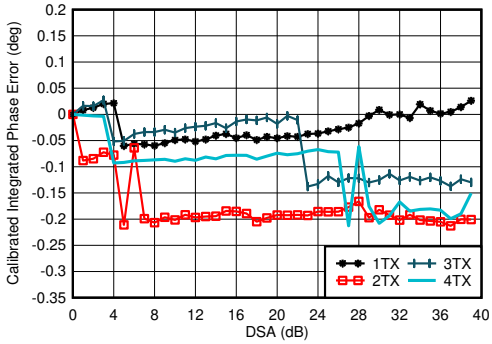
图 5-289. TX Calibrated Differential Phase Error vs DSA Setting and Channel at 0.85 GHz



f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz

Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSA Setting = 0)

图 5-290. TX Uncalibrated Integrated Phase Error vs DSA Setting and Channel at 0.85 GHz



f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz

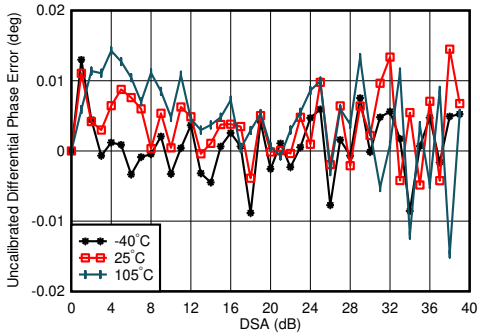
Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSA Setting = 0)

图 5-291. TX Calibrated Integrated Phase Error vs DSA Setting and Channel at 0.85 GHz

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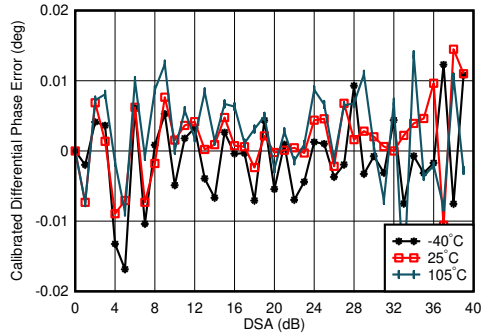
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



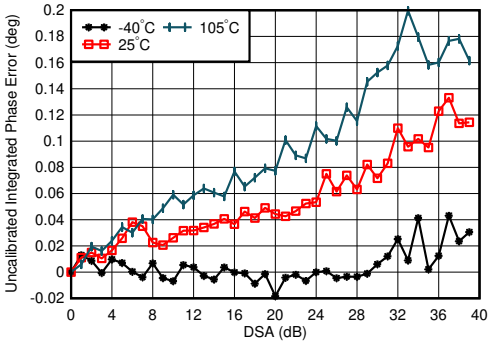
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting) + 1

图 5-292. TX Uncalibrated Differential Phase Error vs DSA Setting and Temperature at 0.85 GHz



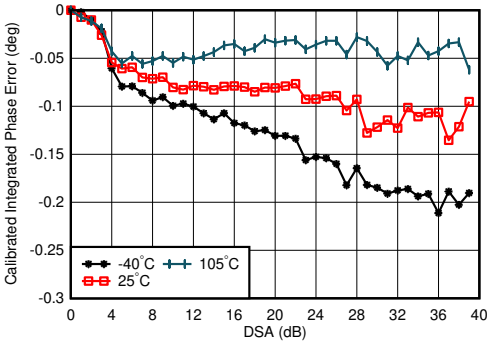
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz, channel with the median variation over DSA setting at 25°C
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting) + 1

图 5-293. TX Calibrated Differential Phase Error vs DSA Setting and Temperature at 0.85 GHz



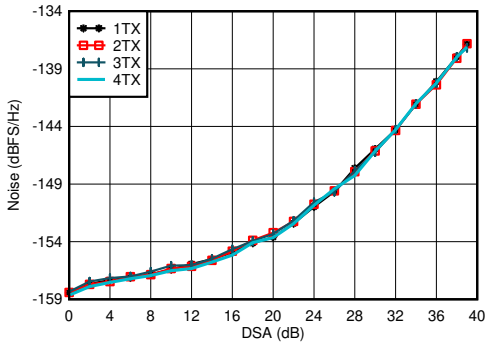
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSA Setting = 0)

图 5-294. TX Uncalibrated Integrated Phase Error vs DSA Setting and Temperature at 0.85 GHz



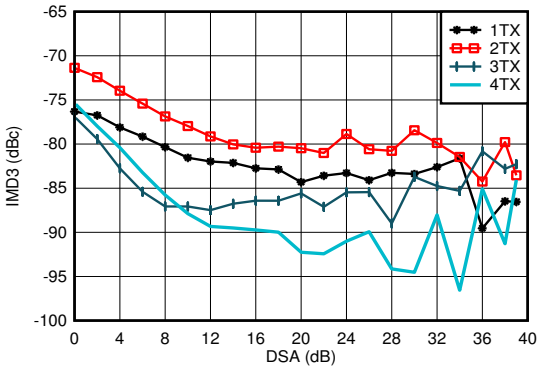
f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz
Integrated Phase Error = $Phase_{OUT}$(DSA Setting) – $Phase_{OUT}$(DSA Setting = 0)

图 5-295. TX Calibrated Integrated Phase Error vs DSA Setting and Temperature at 0.85 GHz



f_{DAC} = 5898.24MSPS, interleave mode, matching at 0.8 GHz, P_{OUT} = – 13 dBFS

图 5-296. TX Output Noise vs Channel and Attenuation at 0.85 GHz



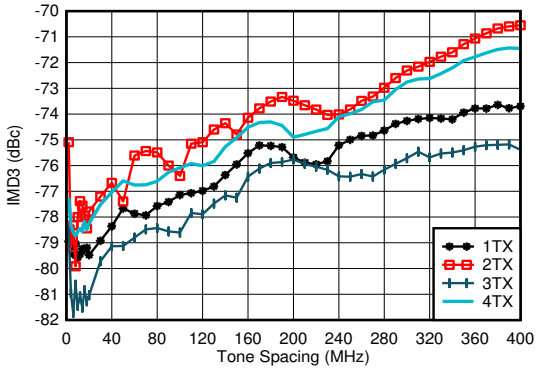
f_{DAC} = 11796.48MSPS, interleave mode, f_{CENTER} = 0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone

图 5-297. TX IMD3 vs DSA Setting at 0.85 GHz

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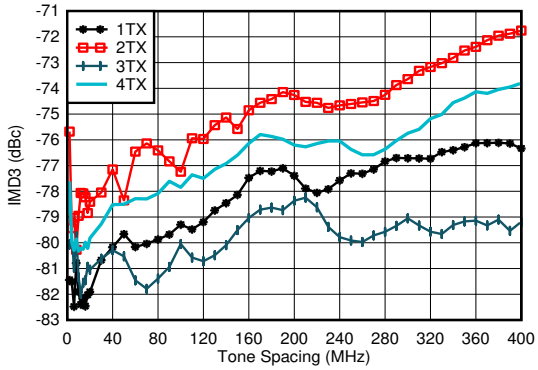
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



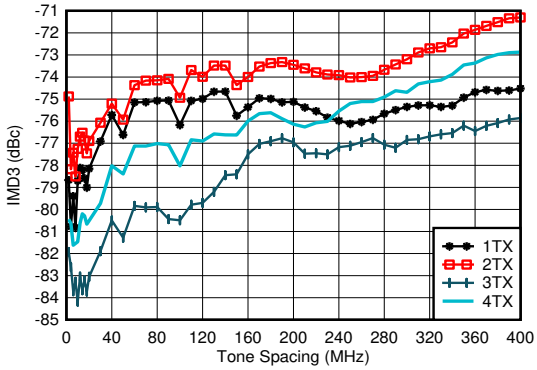
f_{DAC} = 5898.24MSPS, straight mode, f_{CENTER} = 0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone

图 5-298. TX IMD3 vs Tone Spacing and Channel at 0.85 GHz



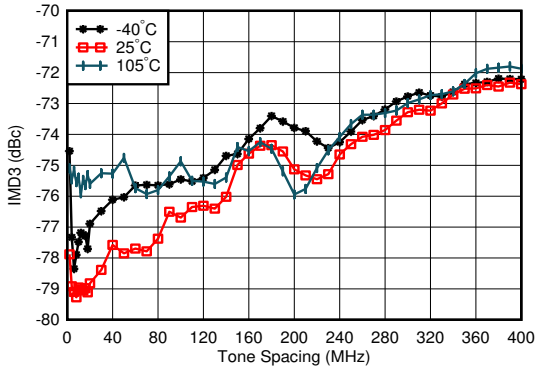
f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone

图 5-299. TX IMD3 vs Tone Spacing and Channel at 0.85 GHz



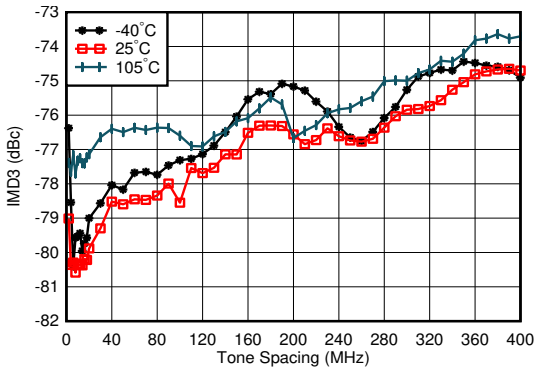
f_{DAC} = 11796.48MSPS, interleave mode, f_{CENTER} = 0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone

图 5-300. TX IMD3 vs Tone Spacing and Channel at 0.85 GHz



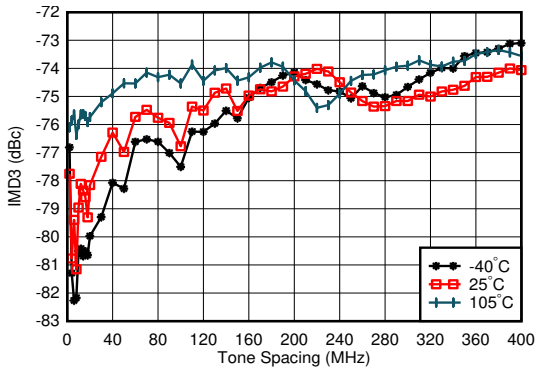
f_{DAC} = 5898.24MSPS, straight mode, f_{CENTER} =0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone, worst channel

图 5-301. TX IMD3 vs Tone Spacing and Temperature at 0.85 GHz



f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} =0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone, worst channel

图 5-302. TX IMD3 vs Tone Spacing and Temperature at 0.85 GHz



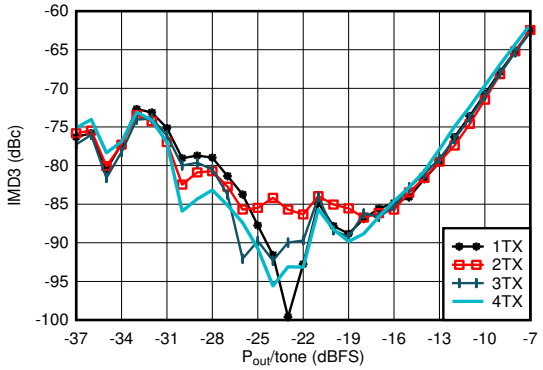
f_{DAC} = 11796.48MSPS, straight mode, f_{CENTER} =0.85 GHz, matching at 0.8 GHz, – 13 dBFS each tone, worst channel

图 5-303. TX IMD3 vs Tone Spacing and Temperature at 0.85 GHz

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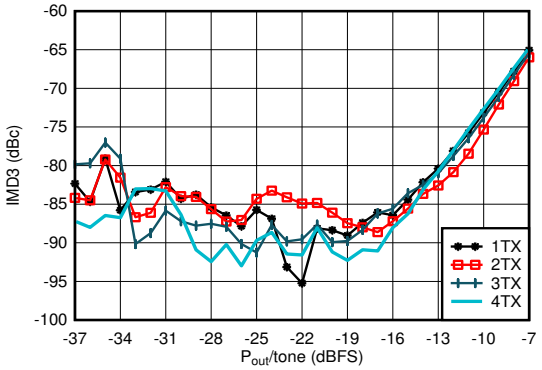
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



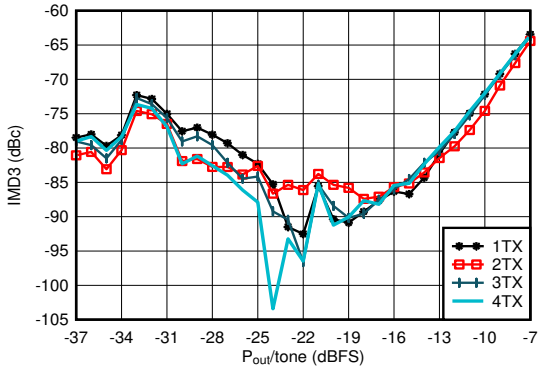
f_{DAC} = 5898.24MSPS, straight mode, f_{CENTER} = 0.85 GHz, $f_{SPACING}$ = 20 MHz, matching at 0.8 GHz

图 5-304. TX IMD3 vs Digital Level at 0.85 GHz



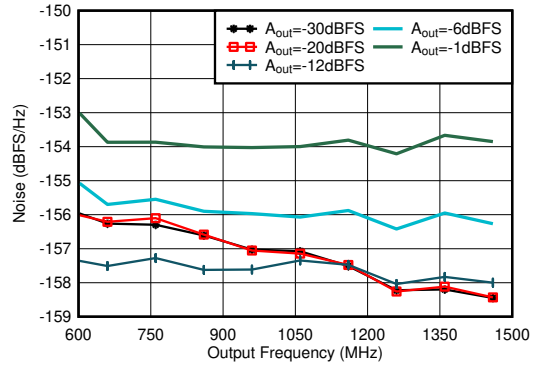
f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 0.85 GHz, $f_{SPACING}$ = 20 MHz, matching at 0.8 GHz

图 5-305. TX IMD3 vs Digital Level at 0.85 GHz



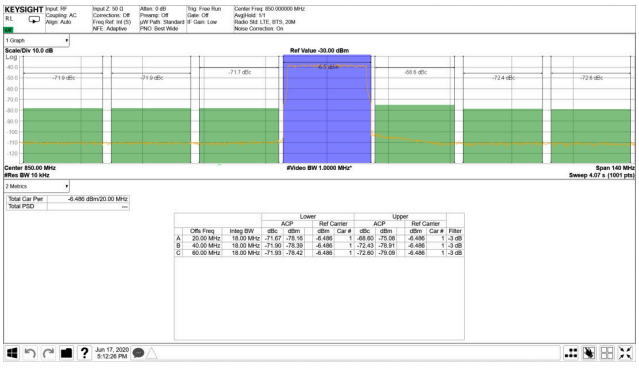
f_{DAC} = 11796.48MSPS, interleave mode, f_{CENTER} = 0.85 GHz, $f_{SPACING}$ = 20 MHz, matching at 0.8 GHz

图 5-306. TX IMD3 vs Digital Level at 0.85 GHz



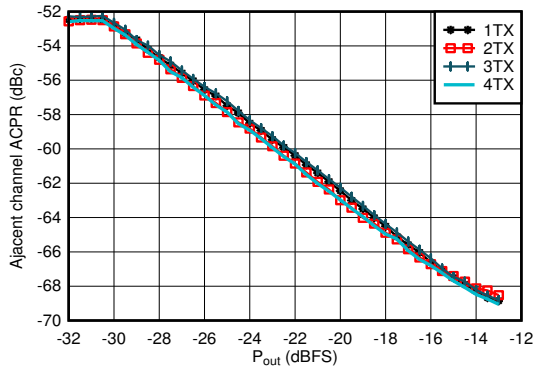
Matching at 0.8 GHz, Single tone, f_{DAC} = 11.79648GSPS, interleave mode, 40-MHz offset, DSA = 0dB

图 5-307. TX Single Tone Output Noise vs Frequency and Amplitude at 0.85 GHz



TM1.1, P_{OUT_RMS} = – 13 dBFS

图 5-308. TX 20-MHz LTE Output Spectrum at 0.85 GHz



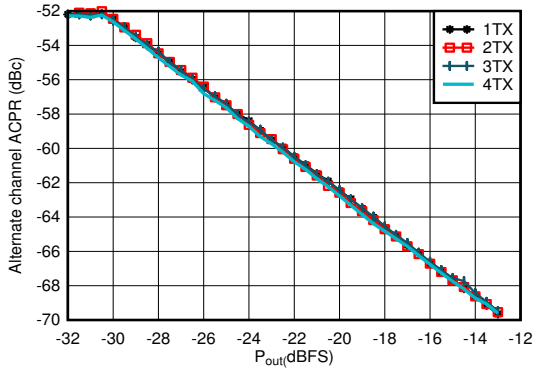
Matching at 0.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-309. TX 20-MHz LTE ACPR vs Digital Level at 0.85 GHz

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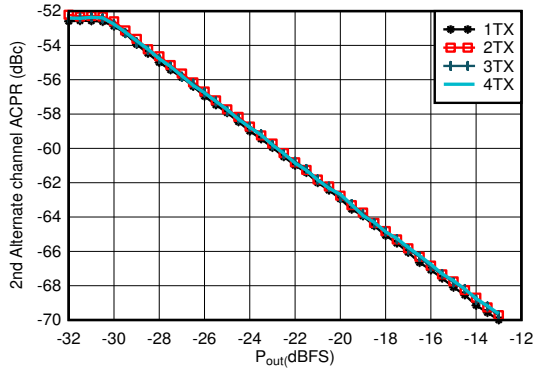
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



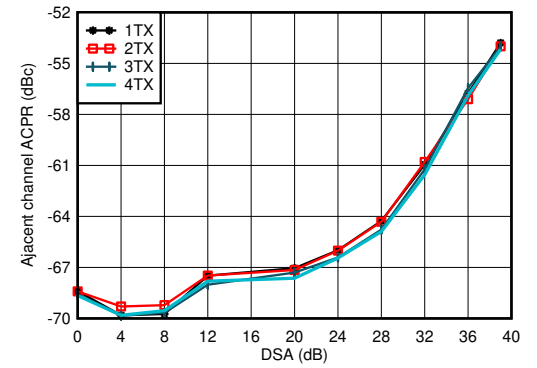
Matching at 0.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-310. TX 20-MHz LTE alt-ACPR vs Digital Level at 0.85 GHz



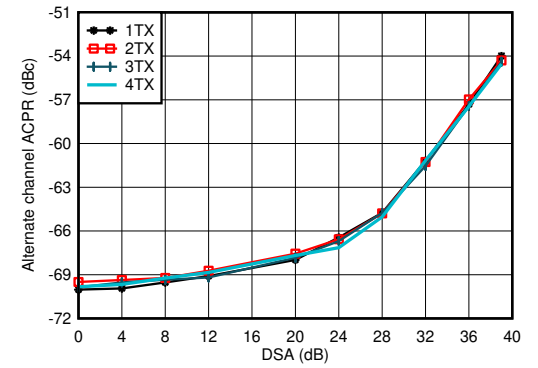
Matching at 0.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-311. TX 20-MHz LTE alt2-ACPR vs Digital Level at 0.85 GHz



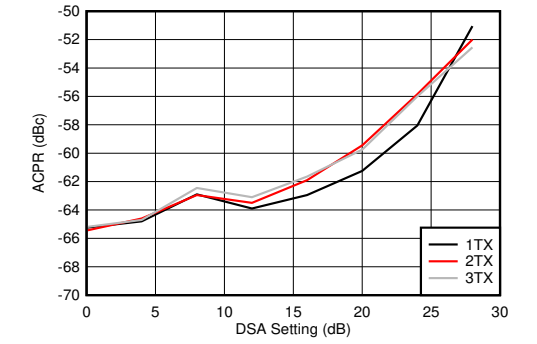
Matching at 0.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-312. TX 20-MHz LTE ACPR vs DSA at 0.85 GHz



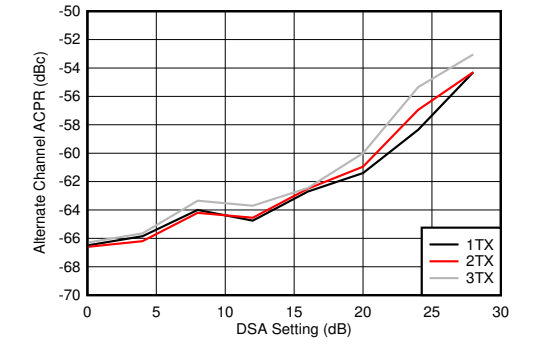
Matching at 0.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-313. TX 20-MHz LTE alt-ACPR vs DSA at 0.85 GHz



Matching at 0.8 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-314. TX 100-MHz NR ACPR vs DSA at 0.85 GHz



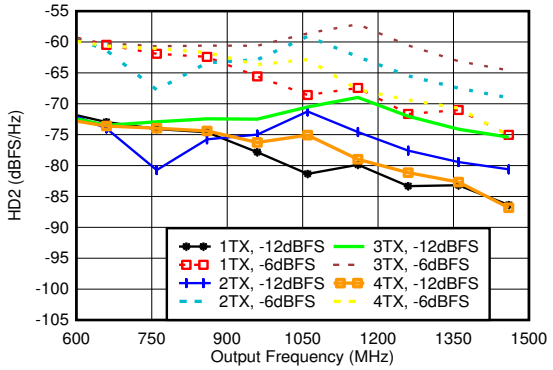
Matching at 0.8 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-315. TX 100-MHz NR alt-ACPR vs DSA at 0.85 GHz

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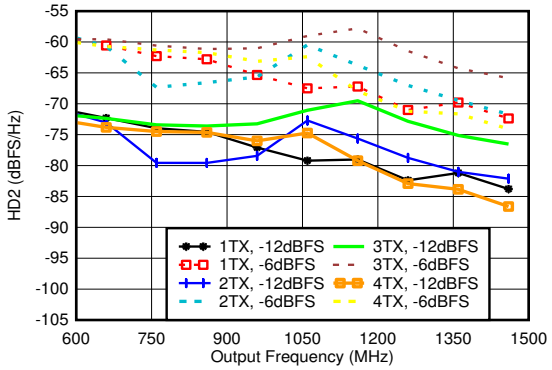
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



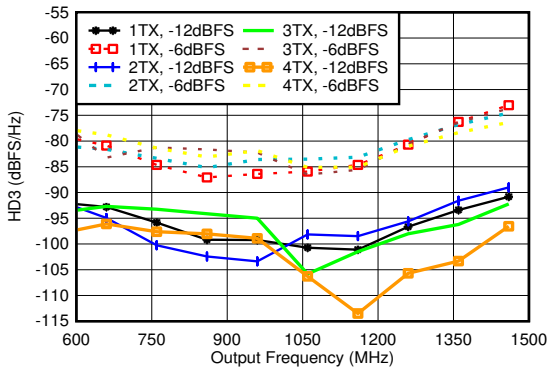
Matching at 0.8 GHz, f_{DAC} = 5898.24GSPS, straight mode

图 5-316. TX HD2 vs Digital Amplitude and Output Frequency at 0.85 GHz



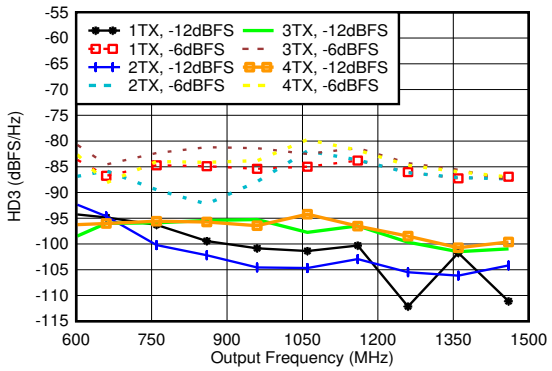
Matching at 0.8 GHz, f_{DAC} = 8847.36GSPS, straight mode

图 5-317. TX HD2 vs Digital Amplitude and Output Frequency at 0.85 GHz



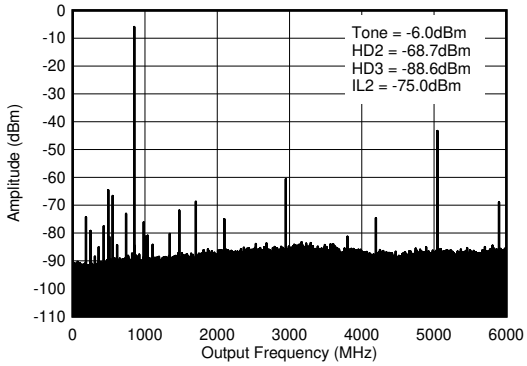
Matching at 0.8 GHz, f_{DAC} = 5898.24MSPS, straight mode, normalized to output power at harmonic frequency

图 5-318. TX HD3 vs Digital Amplitude and Output Frequency at 0.85 GHz



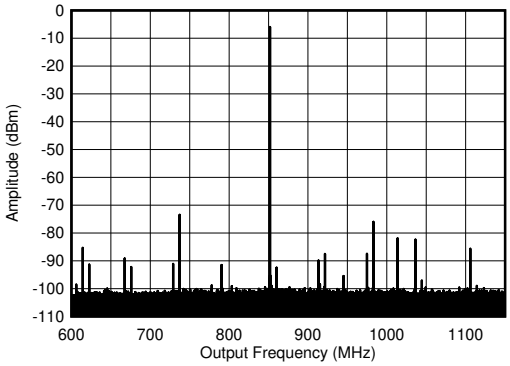
Matching at 0.8 GHz, f_{DAC} = 8847.36MSPS, straight mode, normalized to output power at harmonic frequency

图 5-319. TX HD3 vs Digital Amplitude and Output Frequency at 0.85 GHz



f_{DAC} = 5898.24MSPS, interleave mode, 0.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-320. TX Single Tone (– 12 dBFS) Output Spectrum at 0.85 GHz (0-f_{DAC})



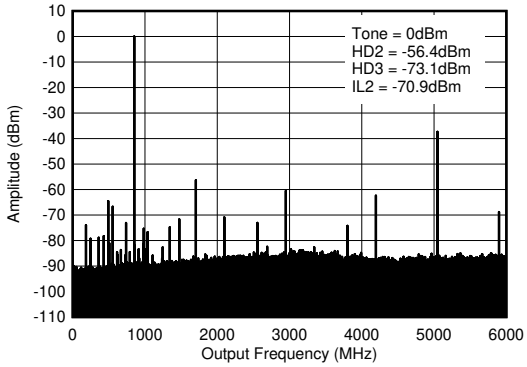
f_{DAC} = 5898.24MSPS, interleave mode, 0.8 GHz matching, includes PCB and cable losses

图 5-321. TX Single Tone (– 12 dBFS) Output Spectrum at 0.85 GHz (±300 MHz)

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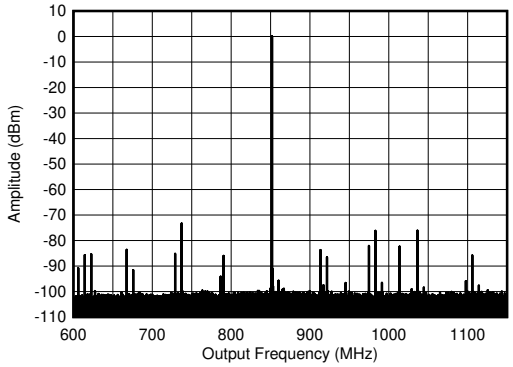
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



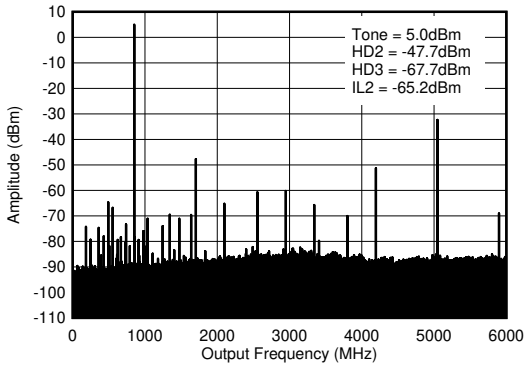
f_{DAC} = 5898.24MSPS, interleave mode, 0.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-322. TX Single Tone (– 6 dBFS) Output Spectrum at 0.85 GHz (0-f_{DAC})



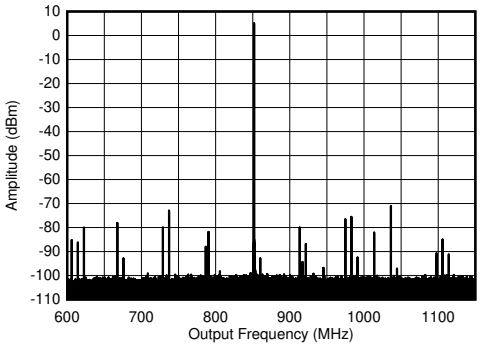
f_{DAC} = 5898.24MSPS, interleave mode, 0.8 GHz matching, includes PCB and cable losses

图 5-323. TX Single Tone (– 6 dBFS) Output Spectrum at 0.85 GHz (±300 MHz)



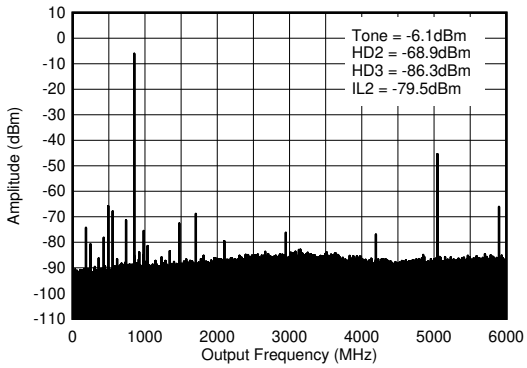
f_{DAC} = 5898.24MSPS, interleave mode, 0.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-324. TX Single Tone (– 1 dBFS) Output Spectrum at 0.85 GHz (0-f_{DAC})



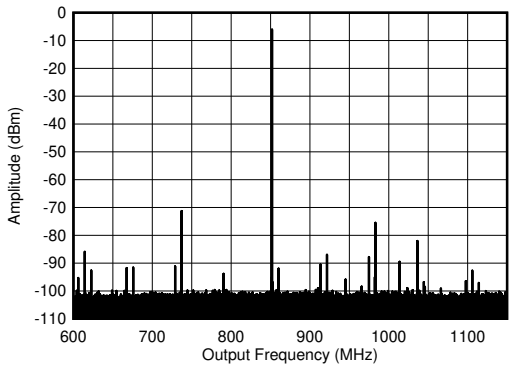
f_{DAC} = 5898.24MSPS, interleave mode, 0.8 GHz matching, includes PCB and cable losses

图 5-325. TX Single Tone (– 1 dBFS) Output Spectrum at 0.85 GHz (±300 MHz)



f_{DAC} = 5898.24MSPS, straight mode, 0.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-326. TX Single Tone (– 12 dBFS) Output Spectrum at 0.85 GHz (0-f_{DAC})



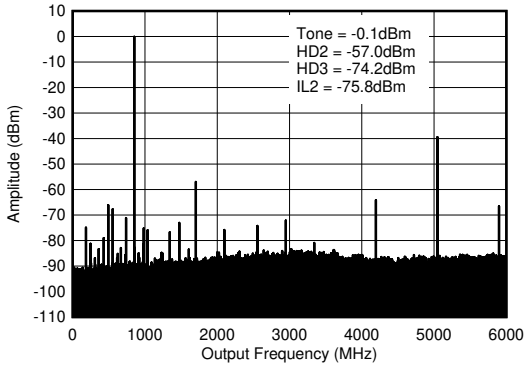
f_{DAC} = 5898.24MSPS, straight mode, 0.8 GHz matching, includes PCB and cable losses

图 5-327. TX Single Tone (– 12 dBFS) Output Spectrum at 0.85 GHz (±300 MHz)

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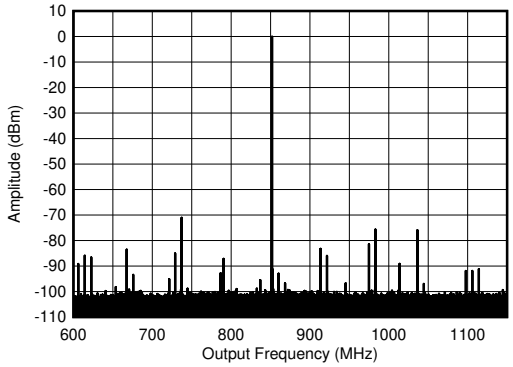
5.12.8 TX Typical Characteristics at 800MHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



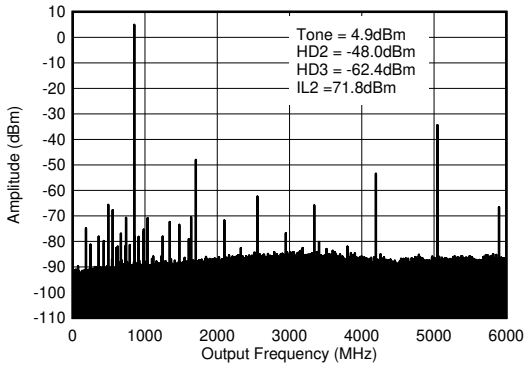
f_{DAC} = 5898.24MSPS, straight mode, 0.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-328. TX Single Tone (– 6 dBFS) Output Spectrum at 0.85 GHz (0-f_{DAC})



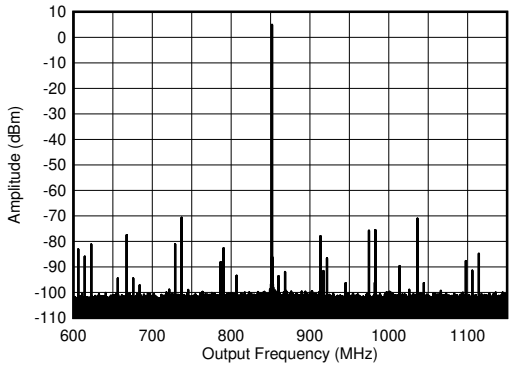
f_{DAC} = 5898.24MSPS, straight mode, 0.8 GHz matching, includes PCB and cable losses

图 5-329. TX Single Tone (– 6 dBFS) Output Spectrum at 0.85 GHz (±300 MHz)



f_{DAC} = 5898.24MSPS, straight mode, 0.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-330. TX Single Tone (– 1 dBFS) Output Spectrum at 0.85 GHz (0-f_{DAC})



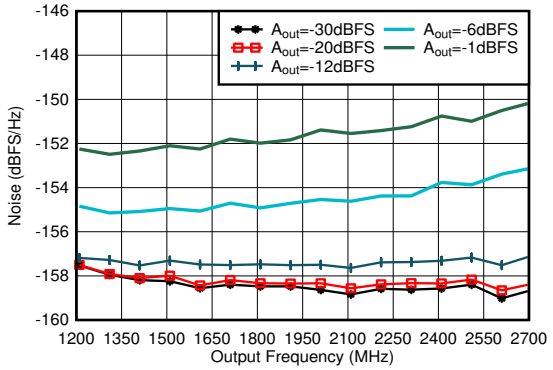
f_{DAC} = 5898.24MSPS, straight mode, 0.8 GHz matching, includes PCB and cable losses

图 5-331. TX Single Tone (– 1 dBFS) Output Spectrum at 0.85 GHz (±300 MHz)

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5.12.9 TX Typical Characteristics at 1.8GHz

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



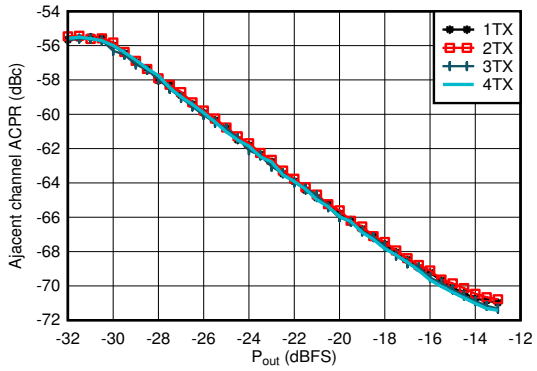
Matching at 1.8 GHz, Single tone, f_{DAC} = 11.79648GSPS, interleave mode, 40-MHz offset

图 5-332. TX Single Tone Output Noise vs Frequency and Amplitude at 1.8 GHz



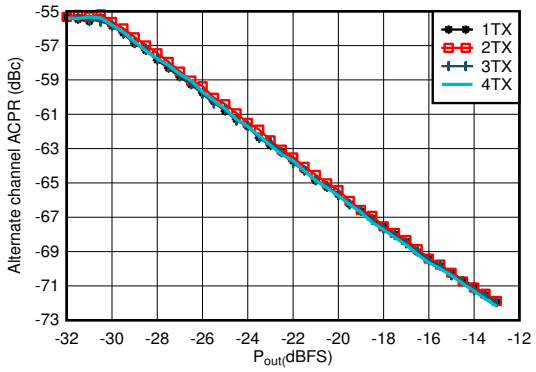
TM1.1, P_{OUT_RMS} = – 13 dBFS

图 5-333. TX 20-MHz LTE Output Spectrum at 1.8425 GHz



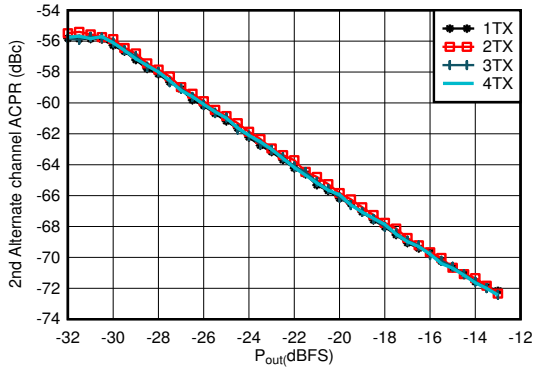
Matching at 1.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-334. TX 20-MHz LTE ACPR vs Digital Level at 1.8425 GHz



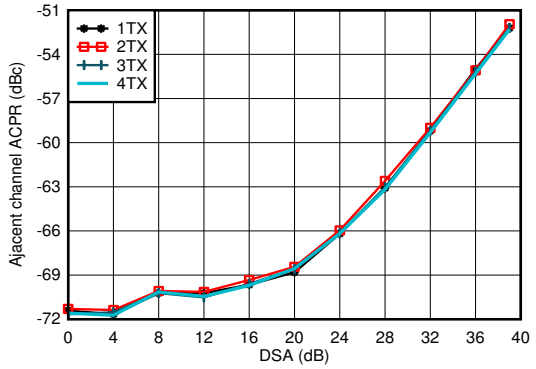
Matching at 1.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-335. TX 20-MHz LTE alt-ACPR vs Digital Level at 1.8425 GHz



Matching at 1.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-336. TX 20-MHz LTE alt2-ACPR vs Digital Level at 1.8425 GHz



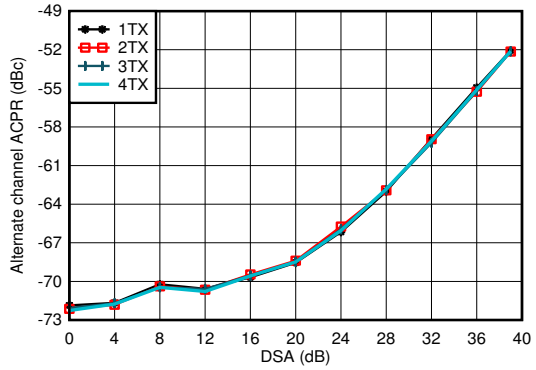
Matching at 1.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-337. TX 20-MHz LTE ACPR vs DSA at 1.8 GHz

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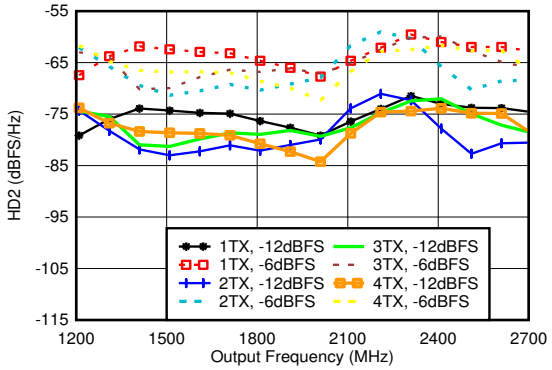
5.12.9 TX Typical Characteristics at 1.8GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



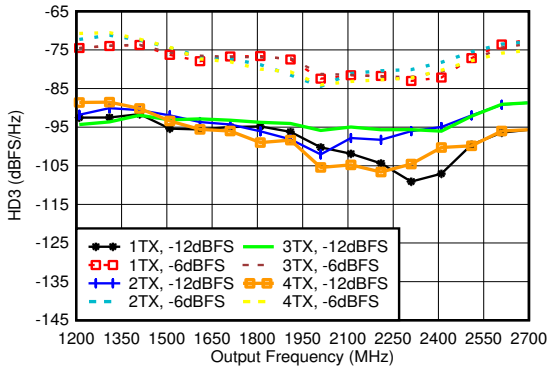
Matching at 1.8 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-338. TX 20-MHz LTE alt-ACPR vs DSA at 1.8 GHz



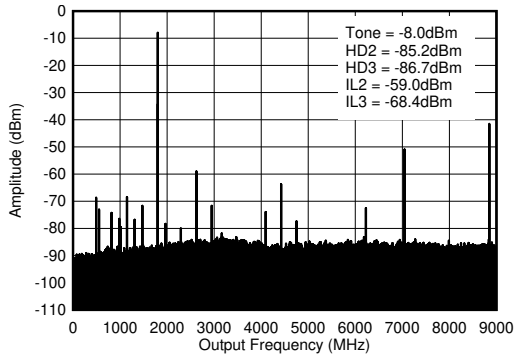
Matching at 1.8 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-339. TX HD2 vs Digital Amplitude and Output Frequency at 1.8 GHz



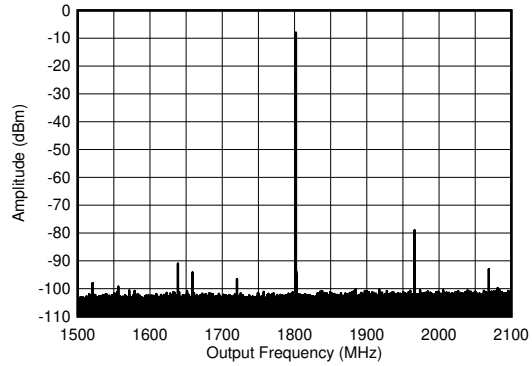
Matching at 1.8 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-340. TX HD3 vs Digital Amplitude and Output Frequency at 1.8 GHz



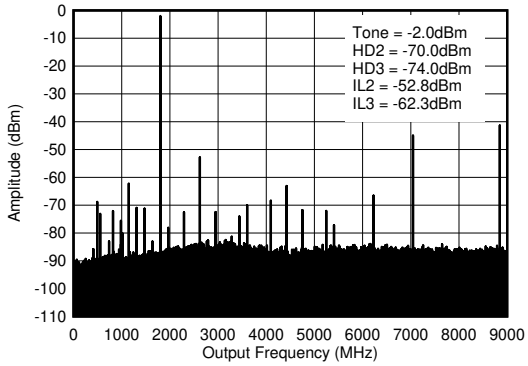
f_{DAC} = 8847.36MSPS, interleave mode, 1.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-341. TX Single Tone (– 12 dBFS) Output Spectrum at 1.8 GHz (0-f_{DAC})



f_{DAC} = 8847.36MSPS, interleave mode, 1.8 GHz matching, includes PCB and cable losses

图 5-342. TX Single Tone (– 12 dBFS) Output Spectrum at 1.8 GHz (±300 MHz)



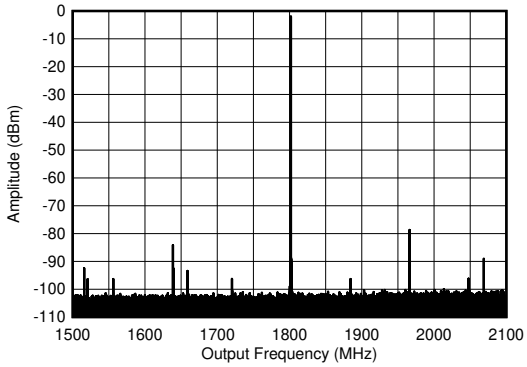
f_{DAC} = 8847.36MSPS, interleave mode, 1.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-343. TX Single Tone (– 6 dBFS) Output Spectrum at 1.8 GHz (0-f_{DAC})

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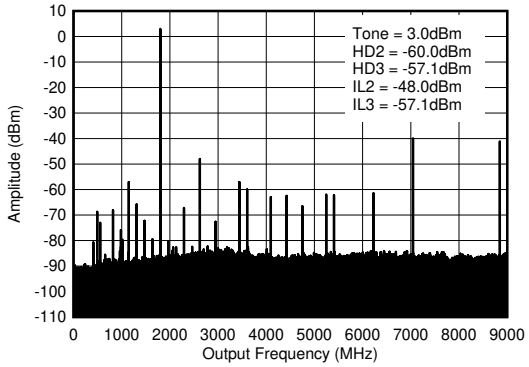
5.12.9 TX Typical Characteristics at 1.8GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



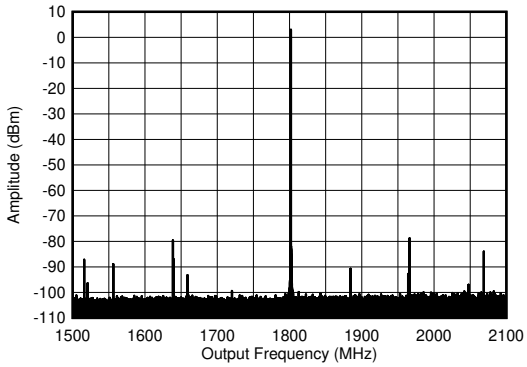
f_{DAC} = 8847.36MSPS, interleave mode, 1.8 GHz matching, includes PCB and cable losses

图 5-344. TX Single Tone (– 6 dBFS) Output Spectrum at 1.8 GHz (±300 MHz)



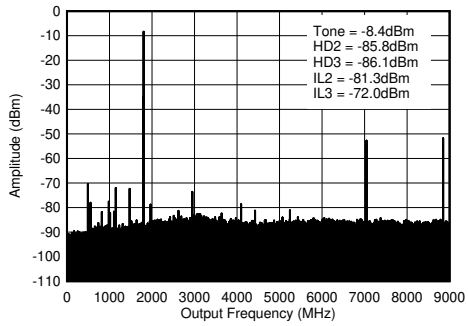
f_{DAC} = 8847.36MSPS, interleave mode, 1.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-345. TX Single Tone (– 1 dBFS) Output Spectrum at 1.8 GHz (0-f_{DAC})



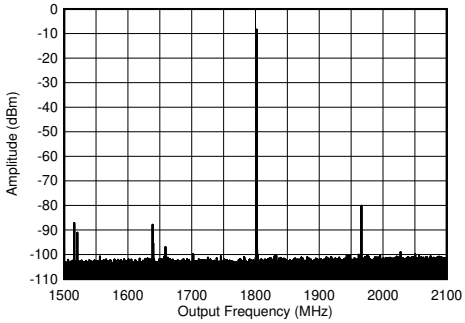
f_{DAC} = 8847.36MSPS, interleave mode, 1.8 GHz matching, includes PCB and cable losses

图 5-346. TX Single Tone (– 1 dBFS) Output Spectrum at 1.8 GHz (±300 MHz)



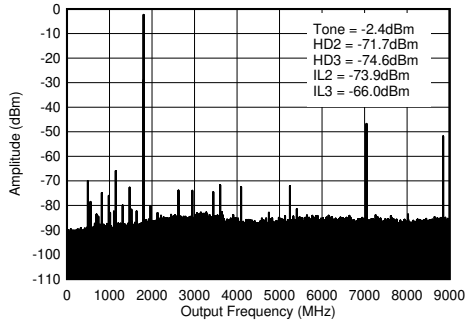
f_{DAC} = 8847.36MSPS, straight mode, 1.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-347. TX Single Tone (– 12 dBFS) Output Spectrum at 1.8 GHz (0-f_{DAC})



f_{DAC} = 8847.36MSPS, straight mode, 1.8 GHz matching, includes PCB and cable losses

图 5-348. TX Single Tone (– 12 dBFS) Output Spectrum at 1.8 GHz (±300 MHz)



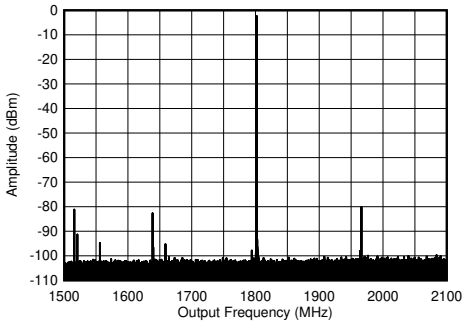
f_{DAC} = 8847.36MSPS, straight mode, 1.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-349. TX Single Tone (– 6 dBFS) Output Spectrum at 1.8 GHz (0-f_{DAC})

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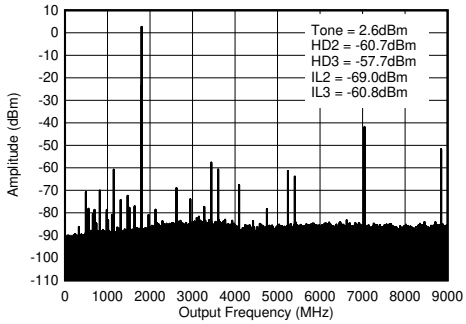
5.12.9 TX Typical Characteristics at 1.8GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



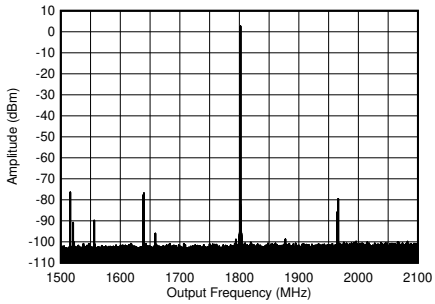
f_{DAC} = 8847.36MSPS, straight mode, 1.8 GHz matching, includes PCB and cable losses

图 5-350. TX Single Tone (– 6 dBFS) Output Spectrum at 1.8 GHz (±300 MHz)



f_{DAC} = 8847.36MSPS, straight mode, 1.8 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-351. TX Single Tone (– 1 dBFS) Output Spectrum at 1.8 GHz (0-f_{DAC})



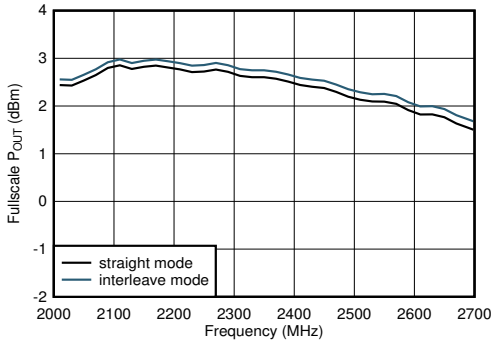
f_{DAC} = 8847.36MSPS, straight mode, 1.8 GHz matching, includes PCB and cable losses

图 5-352. TX Single Tone (– 1 dBFS) Output Spectrum at 1.8 GHz (±300 MHz)

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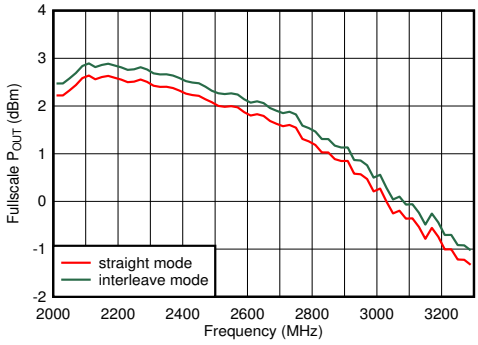
5.12.10 TX Typical Characteristics at 2.6GHz

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



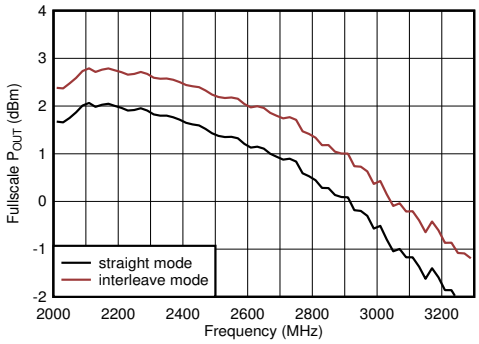
Including PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 2.6 GHz matching

图 5-353. TX Full Scale vs RF Frequency at 5898.24MSPS



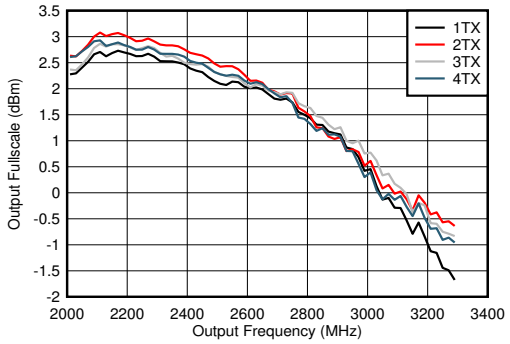
Including PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 2.6 GHz matching

图 5-354. TX Full Scale vs RF Frequency at 8847.36MSPS



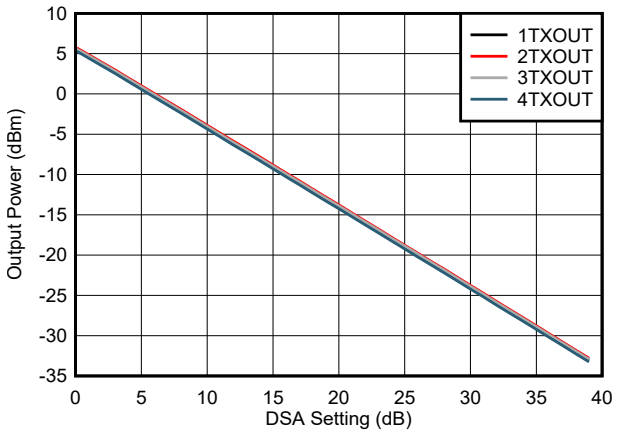
Including PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 2.6 GHz matching

图 5-355. TX Full Scale vs RF Frequency at 11796.48MSPS



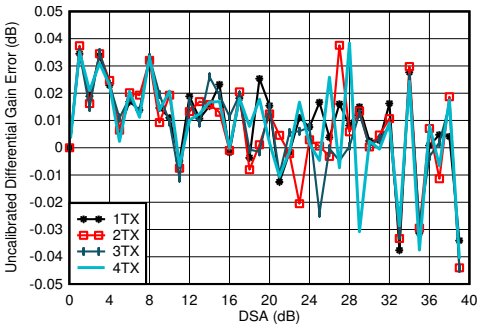
f_{DAC} = 8847.36MSPS, interleave mode, including PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 2.6 GHz matching

图 5-356. TX Output Fullscale vs Output Frequency and Channel



f_{DAC} = 8847.36 MSPS, A_{out} = -0.5dBFS, matching 2.6 GHz

图 5-357. TX Output Power vs DSA Setting and Channel at 2.6 GHz



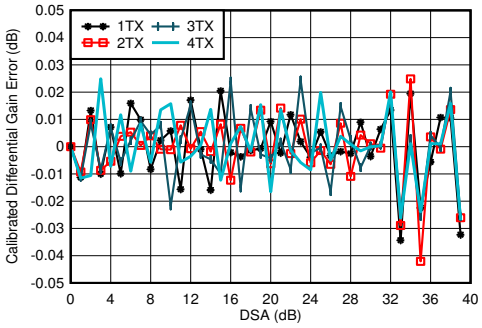
f_{DAC}=8847.36MSPS, straight mode, matching at 2.6 GHz

Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-358. TX Uncalibrated Differential Gain Error vs DSA Setting and Channel at 2.6 GHz

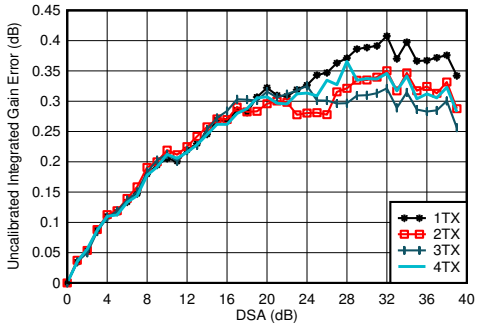
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



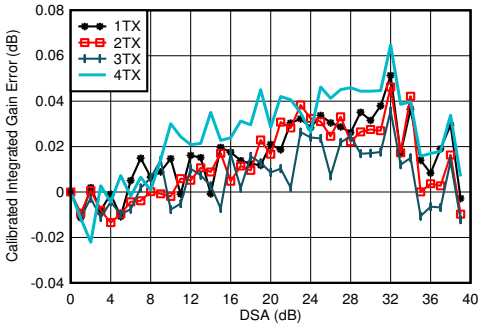
f_{DAC}=8847.36MSPS, straight mode, matching at 2.6 GHz
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-359. TX Calibrated Differential Gain Error vs DSA Setting and Channel at 2.6 GHz



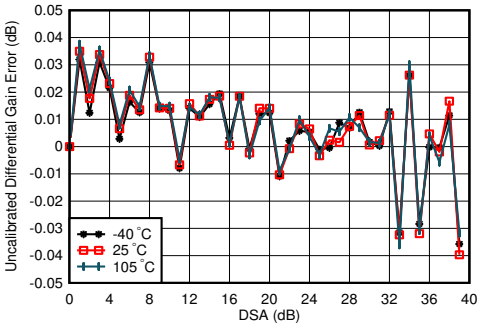
f_{DAC}=8847.36MSPS, straight mode, matching at 2.6 GHz
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-360. TX Uncalibrated Integrated Gain Error vs DSA Setting and Channel at 2.6 GHz



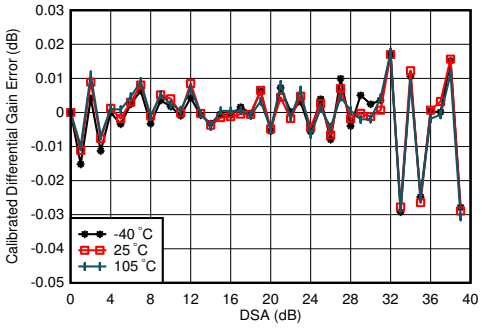
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-361. TX Calibrated Integrated Gain Error vs DSA Setting and Channel at 2.6 GHz



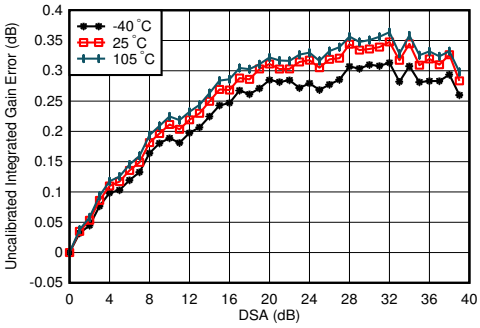
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-362. TX Uncalibrated Differential Gain Error vs DSA Setting and Temperature at 2.6 GHz



f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-363. TX Calibrated Differential Gain Error vs DSA Setting and Temperature at 2.6 GHz



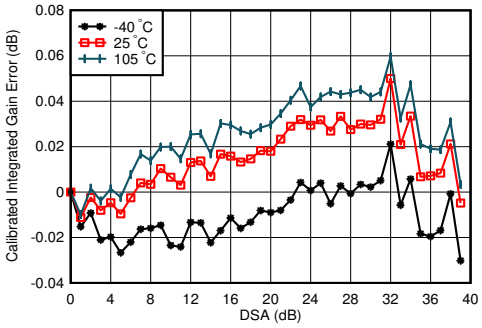
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-364. TX Uncalibrated Integrated Gain Error vs DSA Setting and Temperature at 2.6 GHz

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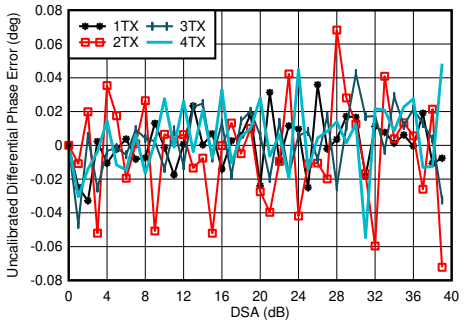
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



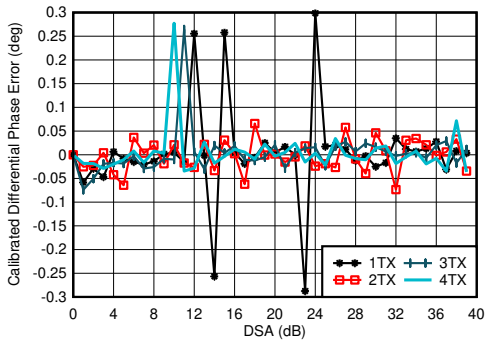
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-365. TX Calibrated Integrated Gain Error vs DSA Setting and Temperature at 2.6 GHz



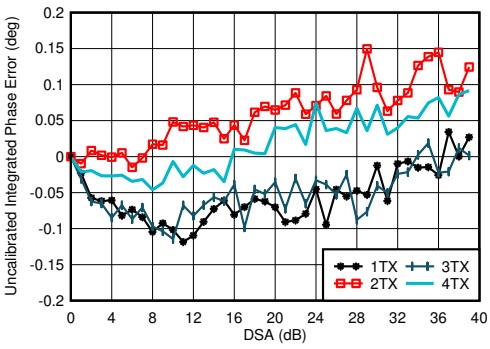
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-366. TX Uncalibrated Differential Phase Error vs DSA Setting and Channel at 2.6 GHz



f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)
Phase DNL spike may occur at any DSA setting.

图 5-367. TX Calibrated Differential Phase Error vs DSA Setting and Channel at 2.6 GHz

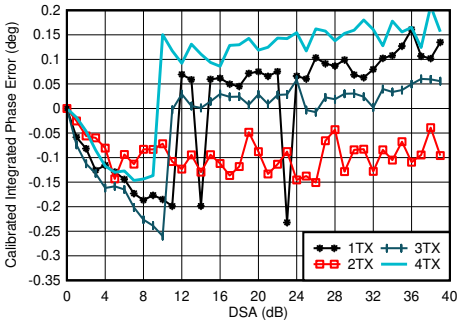


f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-368. TX Uncalibrated Integrated Phase Error vs DSA Setting and Channel at 2.6 GHz

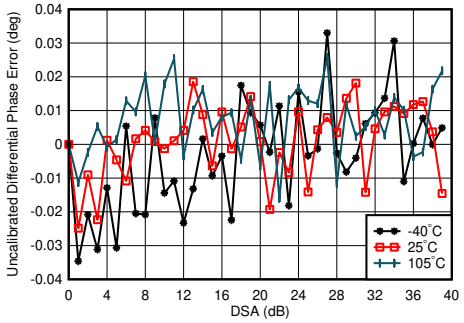
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



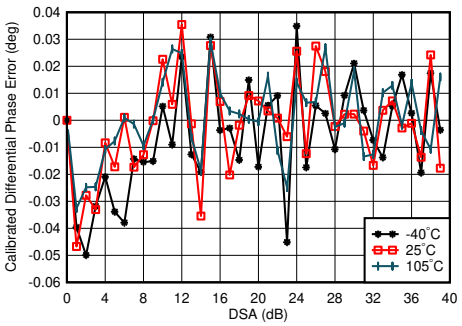
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-369. TX Calibrated Integrated Phase Error vs DSA Setting and Channel at 2.6 GHz



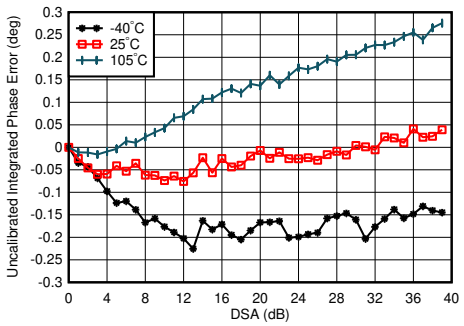
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-370. TX Uncalibrated Differential Phase Error vs DSA Setting and Temperature at 2.6 GHz



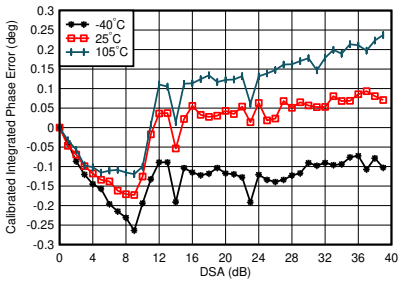
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-371. TX Calibrated Differential Phase Error vs DSA Setting and Temperature at 2.6 GHz



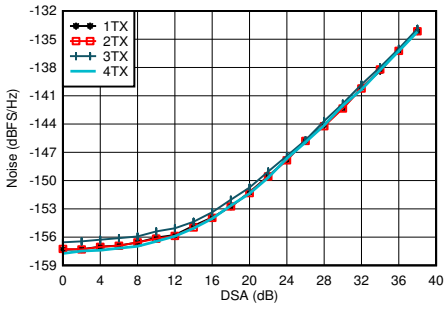
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the medium variation over DSA setting at 25°C
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-372. TX Uncalibrated Integrated Phase Error vs DSA Setting and Temperature at 2.6 GHz



f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, channel with the median variation over DSA setting at 25°C
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-373. TX Calibrated Integrated Phase Error vs DSA Setting and Temperature at 2.6 GHz



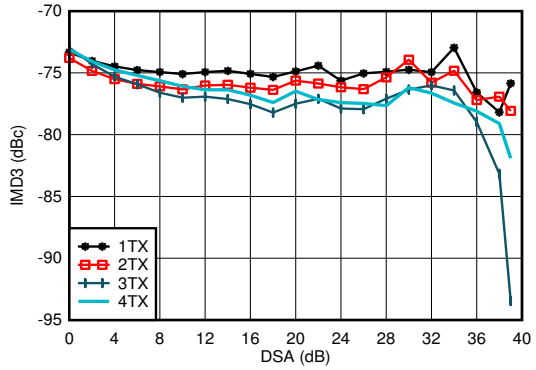
f_{DAC} = 8847.36MSPS, straight mode, matching at 2.6 GHz, P_{OUT} = – 13 dBFS

图 5-374. TX Output Noise vs Channel and Attenuation at 2.6 GHz

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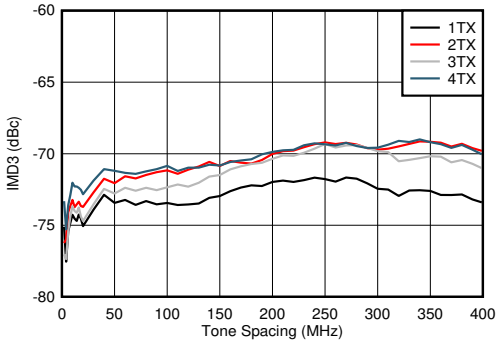
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



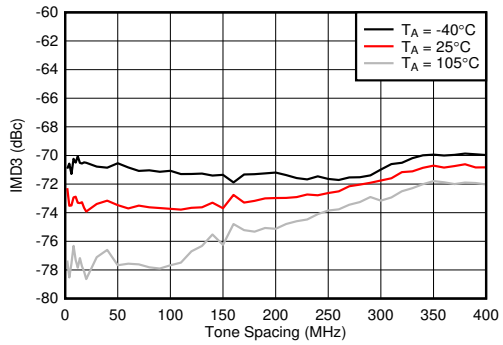
f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 2.6 GHz, matching at 2.6 GHz, – 13 dBFS each tone

图 5-375. TX IMD3 vs DSA Setting at 2.6 GHz



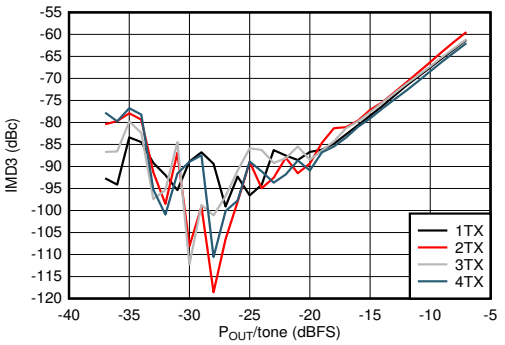
f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 2.6 GHz, matching at 2.6 GHz, – 13 dBFS each tone

图 5-376. TX IMD3 vs Tone Spacing and Channel at 2.6 GHz



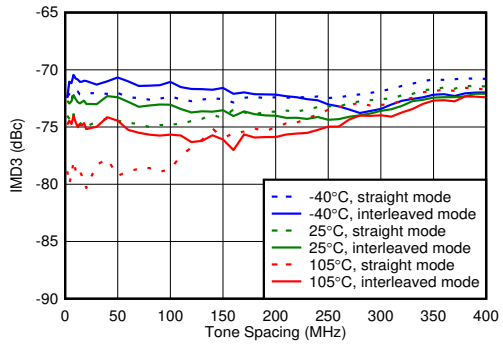
f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 2.6 GHz, matching at 2.6 GHz, – 13 dBFS each tone, worst channel.

图 5-377. TX IMD3 vs Tone Spacing and Temperature at 2.6 GHz



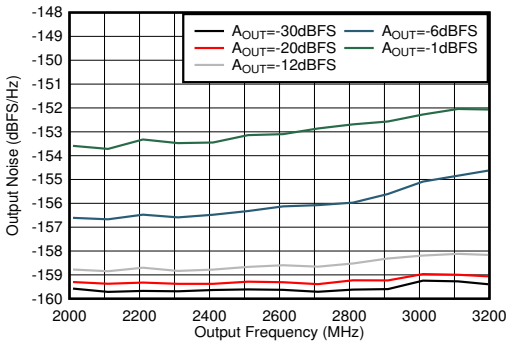
f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 2.6 GHz, $f_{SPACING}$ = 20 MHz, matching at 2.6 GHz

图 5-378. TX IMD3 vs Digital Level at 2.6 GHz



f_{DAC} = 8847.36MSPS, straight mode, f_{CENTER} = 2.6 GHz, matching at 2.6 GHz, – 13 dBFS each tone

图 5-379. TX IMD3 vs Tone Spacing and Temperature



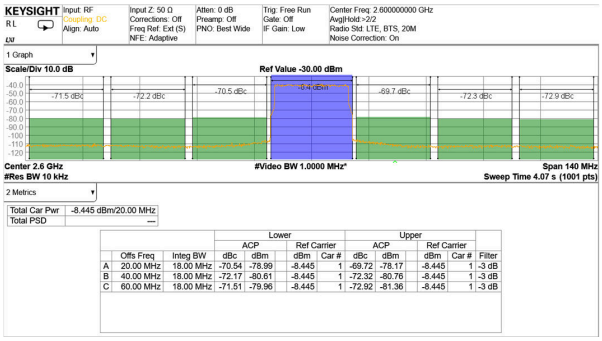
Matching at 2.6 GHz, Single tone, f_{DAC} = 11.79648GSPS, interleave mode, 40-MHz offset

图 5-380. TX Single Tone Output Noise vs Frequency and Amplitude at 2.6 GHz

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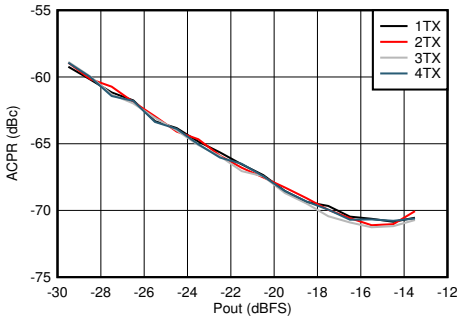
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



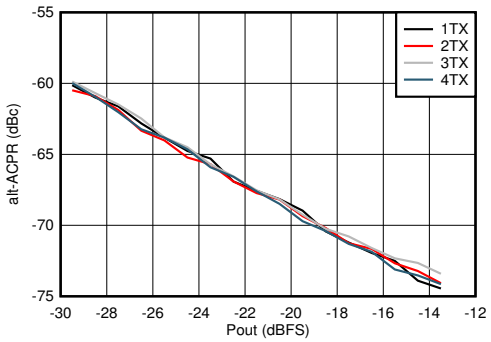
TM1.1, P_{OUT_RMS} = – 13 dBFS

图 5-381. TX 20-MHz LTE Output Spectrum at 2.6 GHz (Band 41)



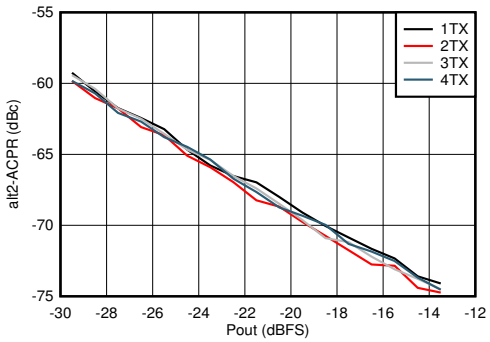
Matching at 2.6 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-382. TX 20-MHz LTE ACPR vs Digital Level at 2.6 GHz



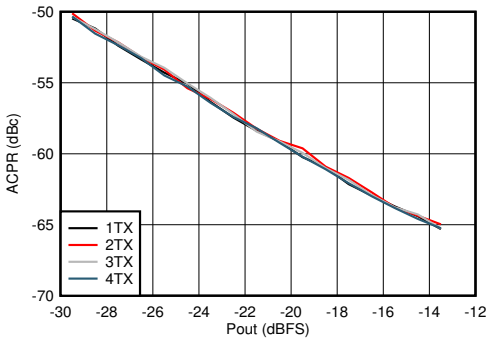
Matching at 2.6 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-383. TX 20-MHz LTE alt-ACPR vs Digital Level at 2.6 GHz



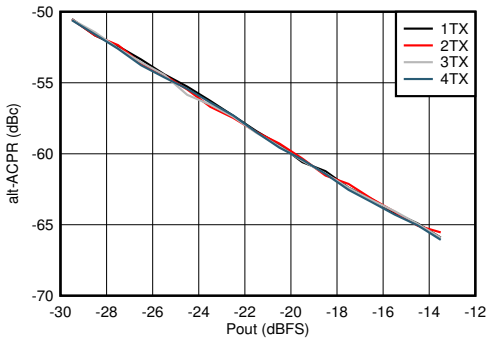
Matching at 2.6 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-384. TX 20-MHz LTE alt2-ACPR vs Digital Level at 2.6 GHz



Matching at 2.6 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-385. TX 100-MHz NR ACPR vs Digital Level at 2.6 GHz



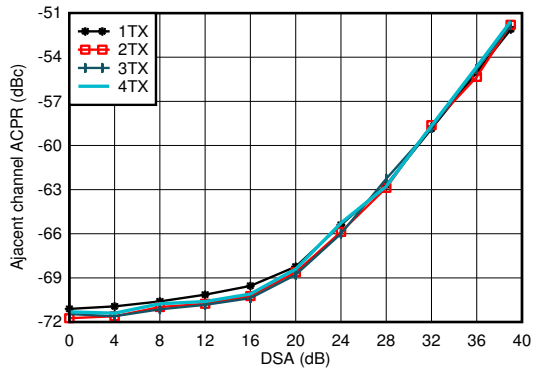
Matching at 2.6 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-386. TX 100-MHz NR alt-ACPR vs Digital Level at 2.6 GHz

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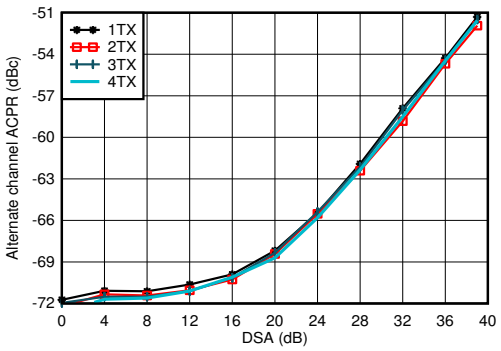
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



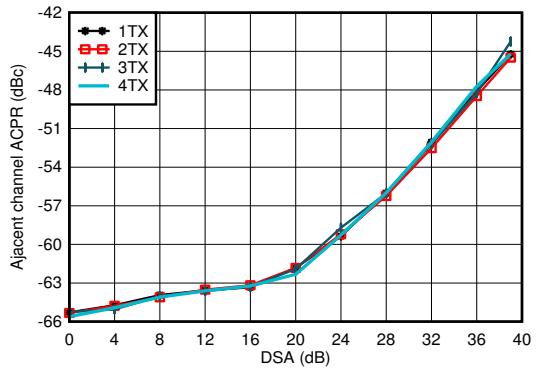
Matching at 2.6 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-387. TX 20-MHz LTE ACPR vs DSA at 2.6 GHz



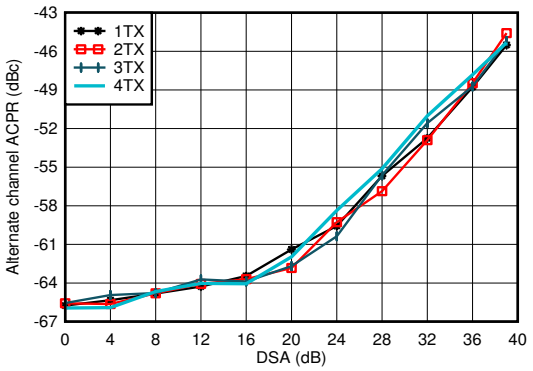
Matching at 2.6 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-388. TX 20-MHz LTE alt-ACPR vs DSA at 2.6 GHz



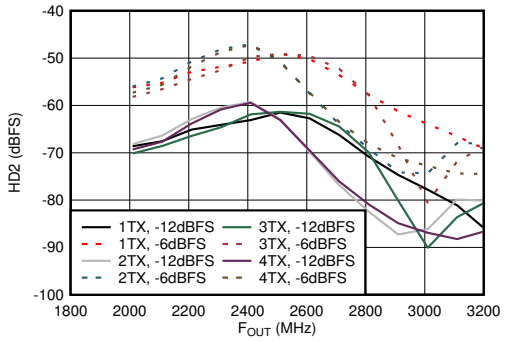
Matching at 2.6 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-389. TX 100-MHz NR ACPR vs DSA at 2.6 GHz



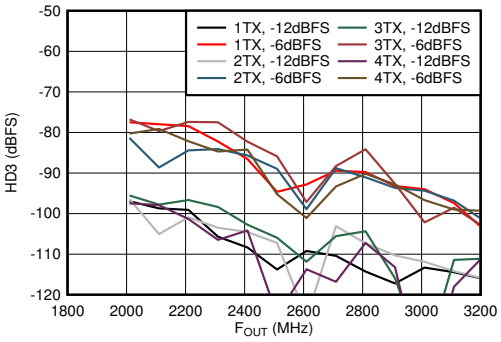
Matching at 2.6 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-390. TX 100-MHz NR alt-ACPR vs DSA at 2.6 GHz



Matching at 2.6 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-391. TX HD2 vs Digital Amplitude and Output Frequency at 2.6 GHz



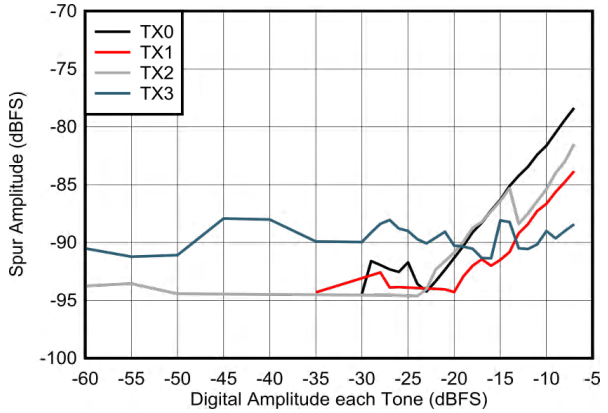
Matching at 2.6 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-392. TX HD3 vs Digital Amplitude and Output Frequency at 2.6 GHz

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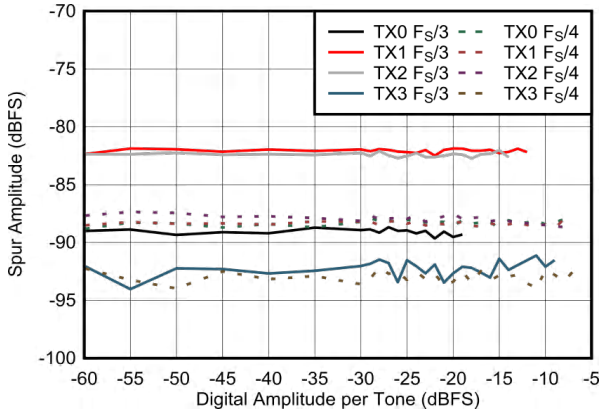
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



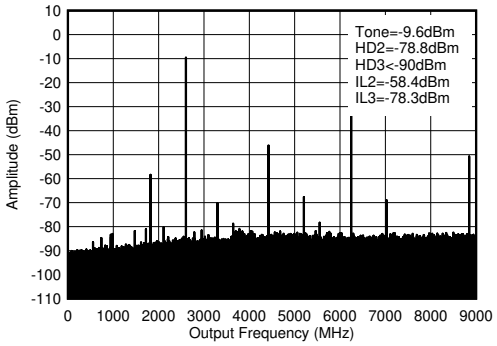
Inband = 2600MHz ± 600MHz, f_{DAC} = 12GSPS, not including F_S/3 and F_S/4, external clock mode, non-interleave mode

图 5-393. Two Tone Inband SFDR vs Digital Amplitude at 2.6 GHz



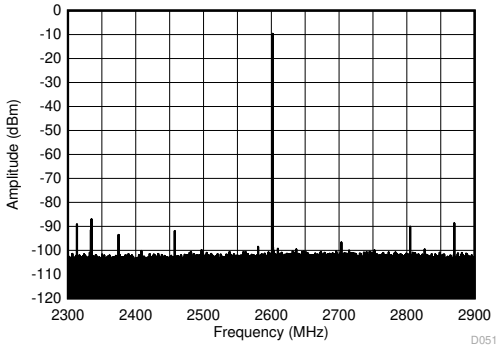
Inband = 2600MHz ± 600MHz, f_{DAC} = 12GSPS, external clock mode, non-interleave mode

图 5-394. Two Tone Inband Fixed Spurs vs Digital Amplitude at 2.6 GHz



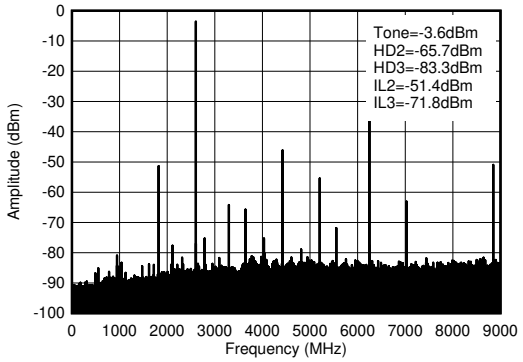
f_{DAC} = 8847.36MSPS, interleave mode, 2.6 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-395. TX Single Tone (– 12 dBFS) Output Spectrum at 2.6 GHz (0-f_{DAC})



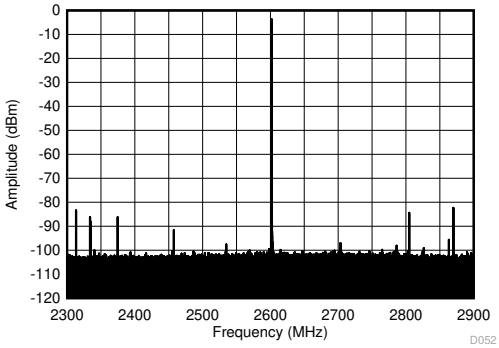
f_{DAC} = 8847.36MSPS, interleave mode, 2.6 GHz matching, includes PCB and cable losses

图 5-396. TX Single Tone (– 12 dBFS) Output Spectrum at 2.6 GHz (±300 MHz)



f_{DAC} = 8847.36MSPS, interleave mode, 2.6 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-397. TX Single Tone (– 6 dBFS) Output Spectrum at 2.6 GHz (0-f_{DAC})



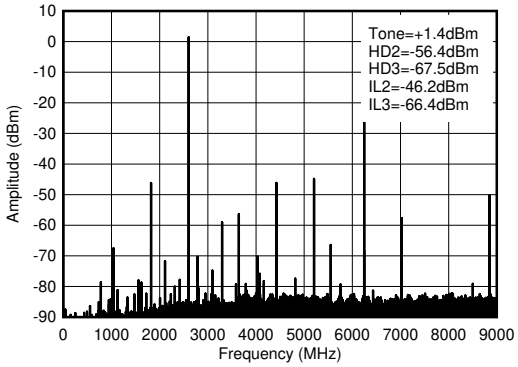
f_{DAC} = 8847.36MSPS, interleave mode, 2.6 GHz matching, includes PCB and cable losses

图 5-398. TX Single Tone (– 6 dBFS) Output Spectrum at 2.6 GHz (±300 MHz)

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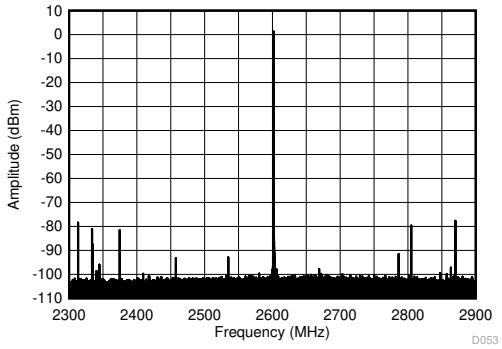
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



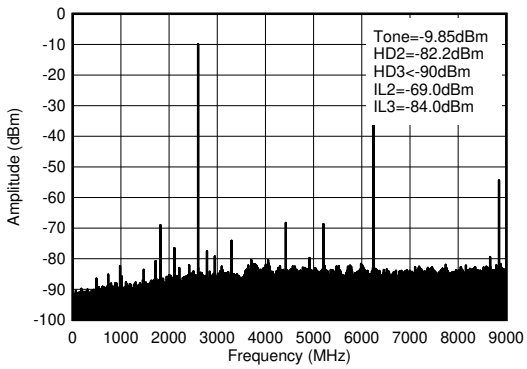
f_{DAC} = 8847.36MSPS, interleave mode, 2.6 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-399. TX Single Tone (– 1 dBFS) Output Spectrum at 2.6 GHz (0-f_{DAC})



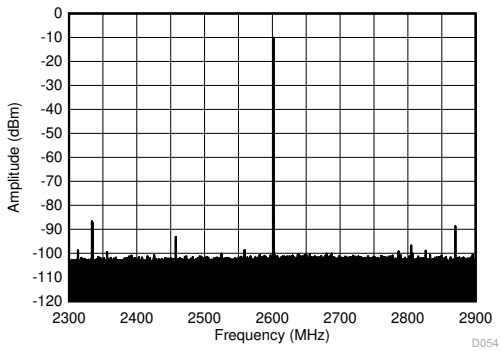
f_{DAC} = 8847.36MSPS, interleave mode, 2.6 GHz matching, includes PCB and cable losses

图 5-400. TX Single Tone (– 1 dBFS) Output Spectrum at 2.6 GHz (±300 MHz)



f_{DAC} = 8847.36MSPS, straight mode, 2.6 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-401. TX Single Tone (– 12 dBFS) Output Spectrum at 2.6 GHz (0-f_{DAC})



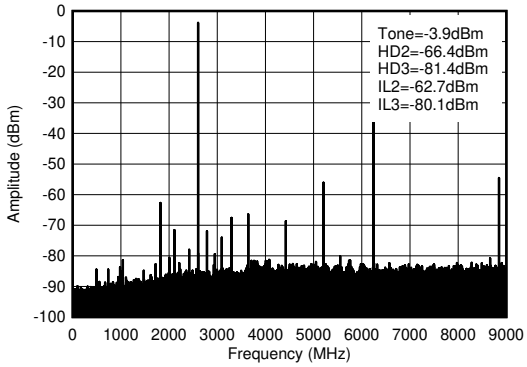
f_{DAC} = 8847.36MSPS, straight mode, 2.6 GHz matching, includes PCB and cable losses

图 5-402. TX Single Tone (– 12 dBFS) Output Spectrum at 2.6 GHz (±300 MHz)

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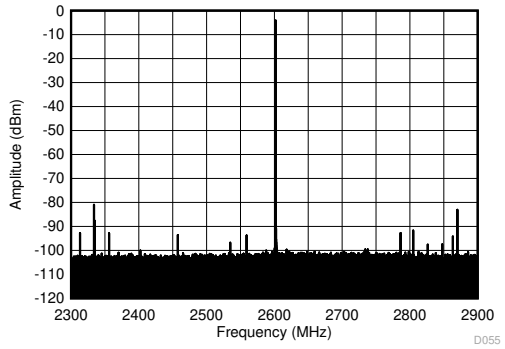
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



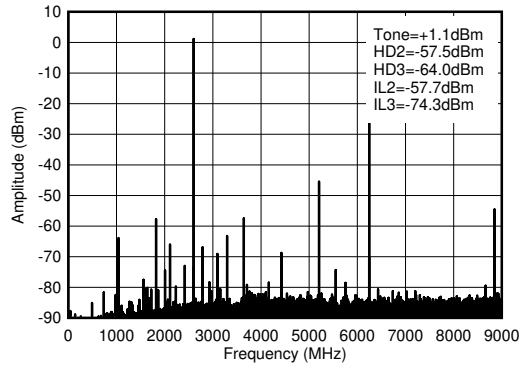
f_{DAC} = 8847.36MSPS, straight mode, 2.6 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-403. TX Single Tone (– 6 dBFS) Output Spectrum at 2.6 GHz (0-f_{DAC})



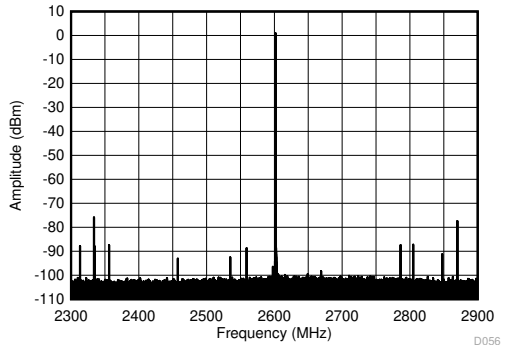
f_{DAC} = 8847.36MSPS, straight mode, 2.6 GHz matching, includes PCB and cable losses

图 5-404. TX Single Tone (– 6 dBFS) Output Spectrum at 2.6 GHz (±300 MHz)



f_{DAC} = 8847.36MSPS, straight mode, 2.6 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$ and is due to mixing with digital clocks.

图 5-405. TX Single Tone (– 1 dBFS) Output Spectrum at 2.6 GHz (0-f_{DAC})



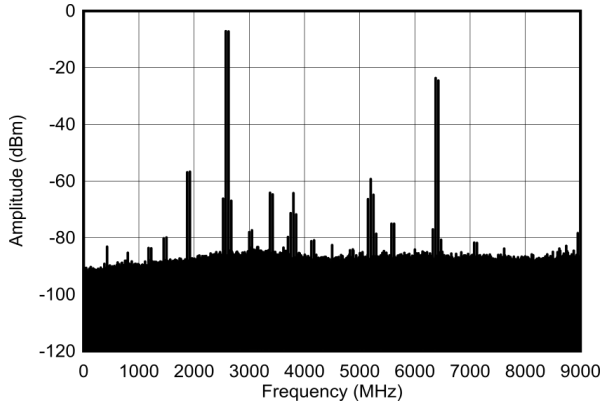
f_{DAC} = 8847.36MSPS, straight mode, 2.6 GHz matching, includes PCB and cable losses

图 5-406. TX Single Tone (– 1 dBFS) Output Spectrum at 2.6 GHz (±300 MHz)

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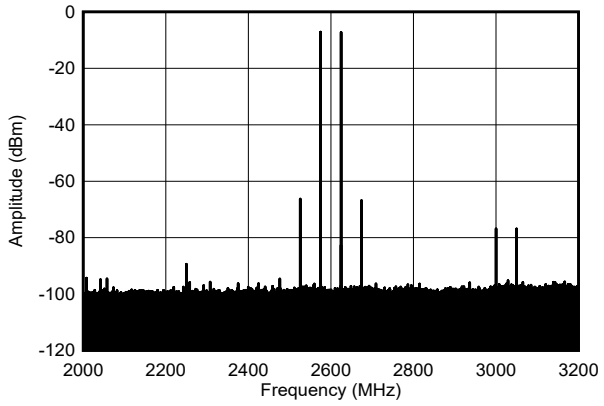
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



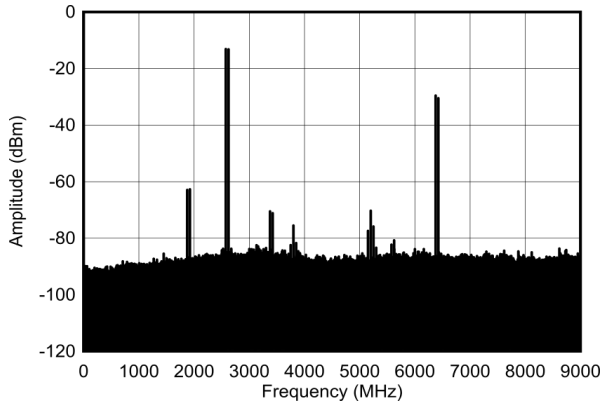
f_{DAC} = 9000MSPS, external clock mode, non-interleave mode

图 5-407. TX Dual Tone Output Spectrum at 2.6 GHz, -7dBFS each (0 - $_{DAC}$)



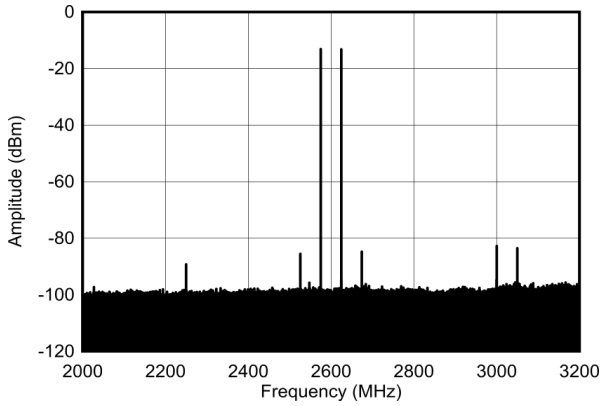
f_{DAC} = 9000MSPS, external clock mode, non-interleave mode

图 5-408. TX Dual Tone Output Spectrum at 2.6 GHz, -7dBFS each (±600 MHz)



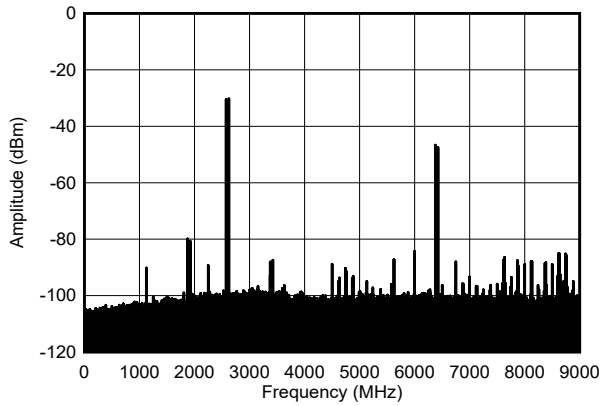
f_{DAC} = 9000MSPS, external clock mode, non-interleave mode

图 5-409. TX Dual Tone Output Spectrum at 2.6 GHz, -13dBFS each (0 - $_{DAC}$)



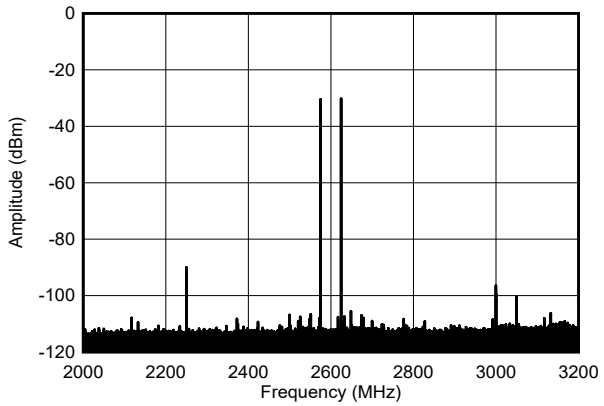
f_{DAC} = 9000MSPS, external clock mode, non-interleave mode

图 5-410. TX Dual Tone Output Spectrum at 2.6 GHz, -13dBFS each (±600 MHz)



f_{DAC} = 9000MSPS, external clock mode, non-interleave mode

图 5-411. TX Dual Tone Output Spectrum at 2.6 GHz, -30dBFS each (0 - $_{DAC}$)



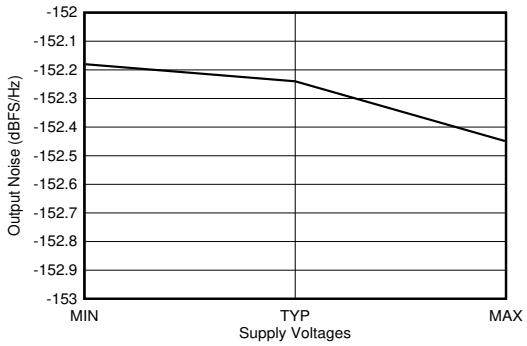
f_{DAC} = 9000MSPS, external clock mode, non-interleave mode

图 5-412. TX Dual Tone Output Spectrum at 2.6 GHz, -30dBFS each (±600 MHz)

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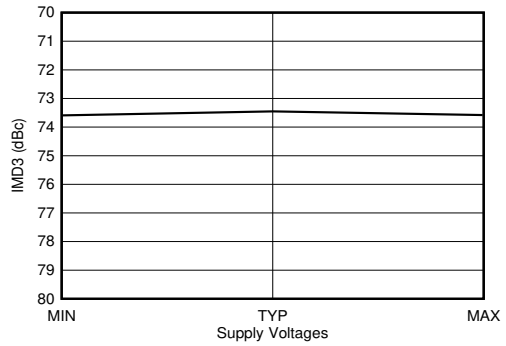
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



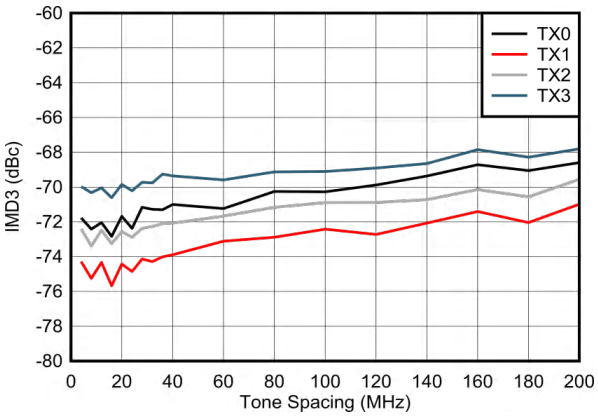
f_{DAC} = 11796.48MSPS, interleave mode, 2.6 GHz matching. 40-MHz offset from tone. Output Power = – 1 dBFS. All supplies simultaneously at MIN, TYP, or MAX voltages.

图 5-413. TX Output Noise vs Supply Voltage at 2.6 GHz



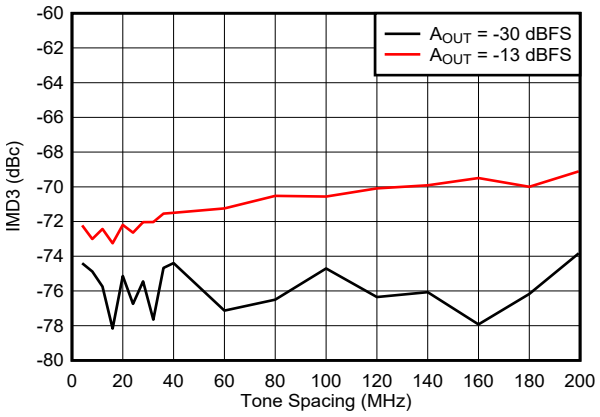
f_{DAC} = 11796.48MSPS, interleave mode, 2.6 GHz matching. 40-MHz offset from tone. Output Power = – 13 dBFS. All supplies simultaneously at MIN, TYP, or MAX voltages.

图 5-414. TX IMD3 vs Supply Voltage at 2.6 GHz



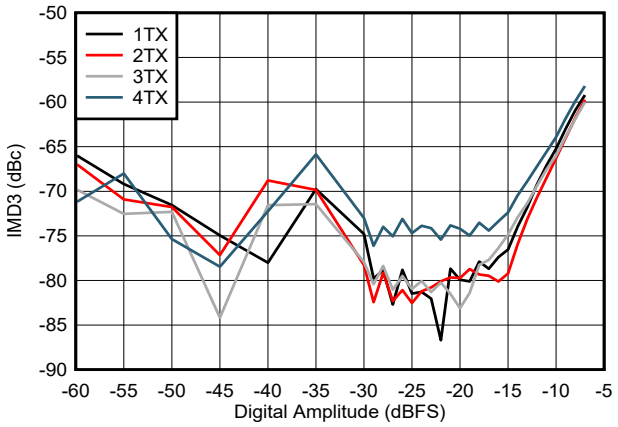
f_{DAC} = 9000MSPS, non-interleave mode, external clock mode

图 5-415. IMD3 vs Tone Spacing and Channel at 2.6 GHz



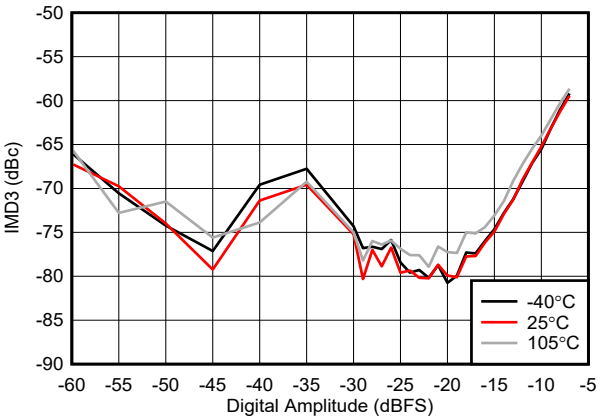
f_{DAC} = 9000MSPS, non-interleave mode, external clock mode

图 5-416. IMD3 vs Tone Spacing and Amplitude at 2.6 GHz



f_{DAC} = 9000MSPS, non-interleave mode, external clock mode

图 5-417. IMD3 vs Digital Amplitude and Channel at 2.6 GHz



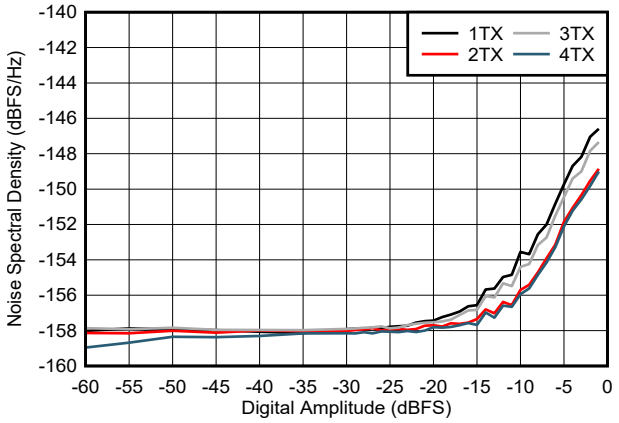
f_{DAC} = 9000MSPS, non-interleave mode, external clock mode

图 5-418. IMD3 vs Digital Amplitude and Temperature at 2.6 GHz

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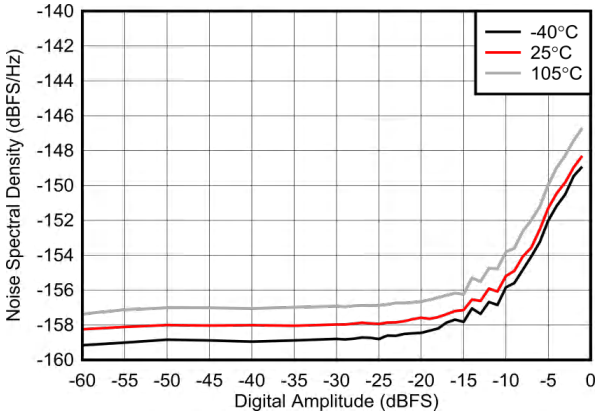
5.12.10 TX Typical Characteristics at 2.6GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



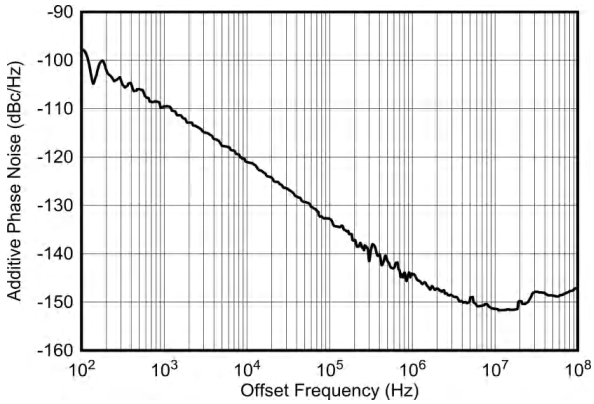
f_{DAC} = 9000MSPS, non-interleave mode, external clock mode, 50MHz offset

图 5-419. NSD vs Digital Amplitude and Channel at 2.6 GHz



f_{DAC} = 9000MSPS, non-interleave mode, external clock mode, 50MHz offset

图 5-420. NSD vs Digital Amplitude and Temperature at 2.6 GHz

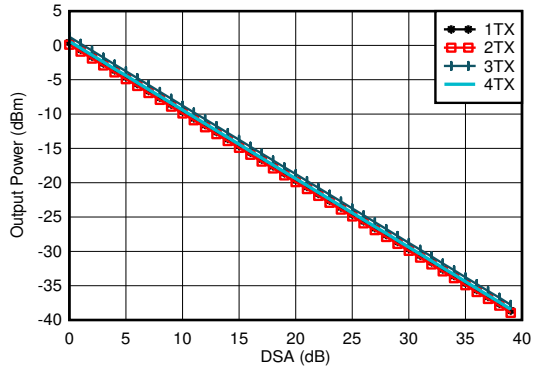


f_{DAC} = f_{CLK} = 9000MSPS, non-interleave mode

图 5-421. External Clock Additive Phase Noise at 2.6 GHz

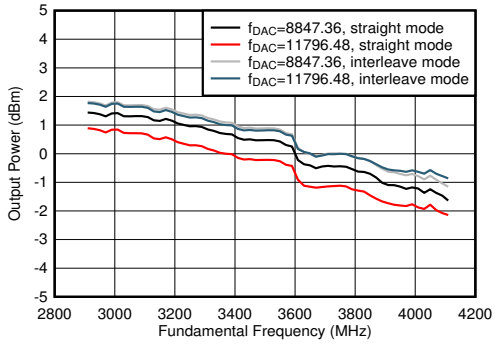
5.12.11 TX Typical Characteristics at 3.5GHz

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



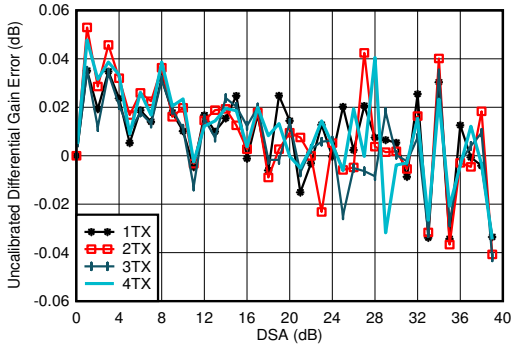
A_{out} = -0.5dFBS, 3.5 GHz Matching, included PCB and cable losses

图 5-422. TX Output Power vs DSA Setting at 3.5 GHz



A_{out} = -0.5dFBS, 3.5 GHz Matching, included PCB and cable losses

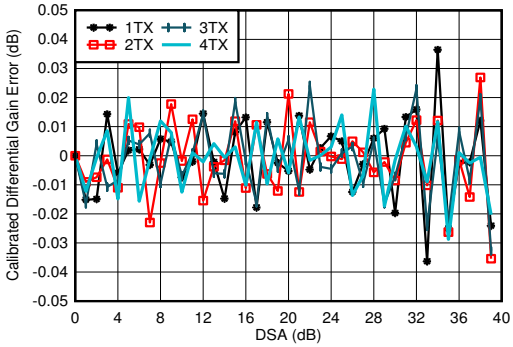
图 5-423. TX Output Power vs Frequency



3.5 GHz Matching, included PCB and cable losses

Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

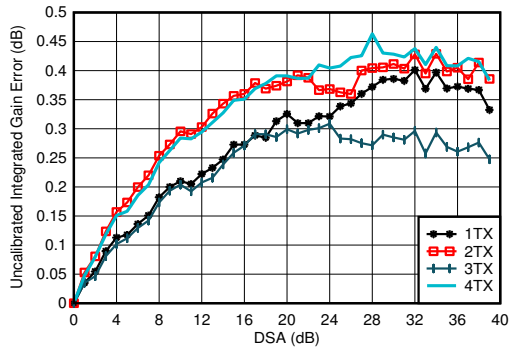
图 5-424. TX Uncalibrated Differential Gain Error vs DSA Setting and Channel at 3.5 GHz



3.5 GHz Matching, included PCB and cable losses

Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

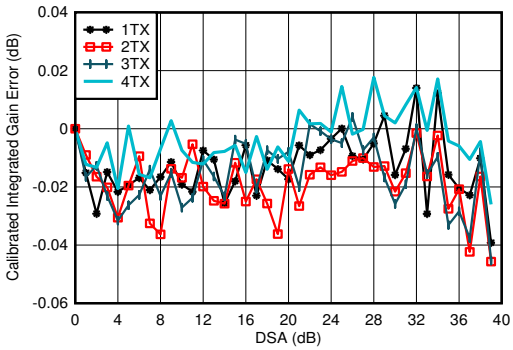
图 5-425. TX Calibrated Differential Gain Error vs DSA Setting and Channel at 3.5 GHz



3.5 GHz Matching, included PCB and cable losses

Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-426. TX Uncalibrated Integrated Gain Error vs DSA Setting and Channel at 3.5 GHz



3.5 GHz Matching, included PCB and cable losses

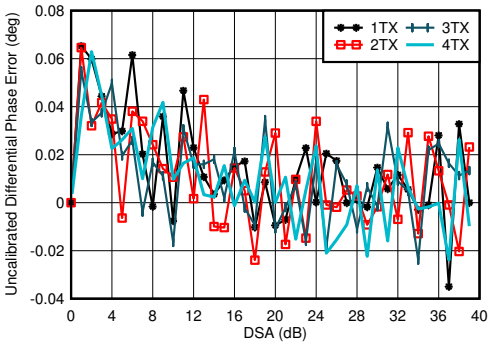
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-427. TX Calibrated Integrated Gain Error vs DSA Setting and Channel at 3.5 GHz

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5.12.11 TX Typical Characteristics at 3.5GHz (continued)

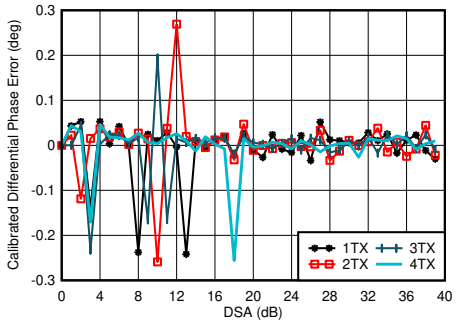
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



3.5 GHz Matching, included PCB and cable losses

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

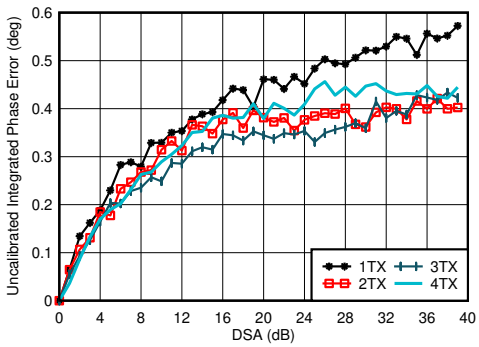
图 5-428. TX Uncalibrated Differential Phase Error vs DSA Setting and Channel at 3.5 GHz



3.5 GHz Matching, included PCB and cable losses

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting). Phase DNL spike may occur at any DSA setting.

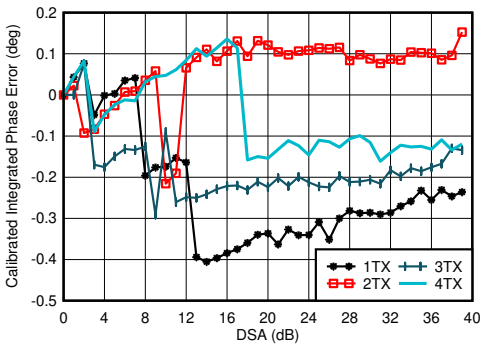
图 5-429. TX Calibrated Differential Phase Error vs DSA Setting and Channel at 3.5 GHz



3.5 GHz Matching, included PCB and cable losses

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-430. TX Uncalibrated Integrated Phase Error vs DSA Setting and Channel at 3.5 GHz



3.5 GHz Matching, included PCB and cable losses

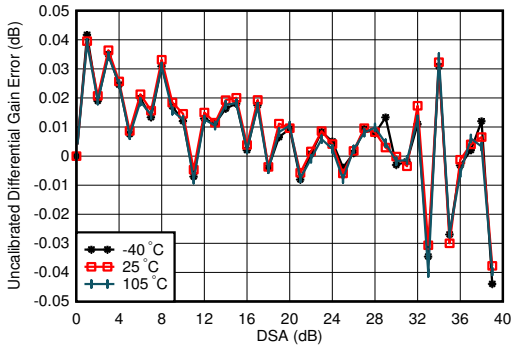
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-431. TX Calibrated Integrated Phase Error vs DSA Setting and Channel at 3.5 GHz

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5.12.11 TX Typical Characteristics at 3.5GHz (continued)

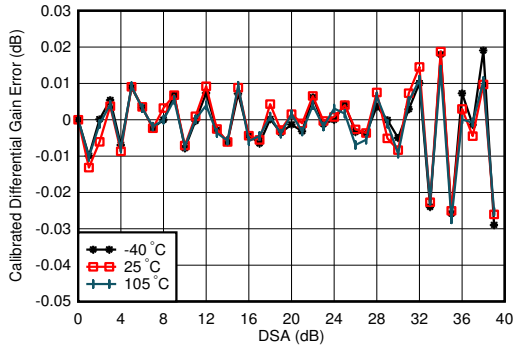
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



3.5 GHz Matching, 1TX

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

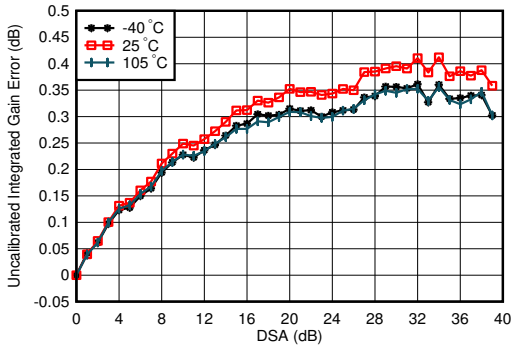
图 5-432. TX Uncalibrated Differential Gain Error vs DSA Setting and Temperature at 3.5 GHz



3.5 GHz Matching, 1TX, Calibrated at 25°C

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

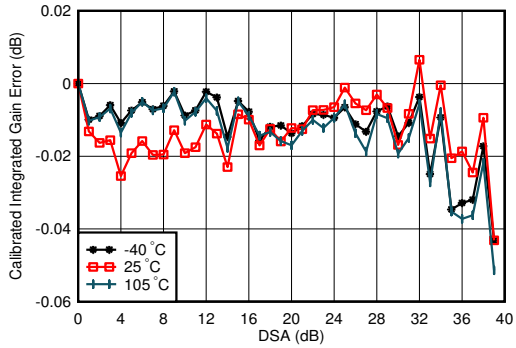
图 5-433. TX Calibrated Differential Gain Error vs DSA Setting and Temperature at 3.5 GHz



3.5 GHz Matching, 1TX

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-434. TX Uncalibrated Integrated Gain Error vs DSA Setting and Temperature at 3.5 GHz



3.5 GHz Matching, 1TX, Calibrated at 25°C

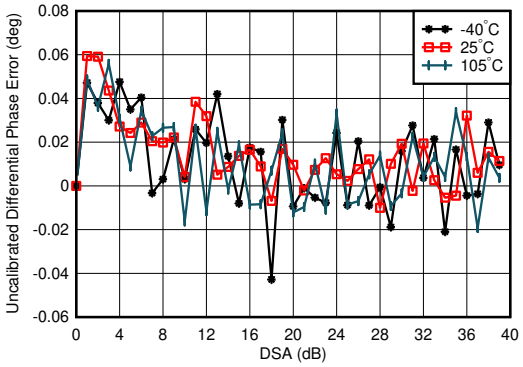
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-435. TX Calibrated Integrated Gain Error vs DSA Setting and Temperature at 3.5 GHz

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5.12.11 TX Typical Characteristics at 3.5GHz (continued)

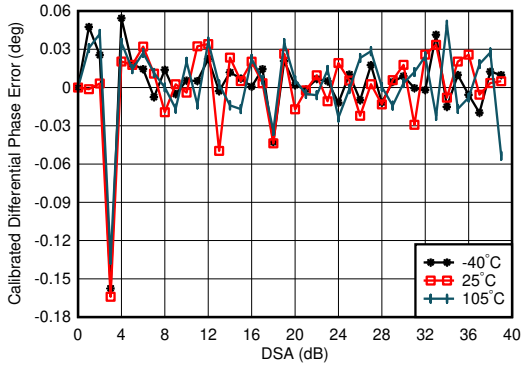
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



3.5 GHz Matching, 1TX

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

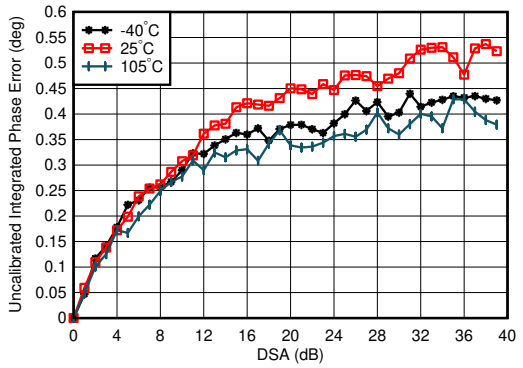
图 5-436. TX Uncalibrated Differential Phase Error vs DSA setting and Temperature at 3.5 GHz



3.5 GHz Matching, 1TX, Calibrated at 25°C

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

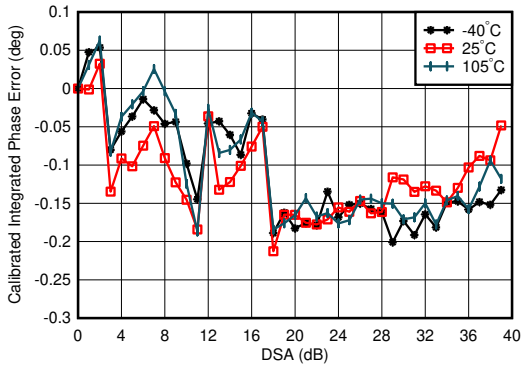
图 5-437. TX Calibrated Differential Phase Error vs DSA Setting and Temperature at 3.5 GHz



3.5 GHz Matching, 1TX

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting=0)

图 5-438. TX Uncalibrated Integrated Phase Error vs DSA Setting and Temperature at 3.5 GHz



3.5 GHz Matching, 1TX, Calibrated at 25°C

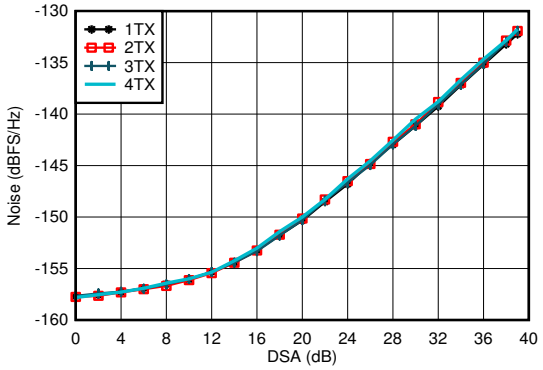
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-439. TX Calibrated Integrated Phase Error vs DSA Setting and Temperature at 3.5 GHz

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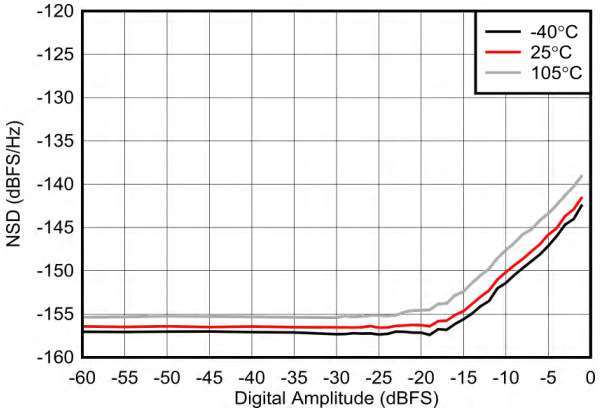
5.12.11 TX Typical Characteristics at 3.5GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



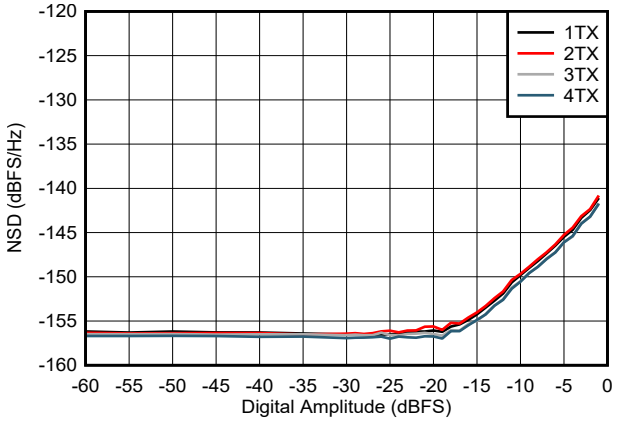
A. f_{DAC}=11796.48MSPS, interleave mode, matching at 3.5GHz, A_{out} = – 13 dBFS.

图 5-440. TX NSD vs DSA Setting at 3.5 GHz



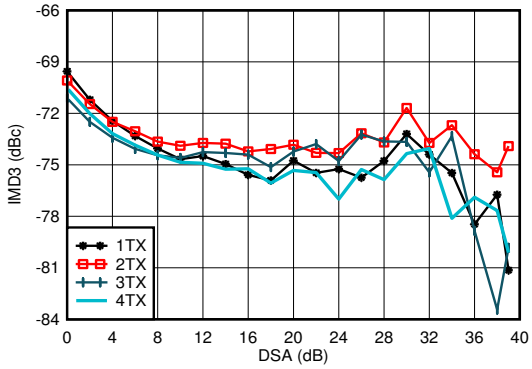
A. f_{DAC}=12MSPS, external clock mode, non-interleave mode

图 5-441. TX NSD vs Digital Amplitude and Temperature at 3.75 GHz



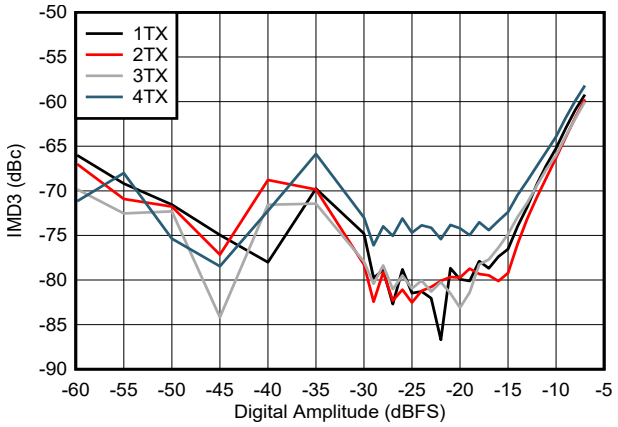
A. f_{DAC}=12MSPS, external clock mode, non-interleave mode

图 5-442. TX NSD vs Digital Amplitude and Channel at 3.75 GHz



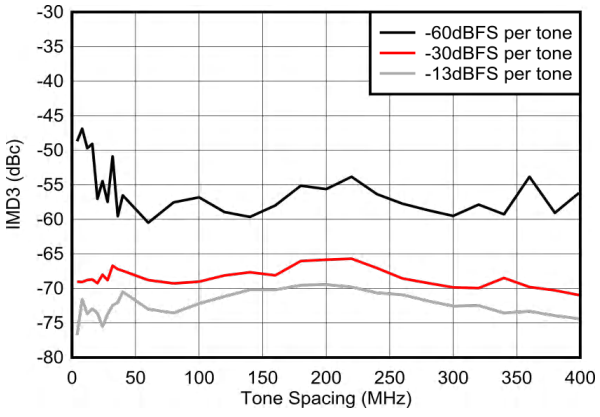
20-MHz tone spacing, 3.5 GHz Matching, – 13 dBFS each tone, included PCB and cable losses

图 5-443. TX IMD3 vs DSA Setting at 3.5 GHz



20-MHz tone spacing, 3.5 GHz Matching

图 5-444. TX IMD3 vs Digital Amplitude and Channel at 3.5 GHz



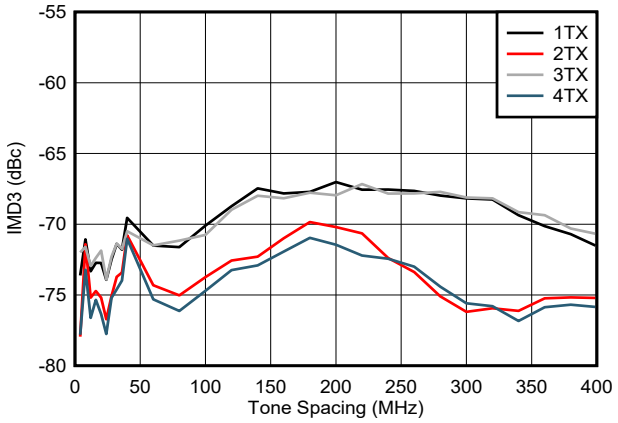
50-MHz tone spacing, external clock mode, non-interleave mode

图 5-445. TX IMD3 vs Tone Spacing and Amplitude at 3.75GHz

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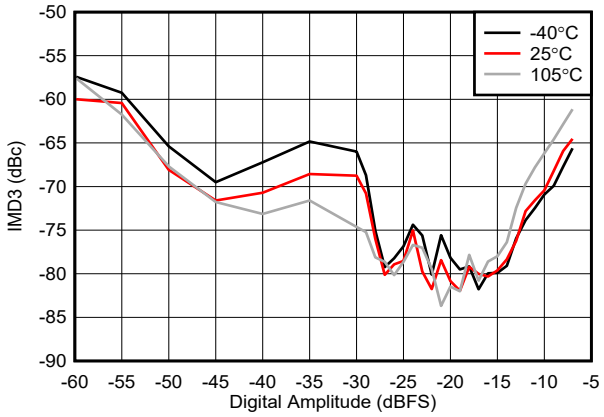
5.12.11 TX Typical Characteristics at 3.5GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



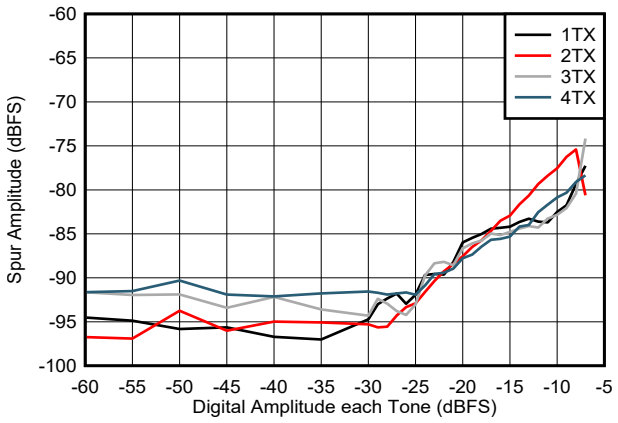
External clock mode, non-interleave mode

图 5-446. TX IMD3 vs Tone Spacing and Channel at 3.75GHz



50-MHz tone spacing, external clock mode, non-interleave mode

图 5-447. TX IMD3 vs Digital Amplitude and Temperature at 3.75GHz



Inband = 3.75GHz ± 600MHz, f_{DAC} = 9GSPS, external clock mode, non-interleave mode.

图 5-448. Two Tone Inband SFDR vs Digital Amplitude at 3.75GHz

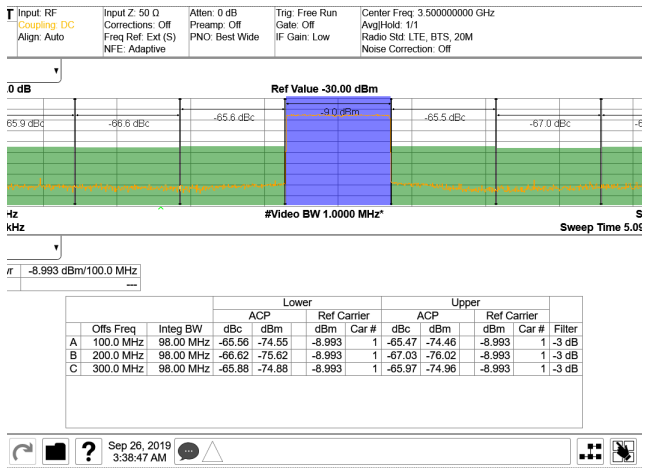


3.5 GHz Matching, single carrier 20-MHz BW TM1.1 LTE

图 5-449. TX 20-MHz LTE Output Spectrum at 3.5 GHz (Band 42)

5.12.11 TX Typical Characteristics at 3.5GHz (continued)

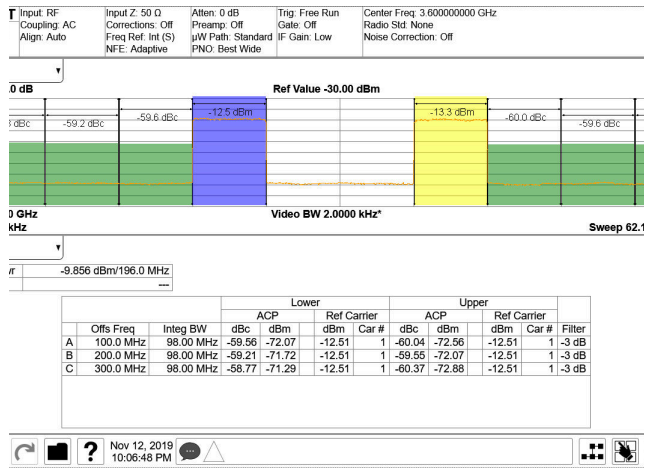
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



			Lower ACP		Lower Ref Carrier		Upper ACP		Upper Ref Carrier		
	Offs Freq	Integ BW	dBc	dBm	dBm	Car #	dBc	dBm	dBm	Car #	Filter
A	100.0 MHz	98.00 MHz	-65.56	-74.55	-8.993	1	-65.47	-74.46	-8.993	1	-3 dB
B	200.0 MHz	98.00 MHz	-66.62	-75.62	-8.993	1	-67.03	-76.02	-8.993	1	-3 dB
C	300.0 MHz	98.00 MHz	-65.88	-74.88	-8.993	1	-65.97	-74.96	-8.993	1	-3 dB

3.5 GHz Matching, single carrier 100-MHz BW NR TM1.1

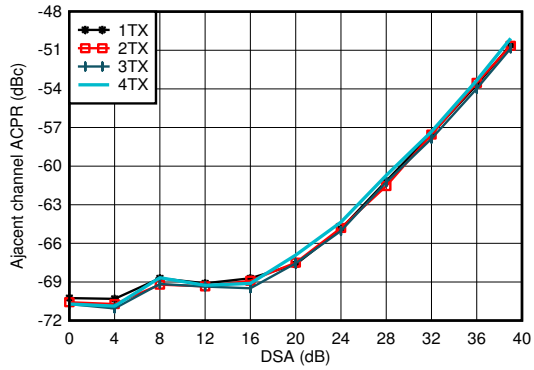
图 5-450. TX 100-MHz NR Output Spectrum at 3.5 GHz (Band 42)



			Lower ACP		Lower Ref Carrier		Upper ACP		Upper Ref Carrier		
	Offs Freq	Integ BW	dBc	dBm	dBm	Car #	dBc	dBm	dBm	Car #	Filter
A	100.0 MHz	98.00 MHz	-59.56	-72.07	-12.51	1	-60.04	-72.56	-12.51	1	-3 dB
B	200.0 MHz	98.00 MHz	-59.21	-71.72	-12.51	1	-59.55	-72.07	-12.51	1	-3 dB
C	300.0 MHz	98.00 MHz	-58.77	-71.29	-12.51	1	-60.37	-72.88	-12.51	1	-3 dB

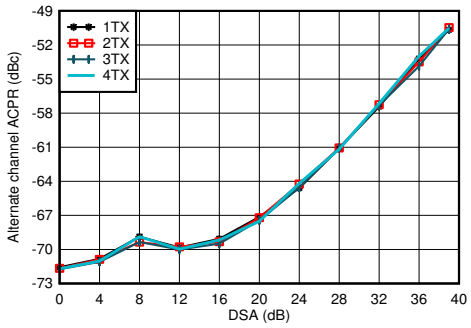
3.5 GHz Matching, single carrier 100-MHz BW NR TM1.1

图 5-451. TX 2 carrier 100-MHz NR Output Spectrum at 3.45 GHz and 3.75 GHz



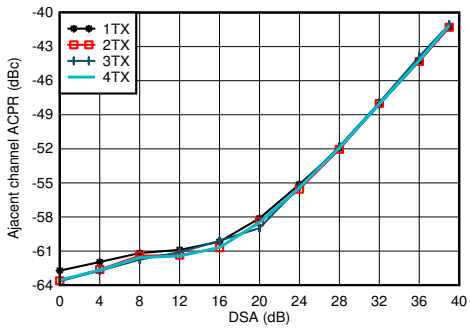
3.5 GHz Matching, single carrier 20-MHz BW TM1.1 LTE

图 5-452. TX 20-MHz LTE ACPR vs DSA Setting at 3.5 GHz



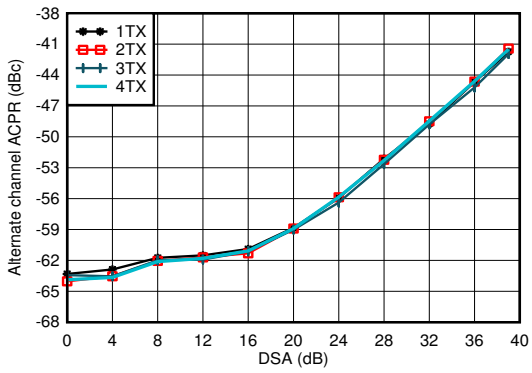
3.5 GHz Matching, single carrier 20-MHz BW TM1.1 LTE

图 5-453. TX 20-MHz LTE alt-ACPR vs DSA Setting at 3.5 GHz



3.5 GHz Matching, single carrier 100-MHz BW NR TM1.1

图 5-454. TX 100-MHz NR ACPR vs DSA Setting at 3.5 GHz



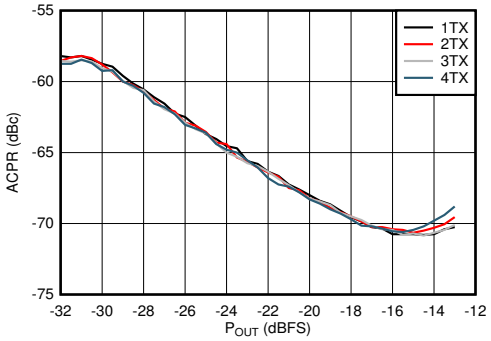
3.5 GHz Matching, single carrier 100-MHz BW NR TM1.1

图 5-455. TX 100-MHz NR alt-ACPR vs DSA Setting at 3.5 GHz

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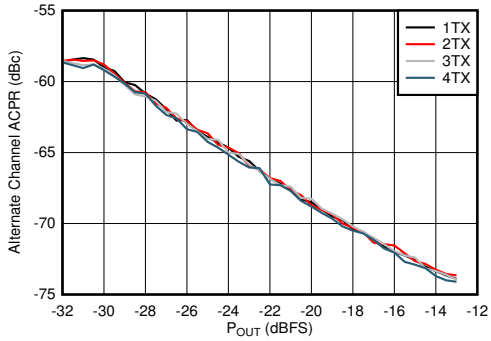
5.12.11 TX Typical Characteristics at 3.5GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



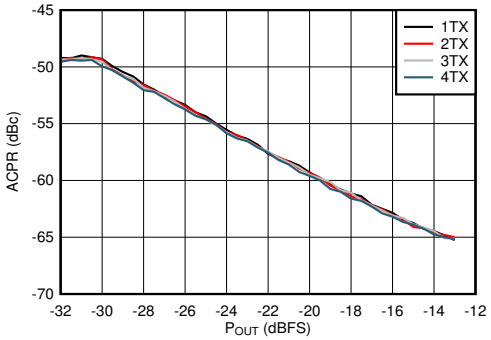
3.5 GHz Matching, single carrier 20-MHz BW TM1.1 LTE

图 5-456. TX 20-MHz LTE ACPR vs Digital Level at 3.5 GHz



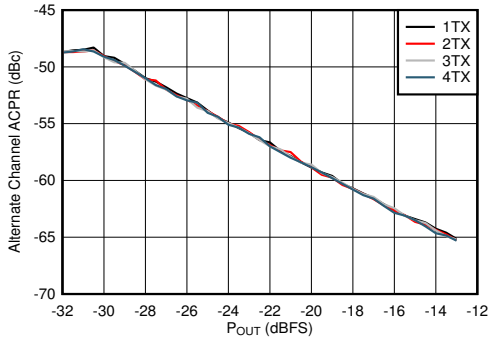
3.5 GHz Matching, single carrier 20-MHz BW TM1.1 LTE

图 5-457. TX 20-MHz LTE alt-ACPR vs Digital Level at 3.5 GHz



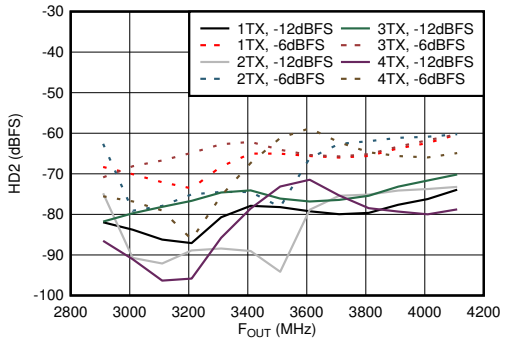
3.5 GHz Matching, single carrier 100-MHz BW NR TM1.1

图 5-458. TX 100-MHz NR ACPR vs Digital Level at 3.5 GHz



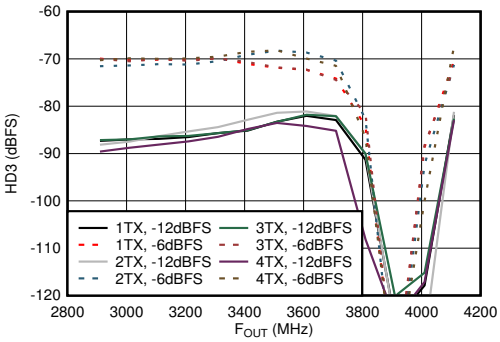
3.5 GHz Matching, single carrier 100-MHz BW NR TM1.1

图 5-459. TX 100-MHz NR alt-ACPR vs Digital Level at 3.5 GHz



Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-460. TX Single Tone HD2 vs Frequency and Digital Level at 3.5 GHz



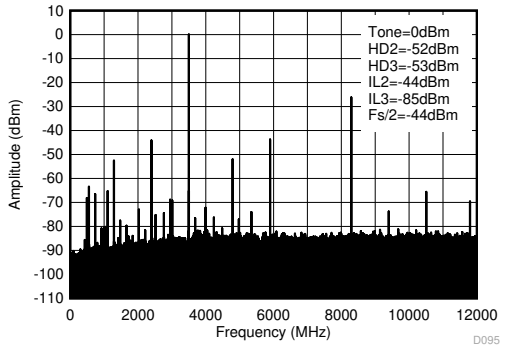
Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency. Dip is due to HD3 falling near DC.

图 5-461. TX Single Tone HD3 vs Frequency and Digital Level at 3.5 GHz

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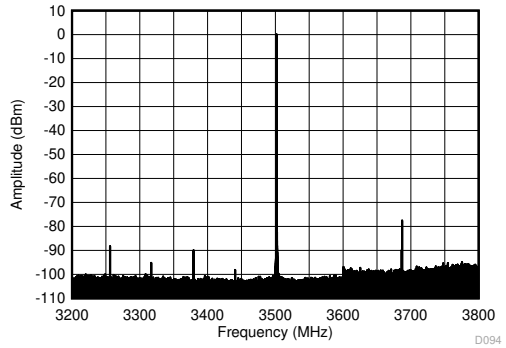
5.12.11 TX Typical Characteristics at 3.5GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



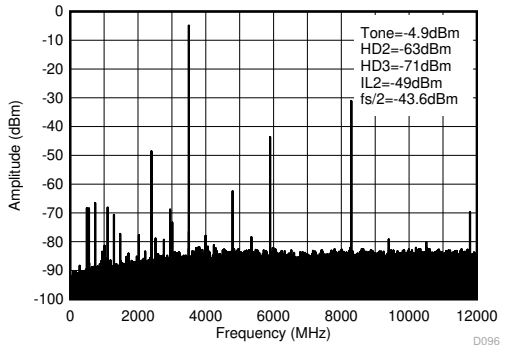
Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode.

图 5-462. TX Single Tone (– 1 dBFS) Output Spectrum at 3.5 GHz (0 - f_{DAC})



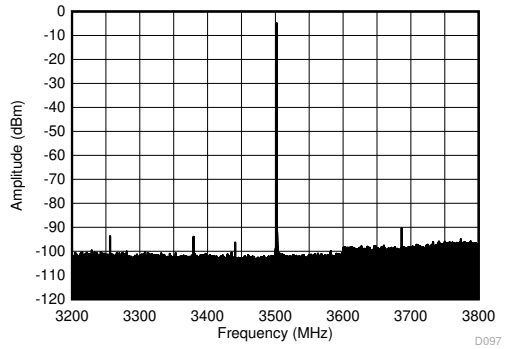
Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode.

图 5-463. TX Single Tone (– 1 dBFS) Output Spectrum at 3.5 GHz (±300 MHz)



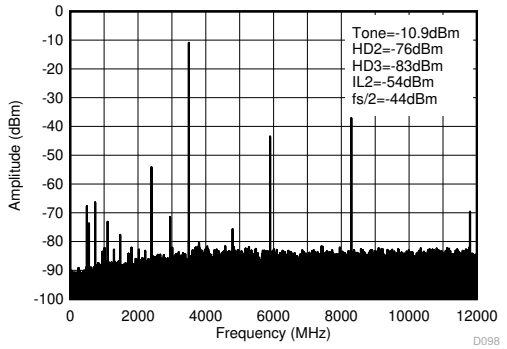
Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode.

图 5-464. TX Single Tone (– 6 dBFS) Output Spectrum at 3.5 GHz (0-f_{DAC})



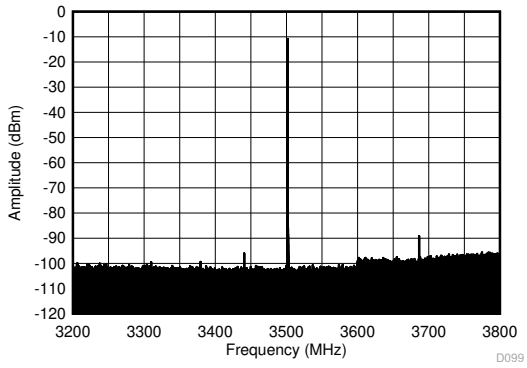
Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode.

图 5-465. TX Single Tone (– 6 dBFS) Output Spectrum at 3.5 GHz (±300 MHz)



Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode.

图 5-466. TX Single Tone (– 12 dBFS) Output Spectrum at 3.5 GHz (0-f_{DAC})



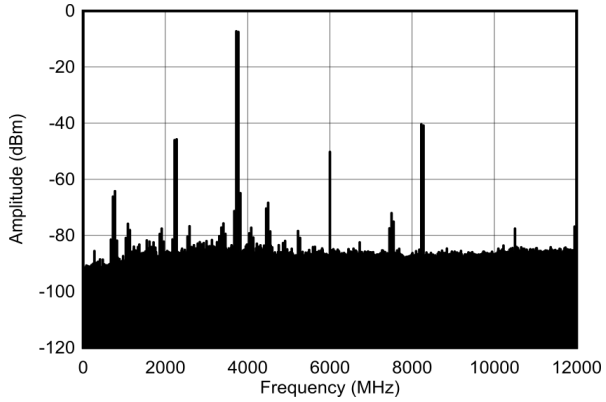
Matching at 3.5 GHz, f_{DAC} = 11.79648GSPS, interleave mode.

图 5-467. TX Single Tone (– 12 dBFS) Output Spectrum at 3.5 GHz (±300 MHz)

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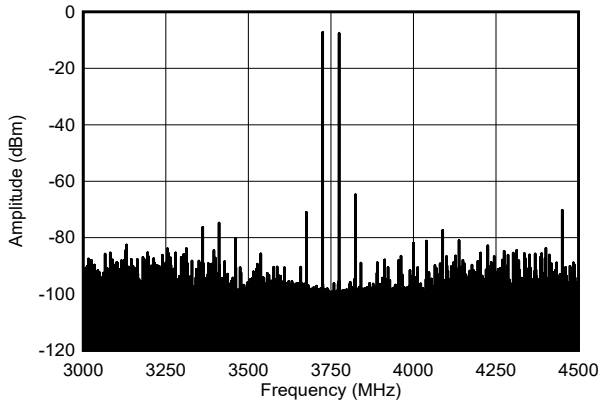
5.12.11 TX Typical Characteristics at 3.5GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



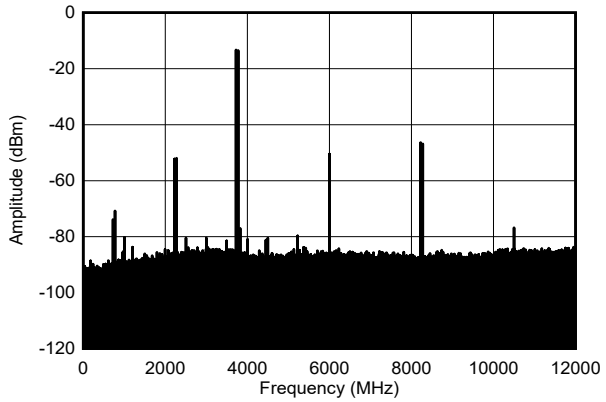
Matching at 3.5 GHz, 50MHz tone spacing, f_{DAC} = 12GSPS, non-interleave mode.

图 5-468. TX Dual Tone Output Spectrum at 3.75 GHz, -7dBFS each (0 - f_{DAC})



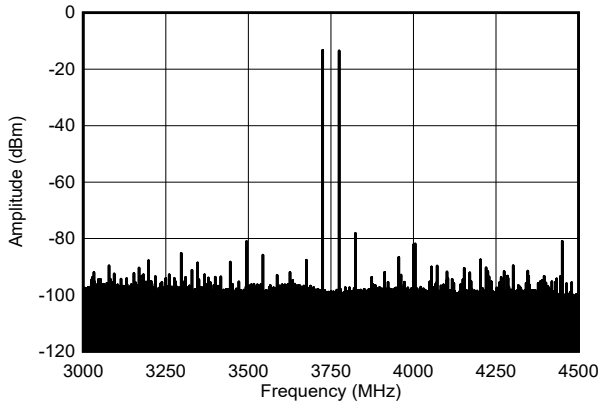
Matching at 3.5 GHz, 50MHz tone spacing, f_{DAC} = 12GSPS, non-interleave mode.

图 5-469. TX Dual Tone Output Spectrum at 3.75 GHz, -7dBFS each (±600 MHz)



Matching at 3.5 GHz, 50MHz tone spacing, f_{DAC} = 12GSPS, non-interleave mode.

图 5-470. TX Dual Tone Output Spectrum at 3.75 GHz, -13dBFS each (0 - f_{DAC})



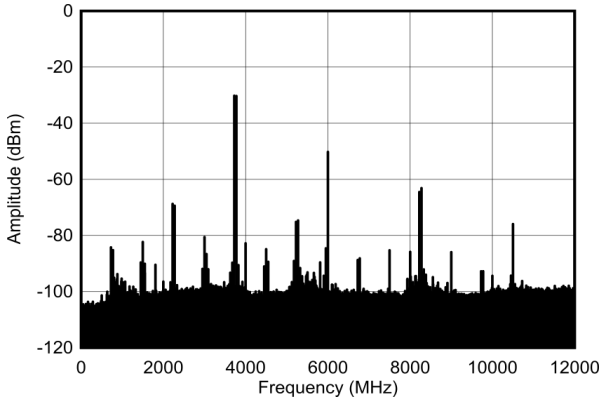
Matching at 3.5 GHz, 50MHz tone spacing, f_{DAC} = 12GSPS, non-interleave mode.

图 5-471. TX Dual Tone Output Spectrum at 3.75 GHz, -13dBFS each (±600 MHz)

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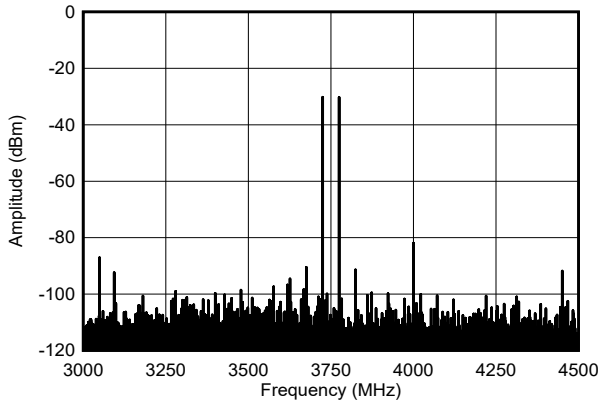
5.12.11 TX Typical Characteristics at 3.5GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



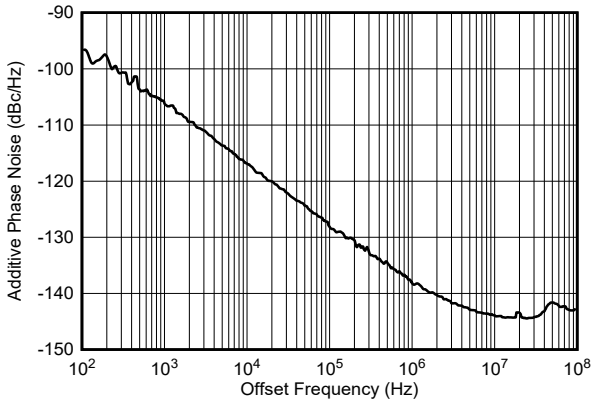
Matching at 3.5 GHz, 50MHz tone spacing, f_{DAC} = 12GSPS, non-interleave mode.

图 5-472. TX Dual Tone Output Spectrum at 3.75 GHz, -30dBFS each (0 - f_{DAC})



Matching at 3.5 GHz, 50MHz tone spacing, f_{DAC} = 12GSPS, non-interleave mode.

图 5-473. TX Dual Tone Output Spectrum at 3.75 GHz, -30dBFS each (±600 MHz)



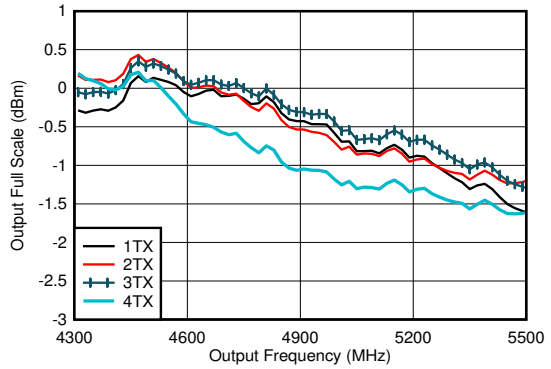
f_{DAC} = f_{CLK} = 12GSPS, non-interleave mode.

图 5-474. External Clock Additive Phase Noise at 3.7GHz

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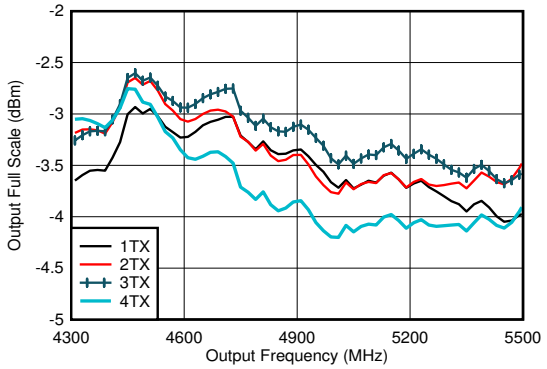
5.12.12 TX Typical Characteristics at 4.9GHz

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



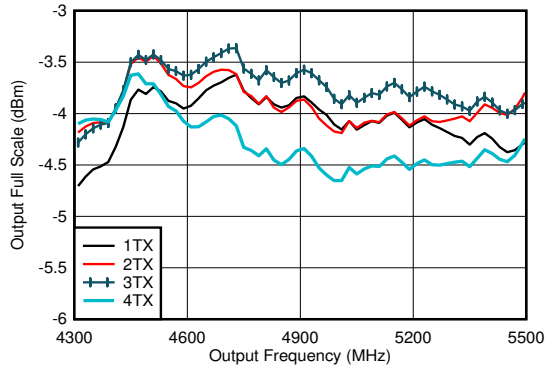
Excluding PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 4.9 GHz matching

图 5-475. TX Full Scale vs RF Frequency and Channel at 11796.48MSPS



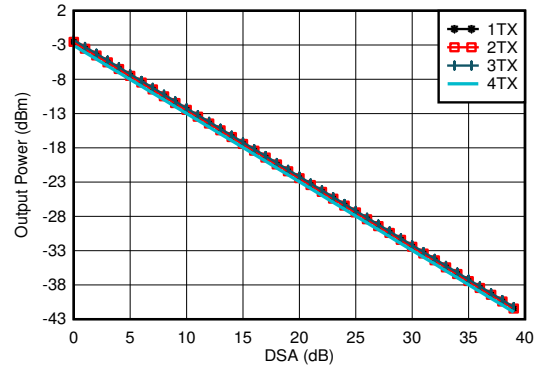
Excluding PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 4.9 GHz matching

图 5-476. TX Full Scale vs RF Frequency and Channel at 5898.24MSPS, Mix Mode, 2nd Nyquist Zone



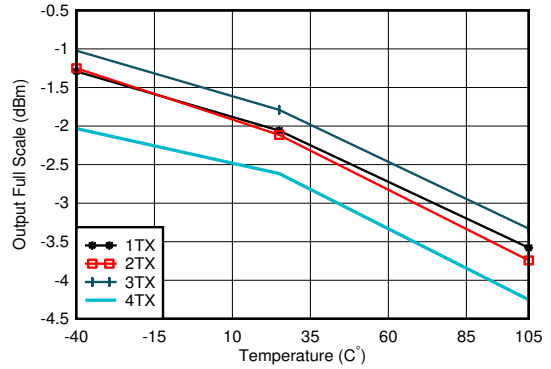
Excluding PCB and cable losses, A_{out} = -0.5dBFS, DSA = 0, 4.9 GHz matching

图 5-477. TX Full Scale vs RF Frequency and Channel at 8847.36MSPS, Mix Mode, 2nd Nyquist Zone



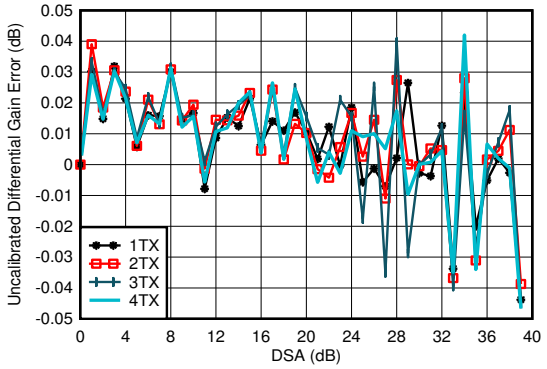
f_{DAC} = 11796.48 MSPS, A_{out} = -0.5dBFS, matching 4.9 GHz

图 5-478. TX Output Power vs DSA Setting and Channel at 4.9 GHz



A_{out} = -0.5dBFS, 4.9 GHz Matching, PCB and cable losses included.

图 5-479. TX Full Scale Output Power vs Temperature and Channel at 4.9 GHz



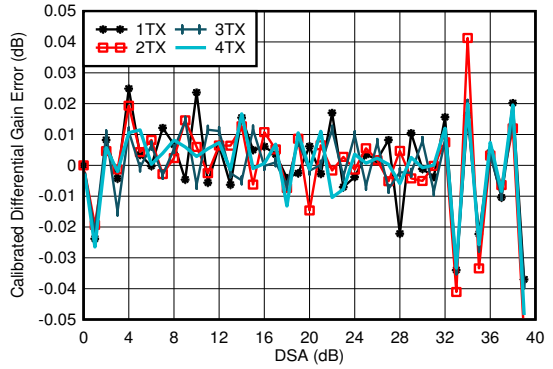
f_{DAC}=11796.48MSPS, interleave mode, matching at 4.9 GHz Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-480. TX Uncalibrated Differential Gain Error vs DSA Setting and Channel at 4.9 GHz

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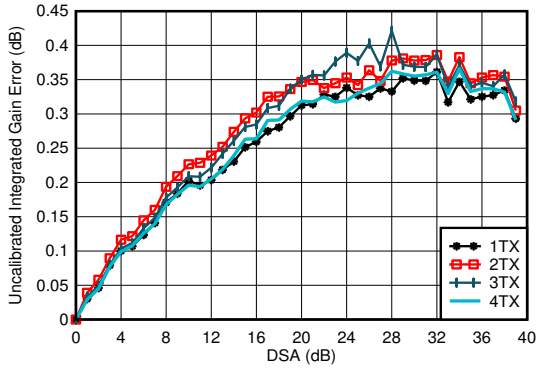
5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



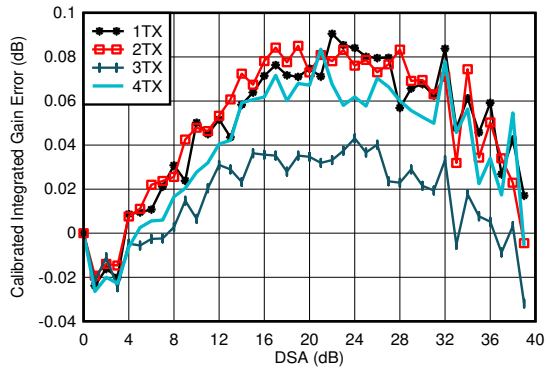
f_{DAC}=11796.48MSPS, interleave mode, matching at 4.9 GHz
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-481. TX Calibrated Differential Gain Error vs DSA Setting and Channel at 4.9 GHz



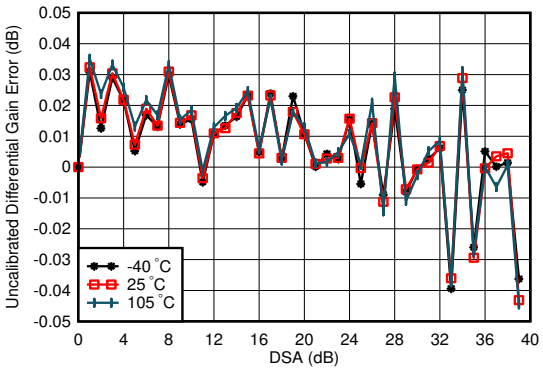
f_{DAC}=11796.48MSPS, interleave mode, matching at 4.9 GHz
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-482. TX Uncalibrated Integrated Gain Error vs DSA Setting and Channel at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleave mode, matching at 4.9 GHz
Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-483. TX Calibrated Integrated Gain Error vs DSA Setting and Channel at 4.9 GHz



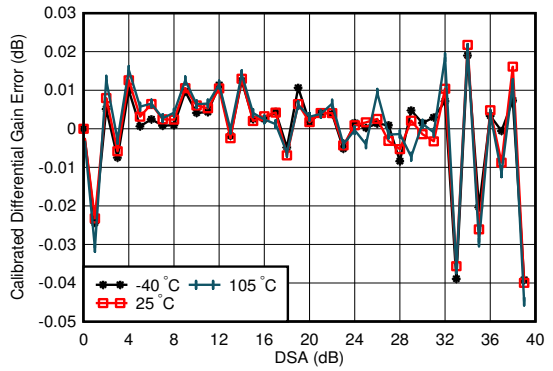
f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz
Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

图 5-484. TX Uncalibrated Differential Gain Error vs DSA Setting and Temperature at 4.9 GHz

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5.12.12 TX Typical Characteristics at 4.9GHz (continued)

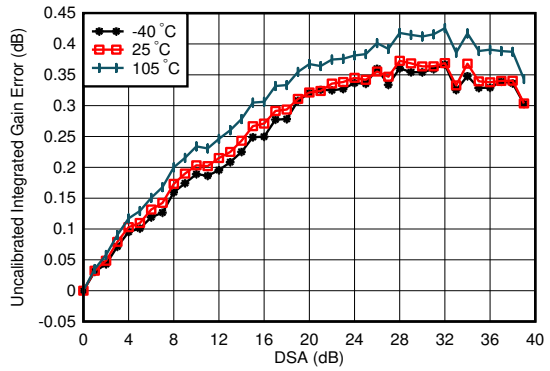
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Differential Gain Error = P_{OUT}(DSA Setting – 1) – P_{OUT}(DSA Setting) + 1

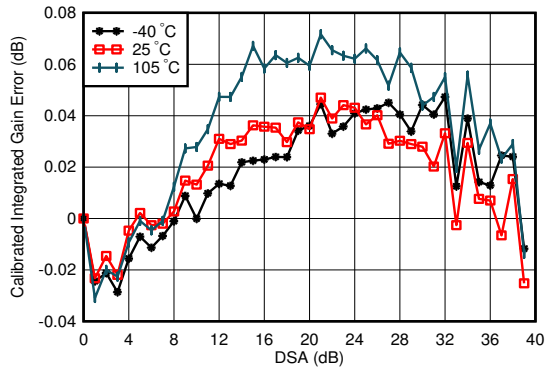
图 5-485. TX Calibrated Differential Gain Error vs DSA Setting and Temperature at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

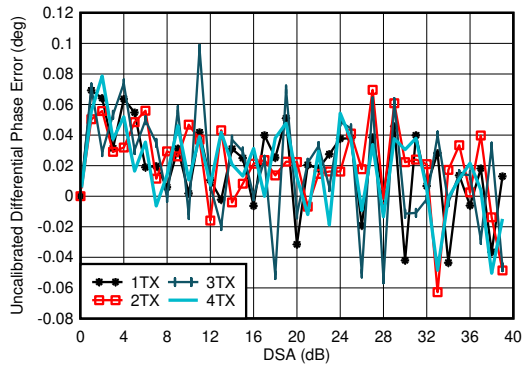
图 5-486. TX Uncalibrated Integrated Gain Error vs DSA Setting and Temperature at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Integrated Gain Error = P_{OUT}(DSA Setting) – P_{OUT}(DSA Setting = 0) + (DSA Setting)

图 5-487. TX Calibrated Integrated Gain Error vs DSA Setting and Temperature at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

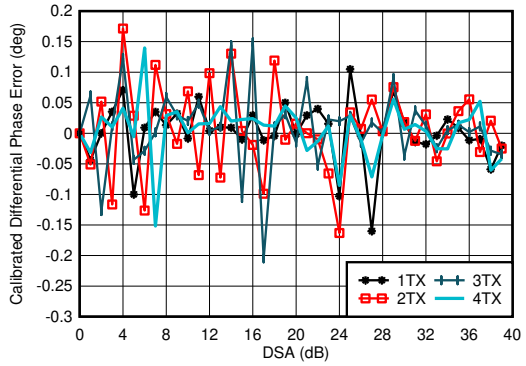
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-488. TX Uncalibrated Differential Phase Error vs DSA Setting and Channel at 4.9 GHz

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5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.

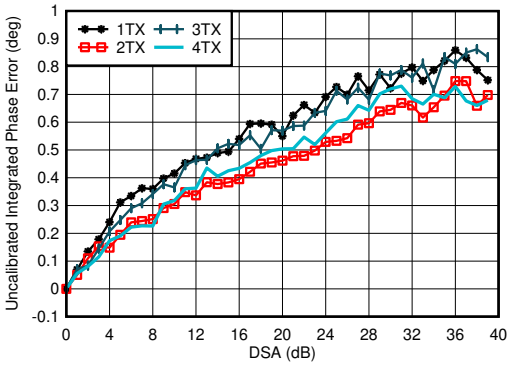


f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

Phase DNL spike may occur at any DSA setting.

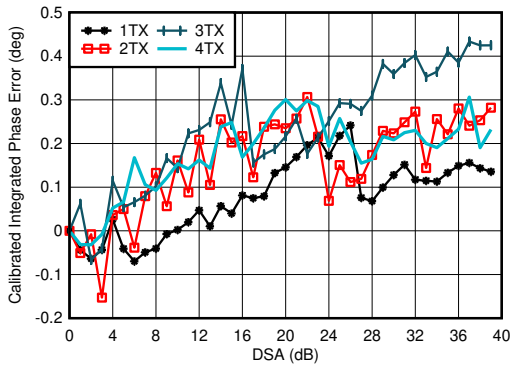
图 5-489. TX Calibrated Differential Phase Error vs DSA Setting and Channel at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

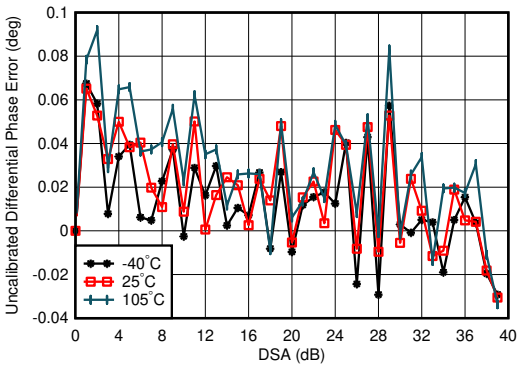
图 5-490. TX Uncalibrated Integrated Phase Error vs DSA Setting and Channel at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-491. TX Calibrated Integrated Phase Error vs DSA Setting and Channel at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

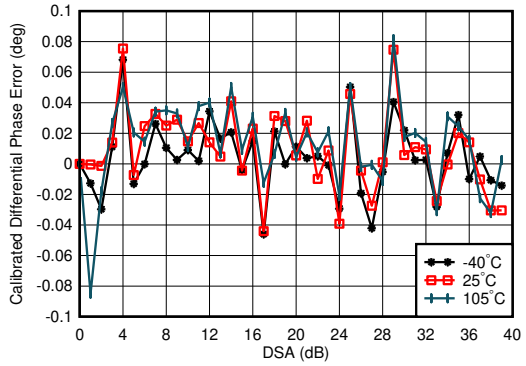
Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

图 5-492. TX Uncalibrated Differential Phase Error vs DSA Setting and Temperature at 4.9 GHz

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5.12.12 TX Typical Characteristics at 4.9GHz (continued)

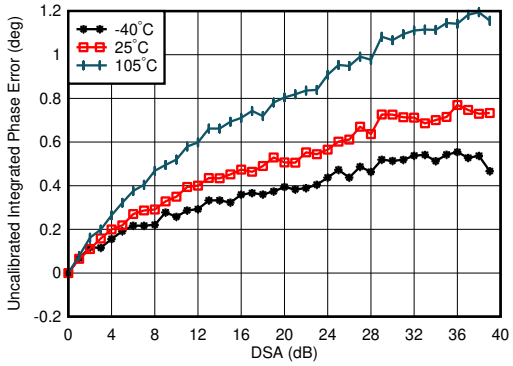
Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Differential Phase Error = $Phase_{OUT}$(DSA Setting – 1) – $Phase_{OUT}$(DSA Setting)

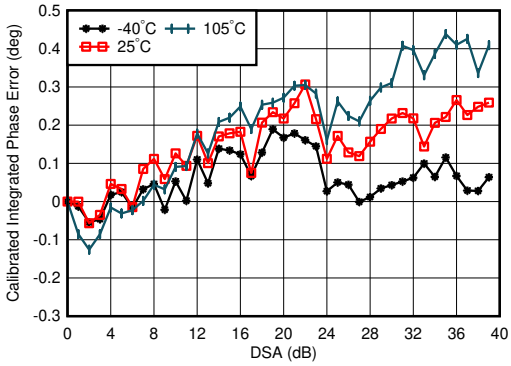
图 5-493. TX Calibrated Differential Phase Error vs DSA Setting and Temperature at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

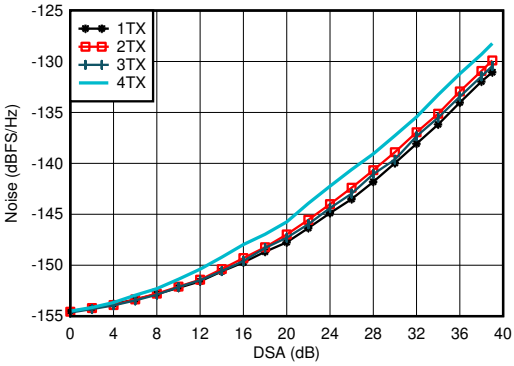
图 5-494. TX Uncalibrated Integrated Phase Error vs DSA Setting and Temperature at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz

Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-495. TX Calibrated Integrated Phase Error vs DSA Setting and Temperature at 4.9 GHz



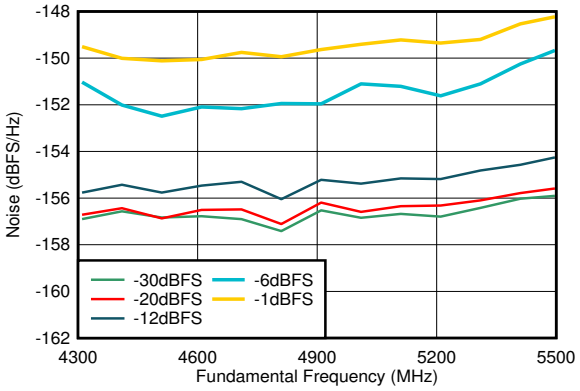
f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz, P_{OUT} = – 13 dBFS

图 5-496. TX Output Noise vs Channel and Attenuation at 4.9 GHz

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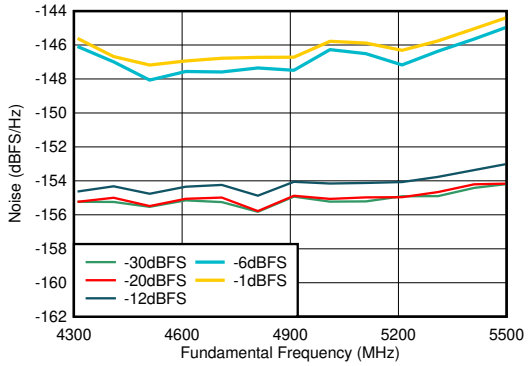
5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



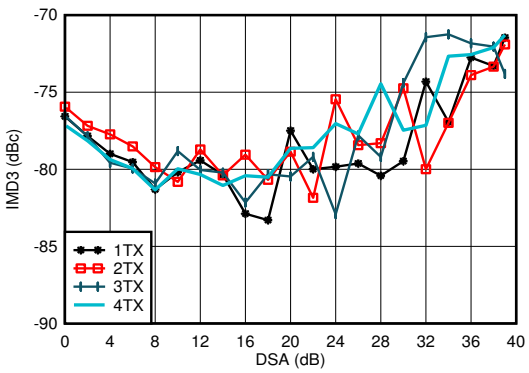
f_{DAC}=11796.48MSPS, interleave mode, matching at 4.9GHz, A_{out} = – 13 dBFS.

图 5-497. TX NSD vs Output Frequency and Digital Amplitude at 4.9 GHz (DSA=0dB)



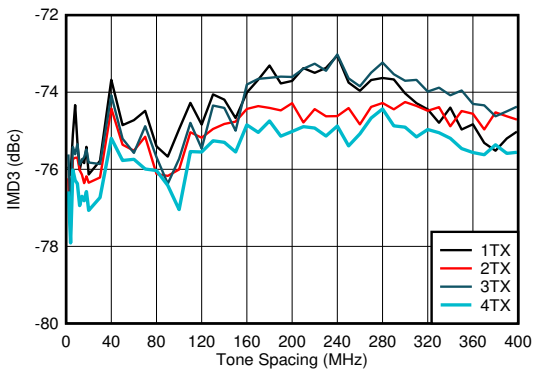
f_{DAC}=11796.48MSPS, interleave mode, matching at 4.9GHz, A_{out} = – 13 dBFS.

图 5-498. TX NSD vs Output Frequency and Digital Amplitude at 4.9GHz (DSA=6dB)



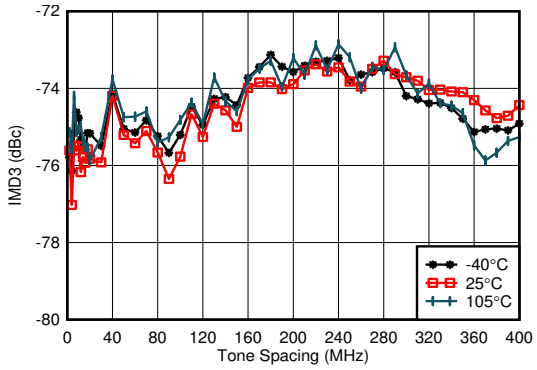
f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz, f_{CENTER} = 4.9GHz, -13 dBFS each tone

图 5-499. TX IMD3 vs DSA Setting at 4.9 GHz



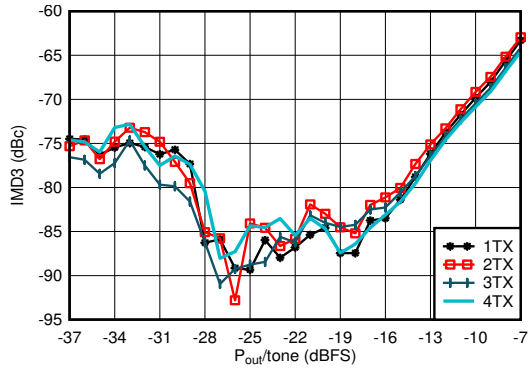
f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz, f_{CENTER} = 4.9GHz, – 13 dBFS each tone

图 5-500. TX IMD3 vs Tone Spacing and Channel at 4.9 GHz



f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz, f_{CENTER} = 4.9GHz, – 13 dBFS each tone, worst channel

图 5-501. TX IMD3 vs Tone Spacing and Temperature at 4.9 GHz



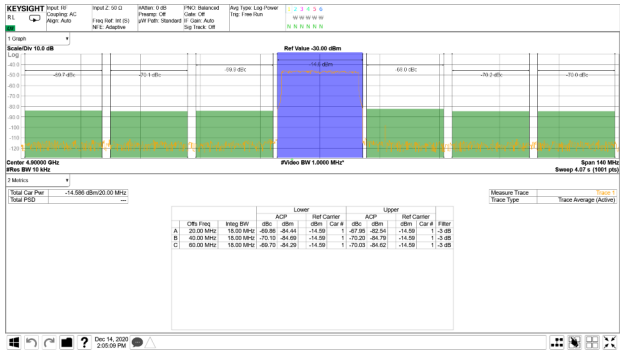
f_{DAC} = 11796.48MSPS, interleaved mode, matching at 4.9 GHz, f_{CENTER} = 4.9GHz, $f_{SPACING}$ = 20 MHz

图 5-502. TX IMD3 vs Digital Level at 4.9 GHz

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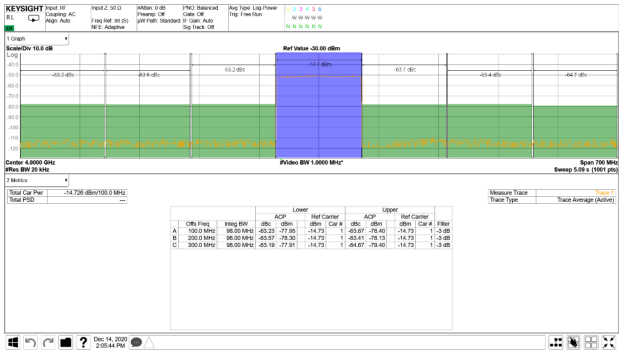
5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



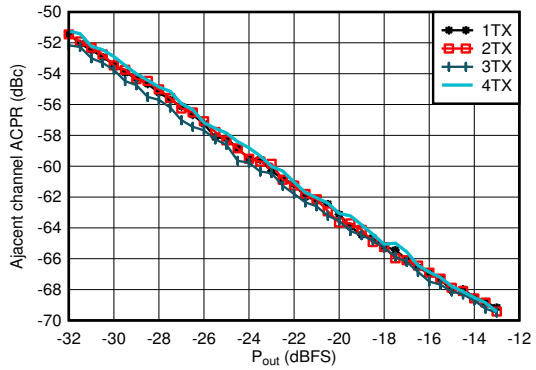
TM1.1, P_{OUT_RMS} = – 13 dBFS

图 5-503. TX 20-MHz LTE Output Spectrum at 4.9 GHz



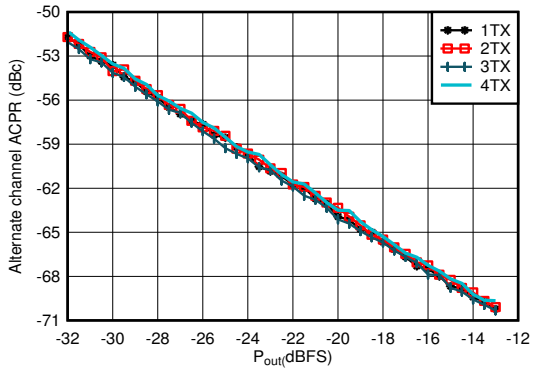
TM1.1, P_{OUT_RMS} = – 13 dBFS

图 5-504. TX 100-MHz NR Output Spectrum at 4.9 GHz



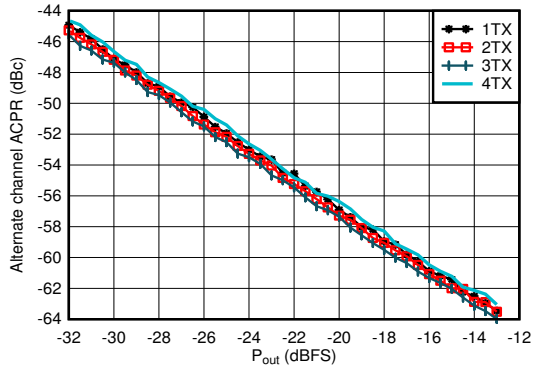
Matching at 4.9 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-505. TX 20-MHz LTE ACPR vs Digital Level at 4.9 GHz



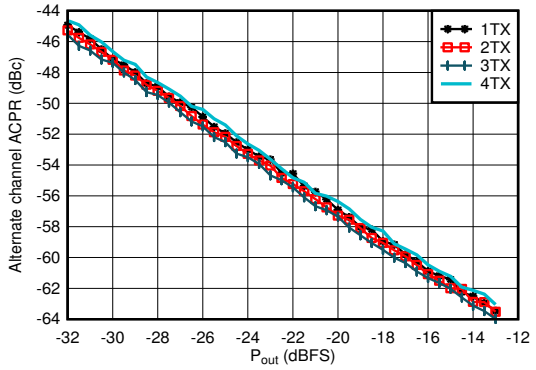
Matching at 4.9 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-506. TX 20-MHz LTE alt-ACPR vs Digital Level at 4.9 GHz



Matching at 4.9 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-507. TX 100-MHz NR ACPR vs Digital Level at 4.9 GHz



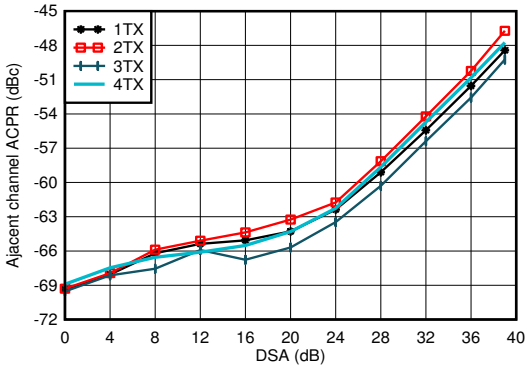
Matching at 4.9 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-508. TX 100-MHz NR alt-ACPR vs Digital Level at 4.9 GHz

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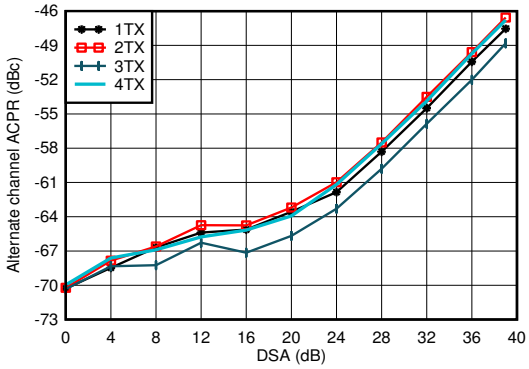
5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



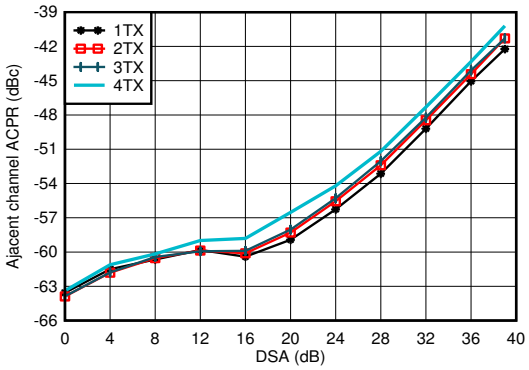
Matching at 4.9 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-509. TX 20-MHz LTE ACPR vs DSA at 4.9 GHz



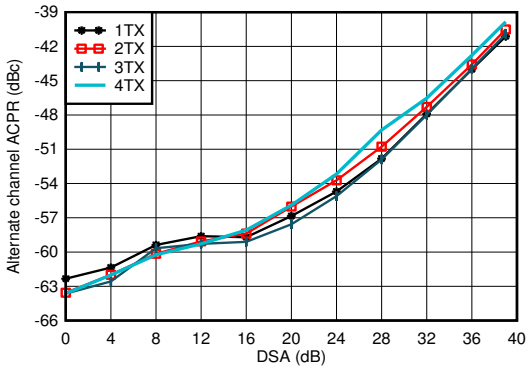
Matching at 4.9 GHz, single carrier 20-MHz BW TM1.1 LTE

图 5-510. TX 20-MHz LTE alt-ACPR vs DSA at 4.9 GHz



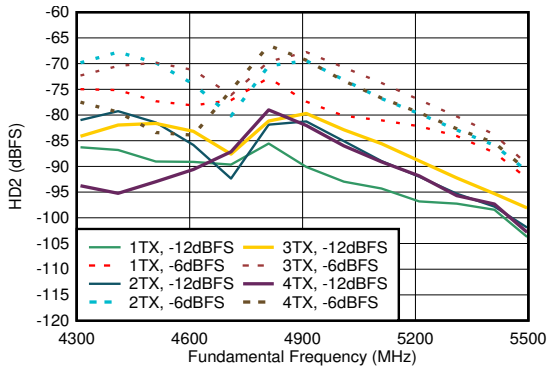
Matching at 4.9 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-511. TX 100-MHz NR ACPR vs DSA at 4.9 GHz



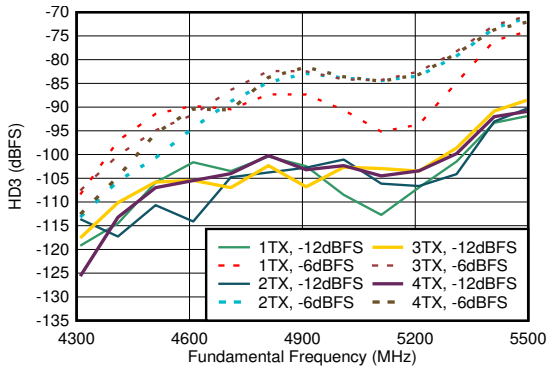
Matching at 4.9 GHz, single carrier 100-MHz BW TM1.1 NR

图 5-512. TX 100-MHz NR alt-ACPR vs DSA at 4.9 GHz



Matching at 4.9 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-513. TX HD2 vs Digital Amplitude and Output Frequency at 4.9 GHz



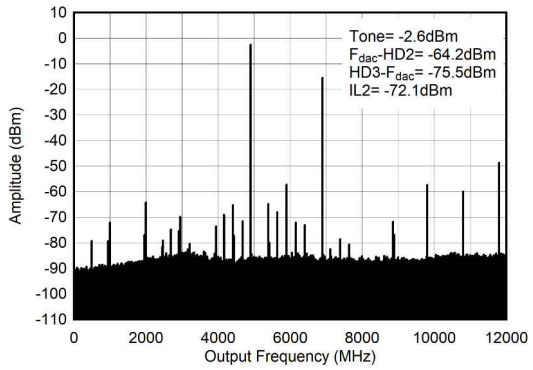
Matching at 4.9 GHz, f_{DAC} = 11.79648GSPS, interleave mode, normalized to output power at harmonic frequency

图 5-514. TX HD3 vs Digital Amplitude and Output Frequency at 4.9 GHz

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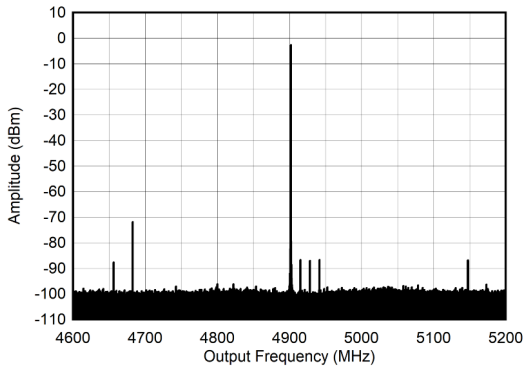
5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



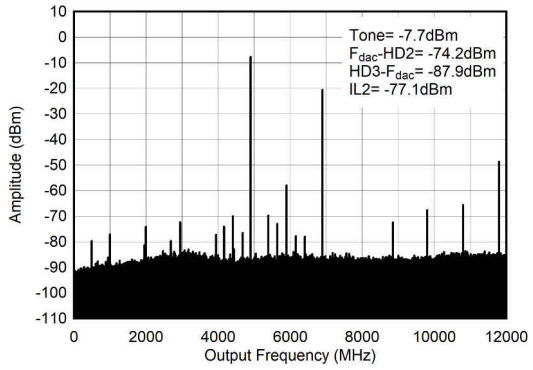
f_{DAC} = 11796.48MSPS, interleave mode, 4.9 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-515. TX Single Tone (– 1 dBFS) Output Spectrum at 4.9 GHz (0-f_{DAC})



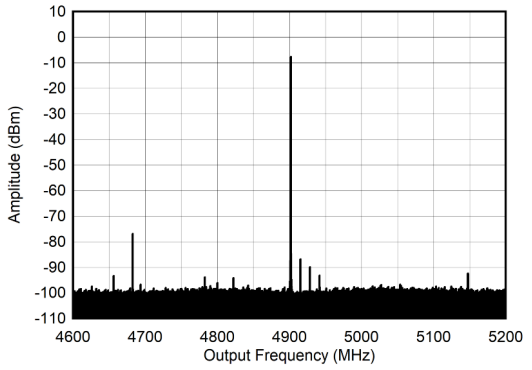
f_{DAC} = 11796.48MSPS, interleave mode, 4.9 GHz matching, includes PCB and cable losses

图 5-516. TX Single Tone (– 1 dBFS) Output Spectrum at 4.9 GHz (±300 MHz)



f_{DAC} = 11796.48MSPS, interleave mode, 4.9 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-517. TX Single Tone (– 6 dBFS) Output Spectrum at 4.9 GHz (0-f_{DAC})



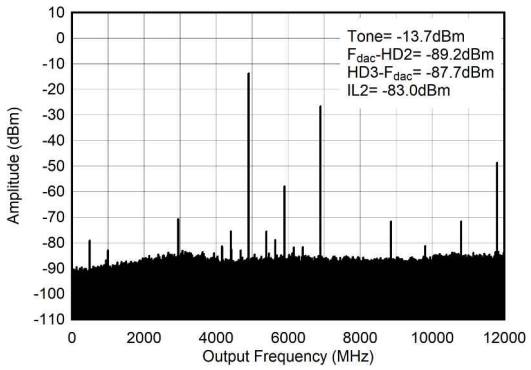
f_{DAC} = 11796.48MSPS, interleave mode, 4.9 GHz matching, includes PCB and cable losses

图 5-518. TX Single Tone (– 6 dBFS) Output Spectrum at 4.9 GHz (±300 MHz)

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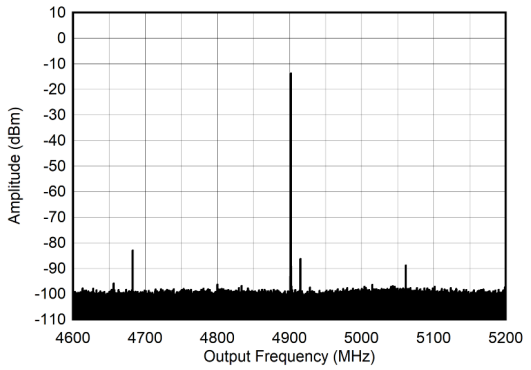
5.12.12 TX Typical Characteristics at 4.9GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 491.52MSPS, f_{DAC} = 11796.48MSPS, interleave mode, A_{OUT} = – 1 dBFS, 1st Nyquist zone output, Internal PLL, f_{REF} = 491.52MSPS, 24x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated.



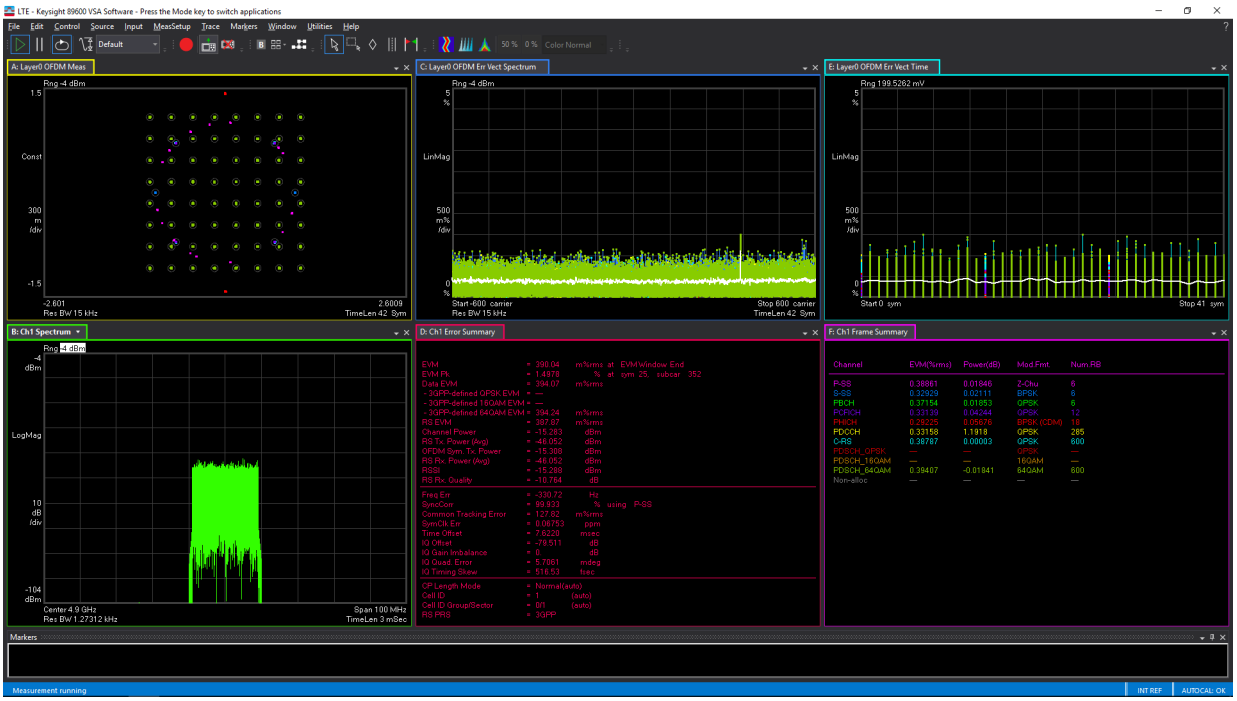
f_{DAC} = 11796.48MSPS, interleave mode, 4.9 GHz matching, includes PCB and cable losses. ILn = $f_S/n \pm f_{OUT}$.

图 5-519. TX Single Tone (– 12 dBFS) Output Spectrum at 4.9 GHz (0-f_{DAC})



f_{DAC} = 11796.48MSPS, interleave mode, 4.9 GHz matching, includes PCB and cable losses

图 5-520. TX Single Tone (– 12 dBFS) Output Spectrum at 4.9 GHz (±300 MHz)



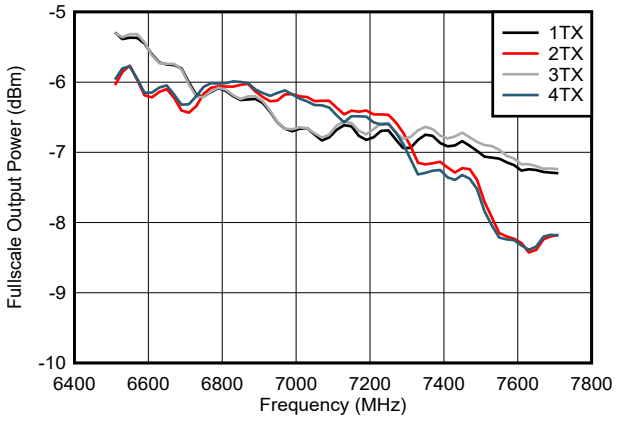
TM1.1, P_{OUT_RMS} = – 13 dBFS

图 5-521. TX 20-MHz LTE Error Vector Magnitude at 4.9 GHz

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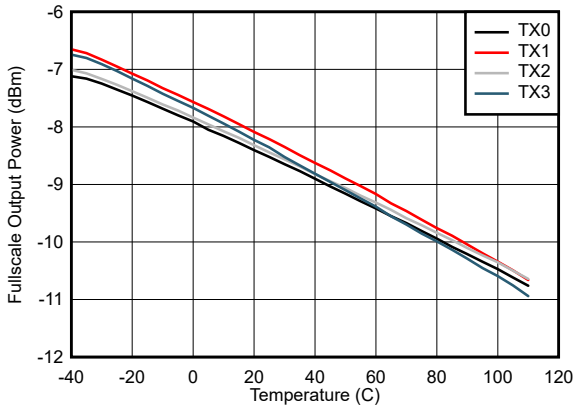
5.12.13 TX Typical Characteristics at 7.1GHz

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.



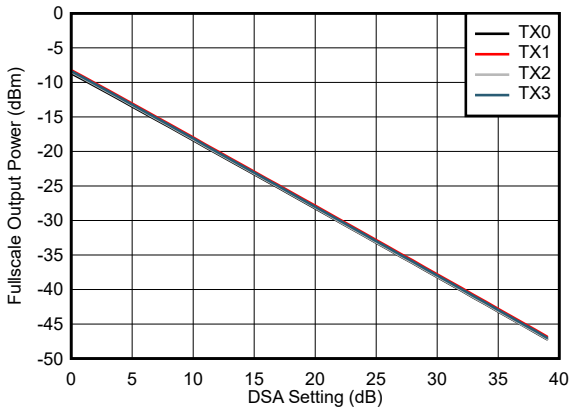
Excluding PCB and cable losses

图 5-522. TX Full Scale vs RF Frequency and Channel



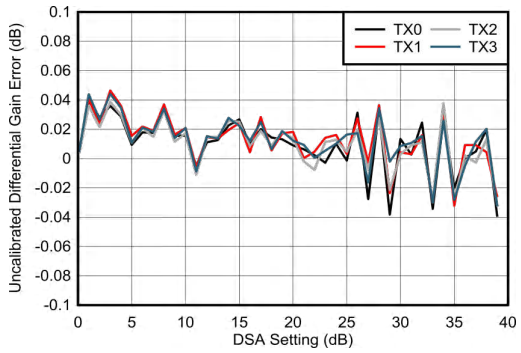
Excluding PCB and cable losses

图 5-523. TX Full Scale vs Temperature and Channel at 7.1GHz



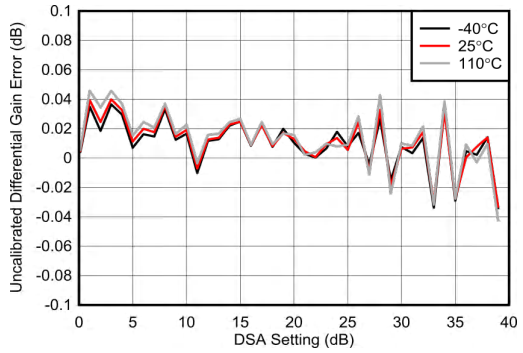
Excluding PCB and cable losses

图 5-524. TX Full Scale vs DSA Setting and Channel at 7.1 GHz



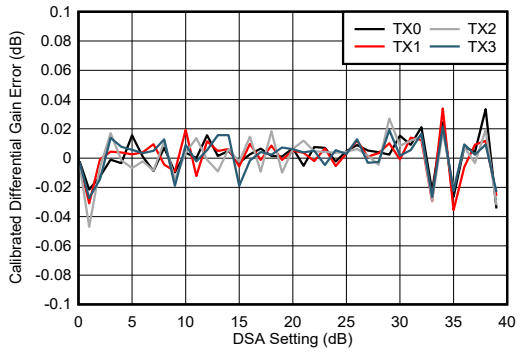
Differential Gain Error = Gain(DSA Setting – 1) – Gain(DSA Setting)

图 5-525. Uncalibrated Differential Gain Error vs Channel at 7.1 GHz



Differential Gain Error = Gain(DSA Setting – 1) – Gain(DSA Setting)

图 5-526. Uncalibrated Differential Gain Error vs Temperature at 7.1 GHz



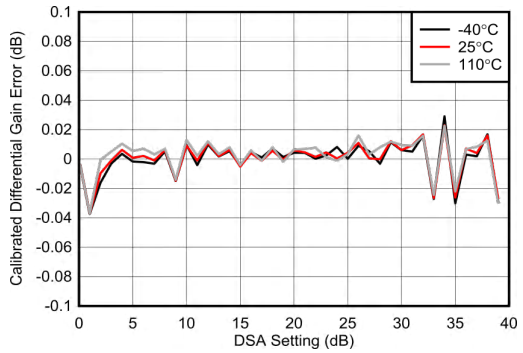
Differential Gain Error = Gain(DSA Setting – 1) – Gain(DSA Setting)

图 5-527. Calibrated Differential Gain Error vs Channel at 7.1 GHz

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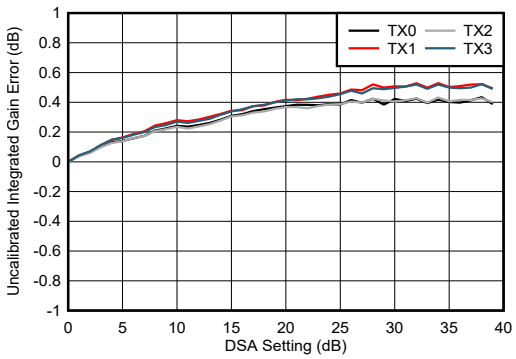
5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.



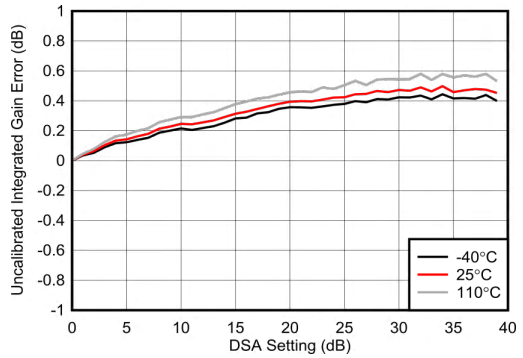
Differential Gain Error = Gain(DSA Setting – 1) – Gain(DSA Setting)

图 5-528. Calibrated Differential Gain Error vs Temperature at 7.1 GHz



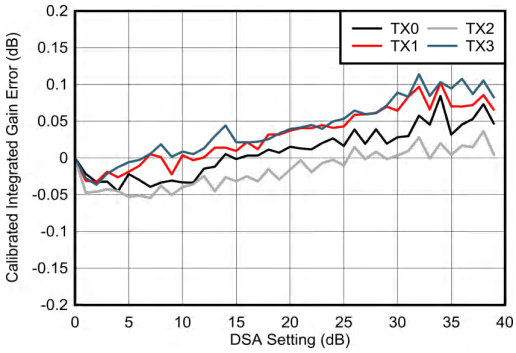
Integrated Gain Error = Gain(DSA Setting) – Gain(DSA Setting = 0).

图 5-529. Uncalibrated Integrated Gain Error vs Channel at 7.1 GHz



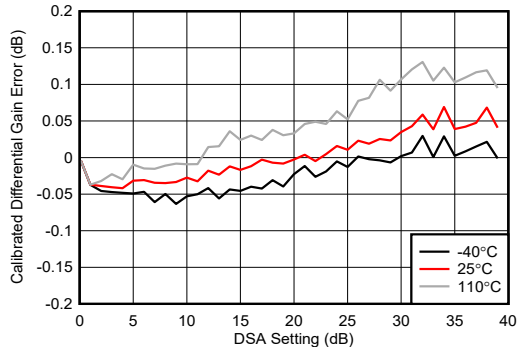
Integrated Gain Error = Gain(DSA Setting) – Gain(DSA Setting = 0).

图 5-530. Uncalibrated Integrated Gain Error vs Temperature at 7.1 GHz



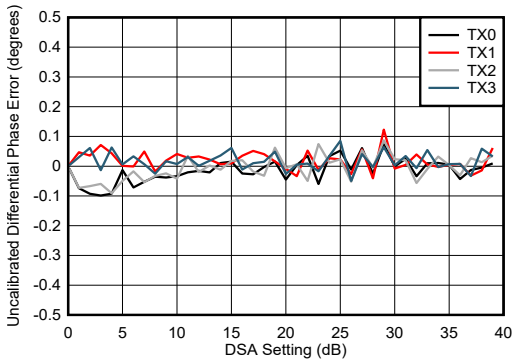
Integrated Gain Error = Gain(DSA Setting) – Gain(DSA Setting = 0).

图 5-531. Calibrated Integrated Gain Error vs Channel at 7.1 GHz



Integrated Gain Error = Gain(DSA Setting) – Gain(DSA Setting = 0).

图 5-532. Calibrated Integrated Gain Error vs Temperature at 7.1 GHz



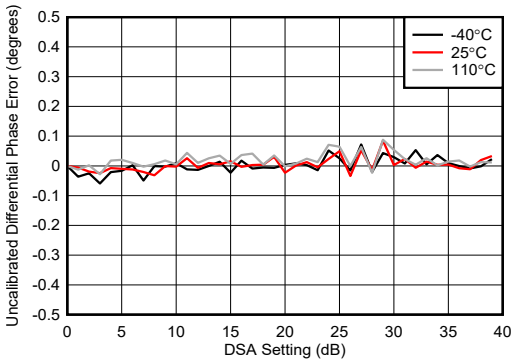
Differential Phase Error = Phase(DSA Setting – 1) – Phase(DSA Setting)

图 5-533. Uncalibrated Differential Phase Error vs Channel at 7.1 GHz

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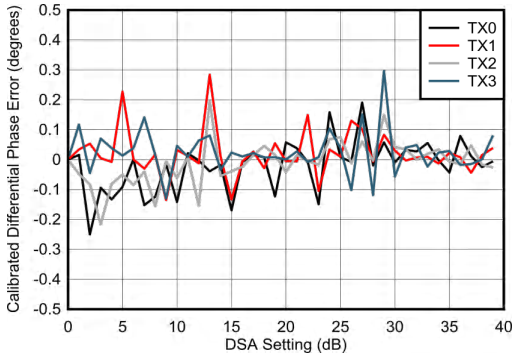
5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.



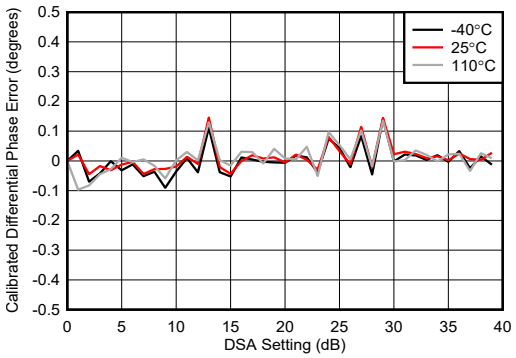
Differential Phase Error = Phase(DSA Setting – 1) – Phase(DSA Setting)

图 5-534. Uncalibrated Differential Phase Error vs Temperature at 7.1 GHz



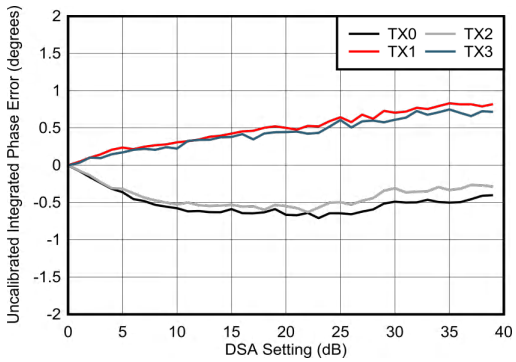
Differential Phase Error = Phase(DSA Setting – 1) – Phase(DSA Setting)

图 5-535. Calibrated Differential Phase Error vs Channel at 7.1 GHz



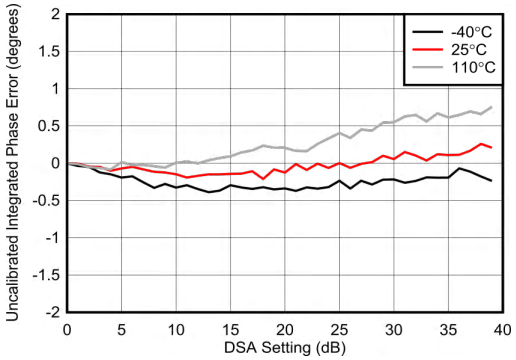
Differential Phase Error = Phase(DSA Setting – 1) – Phase(DSA Setting)

图 5-536. Calibrated Differential Phase Error vs Temperature at 7.1 GHz



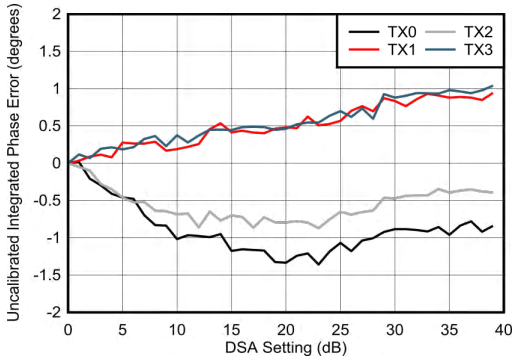
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-537. Uncalibrated Integrated Phase Error vs Channel at 7.1 GHz



Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-538. Uncalibrated Integrated Phase Error vs Temperature at 7.1 GHz



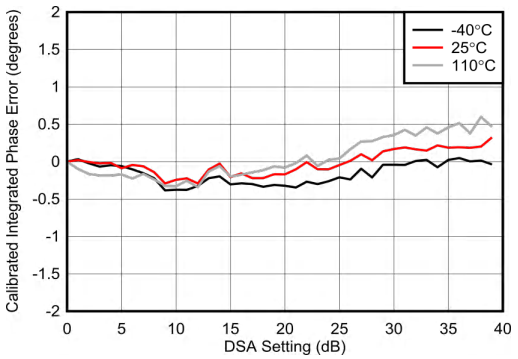
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-539. Calibrated Integrated Phase Error vs Channel at 7.1 GHz

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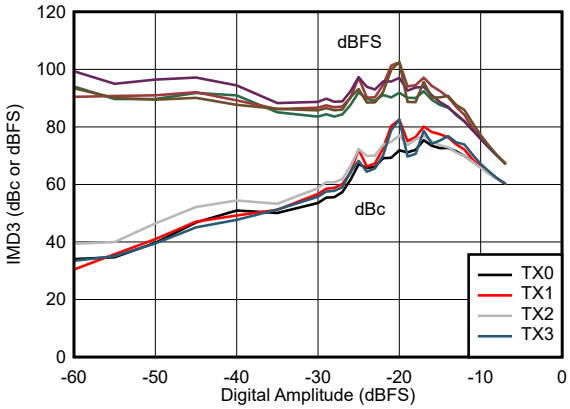
5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.



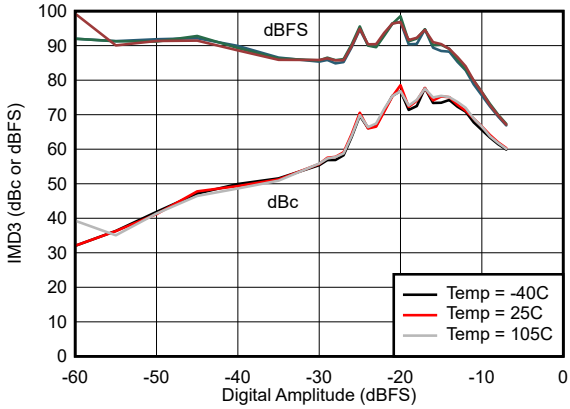
Integrated Phase Error = Phase(DSA Setting) – Phase(DSA Setting = 0)

图 5-540. Calibrated Integrated Phase Error vs Temperature at 7.1 GHz



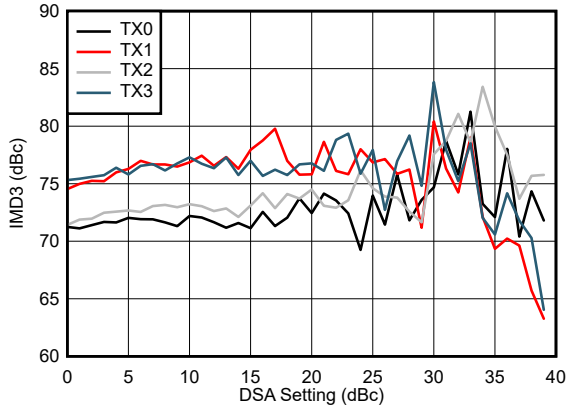
Tone spacing = 50MHz

图 5-541. IMD3 vs Digital Amplitude and Channel at 7.1 GHz



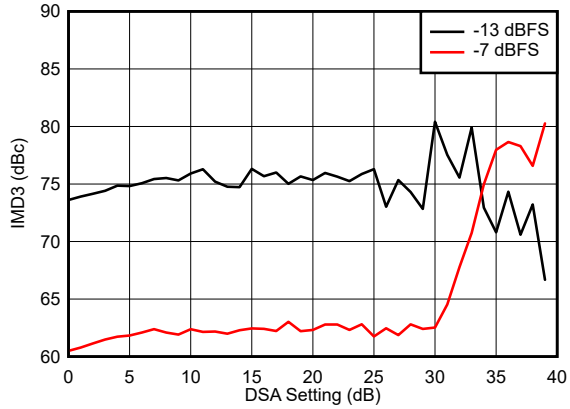
Tone spacing = 50MHz

图 5-542. IMD3 vs Digital Amplitude and Temperature at 7.1 GHz



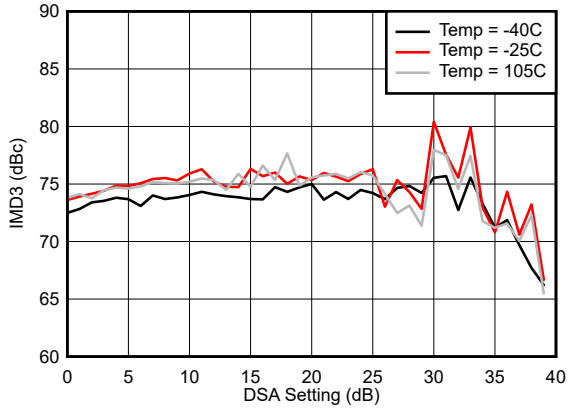
Tone spacing = 50MHz

图 5-543. IMD3 vs DSA Setting and Channel at 7.1 GHz



Tone spacing = 50MHz

图 5-544. IMD3 vs DSA Setting and Digital Amplitude at 7.1 GHz



Tone spacing = 50MHz

图 5-545. IMD3 vs DSA Setting and Temperature at 7.1 GHz

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5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.

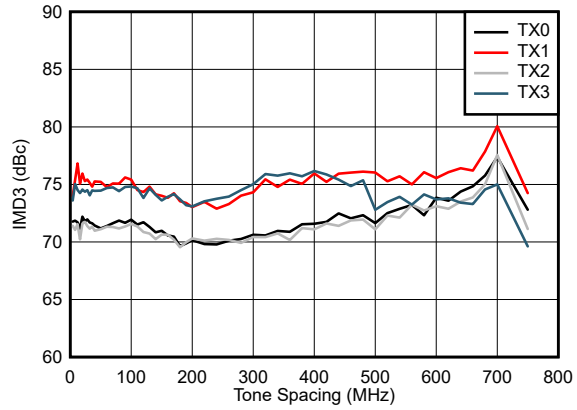


图 5-546. IMD3 vs Tone Spacing and Channel at 7.1 GHz

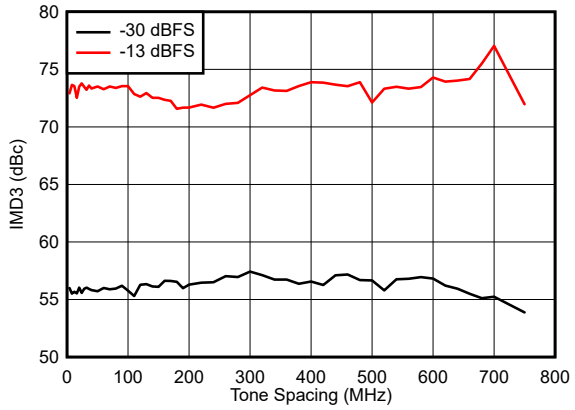


图 5-547. IMD3 vs Tone Spacing and Digital Amplitude at 7.1 GHz

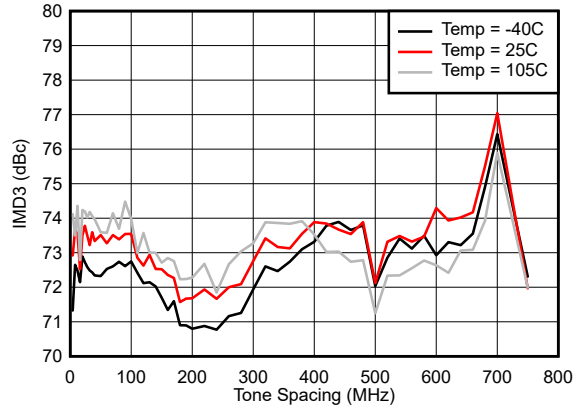
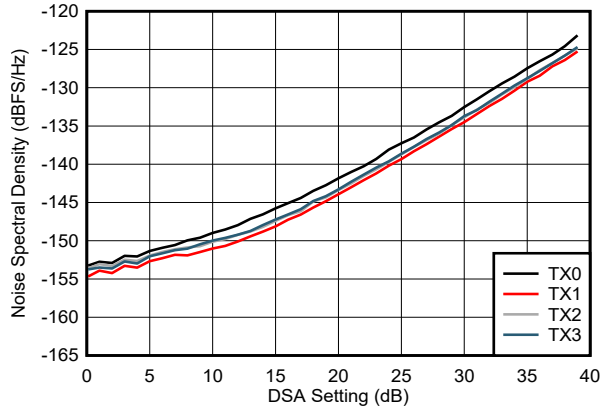
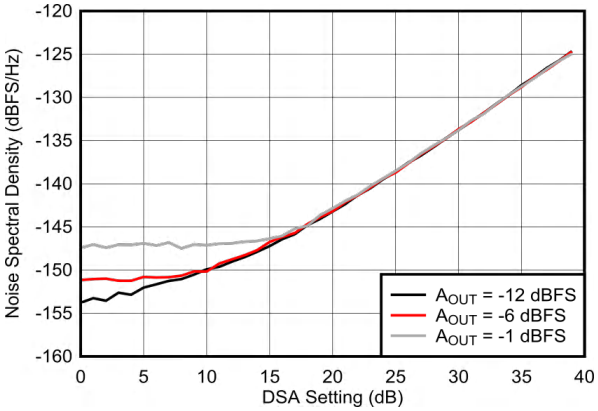


图 5-548. IMD3 vs Tone Spacing and Temperature at 7.1 GHz



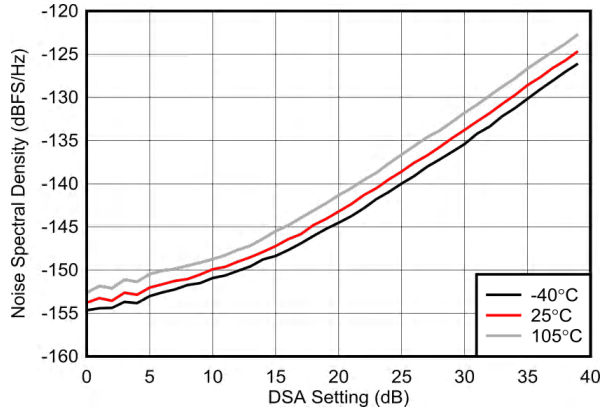
Tone at -12dBFS, 50MHz offset from tone

图 5-549. NSD vs DSA Setting and Channel at 7.1 GHz



50MHz offset from tone

图 5-550. NSD vs DSA Setting and Amplitude at 7.1 GHz



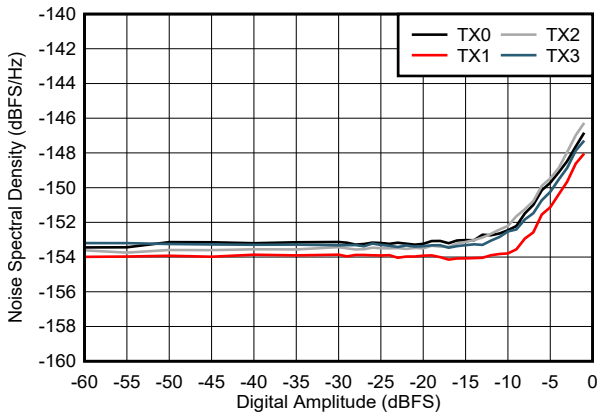
Tone at -12dBFS, 50MHz offset from tone

图 5-551. NSD vs DSA Setting and Temperature at 7.1 GHz

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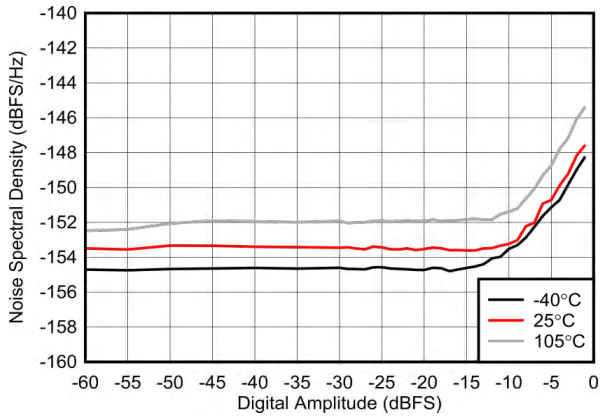
5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.



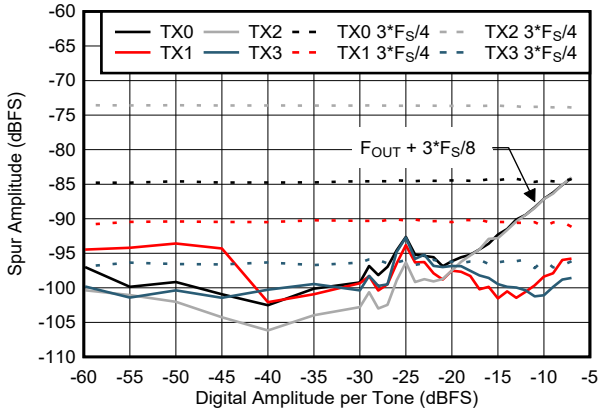
50MHz offset from tone

图 5-552. NSD vs Digital Amplitude and Channel at 7.1 GHz



50MHz offset from tone

图 5-553. NSD vs Digital Amplitude and Temperature at 7.1 GHz



Inband = 7100MHz ± 600MHz, excluding IMD3 components, 3*F_S/4 spur not included and shown separately

图 5-554. Two Tone Inband SFDR vs Digital Amplitude at 7.1 GHz

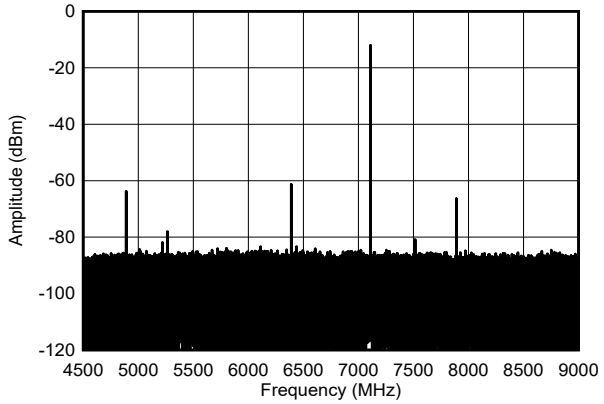


图 5-555. Single Tone Output Spectrum at 7.1GHz, -1dBFS (Nyquist)

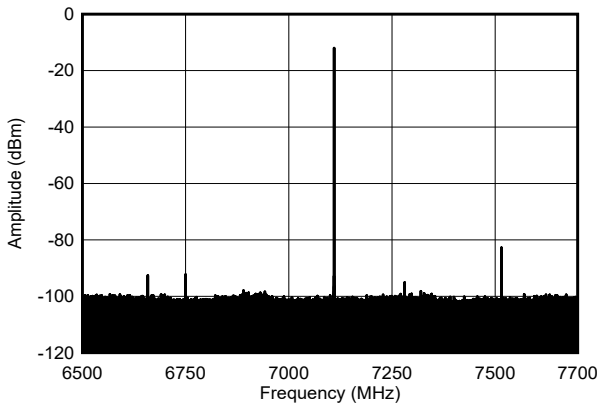


图 5-556. Single Tone Output Spectrum at 7.1GHz, -1dBFS (Inband)

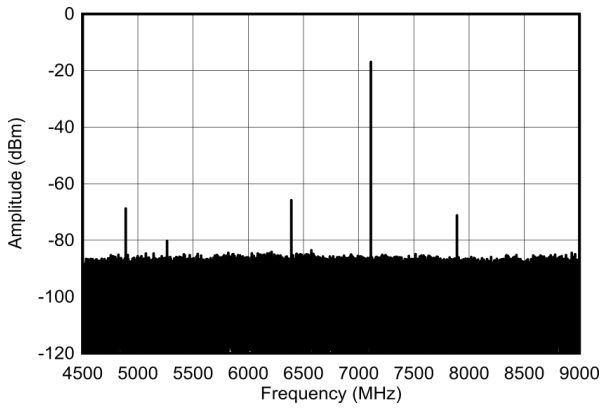


图 5-557. Single Tone Output Spectrum at 7.1GHz, -6dBFS (Nyquist)

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5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.

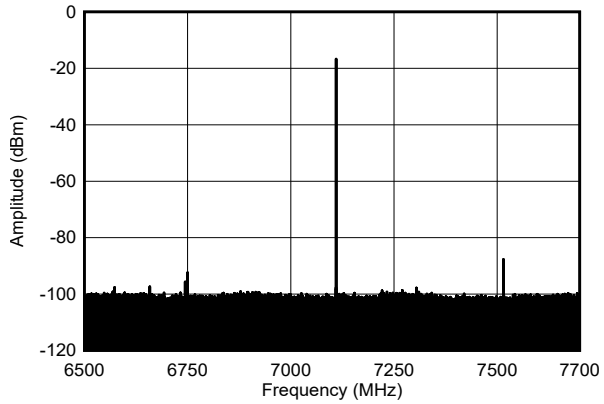


图 5-558. Single Tone Output Spectrum at 7.1GHz, -6dBFS (Inband)

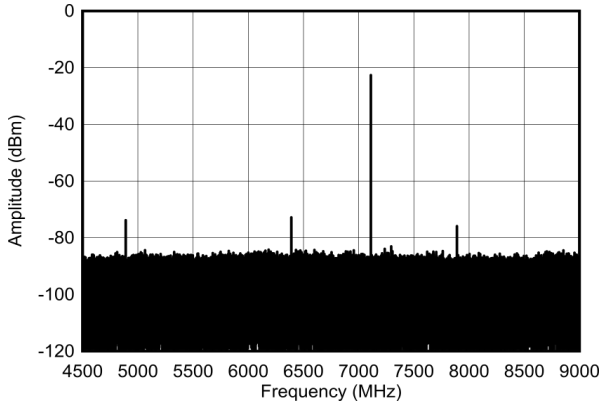


图 5-559. Single Tone Output Spectrum at 7.1GHz, -12dBFS (Nyquist)

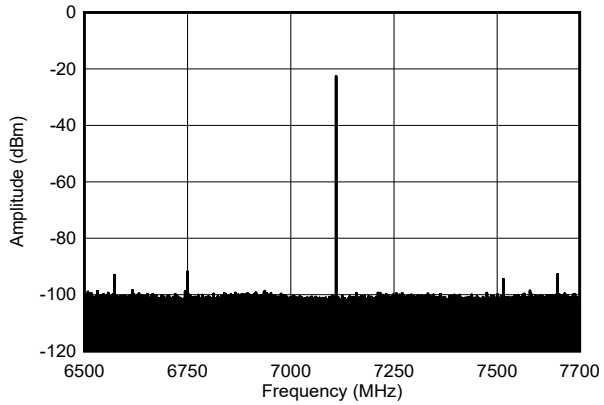
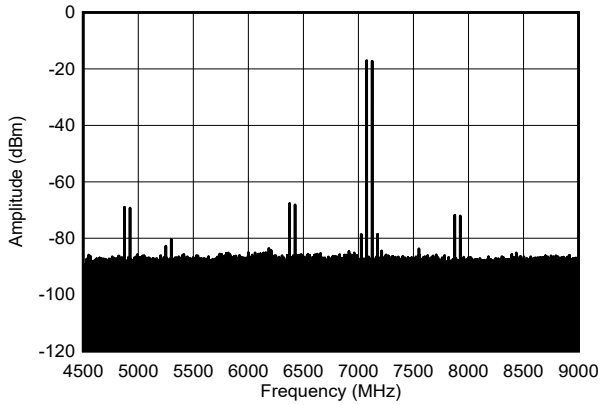
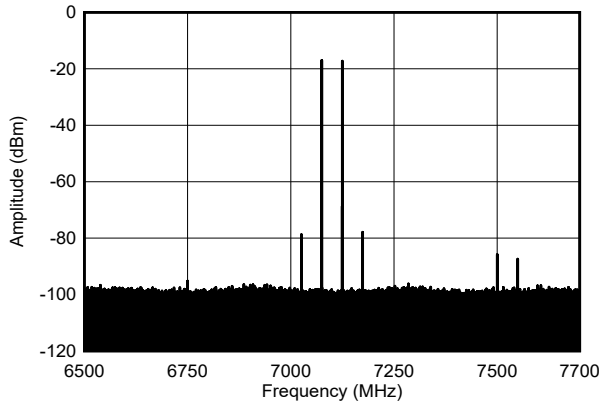


图 5-560. Single Tone Output Spectrum at 7.1GHz, -12dBFS (Inband)



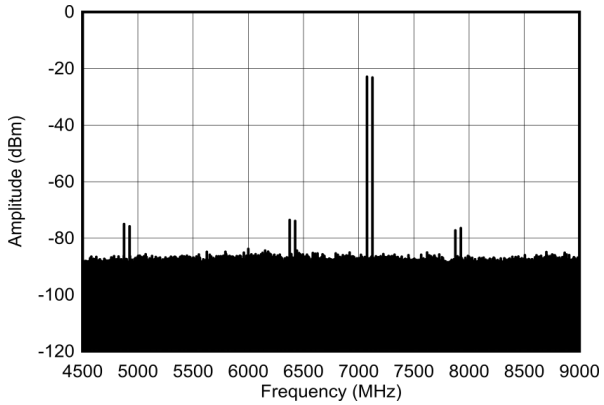
50MHz Tone Spacing

图 5-561. Two Tone Output Spectrum at 7.1GHz, -7dBFS each (Nyquist)



50MHz Tone Spacing

图 5-562. Two Tone Output Spectrum at 7.1GHz, -7dBFS each (Inband)



50MHz Tone Spacing

图 5-563. Two Tone Output Spectrum at 7.1GHz, -13dBFS each (Nyquist)

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5.12.13 TX Typical Characteristics at 7.1GHz (continued)

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, TX input data rate = 750MSPS, f_{DAC} = 9000MSPS, non-interleave mode, A_{OUT} = – 1 dBFS, 2nd Nyquist zone output, External clock mode, 12x Interpolation, DSA = 0 dB, Sin(x)/x enabled, DSA calibrated, TX Clock Dither Enabled, 7.1GHz matching.

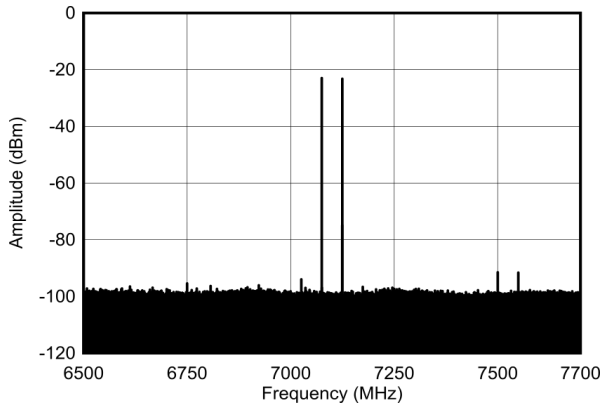


图 5-564. Two Tone Output Spectrum at 7.1GHz, -13dBFS each (Inband)

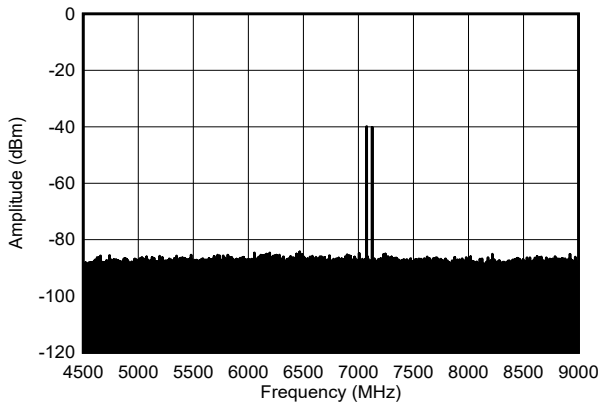


图 5-565. Two Tone Output Spectrum at 7.1GHz, -30dBFS each (Nyquist)

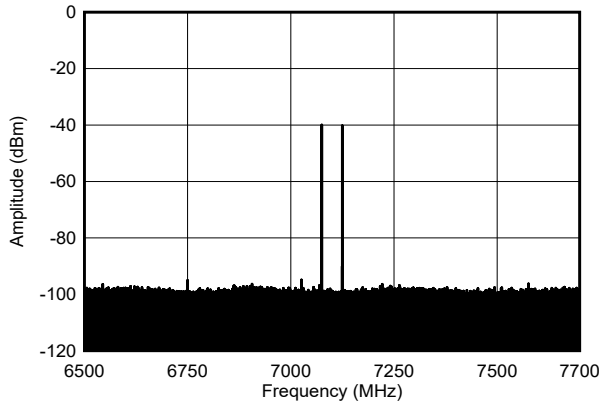


图 5-566. Two Tone Output Spectrum at 7.1GHz, -30dBFS each (Inband)

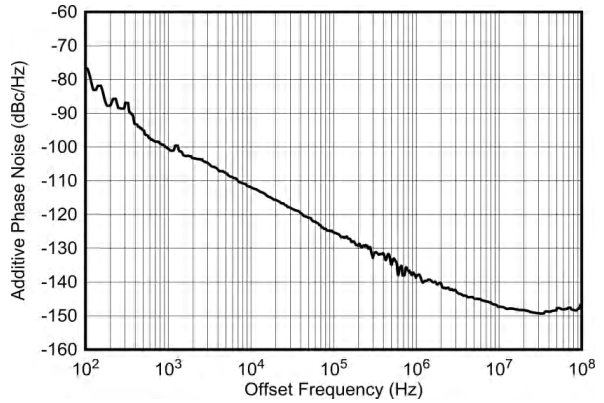
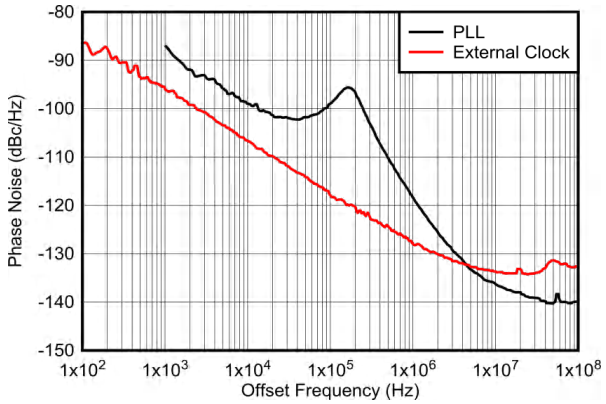


图 5-567. External Clock Additive Phase Noise at 7.1 GHz

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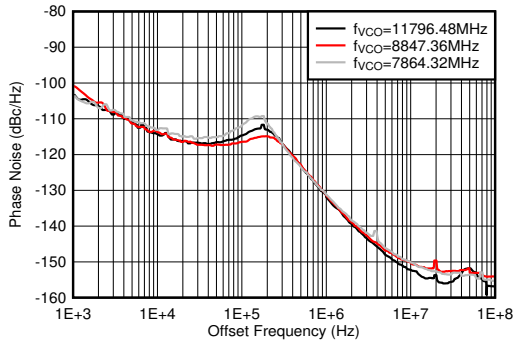
5.12.14 PLL and Clock Typical Characteristics

Typical values at T_A = +25°C with nominal supplies. Unless otherwise noted, f_{REF} = 491.52 MHz, Phase noise measured at TX output



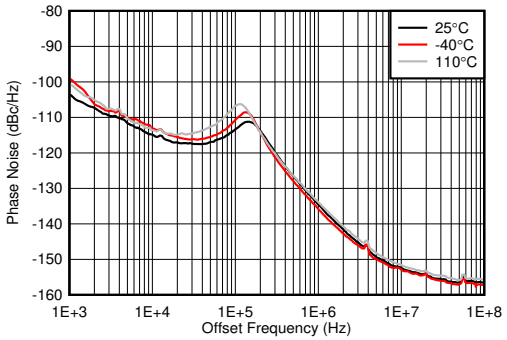
measured at TX output, normalized to 12GHz by 20*log10(12GHz/F_{OUT})

图 5-568. Phase Noise vs Offset Frequency for PLL and External Clock at 12GHz



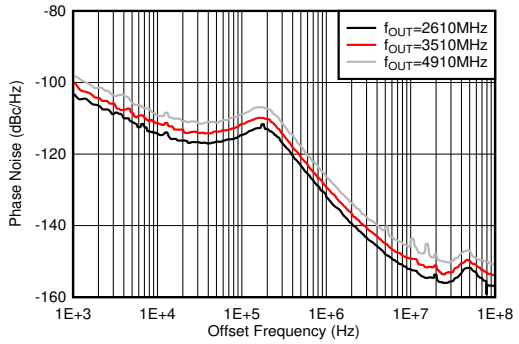
PLL enabled, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-569. Phase Noise vs Offset Frequency and f_{VCO} at f_{OUT} = 2610 MHz



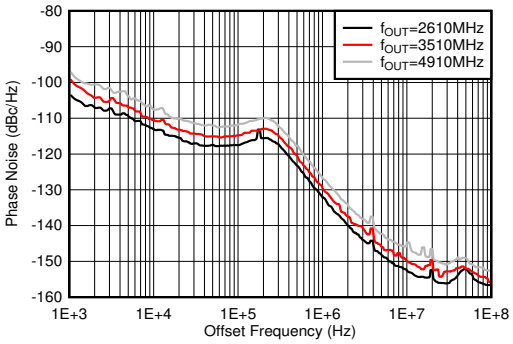
PLL enabled, f_{VCO} = 11796.48 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-570. Phase Noise for 12-GHz VCO vs Offset Frequency and Temperature at f_{OUT} = 1910 MHz



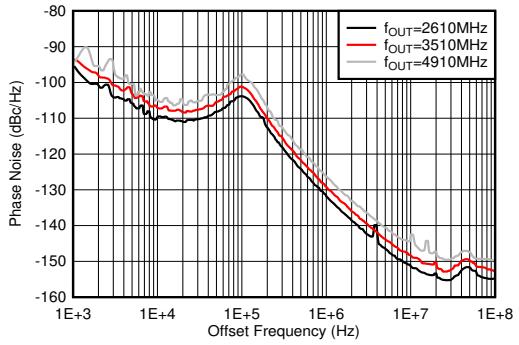
PLL enabled, f_{VCO} = 11796.48 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-571. Phase Noise for 12-GHz VCO vs Offset Frequency and f_{OUT} at 25°C



PLL enabled, f_{VCO} = 11796.48 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

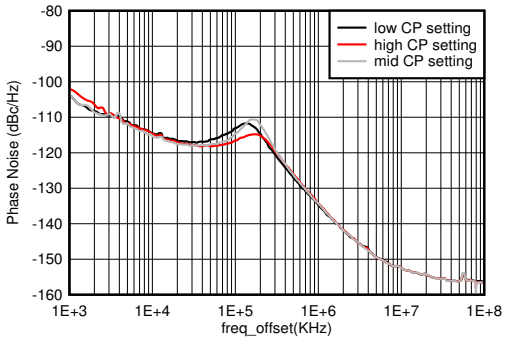
图 5-572. Phase Noise for 12-GHz VCO vs Offset Frequency and f_{OUT} at –40°C



PLL enabled, f_{VCO} = 11796.48 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

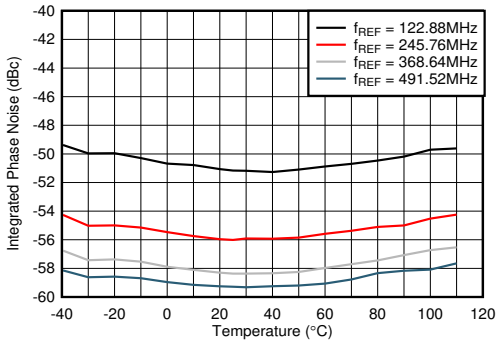
图 5-573. Phase Noise for 12-GHz VCO vs Offset Frequency and f_{OUT} at 110°C

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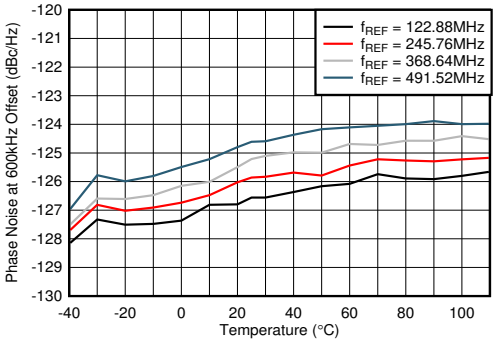
PLL enabled, f_{VCO} = 11796.48 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-574. Phase Noise for 12-GHz VCO vs Offset Frequency and CP Setting at f_{OUT} = 2.6 GHz



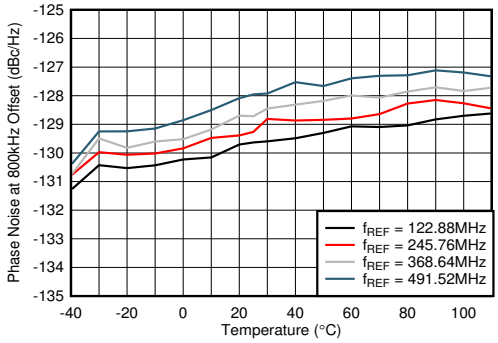
PLL enabled, f_{VCO} = 11796.48 MHz, 1-kHz to 100-MHz, single-sided integration bandwidth, measured at 2TXOUT

图 5-575. Integrated Phase Noise for 12-GHz VCO vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



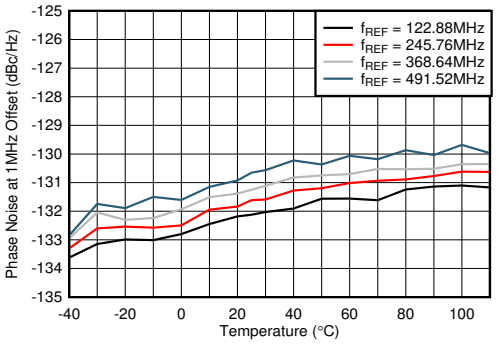
PLL enabled, f_{VCO} = 11796.48 MHz, measured at 2TXOUT

图 5-576. Phase Noise for 12-GHz VCO at 600kHz Offset vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



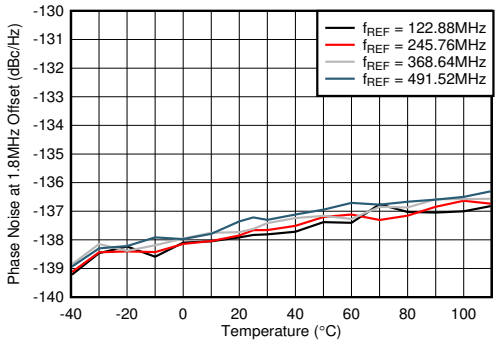
A. PLL enabled, f_{VCO} = 11796.48 MHz, measured at 2TXOUT

图 5-577. Phase Noise for 12-GHz VCO at 800-kHz Offset vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



PLL enabled, f_{VCO} = 11796.48 MHz, measured at 2TXOUT

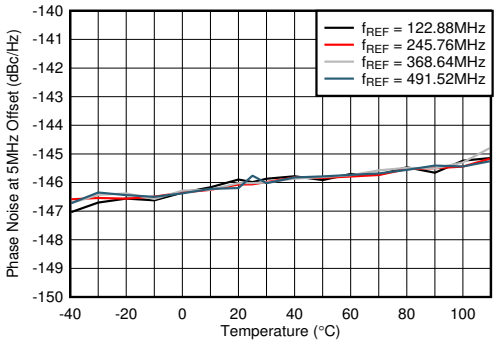
图 5-578. Phase Noise for 12-GHz VCO at 1-MHz Offset vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



PLL enabled, f_{VCO} = 11796.48 MHz, measured at 2TXOUT

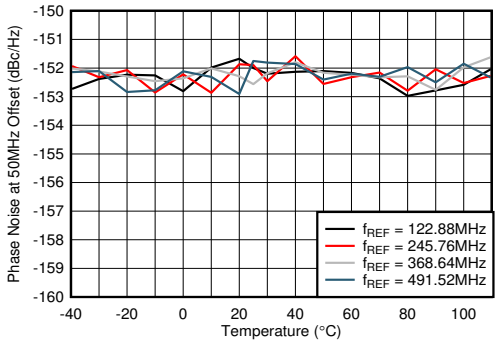
图 5-579. Phase Noise for 12-GHz VCO at 1.8-MHz Offset vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz

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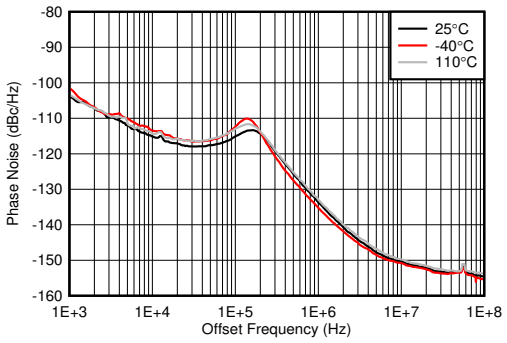
PLL enabled, f_{VCO} = 11796.48 MHz, measured at 2TXOUT

图 5-580. Phase Noise for 12-GHz VCO at 5-MHz Offset vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



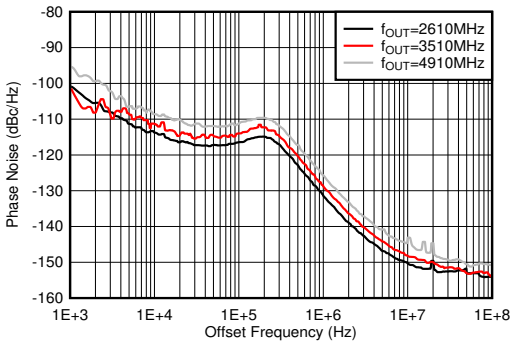
PLL enabled, f_{VCO} = 11796.48 MHz, measured at 2TXOUT

图 5-581. Phase Noise for 12-GHz VCO at 50-MHz Offset vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



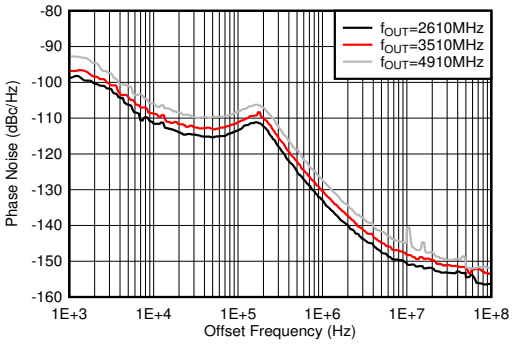
PLL enabled, f_{VCO} = 9830.4 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-582. Phase Noise for 10-GHz VCO vs Offset Frequency and Temperature at f_{OUT} = 1910 MHz



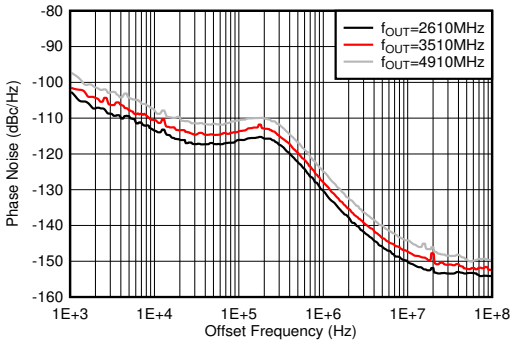
PLL enabled, f_{VCO} = 9830.4 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-583. Phase Noise for 10-GHz VCO vs Offset Frequency and f_{OUT} at 25°C



PLL enabled, f_{VCO} = 9830.4 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

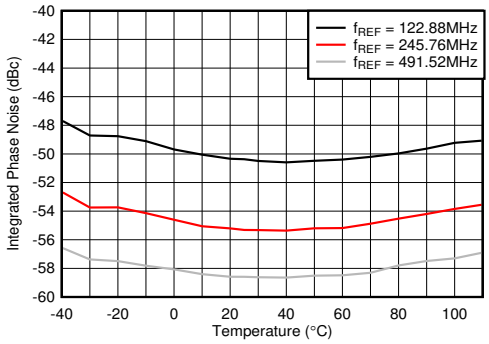
图 5-584. Phase Noise for 10-GHz VCO vs Offset Frequency and f_{OUT} at –40°C



PLL enabled, f_{VCO} = 9830.4 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

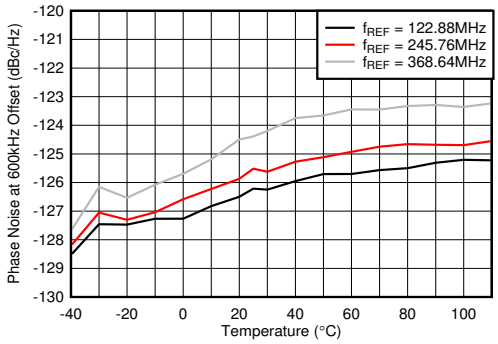
图 5-585. Phase Noise for 10-GHz VCO vs Offset Frequency and f_{OUT} at 110°C

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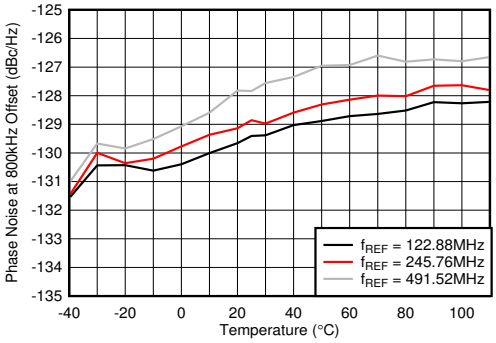
PLL enabled, f_{VCO} = 9830.4 MHz, 1-kHz to 100-MHz, single-sided integration bandwidth, measured at 2TXOUT

图 5-586. Integrated Phase Noise for 10-GHz VCO vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



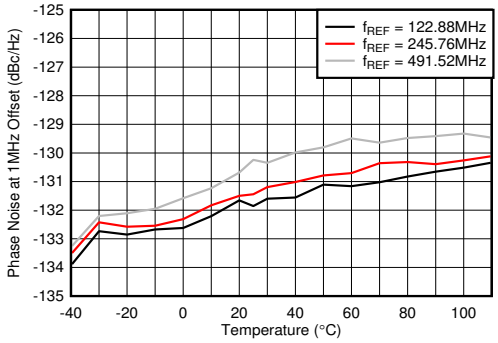
PLL enabled, f_{VCO} = 9830.4 MHz, measured at 2TXOUT

图 5-587. Phase Noise for 10-GHz VCO at 600 kHz vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



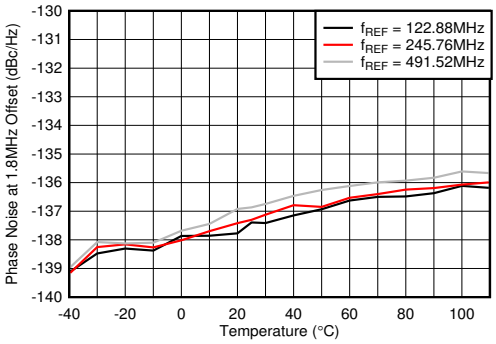
PLL enabled, f_{VCO} = 9830.4 MHz, measured at 2TXOUT

图 5-588. Phase Noise for 10-GHz VCO at 800 kHz vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



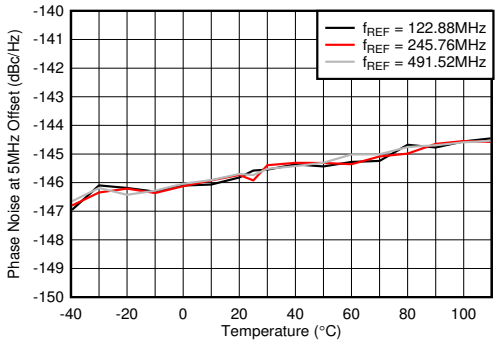
PLL enabled, f_{VCO} = 9830.4 MHz, measured at 2TXOUT

图 5-589. Phase Noise for 10-GHz VCO at 1 MHz vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



PLL enabled, f_{VCO} = 9830.4 MHz, measured at 2TXOUT

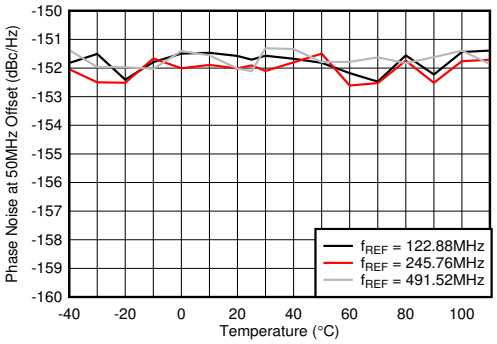
图 5-590. Phase Noise for 10-GHz VCO at 1.8 MHz vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



PLL enabled, f_{VCO} = 9830.4 MHz, measured at 2TXOUT

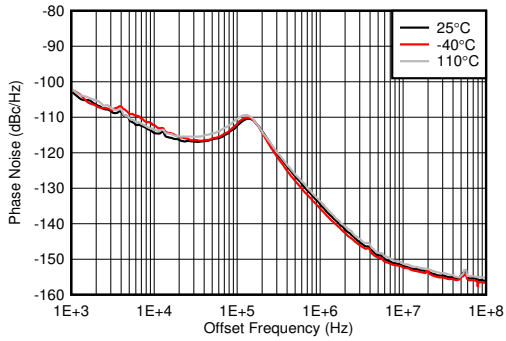
图 5-591. Phase Noise for 10-GHz VCO at 5 MHz vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz

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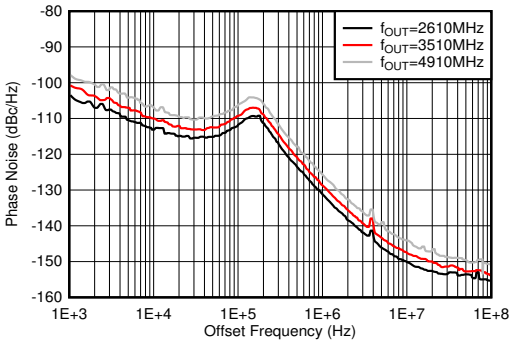
PLL enabled, f_{VCO} = 9830.4 MHz, measured at 2TXOUT

图 5-592. Phase Noise for 10-GHz VCO at 50 MHz vs Temperature and f_{REF} at f_{OUT} = 2.6 GHz



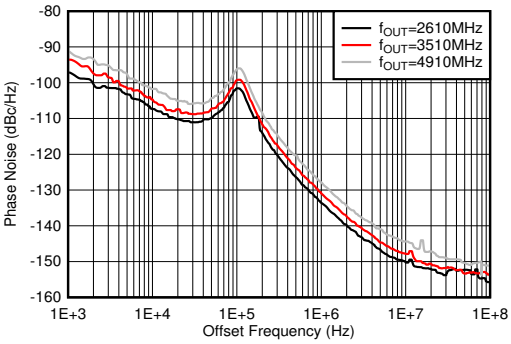
PLL enabled, f_{VCO} = 8847.36 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-593. Phase Noise for 9-GHz VCO vs Offset Frequency and Temperature at f_{OUT} = 1910 MHz



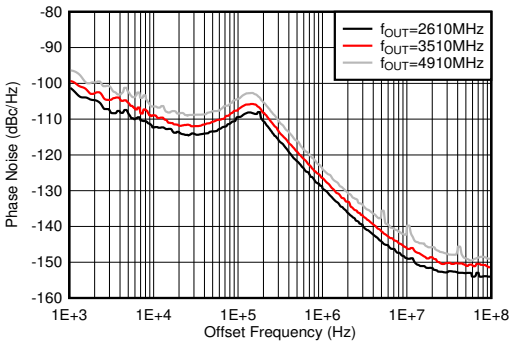
PLL enabled, f_{VCO} = 8847.36 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-594. Phase Noise for 9-GHz VCO vs Offset Frequency and f_{OUT} at 25°C



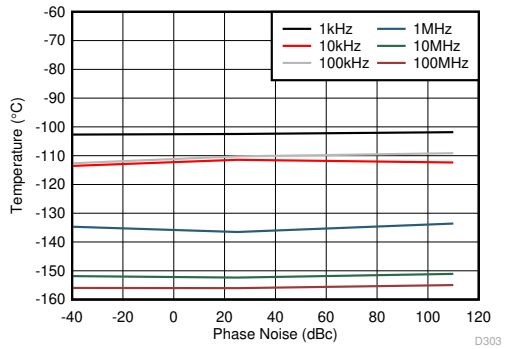
PLL enabled, f_{VCO} = 8847.36 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-595. Phase Noise for 9-GHz VCO vs Offset Frequency and f_{OUT} at –40°C



PLL enabled, f_{VCO} = 8847.36 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

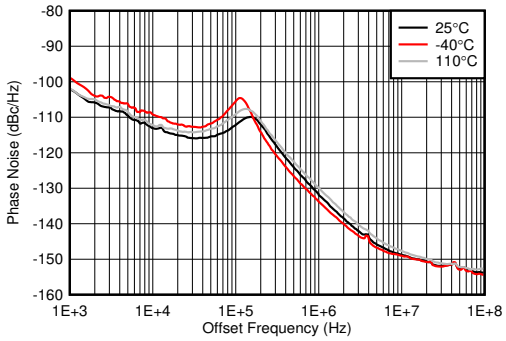
图 5-596. Phase Noise for 9-GHz VCO vs Offset Frequency and f_{OUT} at 110°C



PLL enabled, f_{VCO} = 8847.36 MHz, f_{REF} = 491.52MSPS, minimum LPF BW, measured at 2TXOUT

图 5-597. Phase Noise for 9-GHz VCO vs Temperature Over Offset Frequency at f_{OUT} = 2.6 GHz

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PLL enabled, f_{VCO} = 7864.32 MHz, f_{REF} = 491.52MSPS, measured at 2TXOUT

图 5-598. Phase Noise for 8-GHz VCO vs Offset Frequency and Temperature at f_{OUT} = 1910 MHz

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6 Device and Documentation Support

6.1 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击 *订阅更新* 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

6.2 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

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6.5 术语表

TI 术语表　　本术语表列出并解释了术语、首字母缩略词和定义。

7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
AFE7900IABJ	Active	Production	FCBGA (ABJ) | 400	90 | JEDEC TRAY (5+1)	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	AFE7900I
AFE7900IALK	Active	Production	FCBGA (ALK) | 400	90 | JEDEC TRAY (5+1)	No	SNPB	Level-3-220C-168 HR	-40 to 85	AFE7900 SNPB

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

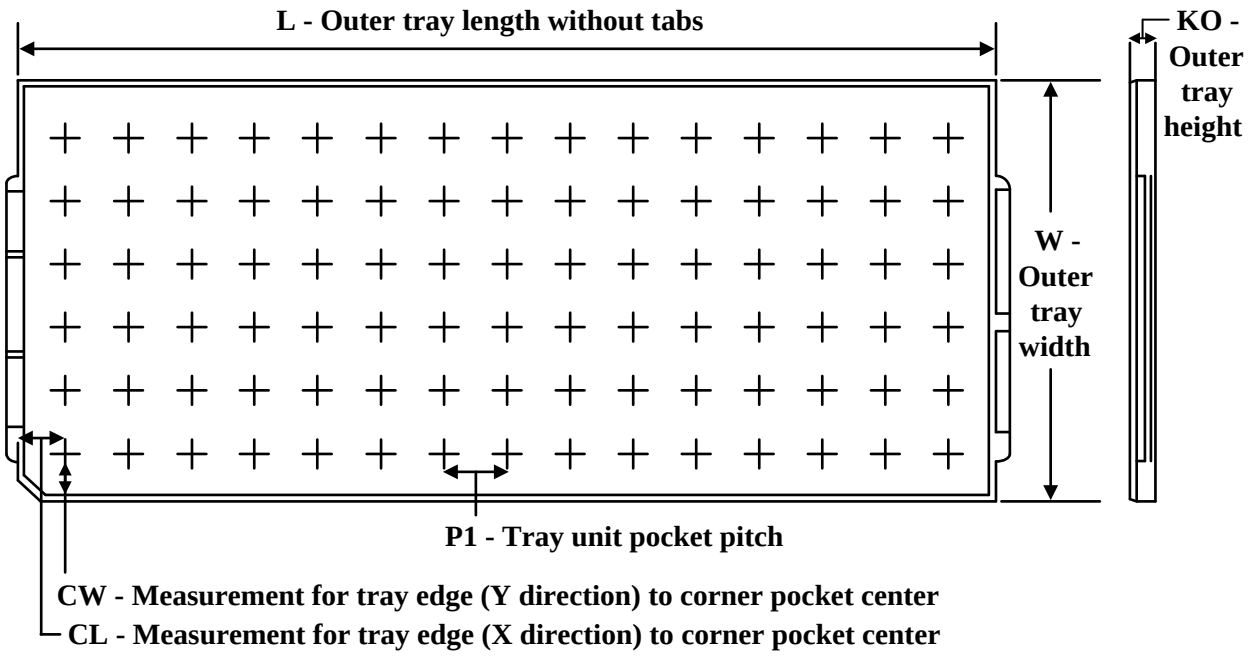
(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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TRAY



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

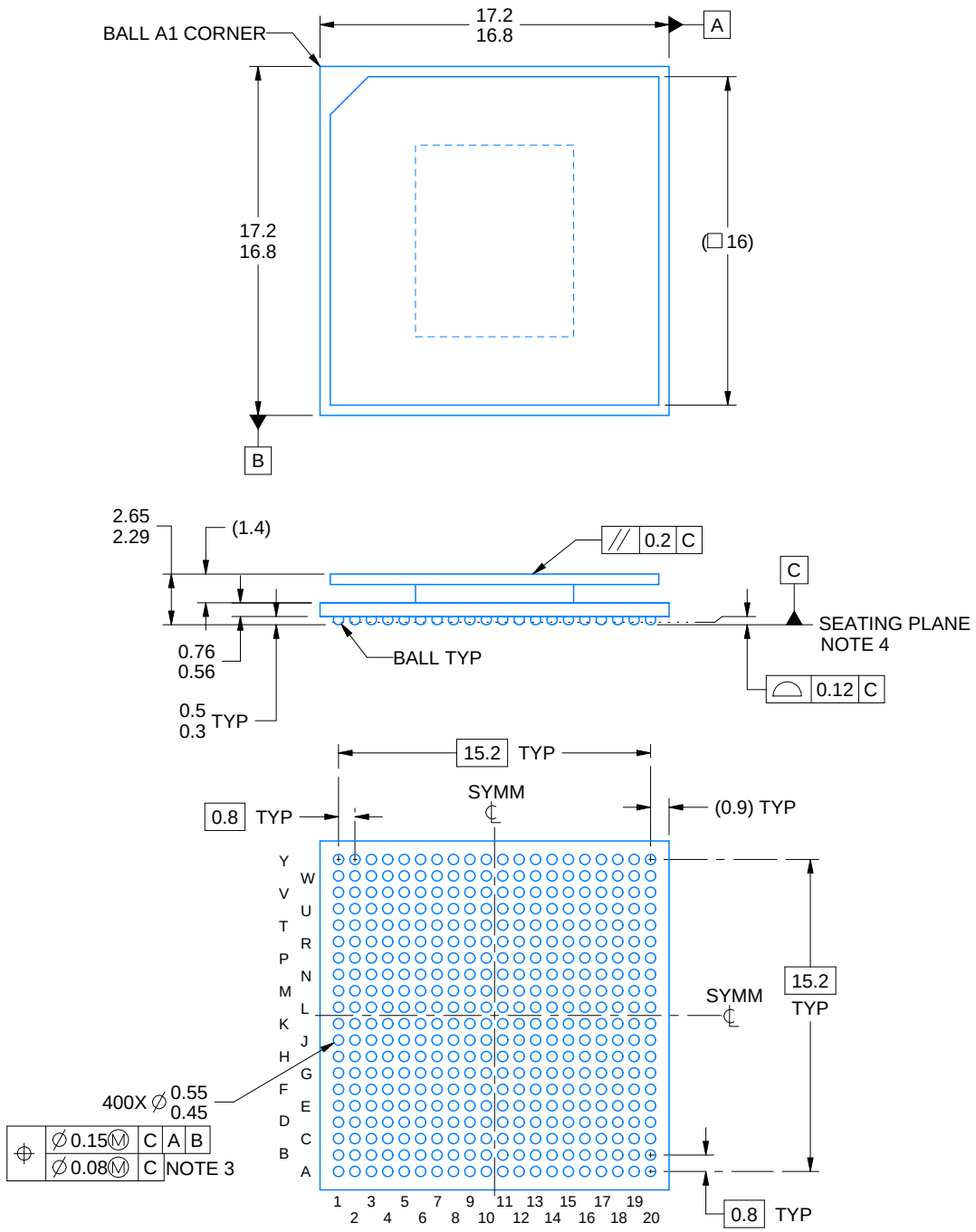
Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	K0 (µm)	P1 (mm)	CL (mm)	CW (mm)
AFE7900IABJ	ABJ	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2
AFE7900IABJ	ABJ	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2
AFE7900IALK	ALK	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2
AFE7900IALK	ALK	FCBGA	400	90	6 x 15	150	315	135.9	7620	19.5	21	19.2

PACKAGE OUTLINE

ABJ0400A

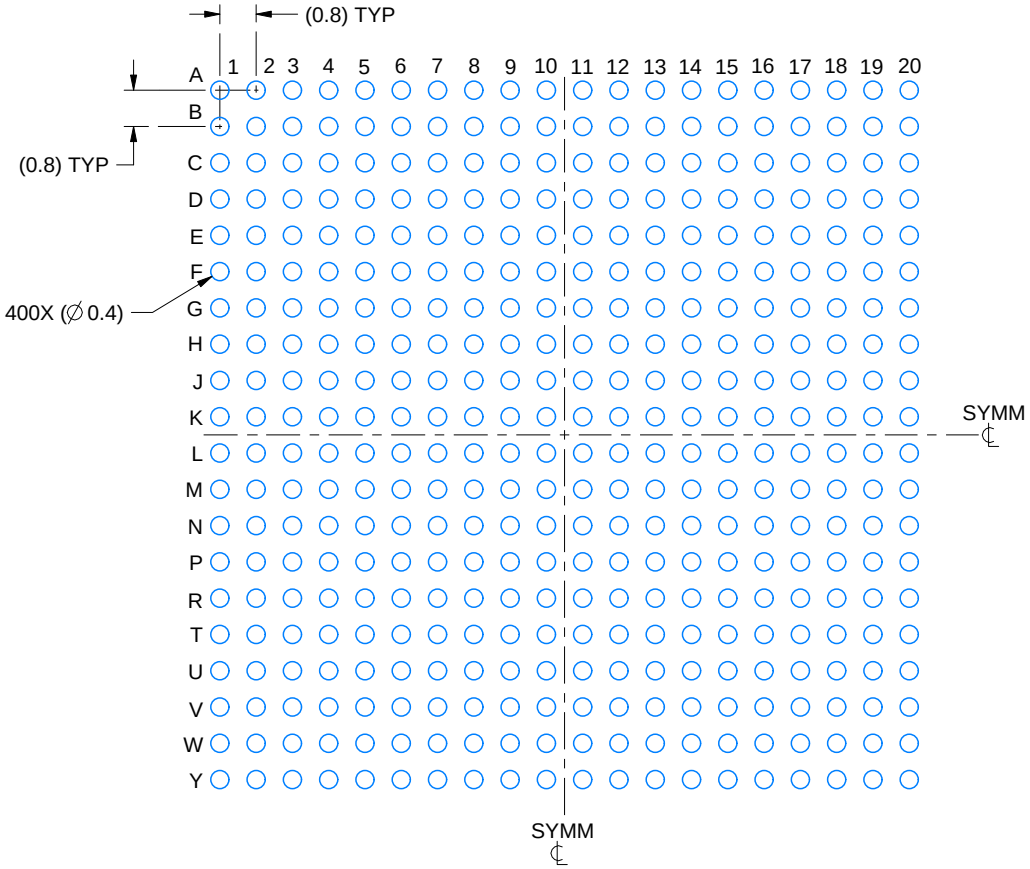
FCBGA - 2.65 mm max height

BALL GRID ARRAY

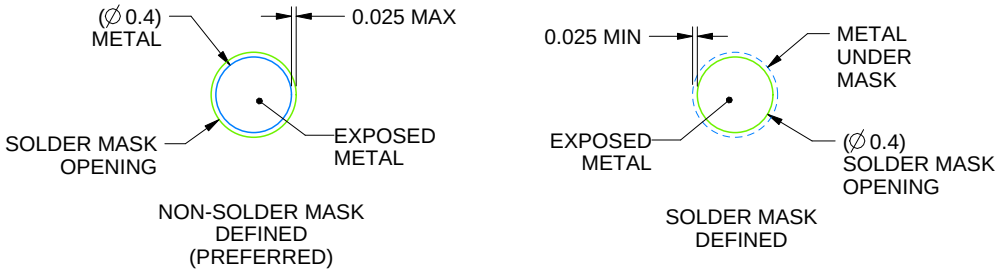


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Dimension is measured at the maximum solder ball diameter, parallel to primary datum C.
4. Primary datum C and seating plane are defined by the spherical crowns of the solder balls.
5. The lids are electrically floating (e.g. not tied to GND).



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X

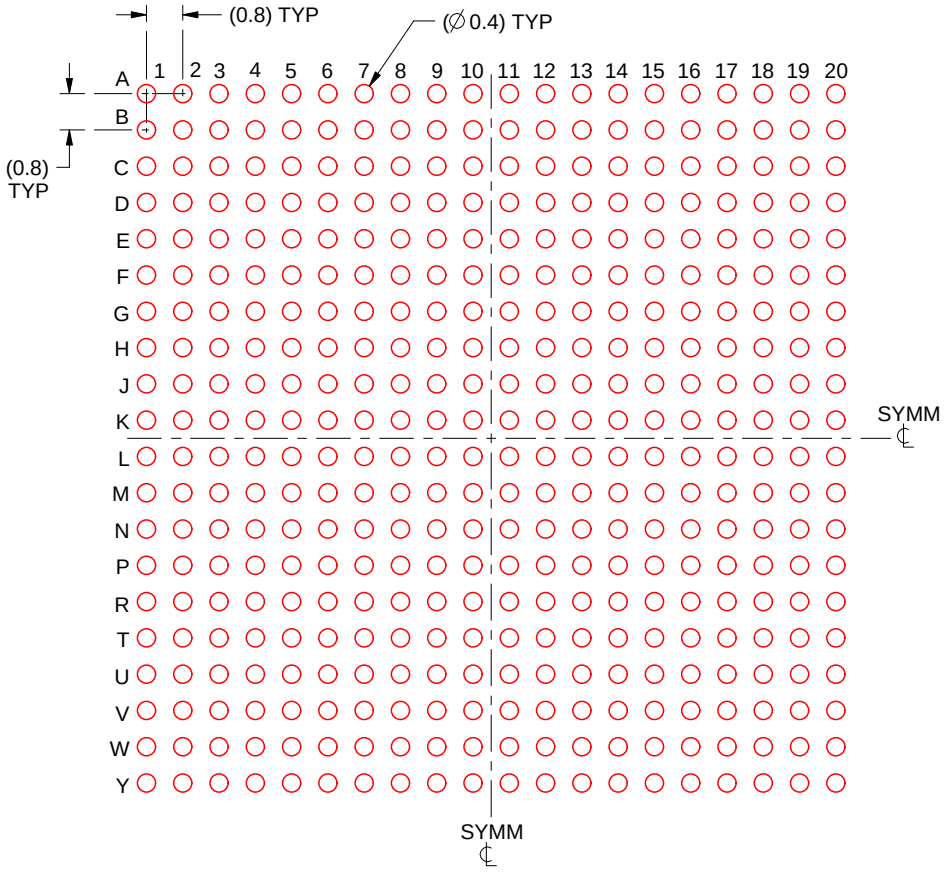


SOLDER MASK DETAILS
NOT TO SCALE

4221311/D 03/2023

NOTES: (continued)

6. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SPRU811 (www.ti.com/lit/spru811).



SOLDER PASTE EXAMPLE
BASED ON 0.15 mm THICK STENCIL
SCALE:6X

4221311/D 03/2023

NOTES: (continued)

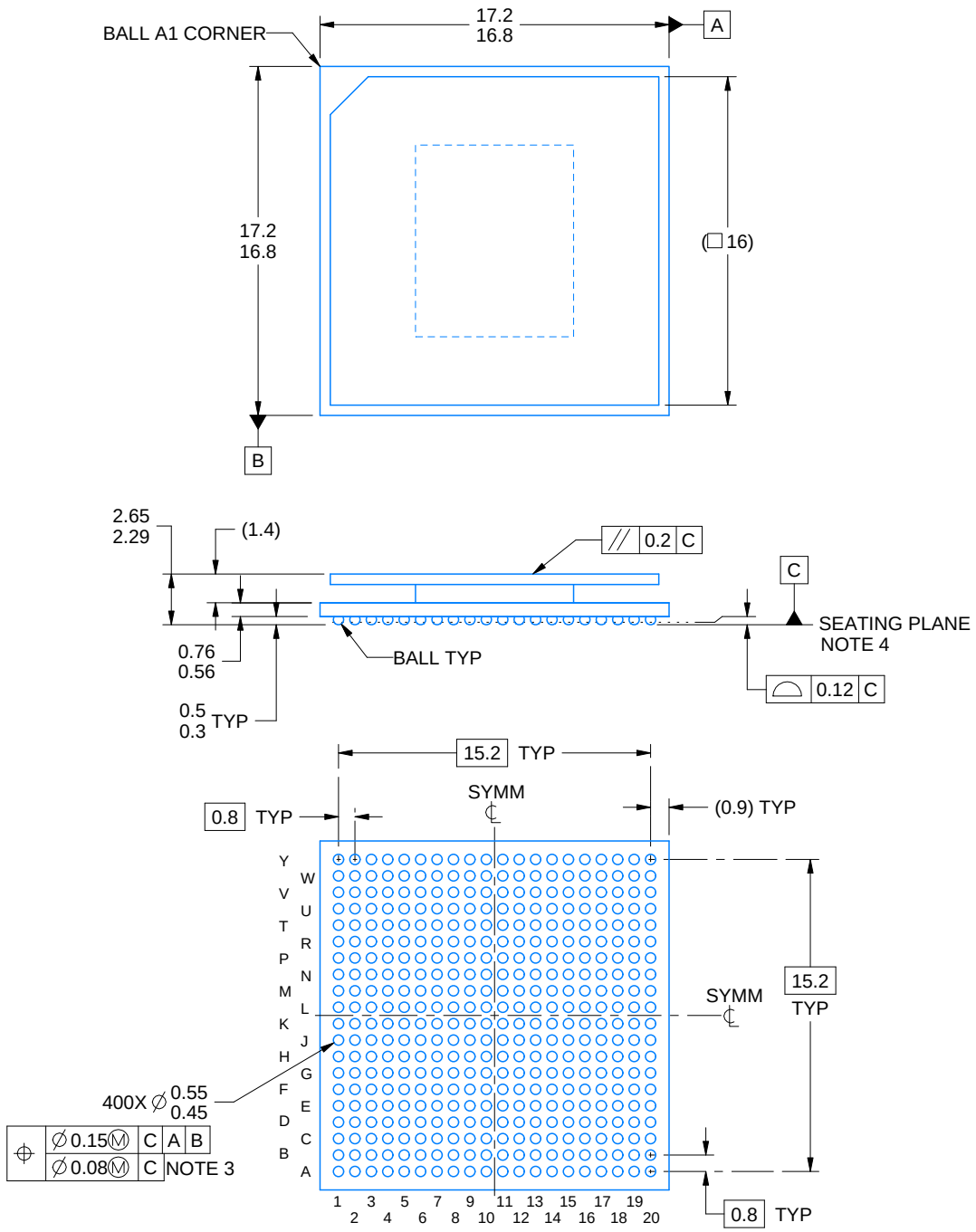
7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

ALK0400A

PACKAGE OUTLINE

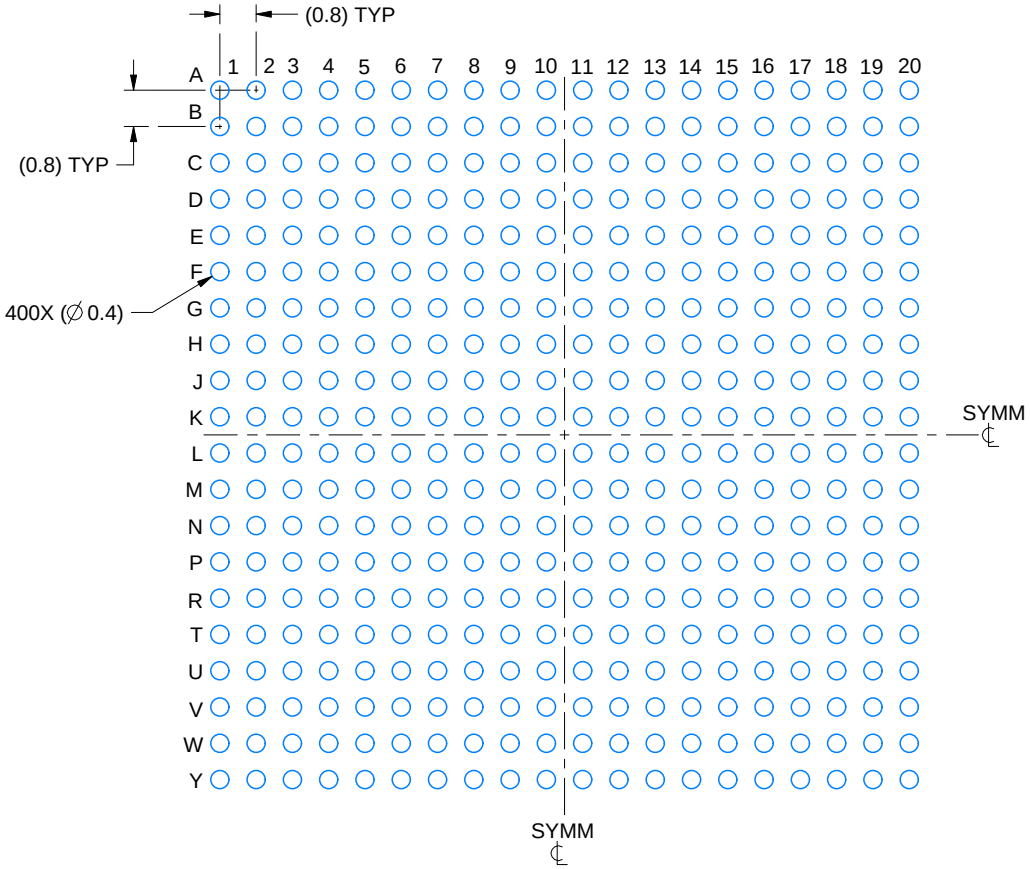
FCBGA - 2.65 mm max height

BALL GRID ARRAY

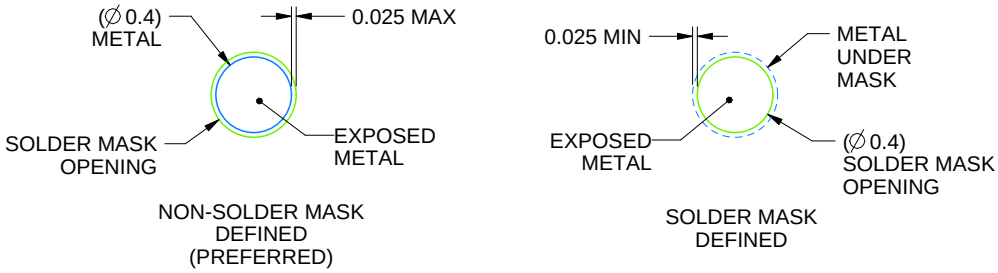


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Dimension is measured at the maximum solder ball diameter, parallel to primary datum C.
4. Primary datum C and seating plane are defined by the spherical crowns of the solder balls.
5. Pb-Free die bump and SnPb solder ball.
6. The lids are electrically floating (e.g. not tied to GND).



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X

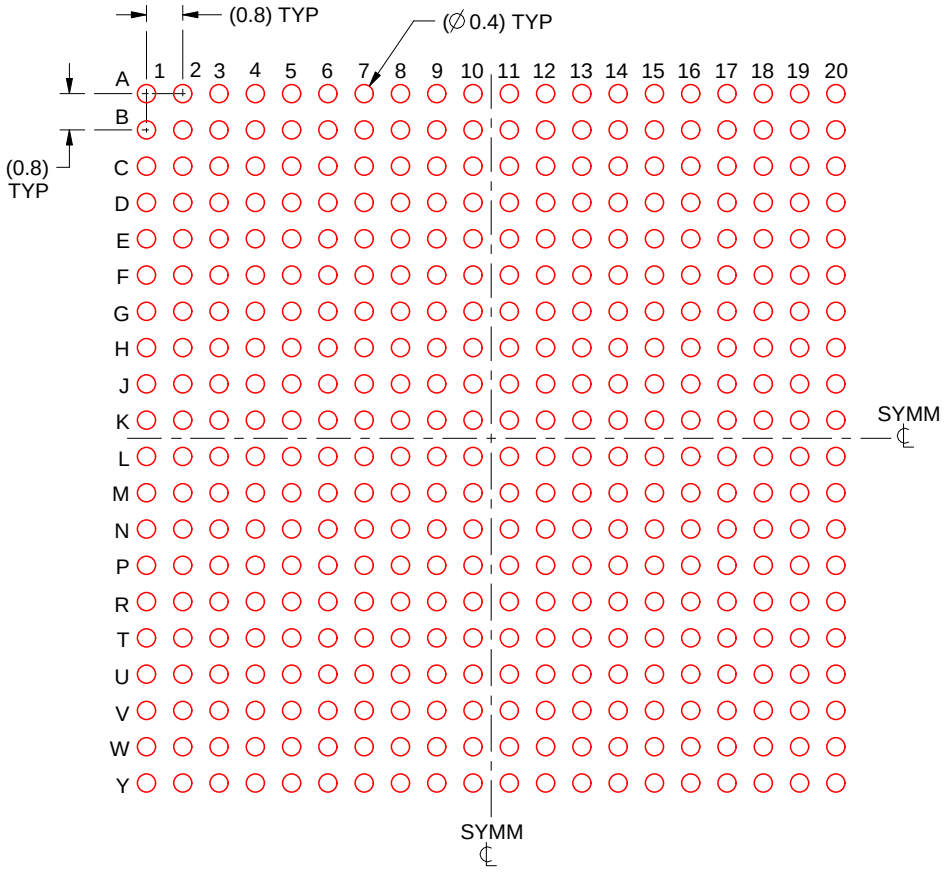


SOLDER MASK DETAILS
NOT TO SCALE

4225930/C 03/2023

NOTES: (continued)

7. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SPRU811 (www.ti.com/lit/spru811).



SOLDER PASTE EXAMPLE
BASED ON 0.15 mm THICK STENCIL
SCALE:6X

4225930/C 03/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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最后更新日期：2025 年 10 月